STM32L4Q5xx



Ultra-low-power Arm[®]Cortex[®]-M4 32-bit MCU+FPU, 150 DMIPS, 1-MB Flash memory, 320-KB SRAM, LCD-TFT, AES+PKA

Datasheet - production data

Features

Ultra-low-power with FlexPowerControl

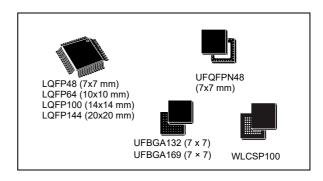
- 1.71 V to 3.6 V power supply
- -40 °C to 85/125 °C temperature range
- Batch acquisition mode (BAM)
- 150 nA in VBAT mode: supply for RTC and 32x32-bit backup registers
- 22 nA Shutdown mode (5 wakeup pins)
- 42 nA Standby mode (5 wakeup pins)
- 190 nA Standby mode with RTC
- 2.95 µA Stop 2 with RTC
- 110 µA/MHz Run mode
- 5 µs wakeup from Stop mode
- Brownout reset (BOR) in all modes except shutdown

Core

Arm[®] 32-bit Cortex[®]-M4 CPU with FPU, adaptive real-time accelerator (ART Accelerator) allowing 0-wait-state execution from Flash memory, frequency up to 120 MHz, MPU, 150 DMIPS/1.25 DMIPS/MHz (Dhrystone 2.1), and DSP instructions

Memories

- 1-Mbyte Flash memory, 2 banks read-whilewrite, proprietary code readout protection
- 320 Kbytes of SRAM including 64 Kbytes with hardware parity check
- External memory interface for static memories supporting SRAM, PSRAM, NOR, NAND and FRAM memories
- 2 x OCTOSPI memory interfaces



General-purpose inputs/outputs

 Up to 136 fast I/Os, most 5 V-tolerant, up to 14 I/Os with independent supply down to 1.08 V

Performance benchmark

- 1.25 DMIPS/MHz (Drystone 2.1)
- 409.20 Coremark[®] (3.41 Coremark/MHz @120 MHz)

Energy benchmark

• 285 ULPMark™CP score

Up to 24 capacitive sensing channels

Support touchkey, linear and rotary touch sensors

Clock management

- 4 to 48 MHz crystal oscillator
- 32 kHz crystal oscillator for RTC (LSE)
- Internal 16 MHz factory-trimmed RC (±1%)
- Internal low-power 32 kHz RC (±5%)
- Internal multispeed 100 kHz to 48 MHz oscillator, auto-trimmed by LSE (better than ±0.25 % accuracy)
- Internal 48 MHz with clock recovery
- 3 PLLs for system clock, USB, audio, ADC

Interconnect matrix

1 AHB bus matrix

14-channel DMA controller

23 communication peripherals

- USB OTG 2.0 full-speed, LPM and BCD
- 2x SAIs (serial audio interface)
- 4x I2C FM+(1 Mbit/s), SMBus/PMBus
- 6x USARTs (ISO 7816, LIN, IrDA, modem)
- 3x SPIs (5x SPIs with the dual OCTOSPI)
- CAN (2.0B Active) and 2x SDMMC
- 8- to 14-bit camera interface up to 32 MHz (black and white) or 10 MHz (color)
- 8-/16-bit parallel synchronous data input/output slave interface (PSSI)

11 analog peripherals (independent supply)

- 2x 12-bit ADC 5 Msps, up to 16-bit with hardware oversampling, 200 μA/Msps
- 2x 12-bit DAC, low-power sample and hold
- · 2x operational amplifiers with built-in PGA
- 2x ultra-low-power comparators
- · 2x digital filters for sigma delta modulator
- 1x temperature sensor

Advanced graphics features

 Chrom-ART Accelerator (DMA2D) for enhanced graphic content creation LCD-TFT controller

16x timers and watchdog

- 2 x 16-bit advanced motor-control
- 2 x 32-bit general purpose timers
- 5 x 16-bit general purpose timers
- 2x 16-bit basic timers
- 2x low-power 16-bit timers (available in Stop mode)
- 2x watchdogs
- 1x SysTick timer
- RTC with HW calendar, alarms and calibration

Cryptographic acceleration

- AES (128/256-bit key)
- Public key accelerator (PKA)

True random generator

CRC calculation unit

HASH (SHA-256) hardware accelerator

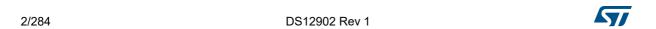
Debug mode

- Serial wire debug (SWD)
- JTAG
- Embedded Trace Macrocell (ETM)

96-bit unique ID

Table 1. Device summary

| Reference | Part numbers |
|-------------|--|
| STM32L4Q5xx | STM32L4Q5AG, STM32L4Q5CG, STM32L4Q5QG, STM32L4Q5RG, STM32L4Q5VG, STM32L4Q5ZG |



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Introduction STM32L4Q5xx

1 Introduction

This document provides the ordering information and mechanical device characteristics of the STM32L4Q5xx microcontrollers.

This document should be read in conjunction with the STM32L4Q5xx reference manual (RM0432). The reference manual is available from the STMicroelectronics website www.st.com.

For information on the Arm^{®(a)} Cortex[®]-M4 core, refer to the Cortex[®]-M4 Technical Reference Manual, available from the www.arm.com website.







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STM32L4Q5xx Description

2 Description

STM32L4Q5xx designates a family of ultra-low-power microcontroller devices (part of STM32L4+ Series) based on the high-performance Arm[®] Cortex[®]-M4 32-bit RISC core. They operate at a frequency of up to 120 MHz.

The Cortex-M4 core features a single-precision floating-point unit (FPU), which supports all the Arm[®] single-precision data-processing instructions and all the data types. The Cortex-M4 core also implements a full set of DSP (digital signal processing) instructions and a memory protection unit (MPU) that enhances the application's security.

These devices embed high-speed memories (1 Mbyte of Flash memory and 320 Kbytes of SRAM), a flexible external memory controller (FSMC) for static memories (for devices with packages of 100 pins and more), two OCTOSPI Flash memory interfaces (for devices with packages of 100 pins or more) and an extensive range of enhanced I/Os and peripherals connected to two APB buses, two AHB buses and a 32-bit multi-AHB bus matrix.

These devices embed several protection mechanisms for embedded Flash memory and SRAM: readout protection, write protection, proprietary code readout protection and a firewall.

These devices offer two fast 12-bit ADCs (5 Msps), two comparators, two operational amplifiers, two DAC channels, an internal voltage reference buffer, a low-power RTC, two general-purpose 32-bit timers, two 16-bit PWM timers dedicated to motor control, seven general-purpose 16-bit timers, and two 16-bit low-power timers. The devices support two digital filters for external sigma delta modulators (DFSDMs). In addition, up to 24 capacitive sensing channels are available.

They also feature standard and advanced communication interfaces such as:

- Four I2Cs
- Three SPIs
- Three USARTs, two UARTs and one low-power UART
- Two SAIs
- Two SDMMCs
- One CAN
- One USB OTG full-speed
- Camera interface
- Synchronous parallel data interface (PSSI)

STM32L4Q5xx devices embed an AES and a PKA hardware accelerator.

The devices operate in the -40 to +85 $^{\circ}$ C (+105 $^{\circ}$ C junction) and -40 to +125 $^{\circ}$ C (+130 $^{\circ}$ C junction) temperature ranges from a 1.71 to 3.6 V power supply. A comprehensive set of power-saving modes allows the design of low-power applications.

Some independent power supplies are supported such as an analog independent supply input for ADC, DAC, OPAMPs and comparators, a 3.3 V dedicated supply input for USB and up to 14 I/Os, which can be supplied independently down to 1.08 V. A VBAT input allows backup of the RTC and the registers.

The STM32L4Q5xx family offers eight packages from 48-pin to 169-pin.



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Description STM32L4Q5xx

Table 2. STM32L4Q5xx features and peripheral counts

| Peripheral | | STM32L4 Q5CG (48 pins) | STM32L4 Q5RG (64 pins) | STM32L4 Q5VG (100 pins) | STM32L4 Q5QG (132 pins) | STM32L4 Q5ZG (144 pins) | STM32L4 Q5AG (169 pins) |
|--------------------------------------|--|------------------------------|------------------------------|-------------------------------|-------------------------------|-------------------------------|-------------------------------|
| Flash mem | nory | | | 1 M | byte | | |
| SRAM | System | | | 320 (128 + 64 | + 128) Kbytes | | |
| SIVAIVI | Backup | | | 128 | oytes | | |
| External m for static m (FSMC) | emory controller nemories | N | No Yes ⁽¹⁾ Yes | | | | |
| OCTOSPI | | | 2 ⁽²⁾ | | | 2 | |
| | Advanced control | | | 2 (16 | 6-bit) | | |
| | General purpose | | | 5 (16 2 (32 | 6-bit) 2-bit) | | |
| | Basic | | | 2 (16 | 6-bit) | | |
| Timers | Low-power | | | 2 (16 | 6-bit) | | |
| | SysTick timer | | | , | 1 | | |
| | Watchdog timers (independent, window) | 2 | | | | | |
| | SPI | 3 | | | | | |
| | I ² C | 4 | | | | | |
| Comm. | USART/UART UART LPUART | 3 2 ⁽³⁾ 1 | | | | | |
| interfaces | SAI | 2 | | | | | |
| | CAN | 1 | | | | | |
| | USB OTG FS | Yes | | | | | |
| | SDMMC | 2 ⁽⁴⁾ | | | | | |
| delta modu | | Yes (2 filters) | | | | | |
| Number of | channels | 4 | | | | | |
| Real time of | clock (RTC) | Yes | | | | | |
| Tamper pir | | 3 | | | | | |
| Camera int | terface | Yes ⁽⁵⁾ | | | | | |
| PSSI | | Yes ⁽⁶⁾ | | | | | |
| Chrom-ART Accelerator | | Yes | | | | | |
| LTDC | | Yes ⁽⁷⁾ Yes | | | | | |
| True rando generator | m number | Yes | | | | | |

STM32L4Q5xx Description

Table 2. STM32L4Q5xx features and peripheral counts (continued)

| Peripheral | STM32L4 Q5CG (48 pins) | STM32L4 Q5RG (64 pins) | STM32L4 Q5VG (100 pins) | STM32L4 Q5QG (132 pins) | STM32L4 Q5ZG (144 pins) | STM32L4 Q5AG (169 pins) |
|--|------------------------------|------------------------------|-------------------------------|-------------------------------|-------------------------------|-------------------------------|
| AES | | | Ye | es | | |
| HASH (SHA-256) | | | Ye | es | | |
| Public key accelerator (PKA) | | | Ye | es | | |
| GPIOs Wakeup pins Nb of I/Os down to 1.08 V | 38 3 0 | 52 4 0 | 83 ⁽⁸⁾ 5 0 | 110 5 14 | 115 5 14 | 136 5 14 |
| Capacitive sensing Number of channels 9 21 | | | 24 | | | |
| 12-bit ADCs | 2 | | | | | |
| Number of channels | 10 | 16 | 16 | 16 | 16 | 16 |
| 12-bit DAC Number of channels | 2 2 | | | | | |
| Internal voltage reference buffer | Yes | | | | | |
| Analog comparator | 2 | | | | | |
| Operational amplifiers | 2 | | | | | |
| Max. CPU frequency | lax. CPU frequency 120 MHz | | | | | |
| Operating voltage (V _{DD}) | D) 1.71 to 3.6 V | | | | | |
| Operating temperature Ambient operating temperature: -40 to 85 °C / -40 to 125 | | | :/-40 to 125 °C | С | | |
| Packages | UFQFPN48/ LQFP48 | LQFP64 | LQFP100/ WLCSP100 | UFBGA132 | LQFP144 | UFBGA169 |

For the LQFP100 package, only FMC bank1 and NAND bank are available. Bank1 can only support a multiplexed NOR/PSRAM memory using the NE1 chip select.

- 5. DCMI is available on devices with packages starting from 64-pin.
- 6. PSSI is available on devices with packages starting from 100-pin.
- 7. For 48-pin and 64-pin packages, only RGB222 parallel output is supported.
- 8. 81 GPIOs available for WLCSP100 package.

^{2.} When multiplexed mode is enabled two OCTOSPIs are available, otherwise only one OCTOSPI is available, for further details on multiplexed mode refer to the RM0432 reference manual.

^{3.} For 48-pin and 64-pin packages only 1x UART is available.

^{4.} For 48 pins packages only one SDMMC2 with SDIO 4-bits is available. SDMMC1 and SDMMC2 are available for packages starting from 64 pins.

Description STM32L4Q5xx

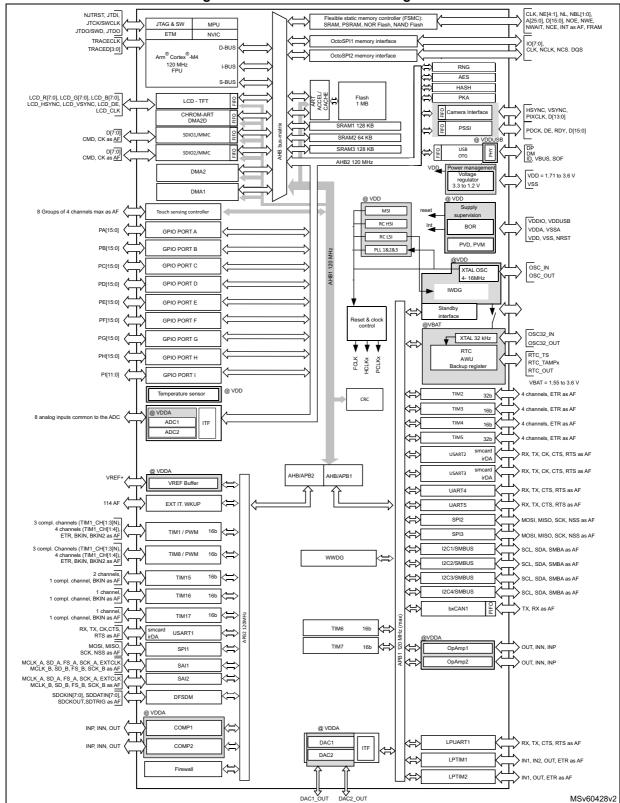


Figure 1. STM32L4Q5xx block diagram

Note: AF: alternate function on I/O pins.



3 Functional overview

3.1 Arm[®] Cortex[®]-M4 core with FPU

The Arm[®] Cortex[®]-M4 with FPU processor is the latest generation of Arm[®] processors for embedded systems. It was developed to provide a low-cost platform that meets the needs of the MCU implementation, with a reduced pin count and with low-power consumption, while delivering outstanding computational performance and an advanced response to interrupts.

The Arm[®] Cortex[®]-M4 with FPU 32-bit RISC processor features an exceptional code-efficiency, delivering the expected high-performance from an Arm[®] core in a memory size usually associated with 8-bit and 16-bit devices.

The processor supports a set of DSP instructions which allows an efficient signal processing and a complex algorithm execution. Its single precision FPU speeds up the software development by using metalanguage development tools to avoid saturation.

With its embedded Arm[®] core, the family is compatible with all Arm[®] tools and software.

Figure 1 shows the general block diagram of the family devices.

3.2 Adaptive real-time memory accelerator (ART Accelerator)

The ART Accelerator is a memory accelerator that is optimized for the STM32 industry-standard Arm[®]Cortex[®]-M4 processors. It balances the inherent performance advantage of the Arm[®] Cortex[®]-M4 over Flash memory technologies, which normally requires the processor to wait for the Flash memory at higher frequencies.

To release the processor near 150 DMIPS performance at 120 MHz, the accelerator implements an instruction prefetch queue and a branch cache, which increases the program's execution speed from the Flash memory. Based on CoreMark benchmark, the performance achieved thanks to the ART accelerator is equivalent to 0 wait state program execution from the Flash memory at a CPU frequency of up to 120 MHz.

3.3 Memory protection unit (MPU)

The memory protection unit (MPU) is used to manage the CPU accesses to the memory and to prevent one task to accidentally corrupt the memory or the resources used by any other active task. This memory area is organized into up to eight protected areas, which can be divided in up into eight subareas each. The protection area sizes range between 32 bytes and the whole 4 gigabytes of addressable memory.

The MPU is especially helpful for applications where some critical or certified code has to be protected against the misbehavior of other tasks. It is usually managed by an RTOS (real-time operating system). If a program accesses a memory location that is prohibited by the MPU, the RTOS can detect it and take action. In an RTOS environment, the kernel can dynamically update the MPU area setting based on the process to be executed.

The MPU is optional and can be bypassed for applications that do not need it.

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3.4 Memories

3.4.1 Embedded Flash memory

The devices feature 1 Mbyte of embedded Flash memory which is available for storing programs and data.

The Flash interface features:

- Single or dual bank operating modes
- Read-while-write (RWW) in dual bank mode

This feature allows to perform a read operation from one bank while an erase or program operation is performed to the other bank. The dual-bank boot is also supported. Each bank contains 128 pages of 4 Kbytes. In Single-bank mode the main Flash memory contains 128 pages of 8 Kbytes.

Flexible protections can be configured thanks to the option bytes:

- Readout protection (RDP) to protect the whole memory. Three levels of protection are available:
 - Level 0: no readout protection
 - Level 1: memory readout protection; the Flash memory cannot be read from or written to if either the debug features are connected or the boot in RAM or bootloader are selected
 - Level 2: chip readout protection; the debug features (Cortex-M4 JTAG and serial wire), the boot in RAM and the bootloader selection are disabled (JTAG fuse). This selection is irreversible.

Debug, boot from RAM or boot **User execution Protection** from system memory (loader) Area level Write Write Read **Erase** Read **Erase** 1 Yes Yes Yes No No No Main memory 2 Yes Yes Yes N/A N/A N/A 1 Yes No No Yes No No System memory 2 Yes Nο Nο N/A N/A N/A 1 Yes Yes Yes Yes Yes Yes Option bytes 2 Yes N/A N/A N/A No No 1 Yes $N/A^{(1)}$ $N/A^{(1)}$ Yes No No Backup registers 2 Yes N/A N/A N/A N/A Yes $No^{(1)}$ Yes⁽¹⁾ 1 Yes Yes No No SRAM2 2 Yes N/A N/A N/A Yes Yes Yes⁽¹⁾ $No^{(1)}$ 1 Yes Yes No No PKA RAM 2 Yes Yes N/A N/A N/A

Table 3. Access status versus readout protection level and execution modes

- Write protection (WRP): the protected area is protected against erasing and programming:
 - In single bank mode, four areas can be selected with 8-Kbyte granularity.
 - In dual bank mode, two areas per bank can be selected with 4-Kbyte granularity.
- Proprietary code readout protection (PCROP): a part of the Flash memory can be
 protected against read and write from third parties. The protected area is execute-only
 and it can only be reached by the STM32 CPU as an instruction code, while all other
 accesses (DMA, debug and CPU data read, write and erase) are strictly prohibited:
 - In single bank mode, two areas can be selected with 128-bit granularity.
 - In dual bank mode, one area per bank can be selected with 64-bit granularity.

An additional option bit (PCROP_RDP) allows to select if the PCROP area is erased or not when the RDP protection is changed from Level 1 to Level 0.

The whole non-volatile memory embeds the error correction code (ECC) feature supporting:

- Single error detection and correction
- Double error detection
- The address of the ECC fail can be read in the ECC register.

3.4.2 Embedded SRAM

The devices feature 320 Kbytes of embedded SRAM. This SRAM is split into three blocks:

- 128 Kbytes mapped at address 0x2000 0000 (SRAM1).
- 64 Kbytes located at address 0x1000 0000 with hardware parity check (SRAM2).
 This memory is also mapped at address 0x2002 0000 offering a contiguous address space with the SRAM1.



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^{1.} Erased when RDP change from Level 1 to Level 0.

This block is accessed through the ICode/DCode buses for maximum performance. Either 64 Kbytes or 4 Kbytes of SRAM2 can be retained in Standby mode. The SRAM2 can be write-protected with 1 Kbyte granularity.

128 Kbytes mapped at address 0x2003 0000 (SRAM3).

The memory can be accessed in read/write at CPU clock speed with 0 wait states.

3.5 Boot modes

At startup, a BOOT0 pin and an nBOOT1 option bit are used to select one of three boot options:

- Boot from user Flash
- Boot from system memory
- Boot from embedded SRAM

The BOOT0 value may come from the PH3-BOOT0 pin or from an option bit depending on the value of a user option bit to free the GPIO pad if needed.

A Flash empty-check mechanism is implemented to force the boot from system Flash if the first Flash memory location is not programmed and if the boot selection is configured to boot from main Flash.

The boot loader is located in the system memory. It is used to reprogram the Flash memory by using USART, I2C, SPI, CAN or USB OTG FS in device mode through the DFU (device firmware upgrade).

3.6 Firewall

These devices embed a firewall which protects code sensitive and secure data from any access performed by a code executed outside of the protected areas.

Each illegal access generates a reset which kills immediately the detected intrusion.

The main features of the firewall are the following:

- Three segments can be protected and defined thanks to the firewall registers:
 - Code segment (located in Flash or SRAM1 if defined as executable protected area)
 - Non-volatile data segment (located in Flash)
 - Volatile data segment (located in SRAM1)
- The start address and the length of each segment are configurable:
 - Code segment: up to 1024 Kbytes with granularity of 256 bytes
 - Non-volatile data segment: up to 1024 Kbytes with granularity of 256 bytes
 - Volatile data segment: up to 128 Kbytes of SRAM1 with a granularity of 64 bytes
- Specific mechanism implemented to open the firewall to get access to the protected areas (call gate entry sequence)
- Volatile data segment can be shared or not with the non-protected code
- Volatile data segment can be executed or not depending on the firewall configuration

The Flash readout protection must be set to level 2 in order to reach the expected level of protection.



3.7 Power supply management

3.7.1 Power supply schemes

The STM32L4Q5xx devices require a 1.71 V to 3.6 V V_{DD} operating voltage supply. Several independent supplies can be provided for specific peripherals:

V_{DD} = 1.71 V to 3.6 V

 V_{DD} is the external power supply for the I/Os, the internal regulator and the system analog such as reset, power management and internal clocks. It is provided externally through the VDD pins.

- V_{DDA} = 1.62 V (ADCs/COMPs) / 1.8 V (DACs/OPAMPs) to 2.4 V (VREFBUF) to 3.6 V V_{DDA} is the external analog power supply for A/D converters, D/A converters, voltage reference buffer, operational amplifiers and comparators. The V_{DDA} voltage level is independent from the V_{DD} voltage and should preferably be connected to V_{DD} when these peripherals are not used.
- VDDUSB = 3.0 V to 3.6 V
 VDDUSB is the external independent power supply for USB transceivers. The
 VDDUSB voltage level is independent from the VDD voltage and should preferably be connected to VDD when the USB is not used.
- VDDIO2 = 1.08 V to 3.6 V
- VDDIO2 is the external power supply for 14 I/Os (port G[15:2]). The VDDIO2 voltage level is independent from the VDD voltage and should preferably be connected to VDD when PG[15:2] are not used.
- V_{BAT} = 1.55 V to 3.6 V

 V_{BAT} is the power supply for RTC, external clock 32 kHz oscillator and backup registers (through power switch) when V_{DD} is not present.

VREF-, VREF+

V_{REF+} is the input reference voltage for ADCs and DACs. It is also the output of the internal voltage reference buffer when enabled.

When V_{DDA} < 2 V V_{REF+} must be equal to V_{DDA} .

When V_{DDA} ≥ 2 V V_{REF+} must be between 2 V and V_{DDA}.

V_{RFF+} can be grounded when ADC and DAC are not active.

The internal voltage reference buffer supports two output voltages, which are configured with VRS bit in the VREFBUF_CSR register:

- V_{REF+} around 2.048 V. This requires V_{DDA} equal to or higher than 2.4 V.
- V_{REF+} around 2.5 V. This requires V_{DDA} equal to or higher than 2.8 V.

VREF- and VREF+ pins are not available on all packages. When not available, they are bonded to VSSA and VDDA, respectively.

When the VREF+ is double-bonded with VDDA in a package, the internal voltage reference buffer is not available and must be kept disable (refer to datasheet for packages pinout description).

 V_{RFF} must always be equal to V_{SSA} .

An embedded linear voltage-regulator is used to supply the internal digital power V_{CORE} . V_{CORE} is the power supply for digital peripherals, SRAM1, SRAM2 and SRAM3. The Flash is supplied by V_{CORE} and V_{DD} .



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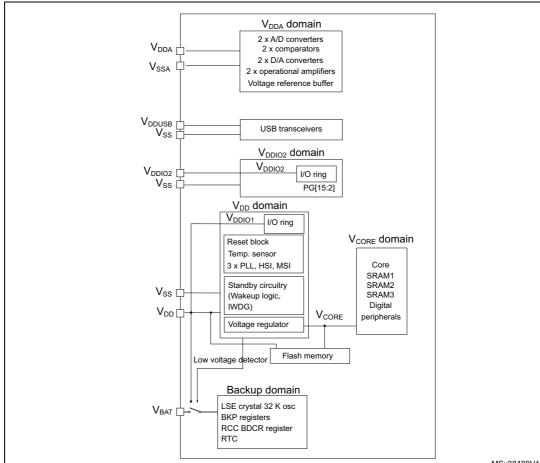


Figure 2. STM32L4Q5xx power supply overview

During power-up and power-down phases, the following power sequence requirements must be respected:

- When V_{DD} is below 1 V, other power supplies (V_{DDA}, V_{DDIO2} and V_{DDUSB}) must remain below VDD +300 mV.
- When V_{DD} is above 1 V, all power supplies are independent.
- During the power-down phase, V_{DD} can temporarily become lower than other supplies only if the energy provided to the MCU remains below 1 mJ; this allows external decoupling capacitors to be discharged with different time constants during the powerdown transient phase.

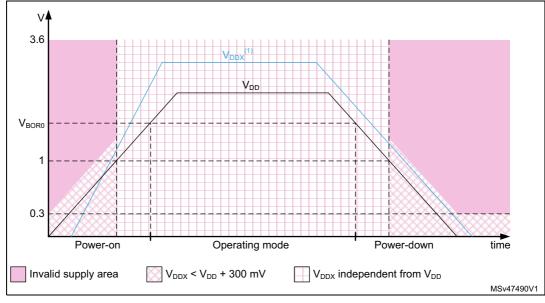


Figure 3. Power-up/down sequence

1. V_{DDX} refers to any power supply among V_{DDA} , V_{DDIO2} and V_{DDUSB} .

3.7.2 Power supply supervisor

The STM32L4Q5xx devices have an integrated ultra-low-power Brownout reset (BOR) active in all modes (except for Shutdown mode). The BOR ensures proper operation of the devices after power-on and during power-down. The devices remain in reset mode when the monitored supply voltage V_{DD} is below a specified threshold, without the need for an external reset circuit.

The lowest BOR level is 1.71 V at power on, and other higher thresholds can be selected through option bytes. The devices feature an embedded programmable voltage detector (PVD) that monitors the V_{DD} power supply and compares it to the VPVD threshold.

An interrupt can be generated when V_{DD} drops below the VPVD threshold and/or when V_{DD} is higher than the VPVD threshold. The interrupt service routine can then generate a warning message and/or put the MCU into a safe state. The PVD is enabled by software.

In addition, the devices embed a peripheral voltage monitor which compares the independent supply voltages V_{DDA}, V_{DDUSB}, V_{DDIO2} with a fixed threshold in order to ensure that the peripheral is in its functional supply range.

3.7.3 Voltage regulator

Two embedded linear voltage regulators supply most of the digital circuitries: the main regulator (MR) and the low-power regulator (LPR).

- The MR is used in the Run and Sleep modes and in the Stop 0 mode.
- The LPR is used in Low-power run, Low-power sleep, Stop 1 and Stop 2 modes. It is also used to supply the 64 Kbytes SRAM2 in standby with RAM2 retention.
- Both regulators are in power-down while they are in standby and Shutdown modes: the regulator output is in high impedance, and the kernel circuitry is powered down thus inducing zero consumption.



The ultra-low-power devices support dynamic voltage scaling to optimize its power consumption in Run mode. The voltage from the main regulator that supplies the logic (VCORE) can be adjusted according to the system's maximum operating frequency.

The main regulator operates in the following ranges:

- Range 1 boost mode with the CPU running at up to 120 MHz.
- Range 1 normal mode with the CPU running at up to 80 MHz.
- Range 2 with a maximum CPU frequency of 26 MHz. All peripheral clocks are also limited to 26 MHz.

The VCORE can be supplied by the low-power regulator, the main regulator being switched off. The system is then in Low-power run mode.

• Low-power run mode with the CPU running at up to 2 MHz. Peripherals with independent clock can be clocked by the HSI16.

Note: The USB can only be used when the main regulator is in Range 1 boost mode.



3.7.4 Low-power modes

The ultra-low-power devices support seven low-power modes to achieve the best compromise between low-power consumption, short startup time, available peripherals and available wake-up sources. The table below shows the related STM32L4Q5xx modes overview.

Table 4. STM32L4Q5xx modes overview

| Mode | Regulator ⁽¹⁾ | CPU | Flash | SRAM | Clocks | DMA and Peripherals ⁽²⁾ | Wakeup source |
|---------|--------------------------|-----|-------------------|-------------------|--|--|---|
| | Range 1 | | | | | All | |
| Run | Range2 | Yes | ON ⁽³⁾ | ON | Any | All except OTG_FS, RNG, LCD-TFT | N/A |
| LPRun | LPR | Yes | ON ⁽³⁾ | ON | Any except PLL | All except OTG_FS, RNG, LCD-TFT | N/A |
| | Range 1 | | | | | All | |
| Sleep | Range 2 | No | ON ⁽³⁾ | ON ⁽⁴⁾ | ON ⁽⁴⁾ Any All except OTG_FS, RNG, LCD-TF | | Any interrupt or event |
| LPSleep | LPR | No | ON ⁽³⁾ | ON ⁽⁴⁾ | Any except PLL | All except OTG_FS, RNG, LCD-TFT | Any interrupt or event |
| Stop 0 | Range 1 Range 2 | No | Off | ON | LSE LSI | BOR, PVD, PVM RTC, IWDG COMPx (x=1,2) DACx (x=1,2) OPAMPx (x=1,2) USARTx (x=15) ⁽⁵⁾ LPUART1 ⁽⁵⁾ I2Cx (x=14) ⁽⁶⁾ LPTIMx (x=1,2) *** All other peripherals are frozen | Reset pin, all I/Os BOR, PVD, PVM RTC, IWDG COMPx (x=12) USARTx (x=15) ⁽⁵⁾ LPUART1 ⁽⁵⁾ I2Cx (x=14) ⁽⁶⁾ LPTIMx (x=1,2) OTG_FS ⁽⁷⁾ |
| Stop 1 | LPR | No | Off | ON | LSE LSI | BOR, PVD, PVM RTC, IWDG COMPx (x=1,2) DACx (x=1,2) OPAMPx (x=1,2) USARTx (x=15) ⁽⁵⁾ LPUART1 ⁽⁵⁾ I2Cx (x=14) ⁽⁶⁾ LPTIMx (x=1,2) *** All other peripherals are frozen | Reset pin, all I/Os BOR, PVD, PVM RTC, IWDG COMPx (x=12) USARTx (x=15) ⁽⁵⁾ LPUART1 ⁽⁵⁾ I2Cx (x=14) ⁽⁶⁾ LPTIMx (x=1,2) OTG_FS ⁽⁷⁾ |

Table 4. STM32L4Q5xx modes overview (continued)

| Mode | Regulator ⁽¹⁾ | CPU | Flash | SRAM | Clocks | DMA and Peripherals ⁽²⁾ | Wakeup source |
|----------|--------------------------|-----------------|-------|----------------|------------|---|---|
| Stop 2 | LPR | No | Off | ON | LSE LSI | BOR, PVD, PVM RTC, IWDG COMPx (x=12) I2C3 ⁽⁶⁾ LPUART1 ⁽⁵⁾ LPTIM1x (x=1,2) *** All other peripherals are frozen | Reset pin, all I/Os BOR, PVD, PVM RTC, IWDG COMPx (x=12) I2C3 ⁽⁶⁾ LPUART1 ⁽⁵⁾ LPTIM1x (x=1,2) |
| | LPR | | | SRAM2 ON | | BOR, RTC, IWDG | |
| Standby | OFF | Power ed Off | Off | Powered Off | LSE LSI | All other peripherals are powered off *** I/O configuration can be floating, pull-up or pull-down | Reset pin 5 I/Os (WKUPx) ⁽⁸⁾ BOR, RTC, IWDG |
| Shutdown | OFF | Power ed Off | Off | Powered Off | LSE | RTC *** All other peripherals are powered off *** I/O configuration can be floating, pull-up or pull-down ⁽⁹⁾ | Reset pin 5 I/Os (WKUPx) ⁽⁸⁾ RTC |

- 1. LPR means Main regulator is OFF and Low-power regulator is ON.
- 2. All peripherals can be active or clock gated to save power consumption.
- 3. The Flash memory can be put in power-down and its clock can be gated off when executing from SRAM.
- 4. The SRAM1, SRAM2 and SRAM3 clocks can be gated on or off independently.
- 5. U(S)ART and LPUART reception is functional in Stop mode, and generates a wakeup interrupt on Start, address match or received frame event.
- 6. I2C address detection is functional in Stop mode, and generates a wakeup interrupt in case of address match.
- 7. OTG_FS wakeup by resume from suspend and attach detection protocol event.
- 8. The I/Os with wakeup from Standby/Shutdown capability are: PA0, PC13, PE6, PA2, PC5.
- 9. I/Os can be configured with internal pull-up, pull-down or floating in Shutdown mode but the configuration is lost when exiting the Shutdown mode.

By default, the microcontroller is in Run mode after a system or a power reset. It is up to the user to select one of the low-power modes described below:

Sleep mode

In Sleep mode, only the CPU is stopped. All peripherals continue to operate and can wake up the CPU when an interrupt/event occurs.

Low-power run mode

This mode is achieved with VCORE supplied by the low-power regulator to minimize the regulator's operating current. The code can be executed from SRAM or from Flash, and the CPU frequency is limited to 2 MHz. The peripherals with independent clock can be clocked by HSI16.

• Low-power sleep mode

This mode is entered from the Low-power run mode. Only the CPU clock is stopped. When wakeup is triggered by an event or an interrupt, the system reverts to the Low-power run mode.

Stop 0, Stop 1 and Stop 2 modes

Stop mode achieves the lowest power consumption while retaining the content of SRAM and registers. All clocks in the VCORE domain are stopped, the PLL, the MSI RC, the HSI16 RC and the HSE crystal oscillators are disabled. The LSE or LSI is still running.

The RTC can remain active (Stop mode with RTC, Stop mode without RTC).

Some peripherals with wake-up capability can enable the HSI16 RC during Stop mode to detect their wake-up condition.

Three Stop modes are available: Stop 0, Stop 1 and Stop 2 modes. In Stop 2 mode, most of the VCORE domain is put in a lower leakage mode.

Stop 1 offers the largest number of active peripherals and wakeup sources, a smaller wakeup time but a higher consumption than Stop 2. In Stop 0 mode, the main regulator remains ON, allowing a very fast wakeup time but with much higher consumption.

The system clock when exiting from Stop 0, Stop 1 or Stop 2 modes can be either MSI up to 48 MHz or HSI16, depending on software configuration.

• Standby mode

The Standby mode is used to achieve the lowest power consumption with BOR. The internal regulator is switched off so that the VCORE domain is powered off. The PLL, the MSI RC, the HSI16 RC and the HSE crystal oscillators are also switched off.

The RTC can remain active (Standby mode with RTC, Standby mode without RTC).

The Brownout reset (BOR) always remains active in Standby mode.

The state of each I/O during Standby mode can be selected by software: I/O with internal pull-up, internal pull-down or floating.

After entering Standby mode, SRAM1, SRAM3 and register contents are lost except for registers in the Backup domain and Standby circuitry. Optionally, the full SRAM2 (or



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only the upper 4 Kbytes) can be retained in Standby mode, supplied by the low-power regulator (standby with RAM2 retention mode).

The device exits Standby mode when an external reset (NRST pin), an IWDG reset, WKUP pin event (configurable rising or falling edge), or an RTC event occurs (alarm, periodic wakeup, timestamp, tamper) or a failure is detected on LSE (CSS on LSE). The system clock after wakeup is MSI up to 8 MHz.

Shutdown mode

The Shutdown mode allows to achieve the lowest power consumption. The internal regulator is switched off so that the VCORE domain is powered off. The PLL, the HSI16, the MSI, the LSI and the HSE oscillators are also switched off.

The RTC can remain active (Shutdown mode with RTC, Shutdown mode without RTC).

The BOR is not available in Shutdown mode. No power voltage monitoring is possible in this mode, therefore the switch to Backup domain is not supported.

SRAM1, SRAM2, SRAM3 and register contents are lost except for registers in the Backup domain.

The device exits Shutdown mode when an external reset (NRST pin), a WKUP pin event (configurable rising or falling edge), or an RTC event occurs (alarm, periodic wakeup, timestamp, tamper).

The system clock after wakeup is MSI at 4 MHz.



Table 5. Functionalities depending on the working mode⁽¹⁾

| | | o. Functi | | | Stop | | Sto | | | ndby | Shute | down | |
|--|------------------|------------------|----------------------|------------------------|------|-------------------|------------------|-------------------|------------------|-------------------|-------|-------------------|------|
| Peripheral | Run | Sleep | Low- power run | Low- power sleep | 1 | Wakeup capability | - | Wakeup capability | - | Wakeup capability | - | Wakeup capability | VBAT |
| CPU | Υ | - | Υ | - | - | - | - | - | - | - | - | - | - |
| Flash memory (2 Mbytes) | O ⁽²⁾ | O ⁽²⁾ | O ⁽²⁾ | O ⁽²⁾ | - | - | - | - | - | - | - | - | - |
| SRAM1 (128 Kbytes) | Y | Y ⁽³⁾ | Y | Y ⁽³⁾ | Y | - | Y | - | - | - | - | 1 | - |
| SRAM2 (64 Kbytes) | Υ | Y ⁽³⁾ | Υ | Y ⁽³⁾ | Υ | - | Υ | - | O ⁽⁴⁾ | - | - | - | - |
| SRAM3 (128 Kbytes) | Y | Y ⁽³⁾ | Y | Y ⁽³⁾ | Y | - | Y ⁽³⁾ | - | - | - | - | , | - |
| FSMC | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| OCTOSPIx (x=1,2) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | | - |
| Backup registers | Υ | Y | Υ | Υ | Υ | - | Υ | - | Υ | - | Υ | - | Υ |
| Brownout reset (BOR) | Υ | Y | Υ | Y | Y | Y | Y | Y | Y | Υ | - | | - |
| Programmable voltage detector (PVD) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | - | - | , | - |
| Peripheral voltage monitor (PVMx; x=1,2,3,4) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | - | - | - | - |
| DMA | 0 | 0 | 0 | 0 | ı | - | - | - | - | - | - | - | - |
| DMA2D | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| High speed internal (HSI16) | 0 | 0 | 0 | 0 | (5) | - | (5) | - | - | - | - | - | - |
| Oscillator HSI48 | 0 | 0 | - | - | - | - | - | - | - | - | - | - | - |
| High speed external (HSE) | 0 | 0 | 0 | 0 | ı | - | - | - | - | - | - | - | - |
| Low speed internal (LSI) | 0 | 0 | 0 | 0 | 0 | - | 0 | - | 0 | - | - | - | - |
| Low speed external (LSE) | 0 | 0 | 0 | 0 | 0 | - | 0 | - | 0 | - | 0 | - | 0 |
| Multi speed internal (MSI) | 0 | 0 | 0 | 0 | 1 | - | - | - | - | - | - | - | - |
| Clock security system (CSS) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |



Table 5. Functionalities depending on the working mode⁽¹⁾ (continued)

| | | | lies dep | | Stop | | | p 2 | | ndby | Shute | down | |
|------------------------------|------|------------------|----------------------|------------------------|------------------|-------------------|------------------|-------------------|---|-------------------|-------|-------------------|------|
| Peripheral | Run | Sleep | Low- power run | Low- power sleep | - | Wakeup capability | • | Wakeup capability | 1 | Wakeup capability | - | Wakeup capability | VBAT |
| Clock security system on LSE | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | - | - |
| RTC / Auto wakeup | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Number of RTC Tamper pins | 3 | 3 | 3 | 3 | 3 | 0 | 3 | 0 | 3 | 0 | 3 | 0 | 3 |
| Camera interface (DCMI) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| PSSI | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| LCD-TFT | 0 | 0 | - | - | - | - | - | - | - | - | - | - | - |
| USB OTG FS | O(8) | O ⁽⁸⁾ | - | - | - | 0 | - | - | - | - | - | - | - |
| USARTx (x=1,2,3,4,5) | 0 | 0 | 0 | 0 | O ⁽⁶⁾ | O ⁽⁶⁾ | - | 1 | - | - | - | 1 | - |
| Low-power UART (LPUART) | 0 | 0 | 0 | 0 | O ⁽⁶⁾ | O ⁽⁶⁾ | O ⁽⁶⁾ | O ⁽⁶⁾ | - | - | - | - | - |
| I2Cx (x=1,2,4) | 0 | 0 | 0 | 0 | O ⁽⁷⁾ | O ⁽⁷⁾ | - | - | • | - | - | - | - |
| I2C3 | 0 | 0 | 0 | 0 | O ⁽⁷⁾ | O ⁽⁷⁾ | O ⁽⁷⁾ | O ⁽⁷⁾ | - | - | - | - | - |
| SPIx (x=1,2,3) | 0 | 0 | 0 | 0 | - | - | - | | - | - | - | | - |
| CAN(x=1,2) | 0 | 0 | 0 | 0 | - | - | • | - | ı | - | - | - | - |
| SDMMC1 | 0 | 0 | 0 | 0 | - | - | • | - | ı | - | - | - | - |
| SDMMC2 | 0 | 0 | 0 | 0 | - | - | - | - | ı | - | - | - | - |
| SAIx (x=1,2) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| DFSDM1 | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| ADCx (x=1,2) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| DACx (x=1,2) | 0 | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - |
| VREFBUF | 0 | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - |
| OPAMPx (x=1,2) | 0 | 0 | 0 | 0 | 0 | - | ı | - | ı | - | - | - | - |
| COMPx (x=1,2) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | ı | - | - | - | - |
| Temperature sensor | 0 | 0 | 0 | 0 | - | - | ı | - | ı | - | - | - | - |
| Timers (TIMx) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| Low-power timer 1 (LPTIM1) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | - | - | - | - |

Table 5. Functionalities depending on the working mode⁽¹⁾ (continued)

| | | | | | | 0/1 | | р 2 | | ndby | Shut | down | |
|--------------------------------|------------------|------------------|----------------------|------------------------|---|-------------------|---|-------------------|-----|-------------------|------|-------------------|------|
| Peripheral | Run | Sleep | Low- power run | Low- power sleep | - | Wakeup capability | - | Wakeup capability | 1 | Wakeup capability | 1 | Wakeup capability | VBAT |
| Low-power timer 2 (LPTIM2) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | - | - | | - |
| Independent watchdog (IWDG) | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | - | ı | - |
| Window watchdog (WWDG) | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| SysTick timer | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| Touch sensing controller (TSC) | 0 | 0 | 0 | 0 | - | | - | - | - | - | - | | - |
| Random number generator (RNG) | O ⁽⁸⁾ | O ⁽⁸⁾ | - | - | - | 1 | - | - | - | - | - | | - |
| AES hardware accelerator | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| PKA | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| HASH hardware accelerator | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| CRC calculation unit | 0 | 0 | 0 | 0 | - | - | - | - | - | - | - | - | - |
| GPIOs | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | (9) | 5 pins (10) | (11) | 5 pins (10) | - |

1. Legend: Y = yes (enable). O = optional (disable by default, can be enabled by software). - = not available.

Gray cells highlight the wakeup capability in each mode.

- 2. The Flash can be configured in power-down mode. By default, it is not in power-down mode.
- 3. The SRAM clock can be gated on or off. In Stop 2 mode, the content of SRAM3 is preserved or not depending on the RRSTP bit in PWR_CR1 register.
- 4. The upper 4 Kbytes or the full SRAM2 content is preserved depending on RRS[1:0] bits configuration in PWR_CR3 register.
- 5. Some peripherals with wakeup from Stop capability can request HSI16 to be enabled. In this case, HSI16 is woken up by the peripheral, and only feeds the peripheral which requested it. HSI16 is automatically put off when the peripheral does not need it anymore.
- 6. UART and LPUART reception is functional in Stop mode, and generates a wakeup interrupt on Start, address match or received frame event.
- 7. I2C address detection is functional in Stop mode, and generates a wakeup interrupt in case of address match.
- 8. Voltage scaling range 1 only.
- 9. I/Os can be configured with internal pull-up, pull-down or floating in Standby mode.
- 10. The I/Os with wakeup from standby/shutdown capability are: PA0, PC13, PE6, PA2, PC5.
- 11. I/Os can be configured with internal pull-up, pull-down or floating in Shutdown mode but the configuration is lost when exiting the Shutdown mode.



3.7.5 Reset mode

In order to improve the consumption under reset, the I/Os state under and after reset is "analog state" (the I/O schmitt trigger is disable). In addition, the internal reset pull-up is deactivated when the reset source is internal.

3.7.6 VBAT operation

The VBAT pin allows the device VBAT domain to be powered from an external battery, an external supercapacitor, or from V_{DD} when there is no external battery and when an external supercapacitor is present. The VBAT pin supplies the RTC with LSE and the backup registers. Three anti-tamper detection pins are available in VBAT mode.

The VBAT operation is automatically activated when V_{DD} is not present. An internal VBAT battery charging circuit is embedded and can be activated when V_{DD} is present.

Note: When the microcontroller is supplied from VBAT, neither external interrupts nor RTC alarm/events exit the microcontroller from the VBAT operation.

3.8 Peripheral and interconnect matrix

Several peripherals have direct connections between them, which allow autonomous communication between them and support the saving of CPU resources (thus power supply consumption). In addition, these hardware connections allow fast and predictable latency.

Depending on the peripherals, these interconnections can operate in Run, Sleep, Low-power run, Low-power Sleep, Stop 0, Stop 1 and Stop 2 modes. See *Table 6* for more details.

| Interconnect source | Interconnect destination | Interconnect action | Run | Sleep | Low-power run | Low-power sleep | Stop 0 / Stop 1 | Stop 2 |
|---------------------|-----------------------------|--|-----|-------|---------------|-----------------|-----------------|--------|
| | TIMx | Timers synchronization or chaining | Υ | Υ | Υ | Υ | - | - |
| TIMx | ADCx DACx DFSDM1 | Conversion triggers | Υ | Υ | Υ | Υ | - | - |
| | DMA | Memory to memory transfer trigger | Υ | Υ | Υ | Υ | - | - |
| | COMPx | Comparator output blanking | Υ | Υ | Υ | Υ | | - |
| COMPx | TIM1, 8 TIM2, 3 | Timer input channel, trigger, break from analog signals comparison | Υ | Υ | Υ | Υ | - | - |
| COIVIFX | LPTIMERx | Low-power timer triggered by analog signals comparison | Υ | Υ | Υ | Υ | Υ | Υ |
| ADCx | TIM1. 8 | Timer triggered by analog watchdog | Υ | Υ | Υ | Υ | - | - |

Table 6. STM32L4Q5xx peripherals interconnect matrix

Table 6. STM32L4Q5xx peripherals interconnect matrix (continued)

| Interconnect source | Interconnect destination | Interconnect action | Run | Sleep | Low-power run | Low-power sleep | Stop 0 / Stop 1 | Stop 2 |
|--|-----------------------------|--|-----|-------|---------------|-----------------|-----------------|--------|
| | TIM16 | Timer input channel from RTC events | Υ | Υ | Υ | Υ | - | - |
| RTC | LPTIMERX | Low-power timer triggered by RTC alarms or tampers | Υ | Υ | Υ | Υ | Υ | Υ |
| All clocks sources (internal and external) | TIM2 TIM15, 16, 17 | Clock source used as input channel for RC measurement and trimming | Y | Y | Y | Υ | • | 1 |
| USB | TIM2 | Timer triggered by USB SOF | Υ | Υ | - | - | - | - |
| CSS CPU (hard fault) RAM (parity error) Flash memory (ECC error) COMPx PVD DFSDM1 (analog watchdog, short circuit detection) | TIM1,8 TIM15,16,17 | Timer break | Y | Y | Y | Y | - | - |
| | TIMx | External trigger | Υ | Υ | Υ | Υ | • | 1 |
| | LPTIMERx | External trigger | Υ | Υ | Υ | Υ | Υ | Υ |
| GPIO | ADC DACx DFSDM1 | Conversion external trigger | Υ | Υ | Υ | Υ | - | 1 |

3.9 Reset and clock controller (RCC)

The clock controller (see *Figure 4*) distributes the clocks coming from the different oscillators to the core and to the peripherals. It also manages the clock gating for low-power modes and ensures the clock robustness. It features:

- Clock prescaler: to get the best trade-off between speed and current consumption, the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler.
- **Safe clock switching:** clock sources can be changed safely on the fly in Run mode through a configuration register.
- **Clock management:** to reduce the power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- System clock source: four different clock sources can be used to drive the master clock SYSCLK:
 - 4 to 48 MHz high-speed external crystal or ceramic resonator (HSE), that can supply a PLL. The HSE can also be configured in bypass mode for an external clock.
 - 16 MHz high-speed internal RC oscillator (HSI16), trimmable by software, that can supply a PLL
 - Multispeed internal RC oscillator (MSI), trimmable by software, able to generate 12 frequencies from 100 kHz to 48 MHz. When a 32.768 kHz clock source is available in the system (LSE), the MSI frequency can be automatically trimmed by hardware to reach better than ±0.25% accuracy. In this mode the MSI can feed the USB device, saving the need of an external high-speed crystal (HSE). The MSI can supply a PLL.
 - System PLL which can be fed by HSE, HSI16 or MSI, with a maximum frequency at 120 MHz.
- RC48 with clock recovery system (HSI48): internal 48 MHz clock source (HSI48)can be used to drive the USB, the SDMMC or the RNG peripherals. This clock can be output on the MCO.
- Auxiliary clock source: two ultra-low-power clock sources that can be used to drive the real-time clock:
 - 32.768 kHz low-speed external crystal (LSE), supporting four drive capability modes. The LSE can also be configured in bypass mode for an external clock.
 - 32 kHz low-speed internal RC (LSI), also used to drive the independent watchdog.
 The LSI clock accuracy is ±5% accuracy.
- Peripheral clock sources: several peripherals (USB, SDMMC, RNG, SAI, USARTs, I2Cs, LPTimers, ADC) have their own independent clock whatever the system clock. Three PLLs, each having three independent outputs allowing the highest flexibility, can generate independent clocks for the ADC, the USB/SDMMC/RNG, the two SAIs, and LCD-TFT.
- **Startup clock:** after reset, the microcontroller restarts by default with an internal 4 MHz clock (MSI). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- Clock security system (CSS): this feature can be enabled by software. If a HSE clock failure occurs, the master clock is automatically switched to HSI16 and a software



interrupt is generated if enabled. LSE failure can also be detected and generated an interrupt.

- Clock-out capability:
 - MCO (microcontroller clock output): it outputs one of the internal clocks for external use by the application
 - LSCO (low-speed clock output): it outputs LSI or LSE in all low-power modes (except VBAT).

Several prescalers allow the AHB frequency, the high speed APB (APB2) and the low-speed APB (APB1) domains to be configured. The maximum frequency of the AHB and the APB domains is 120 MHz.



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Figure 4. Clock tree to IWDG LSI RC 32 kHz LSCO to RTC OSC32_OUT LSE OSC /32 32.768 kHz OSC32_IN to PWR LSE LSI to AHB bus, core, memory and DMA MSI HSI16 мсо / 1→16 HSE HCLK FCLK Cortex free running clock AHB PRESC SYSCLK / 1,2,..512 PLLCLK to Cortex system timer /8 HSI48 Clock PCLK1 source APB1 PRESC control / 1,2,4,8,16 to APB1 peripherals OSC_OUT HSE OSC 4-48 MHz HSE x1 or x2 to TIMx OSC_IN MSI Clock x=2..7 SYSCLK detector HSI16 LSE HSI16 SYSCLK to USARTx X=2..5 to LPUART1 16 MHz HSI16-SYSCLKto I2Cx MSI RC 100 kHz – 48 MHz x=1,2,3,4 LSI-LSE-HSI16-RC 48 MHz to LPTIMx x=1,2 MSI PLL to OCTOSPIx PLLSAI3CLK x=1,2 PLL48M1CLK CRS clock /Q PCLK2 PLLCLK / R APB2 PRESC to APB2 peripherals / 1,2,4,8,16 H<u>SI16</u> x1 or x2 to TIMx / M PLLSAI1 PLLSAI1CLK x=1,8,15,16,17 / P PLL48M2CLK /Q LSE-HSI16-SYSCLKto PLLADC1CLK / R USART1 to SDMMCx MSI H<u>SI16</u> 48 MHz clock to USB, RNG SYSCLK to ADCx X=1,2 MSI HSI16 / M **◄** PLLSAI2 PLLSAI2CLK DFSDM audio clock to SAI1 PLLLCDCLK H<u>SI16</u> PLLSAI2DIVR LTDC clock SAI1_EXTCLK



to SAI2

MSv61129V2

SAI2 EXTCLK

3.10 Clock recovery system (CRS)

The devices embed a special block which allows automatic trimming of the internal 48 MHz oscillator to guarantee its optimal accuracy over the whole device operational range. This automatic trimming is based on the external synchronization signal, which can be either derived from USB SOF signalization, from LSE oscillator, from an external signal on CRS_SYNC pin or generated by user software. For faster lock-in during startup it is also possible to combine automatic trimming with manual trimming action.

3.11 General-purpose inputs/outputs (GPIOs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions. Fast I/O toggling can be achieved thanks to their mapping on the AHB2 bus.

The I/Os alternate function configuration can be locked if needed following a specific sequence in order to avoid spurious writing to the I/Os registers.

3.12 Multi-AHB bus matrix

The 32-bit multi-AHB bus matrix interconnects all the masters (CPU, DMAs, DMA2D, SDMMC1, SDMMC2 and LCD-TFT) and the slaves (Flash memory, RAM, FSMC, OCTOSPI, AHB and APB peripherals). It also ensures a seamless and efficient operation even when several high-speed peripherals work simultaneously.



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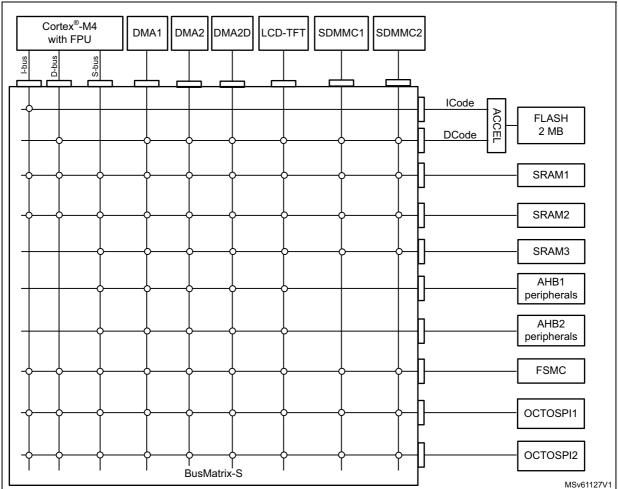


Figure 5. Multi-AHB bus matrix

3.13 Direct memory access controller (DMA)

The device embeds 2 DMAs. Refer to *Table 7: DMA implementation* for the features implementation.

Direct memory access (DMA) is used in order to provide a high-speed data transfer between peripherals and memory as well as from memory to memory. Data can be quickly moved by DMA without any CPU actions. This keeps the CPU resources free for other operations.

The two DMA controllers have 14 channels in total, each one dedicated to manage memory access requests from one or more peripherals. Each controller has an arbiter for handling the priority between DMA requests.

The DMA supports:

- 14 independently configurable channels (requests)
 - Each channel is connected to a dedicated hardware DMA request, a software trigger is also supported on each channel. This configuration is done by software.
- Priorities between requests from channels of one DMA are both software programmable (4 levels: very high, high, medium, low) or hardware programmable in case of equality (request 1 has priority over request 2, etc.)
- Independent source and destination transfer size (byte, half word, word), emulating packing and unpacking. Source/destination addresses must be aligned on the data size
- Support for circular buffer management
- 3 event flags (DMA half transfer, DMA transfer complete and DMA transfer error) logically ORed together in a single interrupt request for each channel
- Memory-to-memory transfer
- Peripheral-to-memory, memory-to-peripheral, and peripheral-to-peripheral transfers
- Access to Flash, SRAM, APB and AHB peripherals as source and destination
- Programmable number of data to be transferred: up to 65536

Table 7. DMA implementation

| DMA features | DMA1 | DMA2 |
|----------------------------|------|------|
| Number of regular channels | 7 | 7 |

3.14 DMA request router (DMAMux)

When a peripheral indicates a request for DMA transfer by setting its DMA request line, the DMA request is pending until it is served and the corresponding DMA request line is reset. The DMA request router allows to route the DMA control lines between the peripherals and the DMA controllers of the product.

An embedded multi-channel DMA request generator can be considered as one of such peripherals. The routing function is ensured by a multi-channel DMA request line multiplexer. Each channel selects a unique set of DMA control lines, unconditionally or synchronously with events on synchronization inputs.

For simplicity, the functional description is limited to DMA request lines. The other DMA control lines are not shown in figures or described in the text. The DMA request generator produces DMA requests following events on DMA request trigger inputs.

3.15 Chrom-ART Accelerator (DMA2D)

Chrom-ART Accelerator (DMA2D) is a graphic accelerator that offers an advanced bit blitting, row data copy and pixel format conversion. It supports the following functions:

- Rectangle filling with a fixed color
- Rectangle copy
- Rectangle copy with pixel format conversion
- Rectangle composition with blending and pixel format conversion.

Various image format coding are supported, from indirect 4 bpp color mode up to 32 bpp direct color. It embeds a dedicated memory to store color lookup tables.

An interrupt can be generated when an operation is complete or at a programmed watermark.

All the operations are fully automatized and are running independently from the CPU or the DMAs.

3.16 Interrupts and events

3.16.1 Nested vectored interrupt controller (NVIC)

The STM32L4Q5xx devices embed a nested vectored interrupt controller which is able to manage 16 priority levels, and to handle up to 95 maskable interrupt channels plus the 16 interrupt lines of the Cortex[®]-M4.

The NVIC benefits are the following:

- Closely coupled NVIC gives low latency interrupt processing
- Interrupt entry vector table address passed directly to the core
- Allows early processing of interrupts
- Processing of late arriving higher priority interrupts
- Support for tail chaining
- Processor state automatically saved
- Interrupt entry restored on interrupt exit with no instruction overhead

The NVIC hardware block provides flexible interrupt management features with minimal interrupt latency.

3.16.2 Extended interrupt/event controller (EXTI)

The extended interrupt/event controller consists of 36 edge detector lines used to generate interrupt/event requests and to wake up the system from the Stop mode. Each external line can be independently configured to select the trigger event (rising edge, falling edge, both) and can be masked independently.

A pending register maintains the status of the interrupt requests. The internal lines are connected to peripherals with wakeup from Stop mode capability. The EXTI can detect an external line with a pulse width shorter than the internal clock period. Up to 114 GPIOs can be connected to the 16 external interrupt lines.

3.17 Cyclic redundancy check calculation unit (CRC)

The CRC (cyclic redundancy check) calculation unit is used to get a CRC code using a configurable generator with polynomial value and size.

Among other applications, the CRC-based techniques are used to verify data transmission or storage integrity. In the scope of the EN/IEC 60335-1 standard, they offer a mean to verify the Flash memory integrity.

The CRC calculation unit helps to compute a signature of the software during runtime, which can be ulteriorly compared with a reference signature generated at link-time and which can be stored at a given memory location.

3.18 Flexible static memory controller (FSMC)

The flexible static memory controller (FSMC) includes two memory controllers:

- The NOR/PSRAM memory controller
- The NAND/memory controller

This memory controller is also named flexible memory controller (FMC).

The main features of the FSMC controller are the following:

- Interface with static-memory mapped devices including:
 - Static random access memory (SRAM)
 - NOR Flash memory/OneNAND Flash memory
 - PSRAM (four memory banks)
 - NAND Flash memory with ECC hardware to check up to 8 Kbytes of data
 - Ferroelectric RAM (FRAM)
- 8-,16- bit data bus width
- Independent chip select control for each memory bank
- Independent configuration for each memory bank
- Write FIFO
- The Maximum FMC_CLK frequency for synchronous accesses is HCLK/2.



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LCD parallel interface

The FMC can be configured to interface seamlessly with most graphic LCD controllers. It supports the Intel 8080 and Motorola 6800 modes, and is flexible enough to adapt to specific LCD interfaces. This LCD parallel interface capability makes it easy to build cost effective graphic applications using LCD modules with embedded controllers or high-performance solutions using external controllers with dedicated acceleration.

3.19 Octo-SPI interface (OCTOSPI)

The OCTOSPI is a specialized communication interface targetting single, dual, quad or octal SPI memories. It can operate in any of the three following modes:

- Indirect mode: all the operations are performed using the OCTOSPI registers
- Status polling mode: the external memory status register is periodically read and an interrupt can be generated in case of flag setting
- Memory-mapped mode: the external memory is memory mapped and is seen by the system as if it were an internal memory supporting read and write operation

The OCTOSPI supports two frame formats:

- Classical frame format with command, address, alternate byte, dummy cycles and data phase over 1, 2, 4 or 8 data pins
- HyperbusTM frame format

The OCTOSPI offers the following features:

- Three functional modes: indirect, status-polling, and memory-mapped
- Read and write support in memory-mapped mode
- Supports for single, dual, quad and octal communication
- Dual-quad mode, where 8 bits can be sent/received simultaneously by accessing two quad memories in parallel.
- SDR and DTR support
- Data strobe support
- Fully programmable opcode for both indirect and memory mapped mode
- Fully programmable frame format for both indirect and memory mapped mode
- Each of the five following phases can be configured independently (enable, length, single/dual/quad communication)
 - Instruction phase
 - Address phase
 - Alternate bytes phase
 - Dummy cycles phase
 - Data phase
- HyperbusTM support
- Integrated FIFO for reception and transmission
- 8, 16, and 32-bit data accesses are allowed
- DMA channel for indirect mode operations



- Timeout management
- Interrupt generation on FIFO threshold, timeout, status match, operation complete, and access error

3.20 Octo-SPI IO manager (OCTOSPIIOM)

The OCTOSPI IO manager is a low level interface allowing:

- Efficient OCTOSPI pin assignment with a full IO Matrix (before alternate function map)
- Multiplexing single/dual/quad/octal SPI interface over the same bus

The OCTOSPI IO manager has the following features:

- Support up to two single/dual/quad/octal SPI Interface
- Support up to eight ports for pin assignment
- Fully programmable IO matrix for pin assignment by function (data/control/clock)
- Muxer for Single/Dual/Quad/Octal SPI interface multiplexing over the same bus



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3.21 Analog-to-digital converter (ADC)

The device embeds two successive approximation analog-to-digital converters with the following features:

- 12-bit native resolution, with built-in calibration
- 5.33 Msps maximum conversion rate with full resolution
 - Down to 18.75 ns sampling time
 - Increased conversion rate for lower resolution (up to 8.88 Msps for 6-bit resolution)
- Up to 16 external channels
- 5 internal channels: internal reference voltage, temperature sensor, VBAT/3, DAC1 and DAC2 outputs
- One external reference pin is available on some package, allowing the input voltage range to be independent from the power supply
- Single-ended and differential mode inputs
- Low-power design
 - Capable of low-current operation at low conversion rate (consumption decreases linearly with speed)
 - Dual clock domain architecture: ADC speed independent from CPU frequency
- Highly versatile digital interface
 - Single-shot or continuous/discontinuous sequencer-based scan mode: 2 groups of analog signals conversions can be programmed to differentiate background and high-priority real-time conversions
 - Each ADC support multiple trigger inputs for synchronization with on-chip timers and external signals
 - Results stored into a data register or in RAM with DMA controller support
 - Data pre-processing: left/right alignment and per channel offset compensation
 - Built-in oversampling unit for enhanced SNR
 - Channel-wise programmable sampling time
 - Analog watchdog for automatic voltage monitoring, generating interrupts and trigger for selected timers
 - Hardware assistant to prepare the context of the injected channels to allow fast context switching

3.21.1 Temperature sensor

The temperature sensor (TS) generates a voltage V_{TS} that varies linearly with temperature. The temperature sensor is internally connected to the ADC1_IN17 input channels which is used to convert the sensor output voltage into a digital value.

The sensor provides good linearity but it has to be calibrated to obtain good overall accuracy of the temperature measurement. As the offset of the temperature sensor varies from chip to chip due to process variation, the uncalibrated internal temperature sensor is suitable for applications that detect temperature changes only.

To improve the accuracy of the temperature sensor measurement, each device is individually factory-calibrated by ST. The temperature sensor factory calibration data are stored by ST in the system memory area, accessible in read-only mode.



| Calibration value name | Description | Memory address | | | |
|------------------------|--|---------------------------|--|--|--|
| TS_CAL1 | TS ADC raw data acquired at a temperature of 30 °C (± 5 °C), V _{DDA} = V _{REF+} = 3.0 V (± 10 mV) | 0x1FFF 75A8 - 0x1FFF 75A9 | | | |
| TS_CAL2 | TS ADC raw data acquired at a temperature of 130 °C (± 5 °C), V _{DDA} = V _{REF+} = 3.0 V (± 10 mV) | 0x1FFF 75CA - 0x1FFF 75CB | | | |

Table 8. Temperature sensor calibration values

3.21.2 Internal voltage reference (V_{REFINT})

The internal voltage reference (VREFINT) provides a stable (bandgap) voltage output for the ADC and the comparators. The VREFINT is internally connected to the ADC1_IN0 input channel. The precise voltage of VREFINT is individually measured for each part by ST during production test and stored in the system memory area. It is accessible in read-only mode.

Table 9. Internal voltage reference calibration values

| Calibration value name | Description | Memory address | | | |
|------------------------|--|---------------------------|--|--|--|
| VREFINT | Raw data acquired at a temperature of 30 °C (± 5 °C), V _{DDA} = V _{REF+} = 3.0 V (± 10 mV) | 0x1FFF 75AA - 0x1FFF 75AB | | | |

3.21.3 V_{BAT} battery voltage monitoring

This embedded hardware enables the application to measure the V_{BAT} battery voltage using the internal ADC channel ADC1_IN18. As the V_{BAT} voltage may be higher than the VDDA, and thus outside the ADC input range, the VBAT pin is internally connected to a bridge divider by 3. As a consequence, the converted digital value is one third of the V_{BAT} voltage.

3.22 Digital to analog converter (DAC)

Two 12-bit buffered DAC channels can be used to convert digital signals into analog voltage signal outputs. The chosen design structure is composed of integrated resistor strings and an amplifier in inverting configuration.

This digital interface supports the following features:

- Up to two DAC output channels
- 8-bit or 12-bit output mode
- Buffer offset calibration (factory and user trimming)
- Left or right data alignment in 12-bit mode
- Synchronized update capability
- Noise-wave generation
- Triangular-wave generation

- Dual DAC channel independent or simultaneous conversions
- DMA capability for each channel
- External triggers for conversion
- Sample and hold low-power mode, with internal or external capacitor

The DAC channels are triggered through the timer update outputs that are also connected to different DMA channels.

3.23 Voltage reference buffer (VREFBUF)

The devices embed a voltage reference buffer which can be used as voltage reference for ADC, DACs and also as voltage reference for external components through the VREF+ pin.

The internal voltage reference buffer supports two voltages:

- 2.048 V
- 2.5 V

An external voltage reference can be provided through the VREF+ pin when the internal voltage reference buffer is off.

The VREF+ pin is double-bonded with VDDA on some packages. In these packages the internal voltage reference buffer is not available.

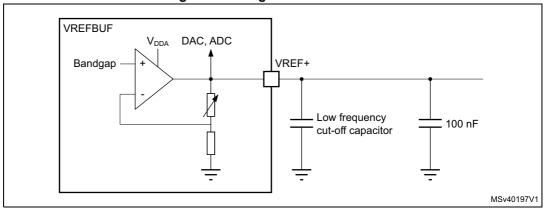


Figure 6. Voltage reference buffer

3.24 Comparators (COMP)

The devices embed two rail-to-rail comparators with programmable reference voltage (internal or external), hysteresis and speed (low speed for low-power) and with selectable output polarity.

The reference voltage can be one of the following:

- External I/O
- DAC output channels
- Internal reference voltage or submultiple (1/4, 1/2, 3/4).

All comparators can wake up from Stop mode, generate interrupts and breaks for the timers and can also be combined into a window comparator.

3.25 Operational amplifier (OPAMP)

The devices embed two operational amplifiers with external or internal follower routing and PGA capability.

The operational amplifier features:

- Low input bias current
- Low offset voltage
- Low-power mode
- Rail-to-rail input

3.26 Digital filter for sigma-delta modulators (DFSDM)

The STM32L4Q5xx devices embed one DFSDM with two digital filters modules and four external input serial channels (transceivers) or alternately four internal parallel inputs support.

The DFSDM peripheral is dedicated to interface the external $\Sigma\Delta$ modulators to the microcontroller and then to perform digital filtering of the received data streams (which represent analog value on $\Sigma\Delta$ modulators inputs).

The DFSDM can also interface the PDM (pulse density modulation) microphones and perform PDM to PCM conversion and filtering in hardware. The DFSDM features optional parallel data stream inputs from microcontrollers memory (through DMA/CPU transfers into DFSDM).

The DFSDM transceivers support several serial interface formats (to support various $\Sigma\Delta$ modulators) and the DFSDM digital filter modules perform digital processing according to the user's selected filter parameters with up to 24-bit final ADC resolution.

The DFSDM peripheral supports:

- 4 multiplexed input digital serial channels:
 - Configurable SPI interface to connect various SD modulator(s)
 - Configurable Manchester coded 1 wire interface support
 - PDM (pulse density modulation) microphone input support
 - Maximum input clock frequency up to 20 MHz (10 MHz for Manchester coding)
 - Clock output for SD modulator(s): 0..20 MHz
- Alternative inputs from 8 internal digital parallel channels (up to 16-bit input resolution):
 - Internal sources: device memory data streams (DMA)
- 2 digital filter modules with adjustable digital signal processing:
 - Sinc^x filter: filter order/type (1..5), oversampling ratio (up to 1..1024)
 - Integrator: oversampling ratio (1..256)
- Up to 24-bit output data resolution, signed output data format
- Automatic data offset correction (offset stored in register by user)
- Continuous or single conversion
- Start-of-conversion triggered by:
 - Software trigger
 - Internal timers



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- External events
- Start-of-conversion synchronously with first digital filter module (DFSDM0)
- Analog watchdog feature:
 - Low value and high-value data threshold registers
 - Dedicated configurable Sincx digital filter (order = 1..3, oversampling ratio = 1..32)
 - Input from final output data or from selected input digital serial channels
 - Continuous monitoring independently from standard conversion
- Short circuit detector to detect saturated analog input values (bottom and top range):
 - Up to 8-bit counter to detect 1..256 consecutive 0's or 1's on serial data stream
 - Monitoring continuously each input serial channel
- Break signal generation on analog watchdog event or on short circuit detector event
- Extremes detector:
 - Storage of minimum and maximum values of final conversion data
 - Refreshed by software
- DMA capability to read the final conversion data
- Interrupts: end of conversion, overrun, analog watchdog, short circuit, input serial channel clock absence
- "Regular" or "injected" conversions:
 - "Regular" conversions can be requested at any time or even in continuous mode without having any impact on the timing of "injected" conversions
 - "Injected" conversions for precise timing and with high conversion priority

3.27 Digital camera interface (DCMI)

The devices embed a camera interface that can connect with any camera modules and CMOS sensors through an 8-bit to 14-bit parallel interface in order to receive video data.

The camera interface can sustain a data transfer rate up to 54 Mbytes/s at 54 MHz. It features:

- Programmable polarity for the input pixel clock and synchronization signals
- Parallel data communication of 8-, 10-, 12- or 14-bit
- Supports 8-bit progressive video monochrome or raw bayer format, YCbCr 4:2:2 progressive video, RGB 565 progressive video or compressed data (like JPEG)
- Supports continuous mode or snapshot (a single frame) mode
- Capability to automatically crop the image.

3.28 LCD-TFT controller (LTDC)

The LCD-TFT display controller provides a 24-bit parallel digital RGB (red, green, blue) and delivers all signals to interface directly to a broad range of LCD and TFT panels with the following features:

- One display layer with dedicated FIFO (64 x 32-bit)
- Color look-up table (CLUT) up to 256 colors (256 x 24-bit) per layer
- Up to 8 input color formats selectable per layer
- Flexible blending between two layers using alpha value (per pixel or constant)
- Flexible programmable parameters for each layer
- Color keying (transparency color)
- Up to four programmable interrupt events

3.29 Touch sensing controller (TSC)

The touch sensing controller provides a simple solution to add capacitive sensing functionality to any application. A capacitive sensing technology is able to detect finger presence near an electrode that is protected from direct touch by a dielectric (glass, plastic or other). The capacitive variation introduced by the finger (or any conductive object) is measured using a proven implementation based on a surface charge transfer acquisition principle.

The touch sensing controller is fully supported by the STMTouch touch sensing firmware library which is free to use and allows touch sensing functionality to be implemented reliably in the end application.

The main features of the touch sensing controller are the following:

- Proven and robust surface charge transfer acquisition principle
- Supports up to 24 capacitive sensing channels
- Up to 3 capacitive sensing channels can be acquired in parallel offering a very good response time
- Spread spectrum feature to improve system robustness in noisy environments
- Full hardware management of the charge transfer acquisition sequence
- Programmable charge transfer frequency
- Programmable sampling capacitor I/O pin
- Programmable channel I/O pin
- Programmable max count value to avoid long acquisition when a channel is faulty
- Dedicated end of acquisition and max count error flags with interrupt capability
- One sampling capacitor for up to 3 capacitive sensing channels to reduce the system components
- Compatible with proximity, touchkey, linear and rotary touch sensor implementation
- Designed to operate with STMTouch touch sensing firmware library

Note: The number of capacitive sensing channels is dependent on the size of the packages and subject to I/O availability.

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3.30 Random number generator (RNG)

All devices embed an RNG that delivers 32-bit random numbers generated by an integrated analog circuit.

3.31 Parallel synchronous slave interface (PSSI)

The PSSI is a generic synchronous 8-/16-bit parallel data input/output slave interface. It allows the transmitter to send a data valid signal to indicate when the data is valid, and the receiver to output a flow control signal to indicate when it is ready to sample the data.

The PSSI main features are:

- The PSSI shares most of the circuitry with the digital camera interface (DCMI). It thus
 cannot be used simultaneously with the DCMI.
- Slave mode operation
- 8- or 16-bit parallel data input or output
- 4-word (16-byte) FIFO
- Data enable (DE) alternate function input and Ready (RDY) alternate function output.
 When enabled, these signals can either allow the transmitter to indicate when the data is valid or the receiver to indicate when it is ready to sample the data, or both.

3.32 Advanced encryption standard hardware accelerator (AES)

The devices embed an AES hardware accelerator that can be used both to encipher and to decipher data using an AES algorithm.

The AES peripheral supports:

- Encryption/decryption using AES Rijndael block cipher algorithm
- NIST FIPS 197 compliant implementation of AES encryption/decryption algorithm
- 128-bit and 256-bit register for storing the encryption, decryption or derivation key (4x 32-bit registers)
- Electronic codebook (ECB), cipher block chaining (CBC), Counter mode (CTR), Galois Counter Mode (GCM), Galois Message Authentication Code mode (GMAC) and Cipher Message Authentication Code mode (CMAC) supported
- Key scheduler
- Key derivation for decryption
- 128-bit data block processing
- 128-bit, 256-bit key length
- 1x32-bit INPUT buffer and 1x32-bit OUTPUT buffer
- Register access supporting 32-bit data width only
- One 128-bit Register for the initialization vector when AES is configured in CBC mode or for the 32-bit counter initialization when CTR mode is selected, GCM mode or CMAC mode
- Automatic data flow control with support of direct memory access (DMA) using 2 channels, one for incoming data, and one for outcoming data
- Suspend a message if another message with a higher priority needs to be processed.



3.33 HASH hardware accelerator (HASH)

The hash processor is a fully compliant implementation of the secure hash algorithm (SHA-1, SHA-224, SHA-256), the MD5 (message-digest algorithm 5) hash algorithm and the HMAC (keyed-hash message authentication code) algorithm suitable for a variety of applications.

It computes a message digest (160 bits for the SHA-1 algorithm, 256 bits for the SHA-256 algorithm and 224 bits for the SHA-224 algorithm, 128 bits for the MD5 algorithm) for messages of up to (264 - 1) bits, while the HMAC algorithms provide a way of authenticating messages by means of hash functions. The HMAC algorithms consist in calling the SHA-1, SHA-224, SHA-256 or MD5 hash function twice.

3.34 Public key accelerator (PKA)

The public key accelerator (PKA) is intended for the computation of cryptographic public key primitives, specifically those related to RSA, Diffie-Hellmann or ECC (elliptic curve cryptography) over GF(p) (Galois fields). To achieve high performance at a reasonable cost, these operations are executed in the Montgomery domain.

All needed computations are performed within the accelerator, so no further hardware/software elaboration is needed to process the inputs or the outputs.

PKA main features:

- Acceleration of RSA, DH and ECC over GF(p) operations, based on the Montgomery method for fast modular multiplications. More specifically:
 - RSA modular exponentiation, RSA Chinese remainder theorem (CRT) exponentiation
 - ECC scalar multiplication, point on curve check
 - ECDSA signature generation and verification
- Capability to handle operands up to 3136 bits for RSA/DH and 640 bits for ECC.
- Arithmetic and modular operations such as addition, subtraction, multiplication, modular reduction, modular inversion, comparison, and Montgomery multiplication.
- Built-in Montgomery domain inward and outward transformations
- AMBA AHB slave peripheral, accessible through 32-bit word single accesses only (otherwise, for writes, an AHB bus error is generated, and write accesses are ignored).

3.35 Timers and watchdogs

The devices include two advanced control timers, up to nine general-purpose timers, two basic timers, two low-power timers, two watchdog timers and a SysTick timer.

Table 10 below compares the features of the advanced control, general-purpose and basic timers.



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DMA Capture/ Counter Counter **Prescaler** Complementary Timer type Timer request compare resolution type factor outputs generation channels Any integer Advanced Up, down, TIM1, TIM8 16-bit between 1 Yes 4 3 control Up/down and 65536 Any integer General-Up, down, TIM2, TIM5 32-bit between 1 Yes 4 No Up/down purpose and 65536 Any integer General-Up, down, TIM3, TIM4 16-bit between 1 Yes 4 No purpose Up/down and 65536 Any integer General-TIM15 16-bit Up between 1 Yes 2 1 purpose and 65536 Any integer General-**TIM16, TIM17** between 1 16-bit Up Yes 1 1 purpose and 65536 Any integer TIM6, TIM7 16-bit 0 Basic Up between 1 Yes No and 65536

Table 10. Timer feature comparison

3.35.1 Advanced-control timer (TIM1, TIM8)

The advanced-control timers can each be seen as a three-phase PWM multiplexed on six channels. They have complementary PWM outputs with programmable inserted dead-times. They can also be seen as complete general-purpose timers.

The four independent channels can be used for:

- Input capture
- Output compare
- PWM generation (edge or center-aligned modes) with full modulation capability (0-100%)
- · One-pulse mode output

In debug mode, the advanced-control timer counter can be frozen and the PWM outputs disabled in order to turn off any power switches driven by these outputs.

Many features are shared with the general-purpose TIMx timers (described in Section 3.35.2) using the same architecture, so the advanced-control timers can work together with the TIMx timers via the Timer Link feature for synchronization or event chaining.



3.35.2 General-purpose timers (TIM2, TIM3, TIM4, TIM5, TIM15, TIM16, TIM17)

There are up to seven synchronizable general-purpose timers embedded in the devices (see *Table 10* for differences).

Each general-purpose timer can be used to generate PWM outputs, or act as a simple time base.

TIM2, TIM3, TIM4 and TIM5

They are full-featured general-purpose timers:

- TIM2 and TIM5 have a 32-bit auto-reload up/downcounter and 32-bit prescaler
- TIM3 and TIM4 have 16-bit auto-reload up/downcounter and 16-bit prescaler.

These timers feature four independent channels for input capture/output compare, PWM or one-pulse mode output. They can work together, or with the other general-purpose timers via the Timer Link feature for synchronization or event chaining.

The counters can be frozen in debug mode.

All have independent DMA request generation and support quadrature encoders.

TIM15, 16 and 17

They are general-purpose timers with mid-range features:

They have 16-bit auto-reload upcounters and 16-bit prescalers.

- TIM15 has two channels and one complementary channel
- TIM16 and TIM17 have one channel and one complementary channel

All channels can be used for input capture/output compare, PWM or one-pulse mode output.

The timers can work together via the Timer Link feature for synchronization or event chaining. The timers have independent DMA request generation.

The counters can be frozen in debug mode.

3.35.3 Basic timers (TIM6 and TIM7)

The basic timers are mainly used for DAC trigger generation. They can also be used as generic 16-bit timebases.

3.35.4 Low-power timer (LPTIM1 and LPTIM2)

The devices embed two low-power timers. These timers have an independent clock and are running in Stop mode if they are clocked by LSE, LSI or an external clock. They are able to wakeup the system from Stop mode.

LPTIM1 and LPTIM2 can be active in Stop 0, Stop 1 and Stop 2 modes.

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This low-power timer supports the following features:

- 16-bit up counter with 16-bit autoreload register
- 16-bit compare register
- Configurable output: pulse, PWM
- Continuous/ one shot mode
- Selectable software/hardware input trigger
- Selectable clock source
 - Internal clock sources: LSE, LSI, HSI16 or APB clock
 - External clock source over LPTIM input (working even with no internal clock source running, used by pulse counter application).
- Programmable digital glitch filter
- Encoder mode (LPTIM1 only)
- Repetition counter.

3.35.5 Independent watchdog (IWDG)

The independent watchdog is based on a 12-bit downcounter and an 8-bit prescaler. It is clocked from an independent 32 kHz internal RC (LSI) and as it operates independently from the main clock, it can operate in Stop and Standby modes. It can be used either as a watchdog to reset the device when a problem occurs, or as a free running timer for application timeout management. It is hardware or software configurable through the option bytes. The counter can be frozen in debug mode.

3.35.6 Window watchdog (WWDG)

The window watchdog is based on a 7-bit downcounter that can be set as free running. It can be used as a watchdog to reset the device when a problem occurs. It is clocked from the main clock. It has an early warning interrupt capability and the counter can be frozen in debug mode.

3.35.7 SysTick timer

This timer is dedicated to real-time operating systems, but could also be used as a standard down counter. It features:

- A 24-bit down counter
- Autoreload capability
- Maskable system interrupt generation when the counter reaches 0.
- Programmable clock source

3.36 Real-time clock (RTC) and backup registers

The RTC is an independent BCD timer/counter. It supports the following features:

- Calendar with subsecond, seconds, minutes, hours (12 or 24 format), week day, date, month, year, in BCD (binary-coded decimal) format
- Automatic correction for 28, 29 (leap year), 30, and 31 days of the month
- Two programmable alarms
- On-the-fly correction from 1 to 32767 RTC clock pulses. This can be used to synchronize it with a master clock
- Reference clock detection: a more precise second source clock (50 or 60 Hz) can be used to enhance the calendar precision
- Digital calibration circuit with 0.95 ppm resolution, to compensate for quartz crystal inaccuracy
- Three anti-tamper detection pins with programmable filter
- Timestamp feature which can be used to save the calendar content. This function can be triggered by an event on the timestamp pin, or by a tamper event, or by a switch to VBAT mode
- 17-bit auto-reload wakeup timer (WUT) for periodic events with programmable resolution and period

The RTC and the 32 backup registers are supplied through a switch that takes power either from the V_{DD} supply when present or from the VBAT pin.

The backup registers are 32-bit registers used to store 128 bytes of user application data when VDD power is not present. They are not reset by a system or power reset, or when the device wakes up from standby or Shutdown mode.

The RTC clock sources can be:

- A 32.768 kHz external crystal (LSE)
- An external resonator or oscillator (LSE)
- The internal low-power RC oscillator (LSI, with typical frequency of 32 kHz)
- The high-speed external clock (HSE) divided by 32

The RTC is functional in VBAT mode and in all low-power modes when it is clocked by the LSE. When clocked by the LSI, the RTC is not functional in VBAT mode, but is functional in all low-power modes except Shutdown mode.

All RTC events (alarm, wake-up timer, Timestamp or Tamper) can generate an interrupt and wakeup the device from the low-power modes.



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3.37 Inter-integrated circuit interface (I2C)

The device embeds four I2C. Refer to *Table 11: I2C implementation* for the features implementation.

The I²C bus interface handles communications between the microcontroller and the serial I²C bus. It controls all I²C bus-specific sequencing, protocol, arbitration and timing.

The I2C peripheral supports:

- I²C-bus specification and user manual rev. 5 compatibility:
 - Slave and master modes, multimaster capability
 - Standard-mode (Sm), with a bitrate up to 100 kbit/s
 - Fast-mode (Fm), with a bitrate up to 400 kbit/s
 - Fast-mode plus (Fm+), with a bitrate up to 1 Mbit/s and 20 mA output drive I/Os
 - 7-bit and 10-bit addressing mode, multiple 7-bit slave addresses
 - Programmable setup and hold times
 - Optional clock stretching
- System management bus (SMBus) specification rev 2.0 compatibility:
 - Hardware PEC (packet error checking) generation and verification with ACK control
 - Address resolution protocol (ARP) support
 - SMBus alert
- Power system management protocol (PMBusTM) specification rev 1.1 compatibility
- Independent clock: a choice of independent clock sources allowing the I2C communication speed to be independent from the PCLK reprogramming. Refer to Figure 4: Clock tree
- Wakeup from Stop mode on address match
- Programmable analog and digital noise filters
- 1-byte buffer with DMA capability

Table 11. I2C implementation

| I2C features ⁽¹⁾ | I2C1 | I2C2 | I2C3 | I2C4 |
|--|------|------|------|------|
| Standard-mode (up to 100 kbit/s) | Х | Х | Х | Х |
| Fast-mode (up to 400 kbit/s) | Х | Х | Х | Х |
| Fast-mode Plus with 20 mA output drive I/Os (up to 1 Mbit/s) | Х | Х | Х | Х |
| Programmable analog and digital noise filters | Х | Х | Х | Х |
| SMBus/PMBus hardware support | Х | Х | Х | Х |
| Independent clock | Х | Х | Х | Х |
| Wakeup from Stop 0, Stop 1 mode on address match | Х | Х | Х | Х |
| Wakeup from Stop 2 mode on address match | - | - | Х | - |

1. X: supported

3.38 Universal synchronous/asynchronous receiver transmitter (USART)

The devices have three embedded universal synchronous receiver transmitters (USART1, USART2 and USART3) and two universal asynchronous receiver transmitters (UART4, UART5).

These interfaces provide asynchronous communication, IrDA SIR ENDEC support, multiprocessor communication mode, single-wire half-duplex communication mode and have LIN master/slave capability. They provide hardware management of the CTS and RTS signals, and RS485 driver enable. They are able to communicate at speeds of up to 10 Mbit/s.

The USART1, USART2 and USART3 also provide a Smartcard mode (ISO 7816 compliant) and an SPI-like communication capability.

All USART have a clock domain independent from the CPU clock, allowing the USARTx (x=1,2,3,4,5) to wake up the MCU from Stop mode using baudrates up to 200 Kbaud. The wake up events from Stop mode are programmable and can be:

- Start bit detection
- Any received data frame
- A specific programmed data frame

All USART interfaces can be served by the DMA controller.

USART modes/features⁽¹⁾ USART1 USART2 USART3 **UART4 UART5** LPUART1 Hardware flow control for modem Χ Χ Χ Χ Χ Χ Χ Χ Χ Χ Χ Χ Continuous communication using DMA Multiprocessor communication Χ Χ Χ Χ Χ Χ Synchronous mode Х Χ Х Smartcard mode Χ Χ Χ Χ Χ Х Χ Single-wire half-duplex communication Χ Х IrDA SIR ENDEC block Χ Χ Х Χ Х LIN mode Χ Χ Χ Χ Χ Dual clock domain Х Χ Х Χ Х Х Wakeup from Stop 0 / Stop 1 modes Х Х Х Χ Χ Х Wakeup from Stop 2 mode _ Χ Receiver timeout interrupt Х Х Х Х Χ Х Х Х Х Х Modbus communication Auto baud rate detection X (4 modes) Χ Driver enable Χ Χ Х Х Χ LPUART/USART data length 7, 8 and 9 bits

Table 12. USART/UART/LPUART features

^{1.} X = supported.



3.39 Low-power universal asynchronous receiver transmitter (LPUART)

The devices embed one low-power UART. The LPUART supports asynchronous serial communication with minimum power consumption. It supports half-duplex single-wire communication and modem operations (CTS/RTS). It allows multiprocessor communication.

The LPUART has a clock domain independent from the CPU clock, and can wakeup the system from Stop mode using baudrates up to 220 Kbaud. The wake up events from Stop mode are programmable and can be:

- Start bit detection
- Any received data frame
- A specific programmed data frame

Only a 32.768 kHz clock (LSE) is needed to allow LPUART communication up to 9600 baud. Therefore, even in Stop mode, the LPUART can wait for an incoming frame while having an extremely low energy consumption. Higher speed clock can be used to reach higher baudrates.

The LPUART interface can be served by the DMA controller.

3.40 Serial peripheral interface (SPI)

Three SPI interfaces allow communication up to slave modes, in half-duplex, full-duplex and simplex modes. The 3-bit prescaler gives eight master mode frequencies and the frame size is configurable from 4 bits to 16 bits. The SPI interfaces support NSS pulse mode, TI mode and hardware CRC calculation.

All SPI interfaces can be served by the DMA controller.

3.41 Serial audio interfaces (SAI)

The devices embed two SAI. Refer to *Table 13: SAI implementation* for the features implementation. The SAI bus interface handles communications between the microcontroller and the serial audio protocol.

The SAI peripheral supports:

- Two independent audio sub-blocks which can be transmitters or receivers with their respective FIFO.
- 8-word integrated FIFOs for each audio sub-block.
- Synchronous or asynchronous mode between the audio sub-blocks.
- Master or slave configuration independent for both audio sub-blocks.
- Clock generator for each audio block to target independent audio frequency sampling when both audio sub-blocks are configured in master mode.
- Data size configurable: 8-, 10-, 16-, 20-, 24-, 32-bit.
- Peripheral with large configurability and flexibility allowing to target as example the following audio protocol: I2S, LSB or MSB-justified, PCM/DSP, TDM, AC'97 and SPDIF out.



Up to 16 slots available with configurable size and with the possibility to select which
ones are active in the audio frame.

- Number of bits by frame may be configurable.
- Frame synchronization active level configurable (offset, bit length, level).
- First active bit position in the slot is configurable.
- LSB first or MSB first for data transfer.
- Mute mode.
- Stereo/Mono audio frame capability.
- Communication clock strobing edge configurable (SCK).
- Error flags with associated interrupts if enabled respectively.
 - Overrun and underrun detection.
 - Anticipated frame synchronization signal detection in slave mode.
 - Late frame synchronization signal detection in slave mode.
 - Codec not ready for the AC'97 mode in reception.
- Interruption sources when enabled:
 - Errors.
 - FIFO requests.
- DMA interface with two dedicated channels to handle access to the dedicated integrated FIFO of each SAI audio sub-block.

| SAI features ⁽¹⁾ | SAI1 | SAI2 |
|--|------------|------------|
| I2S, LSB or MSB-justified, PCM/DSP, TDM, AC'97 | Х | X |
| Mute mode | Х | Х |
| Stereo/Mono audio frame capability. | Х | Х |
| 16 slots | Х | Х |
| Data size configurable: 8-, 10-, 16-, 20-, 24-, 32-bit | Х | X |
| FIFO size | X (8 Word) | X (8 Word) |
| SPDIF | Х | X |
| PDM | Х | - |

Table 13. SAI implementation

3.42 Secure digital input/output and MultiMediaCards Interface (SDMMC)

The devices embed two SDMMC host interfaces. Each SDMMC host interface embeds a dedicated DMA controller allowing high-speed transfers between the interface and the other AHB slaves.

The SD/SDIO, MultiMediaCard (MMC) host interface (SDMMC) provides an interface between the AHB bus and SD memory cards, SDIO cards and MMC devices.

^{1.} X: supported

The SDMMC features include the following:

• Full compliance with MultiMediaCard System Specification Version 4.51. Card support for three different databus modes: 1-bit (default), 4-bit and 8-bit

- Full compatibility with previous versions of MultiMediaCards (backward compatibility)
- Full compliance with SD Memory Card Specifications Version 4.1. (SDR104 SDMMC_CK speed limited to maximum allowed IO speed, SPI mode and UHS-II mode not supported)
- Full compliance with SDIO Card Specification Version 4.0: card support for two different databus modes: 1-bit (default) and 4-bit. (SDR104 SDMMC_CK speed limited to maximum allowed IO speed, SPI mode and UHS-II mode not supported)
- Data transfer up to 104 Mbyte/s for the 8-bit mode (depending maximum allowed IO speed)
- Data and command output enable signals to control external bidirectional drivers.

3.43 Controller area network (CAN)

The CAN is compliant with the 2.0A and B (active) specifications with a bit rate of up to 1 Mbit/s. They can receive and transmit standard frames with 11-bit identifiers as well as extended frames with 29-bit identifiers. The CAN has three transmit mailboxes, two receive FIFOS with three stages and 28 shared scalable filter banks (all of them can be used even if one CAN is used). 256 bytes of SRAM are allocated.

The CAN peripheral supports:

- CAN protocol version 2.0 A, B Active
- Bit rates of up to 1 Mbit/s
- Transmission
 - Three transmit mailboxes
 - Configurable transmit priority
- Reception
 - Two receive FIFOs with three stages
 - Scalable filter banks: 28 filter banks
 - Identifier list feature
 - Configurable FIFO overrun
- Time-triggered communication option
 - Disable automatic retransmission mode
 - 16-bit free running timer
 - Time Stamp sent in last two data bytes
- Management
 - Maskable interrupts
 - Software-efficient mailbox mapping at a unique address space



3.44 Universal serial bus on-the-go full-speed (OTG_FS)

The devices embed an USB OTG full-speed device/host/OTG peripheral with integrated transceivers. The USB OTG FS peripheral is compliant with the USB 2.0 specification and with the OTG 2.0 specification. It has software-configurable endpoint setting and supports suspend/resume.

The USB OTG controller requires a dedicated 48 MHz clock that can be provided by the internal multispeed oscillator (MSI) automatically trimmed by 32.768 kHz external oscillator (LSE). This allows to use the USB device without external high speed crystal (HSE).

The major features are:

- Combined Rx and Tx FIFO size of 1.25 Kbytes with dynamic FIFO sizing
- Supports the session request protocol (SRP) and host negotiation protocol (HNP)
- One bidirectional control endpoint + 5 IN endpoints + 5 OUT endpoints
- Eight host channels with periodic OUT support
- HNP/SNP/IP inside (no need for any external resistor)
- Software configurable to OTG 1.3 and OTG 2.0 modes of operation
- OTG 2.0 Supports ADP (Attach detection Protocol)
- USB 2.0 LPM (Link Power Management) support
- Battery charging specification revision 1.2 support
- Internal FS OTG PHY support

For OTG/Host modes, a power switch is needed in case bus-powered devices are connected.

The synchronization for this oscillator can also be taken from the USB data stream itself (SOF signalization) which allows crystal less operation.

3.45 Development support

3.45.1 Serial wire JTAG debug port (SWJ-DP)

The Arm[®] SWJ-DP interface is embedded, and is a combined JTAG and serial wire debug port that enables either a serial wire debug or a JTAG probe to be connected to the target.

Debug is performed using two pins only instead of five required by the JTAG (JTAG pins could be re-used as GPIO with alternate function): the JTAG TMS and TCK pins are shared with SWDIO and SWCLK, respectively, and a specific sequence on the TMS pin is used to switch between JTAG-DP and SW-DP.



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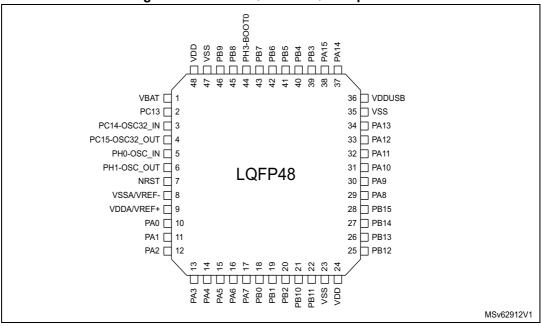
3.45.2 Embedded Trace Macrocell™

The Arm[®] Embedded Trace Macrocell provides a greater visibility of the instruction and data flow inside the CPU core by streaming compressed data at a very high rate from the devices through a small number of ETM pins to an external hardware trace port analyzer (TPA) device. Real-time instruction and data flow activity being recorded and then formatted for display on the host computer that runs the debugger software. TPA hardware is commercially available from common development tool vendors.

The Embedded Trace Macrocell operates with third party debugger software tools.

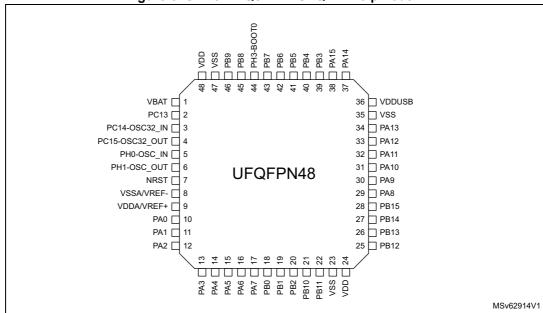
4 Pinouts and pin description

Figure 7. STM32L4Q5Cxxx LQFP48 pinout⁽¹⁾



1. The above figure shows the package top view.

Figure 8. STM32L4Q5Cxxx UFQFPN48 pinout(1)



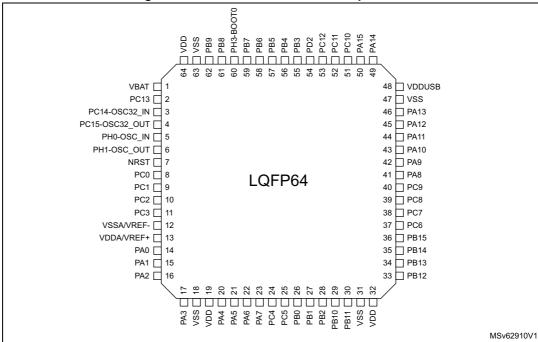


Figure 9. STM32L4Q5Rxxx LQFP64 pinout⁽¹⁾



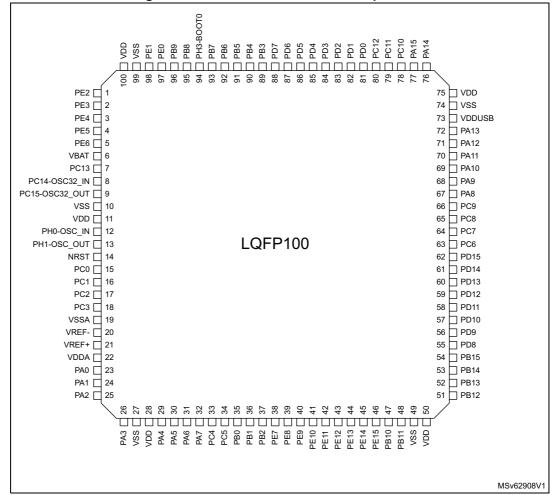


Figure 10. STM32L4Q5Vxxx LQFP100 pinout(1)



Figure 11. STM32L4Q5Vxxx WLCSP100 ballout⁽¹⁾

| | | iguio | | | | | .00 | 00 Dui | | |
|---|--------|-------|------|------|------|-----------|-------|--------|------|--------------------|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 |
| Α | VDDUSB | PA15 | PD1 | VDD | PG10 | VDDIO2 | PB6 | PB9 | vss | VDD |
| В | vss | PA14 | PD0 | PD4 | PG9 | PG12 | PB5 | PB8 | PE2 | PE3 |
| С | PA12 | PA13 | PC11 | PC12 | PD7 | PB3 | PB4 | PE4 | PC13 | VBAT |
| D | PA11 | PA10 | PA9 | PC10 | PD6 | PG11 | PB7 | PE5 | vss | PC14- OSC32_IN |
| E | PC8 | PC9 | PA8 | PD2 | PD5 | РН3-ВООТ0 | PE6 | NRST | VDD | PC15- OSC32_OUT |
| F | VDD | PC6 | PC7 | PD15 | PB2 | PA4 | PC3 | PC1 | PC0 | PH0-OSC_IN |
| G | PD10 | PD9 | PD14 | PE13 | PE12 | PA5 | VREF+ | VREF- | PA0 | PH1- OSC_OUT |
| н | PB15 | PB14 | PD8 | PE15 | PE10 | PC4 | PA2 | PA1 | VSSA | PC2 |
| J | PB12 | PB13 | PB11 | PE14 | PE9 | PB0 | PA7 | VDD | PA3 | VDDA |
| к | VDD | vss | PB10 | PE11 | PE8 | PE7 | PB1 | PC5 | PA6 | vss |
| | | | | | | | | | | |

Figure 12. STM32L4Q5Qxxx UFBGA132 ballout⁽¹⁾

| | | | | | | | XX 01 1 | | | | | |
|---|--------------------|------|-----------------|-----------------|-----|------|---------|------|------|------|--------|------|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 |
| A | PE3 | PE1 | PB8 | РН3-ВООТ0 | PD7 | PD5 | PB4 | PB3 | PA15 | PA14 | PA13 | PA12 |
| В | PE4 | PE2 | PB9 | PB7 | PB6 | PD6 | PD4 | PD3 | PD1 | PC12 | PC10 | PA11 |
| С | PC13 | PE5 | PE0 | VDD | PB5 | PG14 | PG13 | PD2 | PD0 | PC11 | VDDUSB | PA10 |
| D | PC14- OSC32_IN | PE6 | vss | PF2 | PF1 | PF0 | PG12 | PG10 | PG9 | PA9 | PA8 | PC9 |
| E | PC15- OSC32_OUT | VBAT | vss | PF3 | | - | | - | PG5 | PC8 | PC7 | PC6 |
| F | PH0-OSC_IN | vss | PF4 | PF5 | | vss | vss | | PG3 | PG4 | vss | vss |
| G | PH1- OSC_OUT | VDD | PG11 | PG6 | | VDD | VDDIO2 | | PG1 | PG2 | VDD | VDD |
| н | PC0 | NRST | VDD | PG7 | | | | | PG0 | PD15 | PD14 | PD13 |
| J | VSSA/VREF- | PC1 | PC2 | PA4 | PA7 | PG8 | PF12 | PF14 | PF15 | PD12 | PD11 | PD10 |
| к | PG15 | PC3 | PA2 | PA5 | PC4 | PF11 | PF13 | PD9 | PD8 | PB15 | PB14 | PB13 |
| L | VREF+ | PA0 | PA3 | PA6 | PC5 | PB2 | PE8 | PE10 | PE12 | PB10 | PB11 | PB12 |
| М | VDDA | PA1 | OPAMP1_VI NM | OPAMP2_VI NM | PB0 | PB1 | PE7 | PE9 | PE11 | PE13 | PE14 | PE15 |
| | | | • | | | | • | | | | • | MSve |

1. The above figure shows the package top view.



108 VDD 107 VSS PE2 [1 PE3 [2 107 | VSS 106 | VDDUSB 105 | PA13 104 | PA12 103 | PA11 PE4 3 PE5 🛚 4 PE6 🗆 5 VBAT ☐ 6 103 | PAT1 102 | PA10 101 | PA9 100 | PA8 99 | PC9 98 | PC8 97 | PC7 PC13 7 PC14-OSC32_IN 8 PC15-OSC32_OUT 🗖 9 PF0 | 10 PF1 | 11 PF2 | 12 PF3 | 13 PF4 | 14 96 PC6 95 | PC6 95 | VDDIO2 94 | VSS 93 | PG8 92 | PG7 91 | PG6 PF5 🛚 15 VSS | 16 VDD | 17 PF6 | 18 PF7 | 19 LQFP144 90 | PG5 89 | PG4 88 PG3 87 PG2 86 □ PD15 85 PD14 84 VDD PH1-OSC_OUT 24 NRST 🗆 25 PC0 🗆 26 83 🗆 VSS 82 | PD13 81 | PD12 80 | PD11 79 E PD10 78 🗖 PD9 VREF+ 32 77 DD8 VDDA ☐ 33 76 PB15 75 PB14 74 PB13 73 PB12 PA0 🗆 34 PA1 | 35 PA2 | 36 MSv62902V1

Figure 13. STM32L4Q5Zxxx LQFP144 pinout⁽¹⁾



Figure 14. STM32L4Q5Axxx UFBGA169 ballout⁽¹⁾

| | | | | | | | _ | | | | | | |
|---|--------------------|------------|------|-----------------|-----------|--------|------|------|------|------|------|--------|----------|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 |
| A | PI10 | PH2 | VDD | PE0 | PB4 | PB3 | vss | VDD | PA15 | PA14 | PA13 | P10 | PH14 |
| В | P19 | PI7 | vss | PE1 | PB5 | VDDIO2 | PG9 | PD0 | P16 | PI2 | PI1 | PH15 | PH12 |
| С | VDD | vss | PI11 | PB8 | PB6 | PG15 | PD4 | PD1 | PH13 | PI3 | PI8 | vss | VDD |
| D | PE4 | PE3 | PE2 | PB9 | PB7 | PG10 | PD5 | PD2 | PC10 | PI4 | PH9 | PH7 | PA12 |
| E | PC13 | VBAT | PE6 | PE5 | РН3-ВООТ0 | PG11 | PD6 | PD3 | PC11 | PI5 | PH6 | VDDUSB | PA11 |
| F | PC14- OSC32_IN | vss | PF2 | PF1 | PF0 | PG12 | PD7 | PC12 | PA10 | PA9 | PC6 | VDDIO2 | vss |
| G | PC15- OSC32_OUT | VDD | PF3 | PF4 | PF5 | PG14 | PG13 | PA8 | PC9 | PC8 | PG6 | PC7 | VDD |
| н | PH0-OSC_IN | vss | NRST | PF10 | PC4 | PG1 | PE10 | PB11 | PG8 | PG7 | PD15 | vss | VDD |
| J | PH1- OSC_OUT | PC0 | PC1 | PC2 | PC5 | PG0 | PE9 | PE15 | PG5 | PG4 | PG3 | PG2 | PD10 |
| к | PC3 | VSSA/VREF- | PA0 | PA5 | PB0 | PF15 | PE8 | PE14 | PH4 | PD14 | PD12 | PD11 | PD13 |
| L | VREF+ | VDDA | PA4 | PA7 | PB1 | PF14 | PE7 | PE13 | PH5 | PD9 | PD8 | VDD | vss |
| м | OPAMP1_VI NM | PA3 | vss | PA6 | PF11 | PF13 | vss | PE12 | PH10 | PH11 | vss | PB15 | PB14 |
| N | PA2 | PA1 | VDD | OPAMP2_VI NM | PB2 | PF12 | VDD | PE11 | PB10 | PH8 | VDD | PB12 | PB13 |
| | | | | • | | | • | • | • | | • | • | MSv62900 |



Table 14. Legend/abbreviations used in the pinout table

| Na | me | Abbreviation | Definition | | | | | | | |
|-----------|----------------------|---|---|--|--|--|--|--|--|--|
| Pin r | name | Unless otherwise specified in brackets below the pin name, the pin function during and after reset is the same as the actual pin name | | | | | | | | |
| | | S | Supply pin | | | | | | | |
| Pin | type | I | Input only pin | | | | | | | |
| | | I/O | Input / output pin | | | | | | | |
| | | FT | 5 V tolerant I/O | | | | | | | |
| | | TT | 3.6 V tolerant I/O | | | | | | | |
| | | В | Dedicated BOOT0 pin | | | | | | | |
| | | RST | Bidirectional reset pin with embedded weak pull-up resistor | | | | | | | |
| I/O str | ructure | Option for TT or FT I/Os | | | | | | | | |
| | | _f ⁽¹⁾ | I/O, Fm+ capable | | | | | | | |
| | | _u ⁽²⁾ | I/O, with USB function supplied by V _{DDUSB} | | | | | | | |
| | | _a ⁽³⁾ | I/O, with Analog switch function supplied by V _{DDA} | | | | | | | |
| | | _s ⁽⁴⁾ | I/O supplied only by V _{DDIO2} | | | | | | | |
| No | otes | Unless otherwise specified by a note, all I/Os are set as analog inputs during and after reset. | | | | | | | | |
| Pin | Alternate functions | Function | ns selected through GPIOx_AFR registers | | | | | | | |
| functions | Additional functions | Functions direc | tly selected/enabled through peripheral registers | | | | | | | |

^{1.} The related I/O structures are: FT_f, FT_fa, FT_fl, FT_fla.

^{2.} The related I/O structures are: FT_u, FT_lu.

^{3.} The related I/O structures are: FT_a, FT_la, FT_fa, FT_fla, TT_a, TT_la.

^{4.} The related I/O structures are: FT_s, FT_fs.

| | | | | | | Ta | able 1 | 5. STM32L40 |)5xx p | oin de | finit | ions | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| | | | Pin N | umber | | | | | | | | | |
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | D3 | - | M11 | VSS | S | - | - | - | - |
| - | - | 1 | - | 1 | C4 | - | C1 | VDD | S | - | ı | - | - |
| - | 1 | - | - | - | - | - | C3 | PI11 | I/O | FT | - | OCTOSPIM_P2_IO0, PSSI_D15, EVENTOUT | - |
| - | - | - | В9 | 1 | B2 | 1 | D3 | PE2 | I/O | FT_I | - | TRACECK, TIM3_ETR, SAI1_CK1, TSC_G7_IO1, LCD_R7, FMC_A23, SAI1_MCLK_A, EVENTOUT | - |
| - | 1 | - | B10 | 2 | A1 | 2 | D2 | PE3 | I/O | FT_I | - | TRACED0, TIM3_CH1, OCTOSPIM_P1_DQS, TSC_G7_IO2, LCD_R6, FMC_A19, SAI1_SD_B, EVENTOUT | - |
| - | - | - | C8 | 3 | B1 | 3 | D1 | PE4 | I/O | FT | - | TRACED1, TIM3_CH2, SAI1_D2, DFSDM1_DATIN3, TSC_G7_IO3, DCMI_D4/PSSI_D4, LCD_B7, FMC_A20, SAI1_FS_A, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|------------|---|------------------------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | D8 | 4 | C2 | 4 | E4 | PE5 | I/O | FT | - | TRACED2, TIM3_CH3, SAI1_CK2, DFSDM1_CKIN3, TSC_G7_IO4, DCMI_D6/PSSI_D6, LCD_G7, FMC_A21, SAI1_SCK_A, EVENTOUT | - |
| - | - | - | E7 | 5 | D2 | 5 | E3 | PE6 | I/O | FT | - | TRACED3, TIM3_CH4, SAI1_D1, DCMI_D7/PSSI_D7, LCD_G6, FMC_A22, SAI1_SD_A, EVENTOUT | RTC_TAMP3,WKUP3 |
| 1 | 1 | 1 | C10 | 6 | E2 | 6 | E2 | VBAT | S | - | - | - | - |
| 2 | 2 | 2 | C9 | 7 | C1 | 7 | E1 | PC13 | I/O | FT | (1) (2) | EVENTOUT | RTC_TAMP1/RTC_TS/R TC_OUT,WKUP2 |
| 3 | 3 | 3 | D10 | 8 | D1 | 8 | F1 | PC14- OSC32_IN (PC14) | I/O | FT | (1) (2) | EVENTOUT | OSC32_IN |
| 4 | 4 | 4 | E10 | 9 | E1 | 9 | G1 | PC15- OSC32_OUT (PC15) | I/O | FT | (1) (2) | EVENTOUT | OSC32_OUT |
| - | - | - | - | - | D6 | 10 | F5 | PF0 | I/O | FT_f | - | I2C2_SDA, OCTOSPIM_P2_IO0, FMC_A0, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued) Pin Number //O structure Pin type Pin name Notes WLCSP100 UFBGA169 **UFQFPN48** LQFP100 UFBGA132 (function **Additional functions** LQFP144 Alternate functions LQFP48 LQFP64 after reset) I2C2 SCL, PF1 FT f OCTOSPIM P2 IO1, D5 11 F4 I/O FMC A1, EVENTOUT I2C2_SMBA, FT D4 12 F3 PF2 I/O OCTOSPIM P2 IO2, FMC A2, EVENTOUT OCTOSPIM_P2_IO3, FT E4 13 G3 PF3 I/O FMC A3, EVENTOUT OCTOSPIM_P2_CLK, FT F3 14 G4 PF4 I/O FMC A4, EVENTOUT OCTOSPIM P2 NCLK, FT F4 15 G5 PF5 I/O FMC A5, EVENTOUT D9 10 F2 16 F2 VSS S G2 S E9 11 G2 17 VDD TIM5 ETR, TIM5 CH1, FT OCTOSPIM P1 IO3, 18 PF6 I/O SAI1 SD B, EVENTOUT TIM5 CH2, 19 PF7 I/O FT OCTOSPIM P1 IO2, SAI1 MCLK B, EVENTOUT TIM5 CH3, OCTOSPIM P1 IO0, PF8 FT

I/O

SAI1 SCK B, EVENTOUT

20



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin Nu | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | - | 21 | - | PF9 | I/O | FT | - | TIM5_CH4, OCTOSPIM_P1_IO1, SAI1_FS_B, TIM15_CH1, EVENTOUT | - |
| - | 1 | • | ı | - | - | 22 | H4 | PF10 | I/O | FT | - | OCTOSPIM_P1_CLK, PSSI_D15, DFSDM1_CKOUT, DCMI_D11/PSSI_D11, SAI1_D3, TIM15_CH2, EVENTOUT | - |
| 5 | 5 | 5 | F10 | 12 | F1 | 23 | H1 | PH0-OSC_IN (PH0) | I/O | FT | - | EVENTOUT | OSC_IN |
| 6 | 6 | 6 | G10 | 13 | G1 | 24 | J1 | PH1- OSC_OUT (PH1) | I/O | FT | - | EVENTOUT | OSC_OUT |
| 7 | 7 | 7 | E8 | 14 | H2 | 25 | НЗ | NRST | I-O | RST | - | - | - |
| - | - | 8 | F9 | 15 | H1 | 26 | J2 | PC0 | I/O | FT_f la | - | LPTIM1_IN1, I2C3_SCL, SDMMC2_CKIN, LPUART1_RX, LCD_DE, SDMMC1_CMD, SAI2_FS_A, LPTIM2_IN1, EVENTOUT | ADC12_IN1 |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | 9 | F8 | 16 | J2 | 27 | J3 | PC1 | I/O | FT_f la | - | TRACED0, LPTIM1_OUT, SPI2_MOSI, I2C3_SDA, LPUART1_TX, OCTOSPIM_P1_IO4, SAI1_SD_A, EVENTOUT | ADC12_IN2 |
| - | | 10 | H10 | 17 | J3 | 28 | J4 | PC2 | I/O | FT_I a | • | LPTIM1_IN2, SPI2_MISO, DFSDM1_CKOUT, OCTOSPIM_P1_IO5, LCD_HSYNC, EVENTOUT | ADC12_IN3 |
| - | - | 11 | F7 | 18 | K2 | 29 | K1 | PC3 | I/O | FT_ a | - | LPTIM1_ETR, SAI1_D1, SPI2_MOSI, OCTOSPIM_P1_IO6, SAI1_SD_A, LPTIM2_ETR, EVENTOUT | ADC12_IN4 |
| - | - | - | H9 | 19 | - | 30 | - | VSSA | S | - | - | - | - |
| - | - | - | G8 | 20 | - | 31 | - | VREF- | S | - | - | - | - |
| 8 | 8 | 12 | - | - | J1 | - | K2 | VSSA/VREF- | S | - | - | - | - |
| - | - | - | G7 | 21 | L1 | 32 | L1 | VREF+ | S | - | - | - | VREFBUF_OUT |
| - | 1 | - | J10 | 22 | M1 | 33 | L2 | VDDA | S | - | 1 | - | - |
| 9 | 9 | 13 | - | - | - | - | - | VDDA/VREF + | S | - | - | - | - |





Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|---|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 10 | 10 | 14 | G9 | 23 | L2 | 34 | КЗ | PA0 | I/O | FT_ a | - | TIM2_CH1, TIM5_CH1, TIM8_ETR, USART2_CTS_NSS, UART4_TX, SAI1_EXTCLK, TIM2_ETR, EVENTOUT | OPAMP1_VINP, ADC12_IN5, RTC_TAMP2,WKUP1 |
| - | 1 | 1 | - | - | МЗ | - | M1 | OPAMP1_VI NM | I | TT | - | - | - |
| 11 | 11 | 15 | Н8 | 24 | M2 | 35 | N2 | PA1 | I/O | FT_I a | - | TIM2_CH2, TIM5_CH2, I2C1_SMBA, SPI1_SCK, USART2_RTS_DE, UART4_RX, OCTOSPIM_P1_DQS, SDMMC2_CMD, TIM15_CH1N, EVENTOUT | OPAMP1_VINM, ADC12_IN6 |
| 12 | 12 | 16 | H7 | 25 | К3 | 36 | N1 | PA2 | I/O | FT_I a | - | TIM2_CH3, TIM5_CH3, USART2_TX, LPUART1_TX, OCTOSPIM_P1_NCS, SAI2_EXTCLK, TIM15_CH1, EVENTOUT | ADC12_IN7, WKUP4/LSCO |
| 13 | 13 | 17 | J9 | 26 | L3 | 37 | M2 | PA3 | I/O | TT_ a | - | TIM2_CH4, TIM5_CH4, SAI1_CK1, USART2_RX, LPUART1_RX, OCTOSPIM_P1_CLK, SAI1_MCLK_A, TIM15_CH2, EVENTOUT | OPAMP1_VOUT, ADC12_IN8 |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | 18 | K10 | 27 | E3 | 38 | H2 | VSS | S | - | - | - | - |
| - | • | 19 | J8 | 28 | Н3 | 39 | N3 | VDD | S | - | - | - | - |
| 14 | 14 | 20 | F6 | 29 | J4 | 40 | L3 | PA4 | I/O | TT_ a | - | OCTOSPIM_P1_NCS, SPI1_NSS, SPI3_NSS, USART2_CK, DCMI_HSYNC/PSSI_DE, LCD_CLK, SAI1_FS_B, LPTIM2_OUT, EVENTOUT | ADC12_IN9, DAC1_OUT1 |
| 15 | 15 | 21 | G6 | 30 | K4 | 41 | K4 | PA5 | I/O | TT_ a | - | TIM2_CH1, TIM2_ETR, TIM8_CH1N, PSSI_D14, SPI1_SCK, LCD_R7, LPTIM2_ETR, EVENTOUT | ADC12_IN10, DAC1_OUT2 |
| 16 | 16 | 22 | K9 | 31 | L4 | 42 | M4 | PA6 | I/O | FT_ a | - | TIM1_BKIN, TIM3_CH1, TIM8_BKIN, DCMI_PIXCLK/PSSI_PDCK , SPI1_MISO, USART3_CTS_NSS, LPUART1_CTS, OCTOSPIM_P1_IO3, TIM16_CH1, EVENTOUT | OPAMP2_VINP, ADC12_IN11 |
| - | - | - | - | - | M4 | - | N4 | OPAMP2_VI NM | ı | TT | - | - | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | 102L4Q0XX p | | | Ì | , | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|---------------------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 17 | 17 | 23 | J7 | 32 | J5 | 43 | L4 | PA7 | I/O | FT_f la | - | TIM1_CH1N, TIM3_CH2, TIM8_CH1N, I2C3_SCL, SPI1_MOSI, OCTOSPIM_P1_IO2, TIM17_CH1, EVENTOUT | OPAMP2_VINM, ADC12_IN12 |
| - | - | 24 | Н6 | 33 | K5 | 44 | H5 | PC4 | I/O | FT_ a | - | OCTOSPIM_P2_NCS, USART3_TX, OCTOSPIM_P1_IO7, EVENTOUT | COMP1_INM, ADC12_IN13 |
| - | - | 25 | K8 | 34 | L5 | 45 | J5 | PC5 | I/O | FT_ a | (3) | SAI1_D3, PSSI_D15, USART3_RX, LCD_CLK, EVENTOUT | COMP1_INP, ADC12_IN14, WKUP5 |
| 18 | 18 | 26 | J6 | 35 | M5 | 46 | K5 | PB0 | I/O | TT_I a | - | TIM1_CH2N, TIM3_CH3, TIM8_CH2N, SPI1_NSS, USART3_CK, OCTOSPIM_P1_IO1, LCD_B6, COMP1_OUT, SAI1_EXTCLK, EVENTOUT | OPAMP2_VOUT, ADC12_IN15 |
| 19 | 19 | 27 | K7 | 36 | M6 | 47 | L5 | PB1 | I/O | FT_ a | - | TIM1_CH3N, TIM3_CH4, TIM8_CH3N, DFSDM1_DATIN0, USART3_RTS_DE, LPUART1_RTS_DE, OCTOSPIM_P1_IO0, LCD_G6, LPTIM2_IN1, EVENTOUT | COMP1_INM, ADC12_IN16 |

Pin Number

LQFP100

37

WLCSP100

F5

LQFP64

28

UFQFPN48

20

LQFP48

20

| Т | able 1 | 5. STN | 132L4Q5xx p | in de | finitic | ns (| continued) | |
|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| L6 | 48 | N5 | PB2 | I/O | FT_ a | - | RTC_OUT2, LPTIM1_OUT, I2C3_SMBA, DFSDM1_CKIN0, OCTOSPIM_P1_DQS, EVENTOUT | COMP1_INP |
| K6 | 49 | M5 | PF11 | I/O | FT | - | OCTOSPIM_P1_NCLK, LCD_DE, DCMI_D12/PSSI_D12, EVENTOUT | - |
| J7 | 50 | N6 | PF12 | I/O | FT | - | OCTOSPIM_P2_DQS, LCD_B0, FMC_A6, EVENTOUT | - |
| E3 | 51 | H2 | VSS | S | 1 | ı | - | - |
| H3 | 52 | N7 | VDD | S | - | - | - | - |
| K7 | 53 | М6 | PF13 | I/O | FT | - | I2C4_SMBA, LCD_B1, FMC_A7, EVENTOUT | - |

PF14

PF15

PG0

54

55

56

J8

J9

Н9

L6

K6

J6

I/O

I/O

FT_f

FT

I/O FT_f

I2C4_SCL, TSC_G8_IO1, LCD_G0, FMC_A8, EVENTOUT

I2C4_SDA, TSC_G8_IO2, LCD_G1, FMC_A9, EVENTOUT

OCTOSPIM_P2_IO4, TSC_G8_IO3, FMC_A10, EVENTOUT



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | 102L+Q0XX p | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | G9 | 57 | H6 | PG1 | I/O | FT | - | OCTOSPIM_P2_IO5, TSC_G8_IO4, FMC_A11, EVENTOUT | - |
| - | - | - | K6 | 38 | M7 | 58 | L7 | PE7 | I/O | FT | - | TIM1_ETR, DFSDM1_DATIN2,LCD_B6, FMC_D4, SAI1_SD_B, EVENTOUT | - |
| - | - | - | K5 | 39 | L7 | 59 | K7 | PE8 | I/O | FT | - | TIM1_CH1N, DFSDM1_CKIN2, LCD_B7, FMC_D5, SAI1_SCK_B, EVENTOUT | - |
| - | - | - | J5 | 40 | M8 | 60 | J7 | PE9 | I/O | FT | - | TIM1_CH1, DFSDM1_CKOUT, OCTOSPIM_P1_NCLK, LCD_G2, FMC_D6, SAI1_FS_B, EVENTOUT | - |
| - | - | - | - | - | F6 | 61 | M7 | VSS | S | - | - | - | - |
| - | - | - | - | - | G6 | 62 | N7 | VDD | S | - | - | - | - |
| - | - | - | H5 | 41 | L8 | 63 | H7 | PE10 | I/O | FT | - | TIM1_CH2N, TSC_G5_IO1, OCTOSPIM_P1_CLK, LCD_G3, FMC_D7, SAI1_MCLK_B, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | K4 | 42 | M9 | 64 | N8 | PE11 | I/O | FT | - | TIM1_CH2, TSC_G5_IO2, OCTOSPIM_P1_NCS, LCD_G4, FMC_D8, EVENTOUT | - |
| - | - | 1 | G5 | 43 | L9 | 65 | M8 | PE12 | I/O | FT | - | TIM1_CH3N, SPI1_NSS, TSC_G5_IO3, OCTOSPIM_P1_IO0, LCD_G5, FMC_D9, EVENTOUT | - |
| - | - | 1 | G4 | 44 | M10 | 66 | L8 | PE13 | I/O | FT | - | TIM1_CH3, SPI1_SCK, TSC_G5_IO4, OCTOSPIM_P1_IO1, LCD_G6, FMC_D10, EVENTOUT | - |
| - | - | - | J4 | 45 | M11 | 67 | K8 | PE14 | I/O | FT | - | TIM1_CH4, TIM1_BKIN2, SPI1_MISO, OCTOSPIM_P1_IO2, LCD_G7, FMC_D11, EVENTOUT | - |
| - | - | - | H4 | 46 | M12 | 68 | J8 | PE15 | I/O | FT | - | TIM1_BKIN, SPI1_MOSI, OCTOSPIM_P1_IO3, LCD_R2, FMC_D12, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 21 | 21 | 29 | К3 | 47 | L10 | 69 | N9 | PB10 | I/O | FT_f | - | TIM2_CH3, I2C4_SCL, I2C2_SCL, SPI2_SCK, OCTOSPIM_P1_IO3, USART3_TX, LPUART1_RX, TSC_SYNC, OCTOSPIM_P1_CLK, COMP1_OUT, SAI1_SCK_A, EVENTOUT | - |
| 22 | 22 | 30 | J3 | 48 | L11 | 70 | Н8 | PB11 | I/O | FT_f | (3) | TIM2_CH4, I2C4_SDA, I2C2_SDA, USART3_RX, LPUART1_TX, OCTOSPIM_P1_NCS, LCD_VSYNC, COMP2_OUT, EVENTOUT | • |
| - | - | - | - | - | - | - | K9 | PH4 | I/O | FT_f | - | I2C2_SCL, OCTOSPIM_P2_DQS, PSSI_D14, EVENTOUT | - |
| - | - | - | - | - | - | - | L9 | PH5 | I/O | FT_f | - | I2C2_SDA, DCMI_PIXCLK/PSSI_PDCK , EVENTOUT | - |
| - | - | - | - | - | - | - | N10 | PH8 | I/O | FT_f | - | I2C3_SDA, OCTOSPIM_P2_IO3, DCMI_HSYNC/PSSI_DE, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | - | - | M9 | PH10 | I/O | FT | - | TIM5_CH1, OCTOSPIM_P2_IO5, DCMI_D1/PSSI_D1, EVENTOUT | - |
| - | 1 | - | - | - | - | - | M10 | PH11 | I/O | FT | (3) | TIM5_CH2, OCTOSPIM_P2_IO6, DCMI_D2/PSSI_D2, EVENTOUT | - |
| - | - | - | - | - | F6 | 1 | C2 | VSS | S | - | - | - | - |
| - | ı | ı | - | - | G6 | 1 | L12 | VDD | S | - | - | - | - |
| 23 | 23 | 31 | K2 | 49 | F12 | 71 | A7 | VSS | S | - | - | - | - |
| 24 | 24 | 32 | K1 | 50 | G12 | 72 | N11 | VDD | S | - | - | - | - |
| 25 | 25 | 33 | J1 | 51 | L12 | 73 | N12 | PB12 | I/O | FT | - | TIM1_BKIN, I2C2_SMBA, SPI2_NSS, DFSDM1_DATIN1, USART3_CK, LPUART1_RTS_DE, TSC_G1_IO1, OCTOSPIM_P1_NCLK, SDMMC2_CK, SAI2_FS_A, TIM15_BKIN, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 26 | 26 | 34 | J2 | 52 | K12 | 74 | N13 | PB13 | I/O | FT_f | - | TIM1_CH1N, I2C2_SCL, SPI2_SCK, DFSDM1_CKIN1, USART3_CTS_NSS, LPUART1_CTS, TSC_G1_IO2, OCTOSPIM_P1_IO1, SAI2_SCK_A, TIM15_CH1N, EVENTOUT | - |
| 27 | 27 | 35 | H2 | 53 | K11 | 75 | M13 | PB14 | 1/0 | FT_f | - | TIM1_CH2N, TIM8_CH2N, I2C2_SDA, SPI2_MISO, DFSDM1_DATIN2, USART3_RTS_DE, TSC_G1_IO3, OCTOSPIM_P1_IO6, SDMMC2_D0, SAI2_MCLK_A, TIM15_CH1, EVENTOUT | - |
| 28 | 28 | 36 | H1 | 54 | K10 | 76 | M12 | PB15 | I/O | FT | - | RTC_REFIN, TIM1_CH3N, TIM8_CH3N, SPI2_MOSI, DFSDM1_CKIN2, TSC_G1_IO4, OCTOSPIM_P1_IO7, SDMMC2_D1, SAI2_SD_A, TIM15_CH2, EVENTOUT | - |

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | НЗ | 55 | K9 | 77 | L11 | PD8 | I/O | FT | - | USART3_TX, DCMI_HSYNC/PSSI_DE, LCD_R3, FMC_D13, EVENTOUT | - |
| - | - | - | G2 | 56 | K8 | 78 | L10 | PD9 | I/O | FT | - | USART3_RX, DCMI_PIXCLK/PSSI_PDCK , LCD_R4, FMC_D14, SAI2_MCLK_A, EVENTOUT | - |
| - | - | - | G1 | 57 | J12 | 79 | J13 | PD10 | I/O | FT | - | USART3_CK, TSC_G6_IO1, LCD_R5, FMC_D15, SAI2_SCK_A, EVENTOUT | - |
| - | - | - | - | - | F11 | - | L13 | VSS | S | - | - | - | - |
| - | - | 1 | 1 | 1 | Н3 | - | H13 | VDD | S | - | - | - | - |
| - | - | - | - | 58 | J11 | 80 | K12 | PD11 | I/O | FT | - | I2C4_SMBA, USART3_CTS_NSS, TSC_G6_IO2, LCD_R6, FMC_A16, SAI2_SD_A, LPTIM2_ETR, EVENTOUT | - |
| - | - | - | - | 59 | J10 | 81 | K11 | PD12 | I/O | FT_f | - | TIM4_CH1, I2C4_SCL, USART3_RTS_DE, TSC_G6_IO3, LCD_R7, FMC_A17, SAI2_FS_A, LPTIM2_IN1, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | 60 | H12 | 82 | K13 | PD13 | I/O | FT_f | - | TIM4_CH2, I2C4_SDA, TSC_G6_IO4, FMC_A18, LPTIM2_OUT, EVENTOUT | - |
| - | - | - | - | 1 | F11 | 83 | H12 | VSS | S | - | - | - | - |
| - | - | - | F1 | 1 | Н3 | 84 | G13 | VDD | S | - | - | - | - |
| - | - | - | G3 | 61 | H11 | 85 | K10 | PD14 | I/O | FT | - | TIM4_CH3, LCD_B2, FMC_D0, EVENTOUT | - |
| - | - | - | F4 | 62 | H10 | 86 | H11 | PD15 | I/O | FT | - | TIM4_CH4, LCD_B3, FMC_D1, EVENTOUT | - |
| - | - | - | - | - | G10 | 87 | J12 | PG2 | I/O | FT_ s | - | SPI1_SCK, SDMMC2_D4, FMC_A12, SAI2_SCK_B, EVENTOUT | - |
| - | - | - | - | - | F9 | 88 | J11 | PG3 | I/O | FT_ s | - | SPI1_MISO, SDMMC2_D5, FMC_A13, SAI2_FS_B, EVENTOUT | - |
| - | - | - | - | - | F10 | 89 | J10 | PG4 | I/O | FT_ s | - | SPI1_MOSI, SDMMC2_D6, FMC_A14, SAI2_MCLK_B, EVENTOUT | - |
| - | - | - | - | - | E9 | 90 | J9 | PG5 | I/O | FT_ s | - | SPI1_NSS, LPUART1_CTS, SDMMC2_D7, FMC_A15, SAI2_SD_B, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | G4 | 91 | G11 | PG6 | I/O | FT_ s | - | OCTOSPIM_P1_DQS, I2C3_SMBA, LPUART1_RTS_DE, LCD_R1, EVENTOUT | - |
| - | - | - | - | - | H4 | 92 | H10 | PG7 | I/O | FT_f s | 1 | SAI1_CK1, I2C3_SCL, OCTOSPIM_P2_DQS, DFSDM1_CKOUT, LPUART1_TX, FMC_INT, SAI1_MCLK_A, EVENTOUT | - |
| - | - | - | - | - | J6 | 93 | Н9 | PG8 | I/O | FT_f s | - | I2C3_SDA, LPUART1_RX, EVENTOUT | - |
| - | - | - | - | - | F7 | 94 | F13 | VSS | S | 1 | - | - | - |
| - | - | - | - | - | G7 | 95 | F12 | VDDIO2 | S | - | - | - | - |
| - | - | - | F1 | - | НЗ | - | G13 | VDD_15 | - | - | - | - | - |
| - | - | 37 | F2 | 63 | E12 | 96 | F11 | PC6 | I/O | FT | - | TIM3_CH1, TIM8_CH1, DFSDM1_CKIN3, SDMMC2_D6, SDMMC1_D0DIR, TSC_G4_IO1, DCMI_D0/PSSI_D0, LCD_G7, SDMMC1_D6, SAI2_MCLK_A, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | 38 | F3 | 64 | E11 | 97 | G12 | PC7 | I/O | FT | - | TIM3_CH2, TIM8_CH2, DFSDM1_DATIN3, SDMMC2_D7, SDMMC1_D123DIR, TSC_G4_IO2, DCMI_D1/PSSI_D1, LCD_B6, SDMMC1_D7, SAI2_MCLK_B, EVENTOUT | - |
| - | - | 39 | E1 | 65 | E10 | 98 | G10 | PC8 | I/O | FT | - | TIM3_CH3, TIM8_CH3, TSC_G4_IO3, DCMI_D2/PSSI_D2, SDMMC1_D0, EVENTOUT | - |
| - | 1 | 40 | E2 | 66 | D12 | 99 | G9 | PC9 | I/O | FT_f | - | TRACED0, TIM8_BKIN2, TIM3_CH4, TIM8_CH4, DCMI_D3/PSSI_D3, I2C3_SDA, TSC_G4_IO4, OTG_FS_NOE, SDMMC1_D1, SAI2_EXTCLK, EVENTOUT | |
| 29 | 29 | 41 | E3 | 67 | D11 | 100 | G8 | PA8 | I/O | FT_f | - | MCO, TIM1_CH1, SAI1_CK2, USART1_CK, OTG_FS_SOF, LCD_B7, SAI1_SCK_A, LPTIM2_OUT, EVENTOUT | - |

| Table 15. STM | 132L4Q5xx p | in def | finitic | ns (| continued) |
|---------------|-------------|--------|---------|------|------------|
| | | | | | |

| | | | Pin Nu | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 30 | 30 | 42 | D3 | 68 | D10 | 101 | F10 | PA9 | I/O | FT_f lu | - | TIM1_CH2, SPI2_SCK, DCMI_D0/PSSI_D0, USART1_TX, LCD_G7, SAI1_FS_A, TIM15_BKIN, EVENTOUT | OTG_FS_VBUS |
| 31 | 31 | 43 | D2 | 69 | C12 | 102 | F9 | PA10 | I/O | FT_f | - | TIM1_CH3, SAI1_D1, DCMI_D1/PSSI_D1, USART1_RX, OTG_FS_ID, LCD_G6, SAI1_SD_A, TIM17_BKIN, EVENTOUT | - |
| 32 | 32 | 44 | D1 | 70 | B12 | 103 | E13 | PA11 | I/O | FT_ u | - | TIM1_CH4, TIM1_BKIN2, SPI1_MISO, USART1_CTS_NSS, CAN1_RX, OTG_FS_DM, LCD_DE, EVENTOUT | - |
| 33 | 33 | 45 | C1 | 71 | A12 | 104 | D13 | PA12 | I/O | FT_ u | - | TIM1_ETR, SPI1_MOSI, OCTOSPIM_P2_NCS, USART1_RTS_DE, CAN1_TX, OTG_FS_DP, LCD_VSYNC, EVENTOUT | - |
| 34 | 34 | 46 | C2 | 72 | A11 | 105 | A11 | PA13 (JTMS/SWDI O) | I/O | FT | (4) | JTMS/SWDIO, IR_OUT, OTG_FS_NOE, SAI1_SD_B, EVENTOUT | - |
| 35 | 35 | 47 | B1 | - | F11 | - | C12 | VSS | S | - | - | - | - |
| 36 | 36 | 48 | A1 | 73 | C11 | 106 | E12 | VDDUSB | S | - | - | - | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | B1 | 74 | F11 | 107 | C12 | VSS | S | - | - | - | - |
| - | - | - | F1 | 75 | G11 | 108 | C13 | VDD | S | - | - | - | - |
| - | - | - | - | - | - | - | E11 | PH6 | I/O | FT | - | I2C2_SMBA, OCTOSPIM_P2_CLK, DCMI_D8/PSSI_D8, EVENTOUT | - |
| - | - | - | - | - | - | - | D12 | PH7 | I/O | FT_f | - | I2C3_SCL, OCTOSPIM_P2_NCLK, DCMI_D9/PSSI_D9, EVENTOUT | - |
| - | - | - | - | - | - | - | D11 | PH9 | I/O | FT | - | I2C3_SMBA, OCTOSPIM_P2_IO4, DCMI_D0/PSSI_D0, EVENTOUT | - |
| - | - | - | - | - | - | - | B13 | PH12 | I/O | FT | - | TIM5_CH3, OCTOSPIM_P2_IO7, DCMI_D3/PSSI_D3, EVENTOUT | - |
| - | ı | - | - | - | - | ı | A13 | PH14 | I/O | FT | - | TIM8_CH2N, DCMI_D4/PSSI_D4, EVENTOUT | - |
| - | - | - | - | - | - | - | B12 | PH15 | I/O | FT | - | TIM8_CH3N, OCTOSPIM_P2_IO6, DCMI_D11/PSSI_D11, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | - | - | A12 | PI0 | I/O | FT | - | TIM5_CH4, OCTOSPIM_P1_IO5, SPI2_NSS, DCMI_D13/PSSI_D13, EVENTOUT | - |
| - | - | - | - | - | - | - | C11 | PI8 | I/O | FT | - | OCTOSPIM_P2_NCS, DCMI_D12/PSSI_D12, EVENTOUT | - |
| - | - | - | - | - | - | - | B11 | PI1 | I/O | FT | - | SPI2_SCK, DCMI_D8/PSSI_D8, EVENTOUT | - |
| - | - | - | - | - | - | - | B10 | PI2 | I/O | FT | - | TIM8_CH4, SPI2_MISO, DCMI_D9/PSSI_D9, EVENTOUT | - |
| - | - | - | - | - | - | - | C10 | PI3 | I/O | FT | - | TIM8_ETR, SPI2_MOSI, DCMI_D10/PSSI_D10, EVENTOUT | - |
| - | - | - | - | - | - | - | D10 | PI4 | I/O | FT | - | TIM8_BKIN, DCMI_D5/PSSI_D5, EVENTOUT | - |
| - | - | - | - | - | - | - | E10 | PI5 | I/O | FT | - | TIM8_CH1, OCTOSPIM_P2_NCS, DCMI_VSYNC/PSSI_RDY, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | - | - | С9 | PH13 | I/O | FT | - | TIM8_CH1N, CAN1_TX, EVENTOUT | - |
| - | - | - | - | - | - | - | В9 | PI6 | I/O | FT | - | TIM8_CH2, OCTOSPIM_P2_CLK, DCMI_D6/PSSI_D6, EVENTOUT | - |
| 37 | 37 | 49 | B2 | 76 | A10 | 109 | A10 | PA14 (JTCK/SWCL K) | I/O | FT | (4) | JTCK/SWCLK, LPTIM1_OUT, I2C1_SMBA, I2C4_SMBA, OTG_FS_SOF, SAI1_FS_B, EVENTOUT | - |
| 38 | 38 | 50 | A2 | 77 | A9 | 110 | A9 | PA15 (JTDI) | I/O | FT | (4) | JTDI, TIM2_CH1, TIM2_ETR, USART2_RX, SPI1_NSS, SPI3_NSS, USART3_RTS_DE, UART4_RTS_DE, TSC_G3_IO1, LCD_HSYNC, SAI2_FS_B, EVENTOUT | - |
| - | - | 51 | D4 | 78 | B11 | 111 | D9 | PC10 | I/O | FT | - | TRACED1, DCMI_VSYNC/PSSI_RDY, SPI3_SCK, USART3_TX, UART4_TX, TSC_G3_IO2, DCMI_D8/PSSI_D8, SDMMC1_D2, SAI2_SCK_B, EVENTOUT | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | 52 | C3 | 79 | C10 | 112 | E9 | PC11 | I/O | FT | - | DCMI_D2/PSSI_D2, OCTOSPIM_P1_NCS, SPI3_MISO, USART3_RX, UART4_RX, TSC_G3_IO3, DCMI_D4/PSSI_D4, SDMMC1_D3, SAI2_MCLK_B, EVENTOUT | - |
| - | - | 53 | C4 | 80 | B10 | 113 | F8 | PC12 | I/O | FT | - | TRACED3, SPI3_MOSI, USART3_CK, UART5_TX, TSC_G3_IO4, DCMI_D9/PSSI_D9, LCD_R6, SDMMC1_CK, SAI2_SD_B, EVENTOUT | - |
| - | - | 1 | В3 | 81 | C9 | 114 | В8 | PD0 | I/O | FT | - | SPI2_NSS, CAN1_RX, LCD_B4, FMC_D2, EVENTOUT | - |
| - | - | 1 | А3 | 82 | В9 | 115 | C8 | PD1 | I/O | FT | - | SPI2_SCK, CAN1_TX, LCD_B5, FMC_D3, EVENTOUT | - |
| - | - | 54 | E4 | 83 | C8 | 116 | D8 | PD2 | I/O | FT | (3) | TRACED2, TIM3_ETR, USART3_RTS_DE, UART5_RX, TSC_SYNC, DCMI_D11/PSSI_D11, SDMMC1_CMD, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | 84 | В8 | 117 | E8 | PD3 | I/O | FT | - | SPI2_SCK, DCMI_D5/PSSI_D5, SPI2_MISO, DFSDM1_DATIN0, USART2_CTS_NSS, OCTOSPIM_P2_NCS, LCD_CLK, FMC_CLK, EVENTOUT | - |
| - | - | - | B4 | 85 | В7 | 118 | C7 | PD4 | I/O | FT | - | SPI2_MOSI, DFSDM1_CKIN0, USART2_RTS_DE, SDMMC2_CKIN, OCTOSPIM_P1_IO4, FMC_NOE, EVENTOUT | - |
| - | - | - | E5 | 86 | A6 | 119 | D7 | PD5 | I/O | FT | - | USART2_TX, OCTOSPIM_P1_IO5, FMC_NWE, EVENTOUT | - |
| - | - | - | - | - | F11 | 120 | М3 | VSS | S | - | - | - | - |
| - | - | - | A4 | - | G11 | 121 | A8 | VDD | S | - | - | - | - |

Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin Nu | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | 1 | 1 | D5 | 87 | В6 | 122 | E7 | PD6 | I/O | FT | - | SAI1_D1, DCMI_D10/PSSI_D10, SPI3_MOSI, DFSDM1_DATIN1, USART2_RX, SDMMC2_CK, OCTOSPIM_P1_IO6, LCD_DE, FMC_NWAIT, SAI1_SD_A, EVENTOUT | - |
| - | 1 | ı | C5 | 88 | A5 | 123 | F7 | PD7 | I/O | FT | - | DFSDM1_CKIN1, USART2_CK, SDMMC2_CMD, OCTOSPIM_P1_IO7, FMC_NCE/FMC_NE1, EVENTOUT | - |
| - | 1 | 1 | B5 | - | D9 | 124 | В7 | PG9 | I/O | FT_ s | - | OCTOSPIM_P2_IO6, SPI3_SCK, USART1_TX, SDMMC2_D0, FMC_NCE/FMC_NE2, SAI2_SCK_A, TIM15_CH1N, EVENTOUT | - |
| - | - | - | A5 | - | D8 | 125 | D6 | PG10 | I/O | FT_ s | - | LPTIM1_IN1, OCTOSPIM_P2_IO7, SPI3_MISO, USART1_RX, SDMMC2_D1, FMC_NE3, SAI2_FS_A, TIM15_CH1, EVENTOUT | - |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | D6 | - | G3 | 126 | E6 | PG11 | I/O | FT_ s | - | LPTIM1_IN2, OCTOSPIM_P1_IO5, SPI3_MOSI, USART1_CTS_NSS, SDMMC2_D2, SAI2_MCLK_A, TIM15_CH2, EVENTOUT | - |
| - | 1 | - | В6 | - | D7 | 127 | F6 | PG12 | I/O | FT_ s | - | LPTIM1_ETR, OCTOSPIM_P2_NCS, SPI3_NSS, USART1_RTS_DE, SDMMC2_D3, FMC_NE4, SAI2_SD_A, EVENTOUT | - |
| - | - | - | - | - | C7 | 128 | G7 | PG13 | I/O | FT_f | - | I2C1_SDA, USART1_CK, LCD_R0, FMC_A24, EVENTOUT | - |
| - | - | - | - | - | C6 | 129 | G6 | PG14 | I/O | FT_f s | (3) | I2C1_SCL, LCD_R1, FMC_A25, EVENTOUT | - |
| - | - | - | - | - | F7 | 130 | A7 | VSS | S | - | - | - | - |
| - | ı | 1 | A6 | - | G7 | 131 | В6 | VDDIO2 | S | - | - | - | - |
| - | - | - | - | - | K1 | 132 | C6 | PG15 | I/O | FT_ s | (3) | LPTIM1_OUT, I2C1_SMBA, OCTOSPIM_P2_DQS, DCMI_D13/PSSI_D13, EVENTOUT | - |

| | Table 15. STM32L4Q5xx pin definitions (continued) | | | | | | | | | | | | | |
|----------|---|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|--|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions | |
| 39 | 39 | 55 | C6 | 89 | A8 | 133 | A6 | PB3 (JTDO/TRAC ESWO) | I/O | FT_I a | - | JTDO/TRACESWO, TIM2_CH2, OCTOSPIM_P1_IO4, SPI1_SCK, SPI3_SCK, USART1_RTS_DE, OTG_FS_CRS_SYNC, SDMMC2_D2, SAI1_SCK_B, EVENTOUT | COMP2_INM | |
| 40 | 40 | 56 | C7 | 90 | A7 | 134 | A5 | PB4 (NJTRST) | I/O | FT_f a | (4) | NJTRST, TIM3_CH1, OCTOSPIM_P1_IO5, I2C3_SDA, SPI1_MISO, SPI3_MISO, USART1_CTS_NSS, UART5_RTS_DE, TSC_G2_IO1, DCMI_D12/PSSI_D12, SDMMC2_D3, SAI1_MCLK_B, TIM17_BKIN, EVENTOUT | COMP2_INP | |
| 41 | 41 | 57 | В7 | 91 | C5 | 135 | B5 | PB5 | I/O | FT_I a | - | LPTIM1_IN1, TIM3_CH2, OCTOSPIM_P1_IO0, I2C1_SMBA, SPI1_MOSI, SPI3_MOSI, USART1_CK, UART5_CTS, TSC_G2_IO2, DCMI_D10/PSSI_D10, COMP2_OUT, SAI1_SD_B, TIM16_BKIN, EVENTOUT | - | |



Table 15. STM32L4Q5xx pin definitions (continued)

| | | | Pin N | umber | | | | 102Ε+Q3λλ μ | | | | | |
|----------|--------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|---|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| 42 | 42 | 58 | A7 | 92 | B5 | 136 | C5 | PB6 | I/O | FT_f a | - | LPTIM1_ETR, TIM4_CH1, TIM8_BKIN2, I2C1_SCL, I2C4_SCL, USART1_TX, TSC_G2_IO3, DCMI_D5/PSSI_D5, LCD_R6, SAI1_FS_B, TIM16_CH1N, EVENTOUT | COMP2_INP |
| 43 | 43 | 59 | D7 | 93 | В4 | 137 | D5 | PB7 | I/O | FT_f la | - | LPTIM1_IN2, TIM4_CH2, TIM8_BKIN, I2C1_SDA, I2C4_SDA, USART1_RX, UART4_CTS, TSC_G2_IO4, DCMI_VSYNC/PSSI_RDY, LCD_VSYNC, FMC_NL, TIM17_CH1N, EVENTOUT | COMP2_INM, PVD_IN |
| 44 | 44 | 60 | E6 | 94 | A4 | 138 | E5 | PH3-BOOT0 | I/O | FT | - | EVENTOUT | - |
| 45 | 45 | 61 | В8 | 95 | А3 | 139 | C4 | PB8 | I/O | FT_f | (3) | TIM4_CH3, SAI1_CK1, | - |

UFQFPN48

46

47

48

Table 15. STM32L4Q5xx pin definitions (continued) Pin Number //O structure Pin type Pin name Notes WLCSP100 UFBGA169 LQFP100 UFBGA132 (function **Additional functions** LQFP144 Alternate functions LQFP48 LQFP64 after reset) IR OUT, TIM4 CH4, SAI1 D2, I2C1 SDA, SPI2 NSS, SDMMC2 D5, SDMMC1_CDIR, CAN1_TX, PB9 I/O 46 62 A8 96 B3 140 D4 DCMI D7/PSSI D7, SDMMC1 D5, SAI1 FS A, TIM17 CH1, EVENTOUT TIM4 ETR, DCMI D2/PSSI D2, FT PE0 I/O 97 C3 141 A4 LCD HSYNC, FMC_NBL0, TIM16 CH1, EVENTOUT DCMI D3/PSSI D3, (3) PE1 FT LCD VSYNC, FMC NBL1, 98 142 B4 I/O A2 TIM17_CH1, EVENTOUT S 47 63 A9 99 D3 143 B3 VSS 48 64 A10 100 C4 144 A3 VDD S C4 А3 VDD S S D3 B3 VSS OCTOSPIM_P1_IO4, FT A2 PH2 I/O **EVENTOUT**

B2

PI7

I/O

FT

TIM8_CH3, OCTOSPIM P2 NCLK,

DCMI_D7/PSSI_D7, EVENTOUT



Table 15. STM32L4Q5xx pin definitions (continued)

| | Pin Number | | | | | | | | | | | | |
|----------|------------|--------|----------|---------|----------|---------|----------|---------------------------------------|----------|---------------|-------|--|----------------------|
| UFQFPN48 | LQFP48 | LQFP64 | WLCSP100 | LQFP100 | UFBGA132 | LQFP144 | UFBGA169 | Pin name (function after reset) | Pin type | I/O structure | Notes | Alternate functions | Additional functions |
| - | - | - | - | - | - | - | B1 | PI9 | I/O | FT | - | OCTOSPIM_P2_IO2, CAN1_RX, EVENTOUT | - |
| - | - | - | - | - | - | - | A1 | PI10 | I/O | FT | - | OCTOSPIM_P2_IO1, PSSI_D14, EVENTOUT | - |

^{1.} PC13, PC14 and PC15 are supplied through the power switch. Since the switch only sinks a limited amount of current (3 mA), the use of GPIOs PC13 to PC15 in output mode is limited:

⁻ The speed should not exceed 2 MHz with a maximum load of 30 pF
- These GPIOs must not be used as current sources (for example to drive a LED).

^{2.} After a Backup domain power-up, PC13, PC14 and PC15 operate as GPIOs. Their function then depends on the content of the RTC registers which are not reset by the system reset. For details on how to manage these GPIOs, refer to the Backup domain and RTC register descriptions in the RM0432 reference manual.

NC (not-connected) balls must be left unconnected. However, PF8 and PF9 NC' IOs are not bonded. They must be configured by software to output pushpull and forced to 0 in the output data register to avoid extra current consumption in low-power modes.

^{4.} After reset, these pins are configured as JTAG/SW debug alternate functions, and the internal pull-up on PA15, PA13, PB4 pins and the internal pull-down on PA14 pin are activated.

| | | | | Table 16. Alt | ernate function | AF0 to AF7 ⁽¹⁾ | | | |
|--------|------|-------------------------|-----------------------|--------------------|--|---------------------------|---|--|-----------------------|
| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | 12C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PA0 | - | TIM2_CH1 | TIM5_CH1 | TIM8_ETR | - | - | - | USART2_CTS_ NSS |
| | PA1 | - | TIM2_CH2 | TIM5_CH2 | - | I2C1_SMBA | SPI1_SCK | - | USART2_RTS_ DE |
| | PA2 | - | TIM2_CH3 | TIM5_CH3 | - | - | - | - | USART2_TX |
| | PA3 | - | TIM2_CH4 TIM5_CH | | SAI1_CK1 | - | - | - | USART2_RX |
| | PA4 | - | - | - | OCTOSPIM_P1_ NCS | - | SPI1_NSS | SPI3_NSS | USART2_CK |
| | PA5 | - | TIM2_CH1 | TIM2_CH1 TIM2_ETR | | PSSI_D14 | SPI1_SCK | - | - |
| | PA6 | - | TIM1_BKIN | TIM1_BKIN TIM3_CH1 | | DCMI_PIXCLK/P SSI_PDCK | SPI1_MISO | - | USART3_CTS_ NSS |
| | PA7 | - | TIM1_CH1N TIM3_CH2 | | TIM8_CH1N | I2C3_SCL | SPI1_MOSI | - | - |
| Port A | PA8 | MCO | TIM1_CH1 | - | SAI1_CK2 | - | - | - | USART1_CK |
| | PA9 | - | TIM1_CH2 | - | SPI2_SCK | - | DCMI_D0/PSSI_ D0 | - | USART1_TX |
| | PA10 | - | TIM1_CH3 | - | SAI1_D1 | - | DCMI_D1/PSSI_ D1 | - | USART1_RX |
| | PA11 | - | TIM1_CH4 | TIM1_BKIN2 | - | - | SPI1_MISO | - | USART1_CTS_ NSS |
| | PA12 | - | TIM1_ETR | - | - | - | SPI1_MOSI | OCTOSPIM_P2_ NCS | USART1_RTS_ DE |
| | PA13 | JTMS/SWDIO IR_OUT | | - | - | - | - | - | - |
| | PA14 | JTCK/SWCLK LPTIM1_OUT - | | - | - | I2C1_SMBA | I2C4_SMBA | - | - |
| | PA15 | JTDI | TIM2_CH1 | TIM2_ETR | USART2_RX | - | SPI1_NSS | SPI3_NSS | USART3_RTS_ DE |



Table 16. Alternate function AF0 to AF7⁽¹⁾ (continued)

| | AF0 AF1 AF2 AF3 AF4 AF5 AF6 AF7 | | | | | | | | | | | | |
|--------|---------------------------------|-------------------|-----------------------|--------------|--|-----------------|---|--|-----------------------|--|--|--|--|
| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 | | | | |
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 | | | | |
| | PB0 | - | TIM1_CH2N | TIM3_CH3 | TIM8_CH2N | - | SPI1_NSS | - | USART3_CK | | | | |
| | PB1 | • | TIM1_CH3N | TIM3_CH4 | TIM8_CH3N | 1 | - | DFSDM1_DATIN 0 | USART3_RTS_ DE | | | | |
| | PB2 | RTC_OUT2 | LPTIM1_OUT - | | - | I2C3_SMBA | - | DFSDM1_CKIN0 | - | | | | |
| | PB3 | JTDO/TRACES WO | TIM2_CH2 | - | OCTOSPIM_P1_ IO4 | - | SPI1_SCK | SPI3_SCK | USART1_RTS_ DE | | | | |
| | PB4 | NJTRST | - | TIM3_CH1 | OCTOSPIM_P1_ IO5 | I2C3_SDA | SPI1_MISO | SPI3_MISO | USART1_CTS_ NSS | | | | |
| | PB5 | - | LPTIM1_IN1 | TIM3_CH2 | OCTOSPIM_P1_ IO0 | I2C1_SMBA | SPI1_MOSI | SPI3_MOSI | USART1_CK | | | | |
| | PB6 | - | LPTIM1_ETR | TIM4_CH1 | TIM8_BKIN2 | I2C1_SCL | I2C4_SCL | - | USART1_TX | | | | |
| | PB7 | - | LPTIM1_IN2 | TIM4_CH2 | TIM8_BKIN | I2C1_SDA | I2C4_SDA | - | USART1_RX | | | | |
| Port B | PB8 | - | - | TIM4_CH3 | SAI1_CK1 | I2C1_SCL | DFSDM1_CKOU T | - | SDMMC2_D4 | | | | |
| | PB9 | - | IR_OUT | TIM4_CH4 | SAI1_D2 | I2C1_SDA | SPI2_NSS | - | SDMMC2_D5 | | | | |
| | PB10 | - | TIM2_CH3 | - | I2C4_SCL | I2C2_SCL | SPI2_SCK | OCTOSPIM_P1_ IO3 | USART3_TX | | | | |
| | PB11 | - | TIM2_CH4 | - | I2C4_SDA | I2C2_SDA | - | - | USART3_RX | | | | |
| | PB12 | - | TIM1_BKIN | - | TIM1_BKIN | I2C2_SMBA | SPI2_NSS | DFSDM1_DATIN 1 | USART3_CK | | | | |
| | PB13 | - | TIM1_CH1N | - | - | I2C2_SCL | SPI2_SCK | DFSDM1_CKIN1 | USART3_CTS_ NSS | | | | |
| | PB14 | - | TIM1_CH2N | - | TIM8_CH2N | I2C2_SDA | SPI2_MISO | DFSDM1_DATIN 2 | USART3_RTS_ DE | | | | |
| | PB15 | RTC_REFIN | TIM1_CH3N | - | TIM8_CH3N | - | SPI2_MOSI | DFSDM1_CKIN2 | - | | | | |

| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
|--------|------|-------------------|-----------------------|--------------|--|-------------------------|---|--|-----------------------|
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | 12C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PC0 | - | LPTIM1_IN1 | - | - | I2C3_SCL | - | - | SDMMC2_CKIN |
| | PC1 | TRACED0 | LPTIM1_OUT | - | SPI2_MOSI | I2C3_SDA | - | - | - |
| | PC2 | - | LPTIM1_IN2 | - | - | - | SPI2_MISO | DFSDM1_CKOU T | - |
| | PC3 | - | LPTIM1_ETR | - | SAI1_D1 | - | SPI2_MOSI | - | - |
| | PC4 | - | - | - | - | - | OCTOSPIM_P2_ NCS | - | USART3_TX |
| | PC5 | - | - | - | SAI1_D3 | PSSI_D15 | - | - | USART3_RX |
| | PC6 | - | - | TIM3_CH1 | TIM8_CH1 | - | - | DFSDM1_CKIN3 | SDMMC2_D6 |
| Port C | PC7 | - | - | TIM3_CH2 | TIM8_CH2 | - | - | DFSDM1_DATIN 3 | SDMMC2_D7 |
| Port C | PC8 | - | - | TIM3_CH3 | TIM8_CH3 | - | - | - | - |
| | PC9 | TRACED0 | TIM8_BKIN2 | TIM3_CH4 | TIM8_CH4 | DCMI_D3/PSSI_ D3 | - | I2C3_SDA | - |
| | PC10 | TRACED1 | - | - | - | DCMI_VSYNC/P SSI_RDY | - | SPI3_SCK | USART3_TX |
| | PC11 | - | - | - | - | DCMI_D2/PSSI_ D2 | OCTOSPIM_P1_ NCS | SPI3_MISO | USART3_RX |
| | PC12 | TRACED3 | - | - | - | - | - | SPI3_MOSI | USART3_CK |
| | PC13 | - | - | - | - | - | - | - | - |
| | PC14 | | | - | - | - | - | - | - |
| | PC15 | - | - | - | - | - | - | - | - |



Table 16. Alternate function AF0 to AF7⁽¹⁾ (continued)

| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
|--------|------|-------------------|-----------------------|--------------|--|-----------------------|---|--|-----------------------|
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PD0 | - | - | - | - | - | SPI2_NSS | - | - |
| | PD1 | - | - | - | - | - | SPI2_SCK | - | - |
| | PD2 | TRACED2 | - | TIM3_ETR | - | - | - | - | USART3_RTS_ DE |
| | PD3 | - | - | - | SPI2_SCK | DCMI_D5/PSSI_ D5 | SPI2_MISO | DFSDM1_DATIN 0 | USART2_CTS_ NSS |
| | PD4 | - | - | - | - | - | SPI2_MOSI | DFSDM1_CKIN0 | USART2_RTS_ DE |
| | PD5 | - | - | - | - | - | - | - | USART2_TX |
| | PD6 | - | - | - | SAI1_D1 | DCMI_D10/PSSI _D10 | SPI3_MOSI | DFSDM1_DATIN 1 | USART2_RX |
| Port D | PD7 | - | - | - | - | - | - | DFSDM1_CKIN1 | USART2_CK |
| | PD8 | - | - | - | - | - | - | - | USART3_TX |
| | PD9 | - | - | - | - | - | - | - | USART3_RX |
| | PD10 | - | - | - | - | - | - | - | USART3_CK |
| | PD11 | - | - | - | - | I2C4_SMBA | - | - | USART3_CTS_ NSS |
| | PD12 | - | - | TIM4_CH1 | - | I2C4_SCL | - | - | USART3_RTS_ DE |
| | PD13 | - | - | TIM4_CH2 | - | I2C4_SDA | - | - | - |
| | PD14 | - | - | TIM4_CH3 | - | - | - | - | - |
| | PD15 | - | - | TIM4_CH4 | - | - | - | - | - |

| | | | Tab | le 16. Alternate | e function AF0 t | o AF7 ⁽¹⁾ (contir | nued) | | |
|--------|------|-------------------|-----------------------|------------------|--|------------------------------|---|--|-----------------------|
| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PE0 | - | - | TIM4_ETR | - | - | - | - | - |
| | PE1 | - | - | - | - | - | - | - | - |
| | PE2 | TRACECK | - | TIM3_ETR | SAI1_CK1 | - | - | - | - |
| | PE3 | TRACED0 | - | TIM3_CH1 | OCTOSPIM_P1_ DQS | - | - | - | - |
| | PE4 | TRACED1 | - | TIM3_CH2 | SAI1_D2 | - | - | DFSDM1_DATIN | - |
| | PE5 | TRACED2 | - | TIM3_CH3 | SAI1_CK2 | - | - | DFSDM1_CKIN3 | - |
| | PE6 | TRACED3 | - | TIM3_CH4 | SAI1_D1 | - | - | - | - |
| Port E | PE7 | - | TIM1_ETR | - | - | - | - | DFSDM1_DATIN 2 | - |
| | PE8 | - | TIM1_CH1N | - | - | - | - | DFSDM1_CKIN2 | - |
| | PE9 | - | TIM1_CH1 | - | - | - | - | DFSDM1_CKOU T | - |
| | PE10 | - | TIM1_CH2N | - | - | - | - | - | - |
| | PE11 | - | TIM1_CH2 | - | - | - | - | - | - |
| | PE12 | - | TIM1_CH3N | - | - | - | SPI1_NSS | - | - |
| | PE13 | - | TIM1_CH3 | - | - | - | SPI1_SCK | - | - |

TIM1_BKIN2

TIM1_BKIN

SPI1_MISO

SPI1_MOSI



PE14

PE15

TIM1_CH4

TIM1_BKIN

TIM1_BKIN2

Table 16. Alternate function AF0 to AF7⁽¹⁾ (continued)

| | | I | 1 | | iunction Aru t | • | | <u> </u> | |
|--------|------|-------------------|-----------------------|--------------|--|-----------------|---|--|-----------------------|
| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PF0 | - | - | - | - | I2C2_SDA | OCTOSPIM_P2_ IO0 | - | - |
| | PF1 | - | - | - | - | I2C2_SCL | OCTOSPIM_P2_ IO1 | - | - |
| | PF2 | - | - | - | - | I2C2_SMBA | OCTOSPIM_P2_ IO2 | - | - |
| | PF3 | - | - | - | - | - | OCTOSPIM_P2_ IO3 | - | - |
| | PF4 | - | - | - | - | - | OCTOSPIM_P2_ CLK | - | - |
| | PF5 | - | - | - | - | - | OCTOSPIM_P2_ NCLK | - | - |
| D4 E | PF6 | - | TIM5_ETR | TIM5_CH1 | - | - | - | - | - |
| Port F | PF7 | - | - | TIM5_CH2 | - | - | - | - | - |
| | PF8 | - | - | TIM5_CH3 | - | - | - | - | - |
| | PF9 | - | - | TIM5_CH4 | - | - | - | - | - |
| | PF10 | - | - | - | OCTOSPIM_P1_ CLK | PSSI_D15 | - | DFSDM1_CKOU T | - |
| | PF11 | - | - | - | OCTOSPIM_P1_ NCLK | - | - | - | - |
| | PF12 | 2 | | - | - | - | OCTOSPIM_P2_ DQS | - | - |
| | PF13 | | | - | - | I2C4_SMBA | - | - | - |
| | PF14 | - | - | - | - | I2C4_SCL | - | - | - |
| | PF15 | | | - | - | I2C4_SDA | - | - | - |

| Port | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
|--------|------|-------------------|-----------------------|--------------|--|-----------------|---|--|-----------------------|
| | | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PG0 | - | - | - | - | - | OCTOSPIM_P2_ IO4 | - | - |
| | PG1 | - | - | - | - | - | OCTOSPIM_P2_ IO5 | - | - |
| | PG2 | - | - | - | - | - | SPI1_SCK | - | - |
| Port G | PG3 | - | - | - | - | - | SPI1_MISO | - | - |
| | PG4 | - | - | - | - | - | SPI1_MOSI | - | - |
| | PG5 | - | - | - | - | - | SPI1_NSS | - | - |
| | PG6 | - | - | - | OCTOSPIM_P1_ DQS | I2C3_SMBA | - | - | - |
| | PG7 | - | - | - | SAI1_CK1 | I2C3_SCL | OCTOSPIM_P2_ DQS | DFSDM1_CKOU T | - |
| | PG8 | - | - | - | - | I2C3_SDA | - | - | - |
| | PG9 | - | - | - | - | - | OCTOSPIM_P2_ IO6 | SPI3_SCK | USART1_TX |
| | PG10 | - | LPTIM1_IN1 | - | - | - | OCTOSPIM_P2_ IO7 | SPI3_MISO | USART1_RX |
| | PG11 | - | LPTIM1_IN2 | - | OCTOSPIM_P1_ IO5 | - | - | SPI3_MOSI | USART1_CTS_ NSS |
| | PG12 | - | LPTIM1_ETR | - | - | - | OCTOSPIM_P2_ NCS | SPI3_NSS | USART1_RTS_ DE |
| | PG13 | - | - | - | - | I2C1_SDA | - | - | USART1_CK |
| | PG14 | - | - | - | - | I2C1_SCL | - | - | - |
| | PG15 | - | LPTIM1_OUT | - | - | I2C1_SMBA | OCTOSPIM_P2_ DQS | - | - |

Table 16. Alternate function AF0 to AF7⁽¹⁾ (continued)

| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
|--------|------|-------------------|-----------------------|--------------|--|-----------------|---|--|-----------------------|
| Po | ort | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PH0 | - | - | - | - | - | - | - | - |
| | PH1 | - | - | - | - | - | - | - | - |
| | PH2 | - | - | - | OCTOSPIM_P1_ IO4 | - | - | - | - |
| | PH3 | - | - | - | - | - | - | - | - |
| | PH4 | - | - | - | - | I2C2_SCL | OCTOSPIM_P2_ DQS | - | - |
| | PH5 | - | - | - | - | I2C2_SDA | - | - | - |
| | PH6 | - | - | - | - | I2C2_SMBA | OCTOSPIM_P2_ CLK | - | - |
| | PH7 | - | - | - | - | I2C3_SCL | OCTOSPIM_P2_ NCLK | - | - |
| Port H | PH8 | - | - | - | - | I2C3_SDA | OCTOSPIM_P2_ IO3 | - | - |
| | PH9 | - | - | - | - | I2C3_SMBA | OCTOSPIM_P2_ IO4 | - | - |
| | PH10 | - | - | TIM5_CH1 | - | - | OCTOSPIM_P2_ IO5 | - | - |
| | PH11 | - | - | TIM5_CH2 | - | - | OCTOSPIM_P2_ IO6 | - | - |
| | PH12 | - | - | TIM5_CH3 | - | - | OCTOSPIM_P2_ IO7 | - | - |
| | PH13 | - | - | - | TIM8_CH1N | - | - | - | - |
| | PH14 | - | - | - | TIM8_CH2N | - | - | - | - |
| | PH15 | - | - | - | TIM8_CH3N | - | OCTOSPIM_P2_ IO6 | - | - |

Table 16. Alternate function AF0 to AF7⁽¹⁾ (continued)

| | | AF0 | AF1 | AF2 | AF3 | AF4 | AF5 | AF6 | AF7 |
|--------|------|-------------------|-----------------------|--------------|--|-----------------|---|--|-----------------------|
| Port | | OTG_FS/SYS_A F | TIM1/2/5/8/LPTI M1 | TIM1/2/3/4/5 | SPI2/SAI1/I2C4/ USART2/CAN2/ OTG_FS/TIM1/8 /OCTOSPIM_P1/ QUADSPI | I2C1/2/3/4/DCMI | SPI1/2/3/I2C4/D FSDM1/DCMI/O CTOSPIM_P1/2/ QUADSPI | SPI3/I2C3/DFSD M1/COMP1/OCT OSPIM_P1/2/QU ADSPI | USART1/2/3/SD MMC2 |
| | PI0 | - | - | TIM5_CH4 | OCTOSPIM_P1_ IO5 | - | SPI2_NSS | - | - |
| | PI1 | - | - | - | - | - | SPI2_SCK | - | - |
| | PI2 | - | - | - | TIM8_CH4 | - | SPI2_MISO | - | - |
| | PI3 | - | - | - | TIM8_ETR | - | SPI2_MOSI | - | - |
| | PI4 | - | - | - | TIM8_BKIN | - | - | - | - |
| | PI5 | - | - | - | TIM8_CH1 | - | OCTOSPIM_P2_ NCS | - | - |
| Port I | PI6 | - | - | - | TIM8_CH2 | - | OCTOSPIM_P2_ CLK | - | - |
| | PI7 | - | - | - | TIM8_CH3 | - | OCTOSPIM_P2_ NCLK | - | - |
| | PI8 | - | - | - | - | - | OCTOSPIM_P2_ NCS | - | - |
| | PI9 | - | - | - | - | - | OCTOSPIM_P2_ IO2 | - | - |
| | PI10 | - | - | - | - | - | OCTOSPIM_P2_ IO1 | - | - |
| | PI11 | - | - | - | - | - | OCTOSPIM_P2_ IO0 | - | - |

^{1.} Refer to next table for AF8 to AF15.



Table 17. Alternate function AF8 to AF15⁽¹⁾

| | | | 1 | Table 17. Alterna | to ranotion / ti o | 10711 10 | | | |
|------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PA0 | UART4_TX | - | - | - | - | SAI1_EXTCLK | TIM2_ETR | EVENTOUT |
| | PA1 | UART4_RX | - | OCTOSPIM_P1_DQS | - | SDMMC2_CMD | - | TIM15_CH1N | EVENTOUT |
| | PA2 | LPUART1_TX | - | OCTOSPIM_P1_NCS | - | - | SAI2_EXTCLK | TIM15_CH1 | EVENTOUT |
| | PA3 | LPUART1_RX | - | OCTOSPIM_P1_CLK | - | - | SAI1_MCLK_A | TIM15_CH2 | EVENTOUT |
| | PA4 | - | - | DCMI_HSYNC/PSSI_ DE | LCD_CLK | - | SAI1_FS_B | LPTIM2_OUT | EVENTOUT |
| | PA5 | - | - | - | LCD_R7 | - | - | LPTIM2_ETR | EVENTOUT |
| | PA6 | LPUART1_CTS | - | OCTOSPIM_P1_IO3 | - | TIM1_BKIN | TIM8_BKIN | TIM16_CH1 | EVENTOUT |
| Port | PA7 | - | - | OCTOSPIM_P1_IO2 | - | - | - | TIM17_CH1 | EVENTOUT |
| Α | PA8 | - | - | OTG_FS_SOF | LCD_B7 | - | SAI1_SCK_A | LPTIM2_OUT | EVENTOUT |
| | PA9 | - | - | - | LCD_G7 | - | SAI1_FS_A | TIM15_BKIN | EVENTOUT |
| | PA10 | - | - | OTG_FS_ID | LCD_G6 | - | SAI1_SD_A | TIM17_BKIN | EVENTOUT |
| | PA11 | - | CAN1_RX | OTG_FS_DM | LCD_DE | TIM1_BKIN2 | - | - | EVENTOUT |
| | PA12 | - | CAN1_TX | OTG_FS_DP | LCD_VSYNC | - | - | - | EVENTOUT |
| | PA13 | - | - | OTG_FS_NOE | - | - | SAI1_SD_B | - | EVENTOUT |
| | PA14 | - | - | OTG_FS_SOF | - | - | SAI1_FS_B | - | EVENTOUT |
| | PA15 | UART4_RTS_DE | TSC_G3_IO1 | - | LCD_HSYNC | - | SAI2_FS_B | - | EVENTOUT |

Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| | | | | | | , | | | |
|-----------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PB0 | - | - | OCTOSPIM_P1_IO1 | LCD_B6 | COMP1_OUT | SAI1_EXTCLK | - | EVENTOUT |
| | PB1 | LPUART1_RTS_ DE | - | OCTOSPIM_P1_IO0 | LCD_G6 | - | - | LPTIM2_IN1 | EVENTOUT |
| | PB2 | - | - | OCTOSPIM_P1_DQS | - | - | - | - | EVENTOUT |
| | PB3 | - | - | OTG_FS_CRS_SYNC | - | SDMMC2_D2 | SAI1_SCK_B | - | EVENTOUT |
| | PB4 | UART5_RTS_DE | TSC_G2_IO1 | DCMI_D12/PSSI_D12 | - | SDMMC2_D3 | SAI1_MCLK_B | TIM17_BKIN | EVENTOUT |
| | PB5 | UART5_CTS | TSC_G2_IO2 | DCMI_D10/PSSI_D10 | - | COMP2_OUT | SAI1_SD_B | TIM16_BKIN | EVENTOUT |
| | PB6 | - | TSC_G2_IO3 | DCMI_D5/PSSI_D5 | LCD_R6 | TIM8_BKIN2 | SAI1_FS_B | TIM16_CH1N | EVENTOUT |
| Port B | PB7 | UART4_CTS | TSC_G2_IO4 | DCMI_VSYNC/PSSI_ RDY | LCD_VSYNC | FMC_NL | TIM8_BKIN | TIM17_CH1N | EVENTOUT |
| Ь | PB8 | SDMMC1_CKIN | CAN1_RX | DCMI_D6/PSSI_D6 | LCD_DE | SDMMC1_D4 | SAI1_MCLK_A | TIM16_CH1 | EVENTOUT |
| | PB9 | SDMMC1_CDIR | CAN1_TX | DCMI_D7/PSSI_D7 | - | SDMMC1_D5 | SAI1_FS_A | TIM17_CH1 | EVENTOUT |
| | PB10 | LPUART1_RX | TSC_SYNC | OCTOSPIM_P1_CLK | - | COMP1_OUT | SAI1_SCK_A | - | EVENTOUT |
| | PB11 | LPUART1_TX | - | OCTOSPIM_P1_NCS | LCD_VSYNC | COMP2_OUT | - | - | EVENTOUT |
| | PB12 | LPUART1_RTS_ DE | TSC_G1_IO1 | OCTOSPIM_P1_NCL K | - | SDMMC2_CK | SAI2_FS_A | TIM15_BKIN | EVENTOUT |
| | PB13 | LPUART1_CTS | TSC_G1_IO2 | OCTOSPIM_P1_IO1 | - | - | SAI2_SCK_A | TIM15_CH1N | EVENTOUT |
| | PB14 | - | TSC_G1_IO3 | OCTOSPIM_P1_IO6 | SDMMC2_D0 | - | SAI2_MCLK_A | TIM15_CH1 | EVENTOUT |
| | PB15 | - | TSC_G1_IO4 | OCTOSPIM_P1_IO7 | SDMMC2_D1 | - | SAI2_SD_A | TIM15_CH2 | EVENTOUT |



Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| | | | | | | To (Continue) | , | | |
|-----------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PC0 | LPUART1_RX | - | - | LCD_DE | SDMMC1_CMD | SAI2_FS_A | LPTIM2_IN1 | EVENTOUT |
| | PC1 | LPUART1_TX | - | OCTOSPIM_P1_IO4 | - | - | SAI1_SD_A | - | EVENTOUT |
| | PC2 | - | - | OCTOSPIM_P1_IO5 | LCD_HSYNC | - | - | - | EVENTOUT |
| | PC3 | - | - | OCTOSPIM_P1_IO6 | - | - | SAI1_SD_A | LPTIM2_ETR | EVENTOUT |
| | PC4 | - | - | OCTOSPIM_P1_IO7 | - | - | - | - | EVENTOUT |
| | PC5 | - | - | - | LCD_CLK | - | - | - | EVENTOUT |
| | PC6 | SDMMC1_D0DI R | TSC_G4_IO1 | DCMI_D0/PSSI_D0 | LCD_G7 | SDMMC1_D6 | SAI2_MCLK_A | - | EVENTOUT |
| Port C | PC7 | SDMMC1_D123 DIR | TSC_G4_IO2 | DCMI_D1/PSSI_D1 | LCD_B6 | SDMMC1_D7 | SAI2_MCLK_B | - | EVENTOUT |
| | PC8 | - | TSC_G4_IO3 | DCMI_D2/PSSI_D2 | - | SDMMC1_D0 | - | - | EVENTOUT |
| | PC9 | - | TSC_G4_IO4 | OTG_FS_NOE | - | SDMMC1_D1 | SAI2_EXTCLK | TIM8_BKIN2 | EVENTOUT |
| | PC10 | UART4_TX | TSC_G3_IO2 | DCMI_D8/PSSI_D8 | - | SDMMC1_D2 | SAI2_SCK_B | - | EVENTOUT |
| | PC11 | UART4_RX | TSC_G3_IO3 | DCMI_D4/PSSI_D4 | - | SDMMC1_D3 | SAI2_MCLK_B | - | EVENTOUT |
| | PC12 | UART5_TX | TSC_G3_IO4 | DCMI_D9/PSSI_D9 | LCD_R6 | SDMMC1_CK | SAI2_SD_B | - | EVENTOUT |
| | PC13 | - | - | - | - | - | - | - | EVENTOUT |
| | PC14 | - | - | - | - | - | - | - | EVENTOUT |
| | PC15 | - | - | - | - | - | - | - | EVENTOUT |

| Table 17. Alternate function AF8 to AF15 ⁽¹⁾ (e | continued) |
|--|------------|
|--|------------|

| | | Г | - - | The II. Alternate run | | (00:::::::::::: | -7 | ı | 1 |
|------|------|---------------------------------------|-----------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PD0 | - | CAN1_RX | - | LCD_B4 | FMC_D2 | - | - | EVENTOUT |
| | PD1 | - | CAN1_TX | - | LCD_B5 | FMC_D3 | - | - | EVENTOUT |
| | PD2 | UART5_RX | TSC_SYNC | DCMI_D11/PSSI_D11 | - | SDMMC1_CMD | - | - | EVENTOUT |
| | PD3 | - | - | OCTOSPIM_P2_NCS | LCD_CLK | FMC_CLK | - | - | EVENTOUT |
| | PD4 | SDMMC2_CKIN | - | OCTOSPIM_P1_IO4 | - | FMC_NOE | - | - | EVENTOUT |
| | PD5 | - | - | OCTOSPIM_P1_IO5 | - | FMC_NWE | - | - | EVENTOUT |
| | PD6 | SDMMC2_CK | - | OCTOSPIM_P1_IO6 | LCD_DE | FMC_NWAIT | SAI1_SD_A | - | EVENTOUT |
| Port | PD7 | SDMMC2_CMD | - | OCTOSPIM_P1_IO7 | - | FMC_NCE/FMC _NE1 | - | - | EVENTOUT |
| D | PD8 | - | - | DCMI_HSYNC/PSSI_ DE | LCD_R3 | FMC_D13 | - | - | EVENTOUT |
| | PD9 | - | - | DCMI_PIXCLK/PSSI_ PDCK | LCD_R4 | FMC_D14 | SAI2_MCLK_A | - | EVENTOUT |
| | PD10 | - | TSC_G6_IO1 | - | LCD_R5 | FMC_D15 | SAI2_SCK_A | - | EVENTOUT |
| | PD11 | - | TSC_G6_IO2 | - | LCD_R6 | FMC_A16 | SAI2_SD_A | LPTIM2_ETR | EVENTOUT |
| | PD12 | - | TSC_G6_IO3 | - | LCD_R7 | FMC_A17 | SAI2_FS_A | LPTIM2_IN1 | EVENTOUT |
| | PD13 | - | TSC_G6_IO4 | - | - | FMC_A18 | - | LPTIM2_OUT | EVENTOUT |
| | PD14 | - | - | - | LCD_B2 | FMC_D0 | - | - | EVENTOUT |
| | PD15 | - | - | - | LCD_B3 | FMC_D1 | - | - | EVENTOUT |



Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| | | | | bie 17. Aiternate fun | CHOIL ALC TO AL | 10 (continued | 4) | | |
|------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PE0 | - | - | DCMI_D2/PSSI_D2 | LCD_HSYNC | FMC_NBL0 | - | TIM16_CH1 | EVENTOUT |
| | PE1 | - | - | DCMI_D3/PSSI_D3 | LCD_VSYNC | FMC_NBL1 | - | TIM17_CH1 | EVENTOUT |
| | PE2 | - | TSC_G7_IO1 | - | LCD_R7 | FMC_A23 | SAI1_MCLK_A | - | EVENTOUT |
| | PE3 | - | TSC_G7_IO2 | - | LCD_R6 | FMC_A19 | SAI1_SD_B | - | EVENTOUT |
| | PE4 | - | TSC_G7_IO3 | DCMI_D4/PSSI_D4 | LCD_B7 | FMC_A20 | SAI1_FS_A | - | EVENTOUT |
| | PE5 | - | TSC_G7_IO4 | DCMI_D6/PSSI_D6 | LCD_G7 | FMC_A21 | SAI1_SCK_A | - | EVENTOUT |
| | PE6 | - | - | DCMI_D7/PSSI_D7 | LCD_G6 | FMC_A22 | SAI1_SD_A | - | EVENTOUT |
| Port | PE7 | - | - | - | LCD_B6 | FMC_D4 | SAI1_SD_B | - | EVENTOUT |
| E | PE8 | - | - | - | LCD_B7 | FMC_D5 | SAI1_SCK_B | - | EVENTOUT |
| | PE9 | - | - | OCTOSPIM_P1_NCL K | LCD_G2 | FMC_D6 | SAI1_FS_B | - | EVENTOUT |
| | PE10 | - | TSC_G5_IO1 | OCTOSPIM_P1_CLK | LCD_G3 | FMC_D7 | SAI1_MCLK_B | - | EVENTOUT |
| | PE11 | - | TSC_G5_IO2 | OCTOSPIM_P1_NCS | LCD_G4 | FMC_D8 | - | - | EVENTOUT |
| | PE12 | - | TSC_G5_IO3 | OCTOSPIM_P1_IO0 | LCD_G5 | FMC_D9 | - | - | EVENTOUT |
| | PE13 | - | TSC_G5_IO4 | OCTOSPIM_P1_IO1 | LCD_G6 | FMC_D10 | - | - | EVENTOUT |
| | PE14 | - | - | OCTOSPIM_P1_IO2 | LCD_G7 | FMC_D11 | - | - | EVENTOUT |
| | PE15 | - | - | OCTOSPIM_P1_IO3 | LCD_R2 | FMC_D12 | - | - | EVENTOUT |

Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
|------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PF0 | - | - | - | - | FMC_A0 | - | - | EVENTOUT |
| | PF1 | - | - | - | - | FMC_A1 | - | - | EVENTOUT |
| | PF2 | - | - | - | - | FMC_A2 | - | - | EVENTOUT |
| | PF3 | - | - | - | - | FMC_A3 | - | - | EVENTOUT |
| | PF4 | - | - | - | - | FMC_A4 | - | - | EVENTOUT |
| | PF5 | - | - | - | - | FMC_A5 | - | - | EVENTOUT |
| | PF6 | - | - | OCTOSPIM_P1_IO3 | - | - | SAI1_SD_B | - | EVENTOUT |
| Port | PF7 | - | - | OCTOSPIM_P1_IO2 | - | - | SAI1_MCLK_B | - | EVENTOUT |
| F | PF8 | - | - | OCTOSPIM_P1_IO0 | - | - | SAI1_SCK_B | - | EVENTOUT |
| | PF9 | - | - | OCTOSPIM_P1_IO1 | - | - | SAI1_FS_B | TIM15_CH1 | EVENTOUT |
| | PF10 | - | - | DCMI_D11/PSSI_D11 | - | - | SAI1_D3 | TIM15_CH2 | EVENTOUT |
| | PF11 | - | LCD_DE | DCMI_D12/PSSI_D12 | - | - | - | - | EVENTOUT |
| | PF12 | - | - | - | LCD_B0 | FMC_A6 | - | - | EVENTOUT |
| | PF13 | - | - | - | LCD_B1 | FMC_A7 | - | - | EVENTOUT |
| | PF14 | - | TSC_G8_IO1 | - | LCD_G0 | FMC_A8 | - | - | EVENTOUT |
| | PF15 | - | TSC_G8_IO2 | - | LCD_G1 | FMC_A9 | - | - | EVENTOUT |





Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| | | | 1 | T | | TO (CONTINUE) | , | ı | 1 |
|------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PG0 | - | TSC_G8_IO3 | - | - | FMC_A10 | - | - | EVENTOUT |
| | PG1 | - | TSC_G8_IO4 | - | - | FMC_A11 | - | - | EVENTOUT |
| | PG2 | - | - | - | SDMMC2_D4 | FMC_A12 | SAI2_SCK_B | - | EVENTOUT |
| | PG3 | - | - | - | SDMMC2_D5 | FMC_A13 | SAI2_FS_B | - | EVENTOUT |
| | PG4 | - | - | - | SDMMC2_D6 | FMC_A14 | SAI2_MCLK_B | - | EVENTOUT |
| | PG5 | LPUART1_CTS | - | - | SDMMC2_D7 | FMC_A15 | SAI2_SD_B | - | EVENTOUT |
| | PG6 | LPUART1_RTS_ DE | LCD_R1 | - | - | - | - | - | EVENTOUT |
| Port | PG7 | LPUART1_TX | - | - | - | FMC_INT | SAI1_MCLK_A | - | EVENTOUT |
| G | PG8 | LPUART1_RX | - | - | - | - | - | - | EVENTOUT |
| | PG9 | - | - | - | SDMMC2_D0 | FMC_NCE/FMC _NE2 | SAI2_SCK_A | TIM15_CH1N | EVENTOUT |
| | PG10 | - | - | - | SDMMC2_D1 | FMC_NE3 | SAI2_FS_A | TIM15_CH1 | EVENTOUT |
| | PG11 | - | - | - | SDMMC2_D2 | - | SAI2_MCLK_A | TIM15_CH2 | EVENTOUT |
| | PG12 | - | - | - | SDMMC2_D3 | FMC_NE4 | SAI2_SD_A | - | EVENTOUT |
| | PG13 | - | - | - | LCD_R0 | FMC_A24 | - | - | EVENTOUT |
| | PG14 | - | - | - | LCD_R1 | FMC_A25 | - | - | EVENTOUT |
| | PG15 | - | - | DCMI_D13/PSSI_D13 | - | - | - | - | EVENTOUT |

Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| T | | I | | Territoriale fail | | TO (CONTINUE | <u>, </u> | | |
|------|------|---------------------------------------|--------------|--|------------------------|--|--|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PH0 | - | - | - | - | - | - | - | EVENTOUT |
| | PH1 | - | - | - | - | - | - | - | EVENTOUT |
| | PH2 | - | - | - | - | - | - | - | EVENTOUT |
| | PH3 | - | - | - | - | - | - | - | EVENTOUT |
| | PH4 | - | - | PSSI_D14 | - | - | - | - | EVENTOUT |
| | PH5 | - | - | DCMI_PIXCLK/PSSI_ PDCK | - | - | - | - | EVENTOUT |
| | PH6 | - | - | DCMI_D8/PSSI_D8 | - | - | - | - | EVENTOUT |
| Port | PH7 | - | - | DCMI_D9/PSSI_D9 | - | - | - | - | EVENTOUT |
| Н | PH8 | - | - | DCMI_HSYNC/PSSI_ DE | - | - | - | - | EVENTOUT |
| | PH9 | - | - | DCMI_D0/PSSI_D0 | - | - | - | - | EVENTOUT |
| | PH10 | - | - | DCMI_D1/PSSI_D1 | - | - | - | - | EVENTOUT |
| | PH11 | - | - | DCMI_D2/PSSI_D2 | - | - | - | - | EVENTOUT |
| | PH12 | - | - | DCMI_D3/PSSI_D3 | - | - | - | - | EVENTOUT |
| | PH13 | - | CAN1_TX | - | - | - | - | - | EVENTOUT |
| | PH14 | - | - | DCMI_D4/PSSI_D4 | - | - | - | - | EVENTOUT |
| | PH15 | - | - | DCMI_D11/PSSI_D11 | - | - | - | - | EVENTOUT |





Table 17. Alternate function AF8 to AF15⁽¹⁾ (continued)

| 1 | | T | | The IT. Alternate full | | (00:::::::::::::::::::::::::::::::::::: | -, | ı | 1 |
|------|------|---------------------------------------|--------------|--|------------------------|--|-------------|----------------------------|----------|
| | | AF8 | AF9 | AF10 | AF11 | AF12 | AF13 | AF14 | AF15 |
| P | ort | UART4/5/LPUA RT1/CAN2/SDM MC1/2 | CAN1/TSC/LCD | CAN2/OTG_FS/DCMI/ OCTOSPIM_P1/2/QU ADSPI | SDMMC2/LCD/D SI/LCD | SDMMC1/2/COM P1/2/TIM1/8/FM C/SWPMI1 | SAI1/2/TIM8 | TIM2/8/15/16/1 7/LPTIM2 | EVENOUT |
| | PI0 | - | - | DCMI_D13/PSSI_D13 | - | - | - | - | EVENTOUT |
| | PI1 | - | - | DCMI_D8/PSSI_D8 | - | - | - | - | EVENTOUT |
| | PI2 | - | - | DCMI_D9/PSSI_D9 | - | - | - | - | EVENTOUT |
| | PI3 | - | - | DCMI_D10/PSSI_D10 | - | - | - | - | EVENTOUT |
| | PI4 | - | - | DCMI_D5/PSSI_D5 | - | - | - | - | EVENTOUT |
| Port | PI5 | - | - | DCMI_VSYNC/PSSI_ RDY | - | - | - | - | EVENTOUT |
| ' | PI6 | - | - | DCMI_D6/PSSI_D6 | - | - | - | - | EVENTOUT |
| | PI7 | - | - | DCMI_D7/PSSI_D7 | - | - | - | - | EVENTOUT |
| | PI8 | - | - | DCMI_D12/PSSI_D12 | - | - | - | - | EVENTOUT |
| | PI9 | - | CAN1_RX | - | - | - | - | - | EVENTOUT |
| | PI10 | - | - | PSSI_D14 | - | - | - | - | EVENTOUT |
| | PI11 | - | - | PSSI_D15 | - | - | - | - | EVENTOUT |

^{1.} Refer to previous table for AF0 to AF7.

Memory mapping STM32L4Q5xx

5 Memory mapping

For memory map and peripheral register boundary addresses refer to the corresponding section of reference manual RM0432.

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6.1 Parameter conditions

Unless otherwise specified, all voltages are referenced to V_{SS}.

6.1.1 Minimum and maximum values

Unless otherwise specified, the minimum and maximum values are guaranteed in the worst conditions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at $T_A = 25$ °C and $T_A = T_A$ max (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes and are not tested in production. Based on characterization, the minimum and maximum values refer to sample tests and represent the mean value plus or minus three times the standard deviation (mean $\pm 3\sigma$).

6.1.2 Typical values

Unless otherwise specified, typical data are based on $T_A = 25$ °C, $V_{DD} = V_{DDA} = 3$ V. They are given only as design guidelines and are not tested.

Typical ADC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range, where 95% of the devices have an error less than or equal to the value indicated (mean $\pm 2\sigma$).

6.1.3 Typical curves

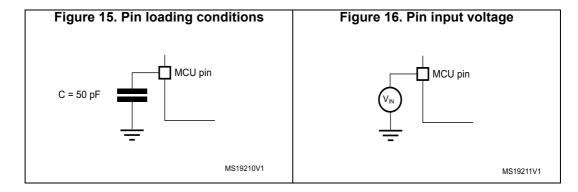
Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

6.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in *Figure 15*.

6.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in Figure 16.



6.1.6 Power supply scheme

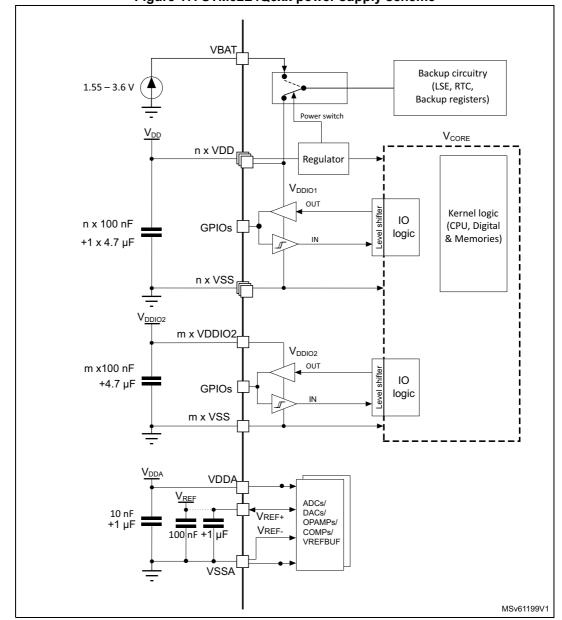


Figure 17. STM32L4Q5xx power supply scheme

Caution:

Each power supply pair (V_{DD}/V_{SS} , V_{DDA}/V_{SSA} etc.) must be decoupled with filtering ceramic capacitors as shown above. These capacitors must be placed as close as possible to, or below, the appropriate pins on the underside of the PCB to ensure the good functionality of the device.

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6.1.7 Current consumption measurement

The I_{DD_ALL} parameters given in *Table 25* to *Table 32* represent the total MCU consumption including the current supplying V_{DD} , V_{DDIO2} , V_{DDA} , V_{DDUSB} and V_{BAT} .

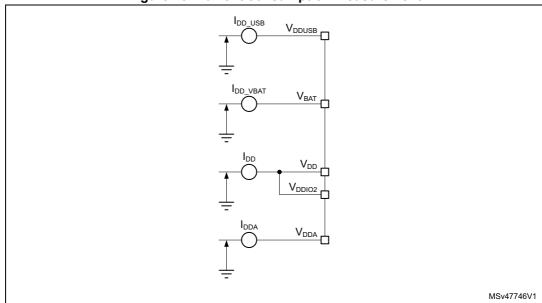


Figure 18. Current consumption measurement

6.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in *Table 18: Voltage characteristics*, *Table 19: Current characteristics* and *Table 20: Thermal characteristics* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability. Device mission profile (application conditions) is compliant with JEDEC JESD47 qualification standard, extended mission profiles are available on demand.

Symbol Ratings Min Max Unit External main supply voltage (including ٧ V_{DDX} - V_{SS} 4.0 -0.3 V_{DD} , V_{DDA} , V_{DDIO2} , V_{DDUSB} , V_{BAT}) $min\;(V_{DD},\,V_{DDA},\,$ Input voltage on FT xxx pins $V_{DDIO2}, V_{DDUSB}) + 4.0^{(3)(4)}$ V_{SS} -0.3 $V_{IN}^{(2)}$ ٧ Input voltage on TT_xx pins V_{SS} -0.3 4.0 Input voltage on any other pins V_{SS} -0.3 4.0 Variations between different V_{DDX} power $|\Delta V_{DDx}|$ 50 pins of the same domain mV Variations between all the different ground $|V_{SSx}-V_{SS}|$ 50 pins⁽⁵⁾

Table 18. Voltage characteristics⁽¹⁾

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- All main power (V_{DD}, V_{DDA}, V_{DDIO2}, V_{DDUSB}, V_{BAT}) and ground (V_{SS}, V_{SSA}) pins must always be connected to the external power supply, in the permitted range.
- V_{IN} maximum must always be respected. Refer to Table 19: Current characteristics for the maximum allowed injected current values.
- This formula has to be applied only on the power supplies related to the IO structure described in the pin definition table.
- 4. To sustain a voltage higher than 4 V the internal pull-up/pull-down resistors must be disabled.
- 5. Include VREF- pin.

Table 19. Current characteristics

| Symbol | Ratings | Max | Unit |
|--------------------------------------|--|----------------------|------|
| ∑IV _{DD} | Total current into sum of all V _{DD} power lines (source) ⁽¹⁾ | 200 | |
| ΣIV _{SS} | Total current out of sum of all V _{SS} ground lines (sink) ⁽¹⁾ | 200 | |
| IV _{DD(PIN)} | Maximum current into each V _{DD} power pin (source) ⁽¹⁾ | 100 | |
| IV _{SS(PIN)} | Maximum current out of each V _{SS} ground pin (sink) ⁽¹⁾ | 100 | |
| | Output current sunk by any I/O and control pin except FT_f | 20 | |
| I _{IO(PIN)} | Output current sunk by any FT_f pin | 20 | m 1 |
| | Output current sourced by any I/O and control pin | 20 | mA |
| V I | Total output current sunk by sum of all I/Os and control pins ⁽²⁾ | 100 | |
| ΣΙ _{ΙΟ(ΡΙΝ)} | Total output current sourced by sum of all I/Os and control pins ⁽²⁾ | 100 | |
| (3) | Injected current on FT_xxx, TT_xx, RST and B pins, except PA4, PA5 | -5/+0 ⁽⁴⁾ | |
| I _{INJ(PIN)} ⁽³⁾ | Injected current on PA4, PA5 | -5/0 | |
| Σ I _{INJ(PIN)} | Total injected current (sum of all I/Os and control pins) ⁽⁵⁾ | 25 | |

- All main power (V_{DD}, V_{DDA}, V_{DDIO2}, V_{DDUSB}, V_{BAT}) and ground (V_{SS}, V_{SSA}) pins must always be connected to the external power supplies, in the permitted range.
- This current consumption must be correctly distributed over all I/Os and control pins. The total output current must not be sunk/sourced between two consecutive power supply pins referring to high pin count QFP packages.
- Positive injection (when V_{IN} > V_{DDIOx}) is not possible on these I/Os and does not occur for input voltages lower than the specified maximum value.
- A negative injection is induced by V_{IN} < V_{SS}. I_{INJ(PIN)} must never be exceeded. Refer also to *Table 18:* Voltage characteristics for the minimum allowed input voltage values.
- When several inputs are submitted to a current injection, the maximum ∑|I_{INJ(PIN)}| is the absolute sum of the negative injected currents (instantaneous values).

Table 20. Thermal characteristics

| Symbol | Ratings | Value | Unit |
|------------------|------------------------------|-------------|------|
| T _{STG} | Storage temperature range | -65 to +150 | °C |
| T _J | Maximum junction temperature | 150 | °C |



6.3 Operating conditions

6.3.1 General operating conditions

Table 21. General operating conditions

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------|---|--|---------------------|--|-------|
| f _{HCLK} | Internal AHB clock frequency | - | 0 | 120 | |
| f _{PCLK1} | Internal APB1 clock frequency | - | 0 | 120 | MHz |
| f _{PCLK2} | Internal APB2 clock frequency | - | 0 | 120 | |
| V_{DD} | Standard operating voltage | - | 1.71 ⁽¹⁾ | 3.6 | ٧ |
| V | PG[15:2] I/Os supply voltage | At least one I/O in PG[15:2] used | 1.08 | 3.6 | |
| V_{DDIO2} | PG[15.2] I/Os supply voltage | PG[15:2] not used | 0 | 3.6 | |
| | | ADC or COMP used | 1.62 | | |
| | | DAC or OPAMP used | 1.8 | | V |
| V_{DDA} | Analog supply voltage | VREFBUF used | 2.4 | 3.6 | |
| | | ADC, DAC, OPAMP, COMP, VREFBUF not used | 0 | | |
| V _{BAT} | Backup operating voltage | - | 1.55 | 3.6 | |
| V | USB supply voltage | USB used | 3.0 | 3.6 | V |
| V _{DDUSB} | USB supply voltage | USB not used | 0 | 3.6 | V |
| | | TT_xx I/O | -0.3 | V _{DDIOx} +0.3 | |
| V _{IN} | I/O input voltage | All I/O except TT_xx | -0.3 | $\begin{array}{c} {\rm MIN(MIN(V_{DD},V_{DDA},\\ V_{DDIO2},\\ V_{DDUSB})+3.6\ V,\\ 5.5\ V)^{(2)(3)} \end{array}$ | V |
| | | LQFP144 | | | |
| | | LQFP100 | | Section 7.9: Thermal teristics for application | |
| | | UFBGA169 | ар | propriate thermal | |
| Б | Power dissipation at T _A = 85 °C for suffix 6 ⁽⁴⁾ | UFBGA132 | | tance and package. er dissipation is then | mW |
| P_{D} | | WLCSP100 | | ted according ambient perature (TA) and | IIIVV |
| | | LQFP48 | m | aximum junction | |
| | | LQFP64 | | nperature (TJ) and ed thermal resistance. | |
| | | UFQFPN48 | 3010010 | og alemia resistance. | |

Table 21. General operating conditions (continued)

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------|---|--------------------------------------|--------|--|-------|
| | | LQFP144 | 0 | 2 (70 7) | |
| | | LQFP100 | | Section 7.9: Thermal teristics for application | |
| | | UFBGA169 | | propriate thermal | |
| P _D | Power dissipation at | UFBGA132 | | tance and package. er dissipation is then | mW |
| r _D | $T_A = 125 ^{\circ}\text{C}$ for suffix $3^{(4)}$ | WLCSP100 | | ted according ambient perature (TA) and | 11100 |
| | | LQFP48 | | aximum junction | |
| | | LGFP64 | | nperature (TJ) and ed thermal resistance. | |
| | | UFQFPN48 | 00,000 | a tromarrodotarios. | |
| | Ambient temperature for the | Maximum power dissipation | -40 | 85 | |
| TA | suffix 6 version | Low-power dissipation ⁽⁵⁾ | -40 | 105 | °C |
| IA | Ambient temperature for the | Maximum power dissipation | -40 | 125 | |
| | suffix 3 version | Low-power dissipation ⁽⁵⁾ | -40 | 130 | |
| TJ | Junction temperature range | Suffix 6 version | -40 | 105 | °C |
| 13 | Junion temperature range | Suffix 3 version | -40 | 130 |] |

^{1.} When RESET is released functionality is guaranteed down to $\rm V_{BOR0}\,Min.$

This formula has to be applied only on the power supplies related to the IO structure described by the pin definition table. Maximum I/O input voltage is the smallest value between MIN(V_{DD}, V_{DDA}, V_{DDIO2}, V_{DDUSB})+3.6 V and 5.5V.

^{3.} For operation with voltage higher than Min (V_{DD} , V_{DDA} , V_{DDIO2} , V_{DDUSB}) +0.3 V, the internal Pull-up and Pull-Down resistors must be disabled.

^{4.} If T_A is lower, higher P_D values are allowed as long as T_J does not exceed T_{Jmax} (see Section 7.9: Thermal characteristics).

In low-power dissipation state, T_A can be extended to this range as long as T_J does not exceed T_{Jmax} (see Section 7.9: Thermal characteristics).

6.3.2 Operating conditions at power-up / power-down

The parameters given in *Table 22* are derived from tests performed under the ambient temperature condition summarized in *Table 21*.

Table 22. Operating conditions at power-up / power-down

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|-----------------------------------|------------|-----|-----|-------|
| | V _{DD} rise time rate | - | 0 | ∞ | μs/V |
| t _{VDD} | V _{DD} fall time rate | ENULP=0 | 10 | 8 | μ5/ ν |
| | V _{DD} rail time rate | ENULP=1 | 100 | ∞ | ms/V |
| + | V _{DDA} rise time rate | | 0 | 8 | μs/V |
| t _{VDDA} | V _{DDA} fall time rate | - | 10 | 8 | μ5/ ν |
| + | V _{DDUSB} rise time rate | | 0 | ∞ | uo/\/ |
| t _{VDDUSB} | V _{DDUSB} fall time rate | - | 10 | ∞ | µs/V |
| 4 | V _{DDIO2} rise time rate | | 0 | ∞ | uo/\/ |
| t _{VDDIO2} | V _{DDIO2} fall time rate | _ | 10 | ∞ | µs/V |

6.3.3 Embedded reset and power control block characteristics

The parameters given in *Table 23* are derived from tests performed under the ambient temperature conditions summarized in *Table 21: General operating conditions*.

Table 23. Embedded reset and power control block characteristics

| Symbol | Parameter | Conditions ⁽¹⁾ | Min | Тур | Max | Unit |
|--------------------------------------|--|---------------------------|------|------|------|------|
| t _{RSTTEMPO} ⁽²⁾ | Reset temporization after BOR0 is detected | V _{DD} rising | - | 250 | 400 | μs |
| V _{BOR0} (2) | Brown-out reset threshold 0 | Rising edge | 1.62 | 1.66 | 1.7 | V |
| VBOR0` | Brown-out reset timeshold o | Falling edge | 1.6 | 1.64 | 1.69 | V |
| V | Brown-out reset threshold 1 | Rising edge | 2.06 | 2.1 | 2.14 | V |
| V _{BOR1} | Brown-out reset timeshold i | Falling edge | 1.96 | 2 | 2.04 | V |
| V | Brown-out reset threshold 2 | Rising edge | 2.26 | 2.31 | 2.35 | V |
| V _{BOR2} | brown-out reset threshold 2 | Falling edge | 2.16 | 2.20 | 2.24 | V |
| V | Brown-out reset threshold 3 | Rising edge | 2.56 | 2.61 | 2.66 | V |
| V _{BOR3} | Brown-out reset threshold 3 | Falling edge | 2.47 | 2.52 | 2.57 | V |
| V | Brown-out reset threshold 4 | Rising edge | 2.85 | 2.90 | 2.95 | V |
| V_{BOR4} | Brown-out reset timeshold 4 | Falling edge | 2.76 | 2.81 | 2.86 | V |
| V | Programmable voltage | Rising edge | 2.1 | 2.15 | 2.19 | V |
| V _{PVD0} | detector threshold 0 | Falling edge | 2 | 2.05 | 2.1 | V |
| V | PVD threshold 1 | Rising edge | 2.26 | 2.31 | 2.36 | V |
| V _{PVD1} | L AD IIII GSHOID I | Falling edge | 2.15 | 2.20 | 2.25 |] |

Table 23. Embedded reset and power control block characteristics (continued)

| Symbol | Parameter | Conditions ⁽¹⁾ | Min | Тур | Max | Unit |
|---|--|-------------------------------|------|------|------|----------|
| | DVD throughold 0 | Rising edge | 2.41 | 2.46 | 2.51 | V |
| V _{PVD2} | PVD threshold 2 | Falling edge | 2.31 | 2.36 | 2.41 | V |
| V | PVD threshold 3 | Rising edge | 2.56 | 2.61 | 2.66 | V |
| V _{PVD3} | FVD tillesiloid 3 | Falling edge | 2.47 | 2.52 | 2.57 | V |
| V _{PVD4} | PVD threshold 4 | Rising edge | 2.69 | 2.74 | 2.79 | \ \ |
| V PVD4 | 1 VD till Colloid 4 | Falling edge | 2.59 | 2.64 | 2.69 | V |
| V _{PVD5} | PVD threshold 5 | Rising edge | 2.85 | 2.91 | 2.96 | \ \ |
| V PVD5 | 1 VD threshold 5 | Falling edge | 2.75 | 2.81 | 2.86 | V |
| V _{PVD6} | PVD threshold 6 | Rising edge | 2.92 | 2.98 | 3.04 | V |
| V PVD6 | 1 VD threshold 0 | Falling edge | 2.84 | 2.90 | 2.96 | V |
| V | Hysteresis voltage of | Hysteresis in continuous mode | - | 20 | - | mV |
| V _{hyst_} BORH0 | BORH0 | Hysteresis in other mode | - | 30 | - | IIIV |
| V _{hyst_BOR_PVD} | Hysteresis voltage of BORH (except BORH0) and PVD | - | - | 100 | - | mV |
| I _{DD} | BOR ⁽³⁾ (except BOR0) and PVD consumption from V _{DD} with ENULP=0 | - | - | 1.1 | 1.6 | μA |
| (BOR_PVD) ⁽²⁾ | BOR ⁽³⁾ (except BOR0) and PVD consumption from V _{DD} with ENULP=1 | - | - | 55 | 1000 | nA |
| V _{PVM1} | V _{DDUSB} peripheral voltage monitoring | - | 1.18 | 1.22 | 1.26 | V |
| V | V _{DDA} peripheral voltage | Rising edge | 1.61 | 1.65 | 1.69 | V |
| V _{PVM3} | monitoring | Falling edge | 1.6 | 1.64 | 1.68 | V |
| V | V _{DDA} peripheral voltage | Rising edge | 1.78 | 1.82 | 1.86 | V |
| V _{PVM4} | monitoring | Falling edge | 1.77 | 1.81 | 1.85 | \ \ |
| V _{hyst_PVM3} | PVM3 hysteresis | - | - | 10 | - | mV |
| V _{hyst_PVM4} | PVM4 hysteresis | - | - | 10 | - | mV |
| I _{DD} (PVM1/PVM2) ⁽²⁾ | PVM1 and PVM2 consumption from V _{DD} | - | - | 0.2 | - | μA |
| I _{DD} (PVM3/PVM4) ⁽²⁾ | PVM3 and PVM4 consumption from V _{DD} | - | | 2 | | μA |

Continuous mode means Run/Sleep modes, or temperature sensor enable in Low-power run/Low-power sleep modes.

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^{2.} Guaranteed by design.

^{3.} BOR0 is enabled in all modes (except shutdown) and its consumption is therefore included in the supply current characteristics tables.

6.3.4 Embedded voltage reference

The parameters given in *Table 24* are derived from tests performed under the ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*.

Table 24. Embedded internal voltage reference

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---|--|-----------------------------------|------------------|-------|---------------------|-----------------------------|
| V _{REFINT} | Internal reference voltage | -40 °C < T _J < +130 °C | 1.182 | 1.212 | 1.232 | V |
| t _{S_vrefint} (1) | ADC sampling time when reading the internal reference voltage | - | 4 ⁽²⁾ | - | - | μs |
| t _{start_vrefint} | Start time of reference voltage buffer when ADC is enable | - | - | 8 | 12 ⁽²⁾ | μs |
| I _{DD} (V _{REFINTBUF}) | V _{REFINT} buffer consumption from V _{DD} when converted by ADC | - | - | 12.5 | 20 ⁽²⁾ | μΑ |
| ΔV_{REFINT} | Internal reference voltage spread over the temperature range | V _{DD} = 3 V | - | 5 | 7.5 ⁽²⁾ | mV |
| T _{Coeff} | Average temperature coefficient | -40°C < T _J < +130°C | - | 30 | 50 ⁽²⁾ | ppm/°C |
| A _{Coeff} | Long term stability | 1000 hours, T = 25°C | - | 300 | 1000 ⁽²⁾ | ppm |
| V _{DDCoeff} | Average voltage coefficient | 3.0 V < V _{DD} < 3.6 V | - | 250 | 1200 ⁽²⁾ | ppm/V |
| V _{REFINT_DIV1} | 1/4 reference voltage | | 24 | 25 | 26 | 0.4 |
| V _{REFINT_DIV2} | 1/2 reference voltage | - | 49 | 50 | 51 | $^{\%}$ V _{REFINT} |
| V _{REFINT_DIV3} | 3/4 reference voltage | | 74 | 75 | 76 | IXLI IINI |

^{1.} The shortest sampling time can be determined in the application by multiple iterations.

^{2.} Guaranteed by design.

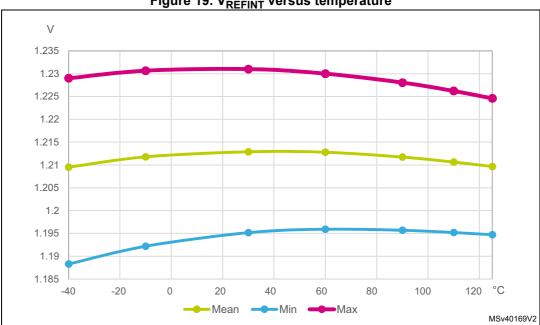


Figure 19. V_{REFINT} versus temperature

6.3.5 Supply current characteristics

The current consumption is a function of several parameters and factors such as the operating voltage, ambient temperature, I/O pin loading, device software configuration, operating frequencies, I/O pin switching rate, program location in memory and executed binary code

The current consumption is measured as described in .

Typical and maximum current consumption

The MCU is placed under the following conditions:

- All I/O pins are in analog input mode
- All peripherals are disabled except when explicitly mentioned
- The Flash memory access time is adjusted with the minimum wait states number, depending on the f_{HCLK} frequency (refer to the table "Number of wait states according to CPU clock (HCLK) frequency" available in the RM0432 reference manual).
- When the peripherals are enabled f_{PCLK} = f_{HCLK}
- The voltage scaling Range 1 is adjusted to f_{HCLK} frequency as follows:
 - Voltage Range 1 Boost mode for 80 MHz < f_{HCLK} <= 120 MHz
 - Voltage Range 1 Normal mode for 26 MHz < f_{HCLK} <= 80 MHz

The parameters given in *Table 25* to *Table 32* are derived from tests performed under ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*.



Table 25. Current consumption in Run and Low-power run modes, code with data processing running from Flash in single Bank, ART enable (Cache ON Prefetch OFF)

| | | Condit | tions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|----------|----------------------------------|---------------------------------|-----------------------|---------|-------|-------|-------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | | 26 MHz | 3.15 | 3.50 | 4.50 | 5.95 | 8.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.05 | 2.40 | 3.35 | 4.80 | 7.35 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 8 MHz | 1.15 | 1.50 | 2.50 | 3.85 | 6.40 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 2 | 4 MHz | 0.69 | 1.00 | 2.00 | 3.40 | 5.95 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 0.46 | 0.79 | 1.75 | 3.15 | 5.70 | TBD | TBD | TBD | TBD | TBD | |
| | | fHCLK = fHSE | | 1 MHz | 0.35 | 0.68 | 1.65 | 3.05 | 5.60 | TBD | TBD | TBD | TBD | TBD | |
| | Cumply | up to 48 MHz included, | | 100 KHz | 0.25 | 0.58 | 1.55 | 2.95 | 5.50 | TBD | TBD | TBD | TBD | TBD | |
| IDD(Run) | Supply current in Run mode | bypass mode PLL ON | Range 1 Boost mode | 120 MHz | 17.50 | 18.00 | 19.50 | 21.50 | 25.00 | TBD | TBD | TBD | TBD | TBD | mA |
| | | above 48 MHz all peripherals | | 80 MHz | 11.00 | 11.50 | 13.00 | 15.00 | 18.00 | TBD | TBD | TBD | TBD | TBD | |
| | | disable | | 72 MHz | 10.00 | 10.50 | 12.00 | 13.50 | 17.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 1 | 64 MHz | 9.05 | 9.55 | 11.00 | 12.50 | 16.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Normal | 48 MHz | 6.80 | 7.30 | 8.55 | 10.50 | 13.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | mode | 32 MHz | 4.65 | 5.10 | 6.35 | 8.10 | 11.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 24 MHz | 3.55 | 4.00 | 5.25 | 7.00 | 10.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.45 | 2.90 | 4.10 | 5.85 | 8.90 | TBD | TBD | TBD | TBD | TBD | |
| | Supply | | | 2 MHz | 420 | 825 | 1900 | 3500 | 6250 | TBD | TBD | TBD | TBD | TBD | |
| IDD | current in | fHCLK = | | 1 MHz | 295 | 680 | 1800 | 3350 | 6100 | TBD | TBD | TBD | TBD | TBD | μA |
| (LPRun) | Low-power run mode | all periphera | als disable | 400 KHz | 205 | 610 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | μ, , |
| | | | | 100 KHz | 190 | 565 | 1650 | 3250 | 6000 | TBD | TBD | TBD | TBD | TBD | |

^{1.} Guaranteed by characterization results, unless otherwise specified.





Table 26. Current consumption in Run and Low-power run modes, code with data processing running from Flash in dual bank, ART enable (Cache ON Prefetch OFF)

| | | Condi | tions | | | | TYP | | | | | MAX ⁽¹⁾ | | | | | |
|--------------|----------------------------------|-----------------------------|-----------------------|---------|-------|--------|-------|-------|-------|------|-------|--------------------|-------|-------|------|-----|--|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit | | |
| | | | | 26 MHz | 3.30 | 3.65 | 4.65 | 6.10 | 8.75 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | | 16 MHz | 2.10 | 2.45 | 3.45 | 4.90 | 7.50 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | | 8 MHz | 1.20 | 1.50 | 2.50 | 3.95 | 6.55 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | Range 2 | 4 MHz | 0.71 | 1.05 | 2.05 | 3.45 | 6.05 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | | 2 MHz | 0.47 | 0.80 | 1.80 | 3.20 | 5.80 | TBD | TBD | TBD | TBD | TBD | | | |
| | | fHCLK = fHSE | | 1 MHz | 0.36 | 0.68 | 1.65 | 3.10 | 5.65 | TBD | TBD | TBD | TBD | TBD | • | | |
| | | up to 48MHz included, | | 100 KHz | 0.25 | 0.58 | 1.55 | 2.95 | 5.55 | TBD | TBD | TBD | TBD | TBD | • | | |
| IDD (Run) | Supply current in Run mode | bypass mode PLL ON above | Range 1 Boost Mode | 120 MHz | 16.00 | 16.50 | 18.00 | 20.00 | 23.50 | TBD | TBD | TBD | TBD | TBD | mA | | |
| | | 48 MHz all peripherals | | 80 MHz | 11.50 | 12.50 | 13.50 | 15.50 | 18.50 | TBD | TBD | TBD | TBD | TBD | | | |
| | | disable | | 72 MHz | 10.50 | 11.00 | 12.50 | 14.50 | 17.50 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | Range 1 | 64 MHz | 9.50 | 10.00 | 11.50 | 13.00 | 16.50 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | Normal | 48 MHz | 7.10 | 7.60 | 8.90 | 10.50 | 14.00 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | Mode | 32 MHz | 4.85 | 5.30 | 6.60 | 8.35 | 11.50 | TBD | TBD | TBD | TBD | TBD | | | |
| | | | | | | 24 MHz | 3.70 | 4.15 | 5.45 | 7.15 | 10.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.60 | 3.00 | 4.25 | 6.00 | 9.10 | TBD | TBD | TBD | TBD | TBD | • | | |
| | 0 | | | 2 MHz | 420 | 840 | 1950 | 3550 | 6350 | TBD | TBD | TBD | TBD | TBD | | | |
| IDD | Supply current in | fHCLK = fMSI | | 1 MHz | 305 | 700 | 1800 | 3400 | 6200 | TBD | TBD | TBD | TBD | TBD | | | |
| (LPRun) | Low-power | all peripherals of | disable | 400 KHz | 225 | 610 | 1700 | 3300 | 6100 | TBD | TBD | TBD | TBD | TBD | μA | | |
| | run mode | | | 100 KHz | 185 | 570 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | | | |

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1. Guaranteed by characterization results, unless otherwise specified.

Table 27. Current consumption in Run and Low-power run modes, code with data processing running from Flash in single bank, ART disable

| | | Condit | ions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|----------|----------------------------------|-----------------------------|-----------------------|---------|-------|-------|-------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | | 26 MHz | 3.60 | 3.95 | 4.95 | 6.40 | 9.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.40 | 2.75 | 3.75 | 5.15 | 7.70 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 8 MHz | 1.35 | 1.70 | 2.70 | 4.10 | 6.60 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 2 | 4 MHz | 0.79 | 1.10 | 2.10 | 3.50 | 6.05 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 0.51 | 0.84 | 1.80 | 3.20 | 5.75 | TBD | TBD | TBD | TBD | TBD | |
| | | fHCLK = fHSE | | 1 MHz | 0.38 | 0.70 | 1.65 | 3.05 | 5.70 | TBD | TBD | TBD | TBD | TBD | |
| | | up to 48MHz included. | | 100 KHz | 0.25 | 0.58 | 1.55 | 2.95 | 5.50 | TBD | TBD | TBD | TBD | TBD | |
| IDD(Run) | Supply current in Run mode | bypass mode PLL ON above | Range 1 Boost Mode | 120 MHz | 17.50 | 18.00 | 19.50 | 21.50 | 25.00 | TBD | TBD | TBD | TBD | TBD | mA |
| | | 48 MHz all peripherals | | 80 MHz | 12.50 | 13.00 | 14.00 | 16.00 | 19.00 | TBD | TBD | TBD | TBD | TBD | |
| | | disable | | 72 MHz | 11.00 | 11.50 | 13.00 | 15.00 | 18.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 1 | 64 MHz | 10.00 | 10.50 | 12.00 | 13.50 | 17.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Normal | 48 MHz | 7.90 | 8.40 | 9.70 | 11.50 | 14.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | Mode | 32 MHz | 5.60 | 6.10 | 7.35 | 9.10 | 12.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 24 MHz | 4.25 | 4.75 | 5.10 | 7.75 | 11.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 3.00 | 3.45 | 4.70 | 6.45 | 9.50 | TBD | TBD | TBD | TBD | TBD | |
| | Supply | | | 2 MHz | 495 | 890 | 2000 | 3550 | 6300 | TBD | TBD | TBD | TBD | TBD | |
| IDD | current in | fHCLK = fMSI | | 1 MHz | 315 | 720 | 1800 | 3400 | 6150 | TBD | TBD | TBD | TBD | TBD | μA |
| (LPRun) | Low-power run mode | all peripherals of | lisable | 400 KHz | 235 | 615 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | μ, τ |
| | | | | 100 KHz | 175 | 575 | 1700 | 3200 | 6000 | TBD | TBD | TBD | TBD | TBD | |





1. Guaranteed by characterization results, unless otherwise specified.

Table 28. Current consumption in Run and Low-power run modes, code with data processing running from Flash in dual bank, ART disable

| | | Condi | tions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|--------------|----------------------------------|--|--------------------------|---------|-------|-------|-------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | | 26 MHz | 3.70 | 4.05 | 5.05 | 6.50 | 9.15 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.50 | 2.85 | 3.85 | 5.25 | 7.85 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 8 MHz | 1.10 | 1.75 | 2.75 | 4.15 | 6.75 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 2 | 4 MHz | 0.82 | 1.15 | 2.15 | 3.55 | 6.15 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 0.53 | 0.86 | 1.85 | 3.20 | 5.85 | TBD | TBD | TBD | TBD | TBD | |
| | | fHCLK = fHSE up to | | 1 MHz | 0.38 | 0.71 | 1.70 | 3.05 | 5.70 | TBD | TBD | TBD | TBD | TBD | |
| | | 48MHz | | 100 KHz | 0.25 | 0.58 | 1.55 | 2.95 | 5.55 | TBD | TBD | TBD | TBD | TBD | |
| IDD (Run) | Supply current in Run mode | included, bypass mode PLL ON above 48 | Range 1 Boost Mode | 120 MHz | 16.00 | 16.50 | 18.00 | 20.00 | 23.50 | TBD | TBD | TBD | TBD | TBD | mA |
| | | MHz all | | 80 MHz | 12.00 | 12.50 | 14.00 | 16.00 | 19.00 | TBD | TBD | TBD | TBD | TBD | |
| | | peripherals disable | | 72 MHz | 11.00 | 11.50 | 13.00 | 14.50 | 18.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 1 | 64 MHz | 9.65 | 10.00 | 11.50 | 13.50 | 16.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | Normal | 48 MHz | 8.10 | 8.65 | 9.95 | 12.00 | 15.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Mode | 32 MHz | 5.80 | 6.30 | 7.60 | 9.35 | 12.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 24 MHz | 4.45 | 4.90 | 6.15 | 7.95 | 11.00 | TBD | TBD | TBD | TBD | TBD | - |
| | | | | 16 MHz | 3.15 | 3.65 | 4.85 | 6.65 | 9.75 | TBD | TBD | TBD | TBD | TBD | |

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Table 28. Current consumption in Run and Low-power run modes, code with data processing running from Flash in dual bank, ART disable (continued)

| | | Condit | tions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|---------|--------------------|-----------------|--------------------|---------|------|------|------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | Cumply | | | 2 MHz | 485 | 900 | 2000 | 3600 | 6400 | TBD | TBD | TBD | TBD | TBD | |
| IDD | Supply current in | fHCLK = fMSI | | 1 MHz | 355 | 730 | 1850 | 3400 | 6200 | TBD | TBD | TBD | TBD | TBD | |
| (LPRun) | Low-power run mode | all peripherals | disable | 400 KHz | 240 | 630 | 1750 | 3300 | 6100 | TBD | TBD | TBD | TBD | TBD | μA |
| | Turrinoue | | | 100 KHz | 175 | 580 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | |

^{1.} Guaranteed by characterization results, unless otherwise specified.





Table 29. Current consumption in Run and Low-power run modes, code with data processing running from SRAM1

| | | Condi | tions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|----------|----------------------------------|-----------------------------|--|---------|-------|-------|-------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | | 26 MHz | 3.00 | 3.35 | 4.35 | 5.80 | 8.40 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 1.95 | 2.25 | 3.25 | 4.70 | 7.30 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 8 MHz | 1.10 | 1.40 | 2.40 | 3.85 | 6.45 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 2 | 4 MHz | 0.66 | 0.99 | 1.95 | 3.40 | 5.95 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 0.45 | 0.78 | 1.75 | 3.20 | 5.75 | TBD | TBD | TBD | TBD | TBD | |
| | | fHCLK = fHSE | | 1 MHz | 0.34 | 0.67 | 1.65 | 3.05 | 5.65 | TBD | TBD | TBD | TBD | TBD | |
| | Supply | up to 48MHz included, | | 100 KHz | 0.25 | 0.58 | 1.55 | 2.95 | 5.55 | TBD | TBD | TBD | TBD | TBD | |
| IDD(Run) | Supply current in Run mode | bypass mode PLL ON above | Range 1 Boost Mode | 120 MHz | 17.00 | 17.50 | 19.00 | 21.00 | 24.50 | TBD | TBD | TBD | TBD | TBD | mA |
| | | 48 MHz all peripherals | | 80 MHz | 10.50 | 11.00 | 12.50 | 14.50 | 17.50 | TBD | TBD | TBD | TBD | TBD | |
| | | disable | | 72 MHz | 9.55 | 10.00 | 11.50 | 13.00 | 16.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 1 | 64 MHz | 8.55 | 9.05 | 10.50 | 12.00 | 15.50 | TBD | TBD | TBD | TBD | TBD | |
| | | | Normal | 48 MHz | 6.45 | 6.90 | 8.20 | 10.00 | 13.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | Mode | 32 MHz | 4.40 | 4.85 | 6.10 | 7.90 | 11.00 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 24 MHz | 3.35 | 3.80 | 5.10 | 6.85 | 9.95 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 2.35 | 2.80 | 4.05 | 5.75 | 8.90 | TBD | TBD | TBD | TBD | TBD | |
| | Supply | | | 2 MHz | 415 | 805 | 1900 | 3500 | 6300 | TBD | TBD | TBD | TBD | TBD | |
| IDD | current in | fHCLK = fMSI | lisahle | 1 MHz | 300 | 660 | 1800 | 3350 | 6150 | TBD | TBD | TBD | TBD | TBD | μA |
| (LPRun) | Low-power | | all peripherals disable FLASH in power-down | 400 KHz | 205 | 595 | 1700 | 3250 | 6100 | TBD | TBD | TBD | TBD | TBD | μΛ |
| | run mode FL | | | 100 KHz | 160 | 560 | 1650 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | |

^{1.} Guaranteed by characterization results, unless otherwise specified.

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Table 30. Typical current consumption in Run and Low-power run modes, with different codes running from Flash, ART enable (Cache ON Prefetch OFF)

| Symbol | Parameter | Conditions | | Code | TYP Single Bank Mode | TYP Dual Bank Mode | Unit | TYP Single Bank Mode | TYP Dual Bank Mode | Unit |
|----------------|-------------------------------|--|--------------------------|-----------------------------|----------------------------|--------------------------|------|----------------------------|---|--------|
| | | - | Voltage scaling | | 25°C | 25°C | | 25°C | 25°C | |
| | | | | Reduced code ⁽¹⁾ | 3.15 | 3.30 | | 121 | 127 | |
| | | | | Coremark | 3.40 | 3.50 | | 131 | 135 | |
| | | | Range2 fHCLK=26MHz | Dhrystone2.1 | 3.80 | 3.70 | mA | 146 | 142 | μΑ/MHz |
| | | | II IOLIX-ZOWI IZ | Fibonacci | 3.45 | 3.65 | | 133 | 140 | |
| | DD Supply current in Run mode | | | While ⁽¹⁾ | 2.90 | 2.90 | | 112 | 112 | |
| | | fHCLK=fHSE up | | Reduced code ⁽¹⁾ | 11.00 | 11.50 | | 138 | 144 | |
| | Supply | to 48 MHZ included, bypass | Range 1 | Coremark | 12.50 | 13.00 | | 156 | 163 | |
| IDD (Run) | current in | mode PLL ON | Normal Mode fHCLK= 80 | Dhrystone2.1 | 13.50 | 13.00 | mA | 169 | 163 | μΑ/MHz |
| (Itali) | Run mode | above 48 MHz all peripherals | MHz | Fibonacci | 12.50 | 13.00 | | 156 | 163 | |
| | | disable | | While ⁽¹⁾ | 10.50 | 10.50 | | 131 | 131 | |
| | | | | Reduced code ⁽¹⁾ | 17.50 | 16.00 | | 146 | 127 135 142 140 112 144 163 163 163 131 133 167 171 175 138 210 238 253 238 | |
| | | | Range 1 | Coremark | 19.50 | 20.00 | | 163 | 167 | |
| | | | Boost Mode fHCLK= 120 | Dhrystone2.1 | 20.00 | 20.50 | mA | 167 | 171 | μΑ/MHz |
| | | | MHz | Fibonacci | 19.50 | 21.00 | | 163 | 175 | |
| | | | | While ⁽¹⁾ | 16.50 | 16.50 | | 138 | 138 | |
| | | | L | Reduced code ⁽¹⁾ | 420 | 420 | | 210 | 210 | |
| | Supply | | | Coremark | 435 | 475 | 1 | 218 | 238 | |
| IDD (LPRun) | current in | fHCLK = fMSI = 2 pripherals disable | MHz all | Dhrystone2.1 | 485 | 505 | μΑ | 243 | 253 | µA/MHz |
| (Li itali) | run | Pripriciais disable | | Fibonacci | 475 | 475 | 1 | 238 | 238 | |
| | DD current in Low-power | | | While ⁽¹⁾ | 375 | 515 | 1 | 188 | 258 | |



^{1.} Reduced code used for characterization results provided in *Table 25*, *Table 27*, *Table 29*.



Table 31. Typical current consumption in Run and Low-power run modes, with different codes running from Flash, ART disable

| Symbol | Parameter | Condi | tions | Code | TYP Single Bank Mode | TYP Dual Bank Mode | Unit | TYP Single Bank Mode | TYP Dual Bank Mode | Unit |
|-----------|------------|-----------------------------|--------------------------|-----------------------------|----------------------------|--------------------------|------|----------------------------|--|--------|
| | | - | Voltage scaling | | 25°C | 25°C | | 25°C | 25°C | |
| | | | | Reduced code ⁽¹⁾ | 3.60 | 3.70 | | 138 | 142 | |
| | | | Range2 | Coremark | 3.75 | 3.45 | | 144 | 133 | |
| | | | fHCLK=26MH | Dhrystone2.1 | 3.80 | 3.50 | mA | 146 | 135 | μΑ/MHz |
| | | fHCLK=fHSE up to 48 MHZ | Z | Fibonacci | 3.70 | 3.20 | | 142 | 123 | |
| | | | | While ⁽¹⁾ | 2.90 | 2.90 | | 112 | 112 | |
| Supr | | | | Reduced code ⁽¹⁾ | 12.50 | 12.00 | | 156 | 150 | |
| | Supply | included, | Range 1 | Coremark | 12.50 | 11.00 | | 156 | 138 | |
| IDD (Run) | current in | bypass mode PLL ON above | Normal Mode fHCLK= 80 | Dhrystone2.1 | 12.50 | 11.50 | mA | 156 | 133 | μΑ/MHz |
| | Run mode | 48 MHz all | MHz | Fibonacci | 12.00 | 10.50 | | 150 | 131 | |
| | | peripherals disable | | While ⁽¹⁾ | 10.50 | 10.50 | | 131 | 131 | |
| | | | | Reduced code ⁽¹⁾ | 17.50 | 16.00 | | 146 | 133 | |
| | | | Range 1 | Coremark | 17.00 | 15.00 | | 142 | 125 | |
| | | | Boost Mode fHCLK= 120 | Dhrystone2.1 | 17.00 | 15.00 | mA | 142 | 125 | μΑ/MHz |
| | | | MHz | Fibonacci | 17.00 | 14.00 | | 142 | 117 |] |
| | | | | While ⁽¹⁾ | 16.50 | 16.50 | | 138 | 8 142 4 133 6 135 2 123 2 112 6 150 6 138 6 144 0 131 1 131 6 133 2 125 2 125 2 117 |] |

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Table 31. Typical current consumption in Run and Low-power run modes, with different codes running from Flash, ART disable (continued)

| Symbol | Parameter | Condi | ions | Code | TYP Single Bank Mode | TYP Dual Bank Mode | Unit | TYP Single Bank Mode | TYP Dual Bank Mode | Unit |
|----------------|-------------------------|---------------------------|----------------------|-----------------------------|----------------------------|--------------------------|------|----------------------------|--------------------------|--------|
| | | - | Voltage scaling | | 25°C | 25°C | | 25°C | 25°C | |
| | | | | Reduced code ⁽¹⁾ | 495 | 485 | | 248 | 243 | |
| 100 | Supply | | | Coremark | 540 | 550 | | 270 | 275 | |
| IDD (LPRun) | current in Low-power | fHCLK = fMS pripherals | | Dhrystone2.1 | 600 | 565 | μA | 300 | 283 | µA/MHz |
| (Li itali) | run | . | | Fibonacci | 550 | 545 | | 275 | 273 | |
| | | | While ⁽¹⁾ | 365 | 720 | | 183 | 360 |] | |

^{1.} Reduced code used for characterization results provided in *Table 25*, *Table 27*, *Table 29*.



Table 32. Typical current consumption in Run and Low-power run modes, with different codes running from SRAM1

| | | Conditions | | | TYP | | TYP | |
|-----------|---------------------------------|---|---------------------------|-----------------------------|-------|---|------|--------|
| Ru (Ruii) | Parameter | - | Voltage scaling | Code | 25°C | Unit | 25°C | Unit |
| | | | | Reduced code ⁽¹⁾ | 3.00 | | 115 | |
| | | | Range2 | Coremark | 3.00 | | 115 | |
| | | | fHCLK=26 | Dhrystone2.1 | 3.00 | mA | 115 | μA/MHz |
| | | | MHz | Fibonacci | 2.95 | | 113 | |
| | | | | While ⁽¹⁾ | 2.85 | | 110 | |
| | | | D 4 | Reduced code ⁽¹⁾ | 10.50 | | 131 | |
| | | fHCLK=fHSE up to 48 | Normal | Coremark | 9.90 | | 124 | |
| IDD (Run) | Supply current in Run mode | | Mode | Code 25°C | 131 | μΑ/MHz | | |
| | | IHz all peripherals disable | e fHCLK= 80 MHz | Fibonacci | 10.50 | | 131 | |
| | | | | While ⁽¹⁾ | 10.50 | | 131 | |
| | | MHZ included, bypass mode PLL ON above 48 MHz all peripherals disable Range 1 | | Reduced code ⁽¹⁾ | 17.00 | | 142 | |
| | | | _ | Coremark | 15.50 | | 129 | |
| | | | Boost Mode fHCI K= 120 | Dhrystone2.1 | 17.00 | mA | 142 | μA/MHz |
| | | | MHz | Fibonacci | 16.50 | | 138 | |
| | | | | While ⁽¹⁾ | 16.50 | | 138 | |
| | | | | Reduced code ⁽¹⁾ | 415 | | 208 | |
| | | | | Coremark | 300 | | 150 | |
| | Supply current in Low-power run | fHCLK = fMSI = 2MHz all pi disable | ripherals | Dhrystone2.1 | 425 | μΑ | 213 | μΑ/MHz |
| | | | | Fibonacci | 410 | mA 131 131 131 131 142 129 mA 142 138 138 208 150 | | |
| | | | | While ⁽¹⁾ | 420 | | 210 | |

^{1.} Reduced code used for characterization results provided in *Table 25*, *Table 27*, *Table 29*.

Table 33. Current consumption in Sleep and Low-power sleep mode, Flash ON

| | | Condit | ions | | | | TYP | | | | | MAX ⁽¹⁾ | | | |
|----------------|------------------------------------|--|--------------------------|---------|------|------|------|-------|-------|------|------|--------------------|-------|-------|------------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | | 26 MHz | 0.98 | 1.30 | 2.30 | 3.75 | 6.35 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 16 MHz | 0.70 | 1.05 | 2.00 | 3.45 | 6.05 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 8 MHz | 0.47 | 0.80 | 1.75 | 3.20 | 5.80 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 2 | 4 MHz | 0.35 | 0.69 | 1.65 | 3.10 | 5.65 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 0.30 | 0.63 | 1.60 | 3.00 | 5.60 | TBD | TBD | TBD | TBD | TBD | |
| | | fHCLK = fHSE | | 1 MHz | 0.27 | 0.60 | 1.55 | 3.00 | 5.55 | TBD | TBD | TBD | TBD | TBD | |
| | | up to 48MHz | | 100 KHz | 0.24 | 0.57 | 1.55 | 2.95 | 5.55 | TBD | TBD | TBD | TBD | TBD | |
| IDD (Sleep) | Supply current in Sleep mode | included, bypass mode PLL ON above 48 MHz all | Range 1 Boost Mode | 120 MHz | 4.70 | 5.20 | 6.55 | 8.50 | 12.00 | TBD | TBD | TBD | TBD | TBD | mA |
| | | peripherals disable | | 80 MHz | 3.05 | 3.50 | 4.75 | 6.50 | 9.60 | TBD | TBD | TBD | TBD | TBD | |
| | | uisable | | 72 MHz | 2.80 | 3.25 | 4.45 | 6.20 | 9.35 | TBD | TBD | TBD | TBD | TBD | |
| | | | Range 1 | 64 MHz | 2.50 | 2.95 | 4.20 | 5.95 | 9.05 | TBD | TBD | TBD | TBD | TBD | |
| | | | Normal | 48 MHz | 1.90 | 2.35 | 3.60 | 5.35 | 8.45 | TBD | TBD | TBD | TBD | TBD | |
| | | | Mode | 32 MHz | 1.40 | 1.80 | 3.05 | 4.80 | 7.90 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 24 MHz | 1.10 | 1.55 | 2.75 | 4.50 | 7.60 | TBD | TBD | TBD | TBD | TBD | |
| | 000 | | | 16 MHz | 0.84 | 1.25 | 2.50 | 4.20 | 7.30 | TBD | TBD | TBD | TBD | TBD | |
| | | | | 2 MHz | 235 | 620 | 1750 | 3300 | 6100 | TBD | TBD | TBD | TBD | TBD | |
| IDD | | fHCLK = fMSI | | 1 MHz | 205 | 590 | 1700 | 3300 | 6050 | TBD | TBD | TBD | TBD | TBD | μA |
| (LPSleep) | Low-power sleep mode | all peripherals of | disable | 400 KHz | 190 | 575 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | <u>μ</u> Α |
| | 000 | | | 100 KHz | 170 | 560 | 1650 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | |

^{1.} Guaranteed by characterization results, unless otherwise specified.





Table 34. Current consumption in Low-power sleep mode, Flash in power-down

| | | Con | ditions | | | | TYP | | | | | MAX ⁽ | 1) | | |
|-----------|--------------|--------------|--------------------|---------|------|------|------|-----------|-----------|------|------|------------------|-------|-------|------|
| Symbol | Parameter | - | Voltage scaling | fHCLK | 25°C | 55°C | 85°C | 105° C | 125° C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| Supply | Cupply | | | 2 MHz | 225 | 605 | 1700 | 3300 | 6100 | TBD | TBD | TBD | TBD | TBD | |
| IDD | San Sine iii | fHCLK = fMSI | 1 MHz | 185 | 585 | 1700 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | | |
| (LPSleep) | | s disable | 400 KHz | 165 | 560 | 1650 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | μΑ | |
| sle | | node - | | 100 KHz | 155 | 550 | 1650 | 3250 | 6050 | TBD | TBD | TBD | TBD | TBD | |

^{1.} Guaranteed by characterization results, unless otherwise specified.

Table 35. Current consumption in Stop 2 mode, SRAM3 disabled

| т | 1 | 1 | | • | | • | | | | | | | | |
|----------|--------------|---|-------|------|------|------|-------|-------|--------------------|------|------|-------|-------|------|
| Symbol | Parameter | Conditions | | | | TYP | | | MAX ⁽¹⁾ | | | | | Unit |
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | 1.8 V | 2.90 | 11.0 | 42.0 | 96.5 | 210 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC disabled | 2.4 V | 2.90 | 11.0 | 42.5 | 97.5 | 215 | TBD | TBD | TBD | TBD | TBD | |
| | Supply | | 3 V | 2.95 | 11.0 | 43.0 | 98.5 | 215 | TBD | TBD | TBD | TBD | TBD | |
| IDD | current in | | 3.6 V | 3.00 | 11.5 | 43.5 | 100.0 | 220 | TBD | TBD | TBD | TBD | TBD | μA |
| (Stop 2) | Stop 2 mode, | 2 mode, C disabled RTC disabled ENULP=1 | 1.8 V | 2.80 | - | - | - | - | - | - | ı | - | - | μΛ |
| | RTC disabled | | 2.4 V | 2.85 | - | - | - | - | - | - | - | - | - | |
| | | | 3 V | 2.95 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 2.95 | 1 | - | - | - | - | - | 1 | _ | - | |

Table 35. Current consumption in Stop 2 mode, SRAM3 disabled (continued)

| Symbol | Parameter | Conditions | | | | TYP | | | | | MAX ⁽¹⁾ | | | Unit |
|--------------------------------|----------------------------|---|-------|------|------|------|-------|-------|------|------|--------------------|-------|-------|-------|
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Oilit |
| | | | 1.8 V | 3.30 | 11.5 | 42.5 | 97.0 | 210 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI | 2.4 V | 3.40 | 11.5 | 43.0 | 98.0 | 215 | TBD | TBD | TBD | TBD | TBD | |
| | | THO SIGOROG BY EST | 3 V | 3.60 | 12.0 | 43.5 | 99.0 | 215 | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 3.90 | 12.0 | 44.5 | 100.0 | 225 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI | 1.8 V | 2.95 | - | - | - | - | - | - | - | - | - | |
| | | ENULP=1 | 2.4 V | 2.95 | - | - | - | - | - | - | - | - | - | |
| | | LPCAL=1 LSIPREDIV = 1 | 3 V | 3.05 | - | - | - | - | - | - | - | - | - | |
| | | LSIPKEDIV - I | 3.6 V | 3.10 | - | - | - | - | - | - | - | - | - | |
| | | RTC clocked by LSE | 1.8 V | 2.90 | - | - | - | - | ı | - | - | - | - | |
| IDD (Stop 2 | Supply current in | bypassed at 32768 Hz ENULP=1 | 2.4 V | 2.95 | - | - | - | - | - | - | - | - | - | |
| with RTC) | Stop 2 mode, | LPCAL=1 | 3 V | 3.00 | - | - | - | - | - | - | - | - | - | μA |
| with RTC) | RTC enabled | LSESYSDIS =1 | 3.6 V | 3.15 | - | - | - | - | - | - | - | - | - | |
| | | | 1.8 V | 3.45 | 12.0 | 44.0 | 100.0 | - | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSE | 2.4 V | 3.65 | 12.0 | 45.0 | 100.0 | - | TBD | TBD | TBD | TBD | TBD | |
| | | quartz in low drive mode | 3 V | 3.95 | 12.5 | 45.5 | 105.0 | - | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 4.30 | 13.0 | 46.5 | 105.0 | - | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSE | 1.8 V | 2.95 | 11.0 | 42.5 | 96.5 | - | - | - | - | - | - | |
| | | quartz in low drive mode ENULP = 1 | 2.4 V | 2.95 | 11.0 | 43.0 | 97.5 | - | ı | - | - | - | - | |
| | | LPCAL = 1 | 3 V | 3.10 | 11.5 | 43.5 | 98.5 | - | • | - | - | - | - | |
| | | LSESYSDIS =1 | 3.6 V | 3.25 | 12.0 | 45.0 | 100.0 | - | • | - | - | - | - | |
| | Supply | Wakeup clock is MSI = 48 MHz, voltage Range 1 ⁽²⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | |
| IDD (wakeup from Stop 2) | current during wakeup from | Wakeup clock is MSI = 4 MHz, voltage Range 2 ⁽²⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | mA |
| | Stop 2 | Wakeup clock is HSI = 16 MHz, voltage Range 1 ⁽²⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | |

^{1.} Guaranteed by characterization results, unless otherwise specified.





2. Wakeup with code execution from Flash. Average value given for a typical wakeup time as specified in *Table 43: Low-power mode wakeup timings*.

Table 36. Current consumption in Stop 2 mode, SRAM3 enabled

| IDD (Stop 2) | Doromotor | Conditions | | | | TYP | | | MAX ⁽¹⁾ | | | | | Unit |
|--------------|--------------------------------|--------------|-------|------|------|------|-------|-------|--------------------|------|------|-------|-------|------|
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | |
| | | | 1.8 V | 3.55 | 14.0 | 55.0 | 125 | 280 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC disabled | 2.4 V | 3.60 | 14.0 | 55.5 | 130 | 280 | TBD | TBD | TBD | TBD | TBD | |
| | | KTC disabled | 3 V | 3.65 | 14.0 | 56.0 | 130 | 285 | TBD | TBD | TBD | TBD | TBD | |
| IDD (Stop 2) | Supply current in Stop 2 mode, | | 3.6 V | 3.70 | 14.5 | 56.5 | 130 | 290 | TBD | TBD | TBD | TBD | TBD | μA |
| (Stop 2) | RTC disabled | | 1.8 V | 3.45 | - | - | - | - | - | - | - | - | - | μΑ |
| | | RTC disabled | 2.4 V | 3.45 | - | - | - | - | - | - | - | - | - | |
| | | ENULP=1 | 3 V | 3.55 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 3.65 | - | - | - | - | - | - | - | - | - | |

| Table 36. | Current | consumption | in Stop | 2 mode, | SRAM3 | enabled | (continued) |) |
|-----------|---------|-------------|---------|---------|-------|---------|-------------|---|
| | | | | | | | | |

| Cumbal | Davamatav | Conditions | | | | TYP | | | | | MAX ⁽¹⁾ | | | Unit |
|----------------------|---|---|-------|------|------|------|-------|-------|------|------|--------------------|-------|-------------------|------|
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | 1.8 V | 3.95 | 14.5 | 55.5 | 125 | 280 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI | 2.4 V | 4.15 | 14.5 | 56.0 | 130 | 280 | TBD | TBD | TBD | TBD | TBD | |
| | | | 3 V | 4.20 | 15.0 | 56.5 | 130 | 285 | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 4.60 | 15.0 | 57.5 | 130 | 290 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI | 1.8 V | 3.55 | - | - | - | - | - | - | - | - | - | |
| | | ENULP=1 | 2.4 V | 3.55 | - | - | - | - | - | - | - | - | - | ! |
| | | LPCAL=1 LSIPREDIV=1 | 3 V | 3.70 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 3.80 | - | - | - | - | - | - | - | - | | |
| | | RTC clocked by LSE bypassed at 32768 Hz | 1.8 V | 3.60 | - | - | - | - | - | - | - | - | - | |
| IDD | Supply current in | ENULP=1 | 2.4 V | 3.60 | - | - | - | - | - | - | - | - | - | |
| (Stop 2 with | Stop 2 mode, | LPCAL=1 | 3 V | 3.80 | • | - | - | - | - | - | - | - | - | μΑ |
| RTC) | RTC enabled | LSESYSDIS=1 | 3.6 V | 3.85 | - | - | - | - | - | - | - | - | D TBD D TBD D TBD | |
| | | | 1.8 V | 4.20 | 15.0 | 57.5 | 135 | - | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSE | 2.4 V | 4.30 | 15.0 | 58.5 | 135 | - | TBD | TBD | TBD | TBD | TBD | |
| | | quartz in low drive mode | 3 V | 4.55 | 15.5 | 59.0 | 135 | - | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 4.85 | 16.0 | 60.0 | 140 | - | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSE | 1.8 V | 3.50 | 14.0 | 55.5 | 125 | - | - | - | - | - | - | |
| | | bypassed at 32768 Hz ENULP=1 | 2.4 V | 3.65 | 14.5 | 56.0 | 130 | - | - | - | - | - | - | |
| | | LPCAL=1 | 3 V | 3.70 | 14.5 | 56.5 | 130 | - | - | - | - | - | - | |
| | | LSESYSDIS =1 | 3.6 V | 3.95 | 15.0 | 57.5 | 130 | - | - | - | - | - | - | |
| | | Wakeup clock is MSI = 48 MHz, voltage Range 1 ⁽²⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | |
| (wakeup from Stop 2) | Supply current during wakeup from Stop 2 mode | Wakeup clock is MSI = 4 MHz, voltage Range 2 ⁽²⁾ | 3 V | TBD | i | - | | - | - | - | | - | - | mA |
| -107 2/ | | Wakeup clock is HSI = 16 MHz, voltage Range 1 ⁽²⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | |



- 1. Guaranteed by characterization results, unless otherwise specified.
- 2. Wakeup with code execution from Flash. Average value given for a typical wakeup time as specified in *Table 43: Low-power mode wakeup timings*.

Table 37. Current consumption in Stop 1 mode

| Symbol | Parameter | Conditions | | | | TYP | | | | | MAX ⁽¹ | 1) | | Unit |
|---------------------|--------------------------|---|-------|------|------|------|-------|-------|------|------|-------------------|-------|-------|------|
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | Cupply ourront | | 1.8 V | 115 | 400 | 1250 | 2450 | 4600 | TBD | TBD | TBD | TBD | TBD | |
| IDD | Supply current in Stop 1 | _ | 2.4 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| (Stop 1) | mode, RTC disabled | - | 3 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| | TTTO disabled | | 3.6 V | 115 | 405 | 1250 | 2500 | 4700 | TBD | TBD | TBD | TBD | TBD | |
| | | | 1.8 V | 115 | 400 | 1250 | 2450 | 4600 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI | 2.4 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| | | TYTO Glocked by EST | 3 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 115 | 410 | 1300 | 2500 | 4700 | TBD | TBD | TBD | TBD | TBD | μΑ |
| | Supply current in STOP 1 | n STOP 1 RTC clocked by LSE | 1.8 V | 115 | 405 | 1250 | 2450 | 4600 | TBD | TBD | TBD | TBD | TBD | μΑ |
| IDD (Stop 1 with | | | 2.4 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| (Stop 1 with RTC) | mode, | | 3 V | 115 | 405 | 1250 | 2500 | 4650 | TBD | TBD | TBD | TBD | TBD | |
| | TYTO CHADICA | | 3.6 V | 115 | 405 | 1250 | 2500 | 4700 | TBD | TBD | TBD | TBD | TBD | |
| | | | 1.8 V | 115 | 415 | 1300 | 2550 | - | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSE | 2.4 V | 115 | 420 | 1300 | 2550 | - | TBD | TBD | TBD | TBD | TBD | |
| | | quartz ⁽²⁾ in low drive mode | 3 V | 120 | 420 | 1300 | 2550 | - | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 120 | 420 | 1300 | 2600 | - | TBD | TBD | TBD | TBD | TBD | |
| | I SIINNIV CIITTANT I | Wakeup clock is MSI = 48 | 3 V | TBD | - | - | - | - | - | - | - | - | - | |
| (wakeup from wa | during wakeup from | Wakeup clock is MSI = 4 MHz, voltage Range 2 ⁽³⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | mA |
| | Stop 1 mode | Wakeup clock is HSI = 16 MHz, voltage Range 1 ⁽³⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | |

DS12902 Rev 1

- 1. Guaranteed by characterization results, unless otherwise specified.
- 2. Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8 pF loading capacitors.
- 3. Wakeup with code execution from Flash. Average value given for a typical wakeup time as specified in *Table 43: Low-power mode wakeup timings*

Table 38. Current consumption in Stop 0 mode

| Symbol | Parameter | Condit | ions | | | TYP | | | | | MAX ⁽¹⁾ | | | Unit | | |
|--------------|---|----------------|-------------|------|------|------|-------|-------|------|------|--------------------|-------|-------|-------|-----|----|
| Symbol | Symbol Farameter — | | V DD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Oilit | | |
| | | | 1.8 V | 275 | 695 | 1850 | 3550 | 6450 | TBD | TBD | TBD | TBD | TBD | | | |
| IDD(Stop (1) | Supply current in Stop 0 mode, - RTC disabled | 2.4 V | 275 | 695 | 1850 | 3550 | 6450 | TBD | TBD | TBD | TBD | TBD | | | | |
| IDD(Stop 0) | | <i>'</i> ' ' | (0.15) | - | 3 V | 275 | 695 | 1850 | 3500 | 6450 | TBD | TBD | TBD | TBD | TBD | μΑ |
| | | | 3.6 V | 280 | 695 | 1900 | 3550 | 6500 | TBD | TBD | TBD | TBD | TBD | | | |

1. Guaranteed by characterization results, unless otherwise specified.





Table 39. Current consumption in Standby mode

| | T | Table 39. Curre | | Jampa | 011 111 0 | , turius | y illoud | <u>'</u> | 1 | | | | | 1 |
|-----------|--|---------------------------------------|-------------|-------|-----------|----------|----------|----------|------|------|------------------|-------|-------|------|
| Cumbal | Parameter | Conditions | | | | TYP | | | | | MAX ⁽ | 1) | | Unit |
| Symbol | Farameter | - | V DD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | |
| | | | 1.8 V | 110 | 325 | 1650 | 4650 | 13000 | TBD | TBD | TBD | TBD | TBD | |
| | | No independent | 2.4 V | 120 | 380 | 1900 | 5350 | 15000 | TBD | TBD | TBD | TBD | TBD | |
| | | watchdog | 3 V | 135 | 455 | 2250 | 6450 | 17500 | TBD | TBD | TBD | TBD | TBD | |
| | | | 3.6 V | 175 | 560 | 2750 | 7700 | 21000 | TBD | TBD | TBD | TBD | TBD | |
| | Supply current in Standby mode (backup registers | No independent watchdog ENULP=1 | 1.8 V | 42 | - | - | - | - | - | - | - | - | - | |
| | | | 2.4 V | 60 | - | - | - | - | - | - | - | - | - | |
| | | | 3 V | 86 | - | - | - | - | - | - | - | - | - | |
| IDD | | | 3.6 V | 135 | - | - | - | - | - | - | - | - | - | nA |
| (Standby) | retained), RTC disabled | | 1.8 V | 340 | - | - | - | - | - | - | - | - | - | 111/ |
| | RTC disabled | With independent | 2.4 V | 415 | - | - | - | - | - | - | - | - | - | |
| | | watchdog | 3 V | 500 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 605 | - | - | - | - | - | - | - | - | - | |
| | | | 1.8 V | 270 | - | - | - | - | - | - | - | - | - | |
| | | With independent | 2.4 V | 350 | - | - | - | - | - | - | - | - | - | |
| | | watchdog — | 3 V | 445 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 565 | - | - | - | - | - | - | - | - | - | |

Electrical characteristics

Table 39. Current consumption in Standby mode (continued)

| | 1 | - Con Carronic Cons | | | | , | - \ | , , | | | | | | |
|--------------------|--|------------------------------------|-------------|------|------|------|-------|-------|------|------|------------------|-------|-------|------|
| Symbol | Parameter | Conditions | | | | TYP | | | | | MAX ⁽ | 1) | | Unit |
| Symbol | Parameter | - | V DD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | 1.8 V | 500 | 715 | 2000 | 4900 | 13000 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI, no independent | 2.4 V | 635 | 890 | 2350 | 5750 | 15000 | TBD | TBD | TBD | TBD | TBD | |
| | | watchdog | 3 V | 790 | 1100 | 2850 | 6850 | 17500 | TBD | TBD | TBD | TBD | TBD | |
| | Supply current in Standby mode (backup registers | | 3.6 V | 980 | 1350 | 3550 | 8400 | 21500 | TBD | TBD | TBD | TBD | TBD | |
| | | RTC clocked by LSI, | 1.8 V | 550 | - | - | - | - | - | - | - | - | - | |
| IDD | | | 2.4 V | 705 | - | - | - | - | - | - | - | - | - | |
| (Standby with RTC) | retained), | with independent watchdog | 3 V | 885 | - | - | - | - | - | - | - | - | - | nA |
| (10) | RTC enabled | | 3.6 V | 1100 | - | - | - | - | - | - | - | - | - | |
| | | RTC clocked by LSI, | 1.8 V | 125 | - | - | - | - | - | - | - | - | - | |
| | | with independent watchdog | 2.4 V | 165 | - | - | - | - | - | - | - | - | - | |
| | | watchdog ENULP = 1 | 3 V | 205 | - | - | - | - | - | - | - | - | - | |
| | | LPCAL = 1 LSIPREDIV =1 | 3.6 V | 265 | - | - | - | - | - | - | - | - | - | |

Table 39. Current consumption in Standby mode (continued)

| Symbol | Parameter | Conditions | | | | TYP | | | | | MAX ⁽ | 1) | | Unit |
|---------------------------|--|---|-------|------|------|------|-------|-------|------|------|------------------|-------|-------|----------------|
| Symbol | Parameter | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | |
| | | RTC clocked by | 1.8 V | 84 | 370 | - | - | - | - | - | - | - | - | |
| | | LSE bypassed at 32768 Hz | 2.4 V | 135 | 515 | - | - | - | - | - | - | - | - | |
| | | ENULP = 1 | 3 V | 195 | 690 | - | - | - | - | - | - | - | - | |
| | | LPCAL = 1 LSESYSDIS =1 | 3.6 V | 285 | 940 | - | - | - | - | - | - | - | - | |
| | Overally symmetric Other Iller | | 1.8 V | 560 | 810 | 2200 | 5350 | 13500 | - | - | - | - | - | |
| IDD | Supply current in Standby mode (backup registers | RTC clocked by LSE guartz ⁽²⁾ in | 2.4 V | 755 | 1050 | 2650 | 6300 | 15500 | - | - | - | - | - | |
| (Standby with RTC) | retained), RTC enabled | Low-drive mode | 3 V | 1000 | 1350 | 3200 | 7550 | 18500 | - | - | - | - | - | |
| KTC enabled | RTC enabled | | 3.6 V | 1300 | 1750 | 4050 | 9250 | 22000 | - | - | - | - | - | |
| | | RTC clocked by LSE quartz ⁽²⁾ in Low-drive mode ENULP=1 | 1.8 V | 190 | 470 | - | - | - | - | - | - | - | - | |
| | | | 2.4 V | 230 | 595 | - | - | - | - | - | - | - | - | ₅ Λ |
| | | | 3 V | 280 | 765 | - | - | - | - | - | - | - | - | nA |
| | | LPCAL = 1 LSESYSDIS =1 | 3.6 V | 380 | 1000 | - | - | - | - | - | - | - | - | |
| | | | 1.8 V | 200 | - | - | - | - | - | - | - | - | - | |
| IDD (SRAM2 | Supply current in Standby mode when 4 Kbytes of | | 2.4 V | 210 | - | - | - | - | - | - | - | - | - | |
| 4 KBytes) ⁽³⁾ | SRAM2 are retained | - | 3 V | 230 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 265 | - | - | - | - | - | - | - | - | - | |
| | | | 1.8 V | TBD | - | - | - | - | - | - | - | - | - | |
| IDD | Supply current in Standby mode when the full 64 Kbytes | _ | 2.4 V | TBD | - | - | - | - | - | - | - | - | ı | |
| | of SRAM2 are retained | - | 3 V | TBD | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | TBD | - | - | - | - | - | - | - | - | - | |
| IDD (wakeup from Standby) | Supply current during wakeup from Standby mode | Wakeup clock is MSI = 4 MHz ⁽⁴⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | mA |

^{1.} Guaranteed by characterization results, unless otherwise specified.

- 2. Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8 pF loading capacitors.
- 3. The supply current in Standby with SRAM2 mode is: IDD_ALL(Standby) + IDD_ALL(SRAM2). The supply current in Standby with RTC with SRAM2 mode is: IIDD_ALL(Standby + RTC) + IDD_ALL(SRAM2).
- 4. Wakeup with code execution from Flash. Average value given for a typical wakeup time as specified in Table 43: Low-power mode wakeup timings.

Table 40. Current consumption in Shutdown mode

| Symbol | Parameter | Conditions | | | | TYP | | | | | MAX ⁽¹⁾ | | | Unit |
|-------------------------------|---|--|-------|------|------|------|-------|-------|------|------|--------------------|-------|-------|------|
| Symbol | raiametei | - | VDD | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | Supply current in | | 1.8 V | 22 | 155 | 985 | 3100 | 9400 | TBD | TBD | TBD | TBD | TBD | |
| IDD | Shutdown mode | | 2.4 V | 31 | 190 | 1150 | 3600 | 11000 | TBD | TBD | TBD | TBD | TBD | |
| (Shutdown) | (backup registers retained) RTC | - | 3 V | 44 | 240 | 1450 | 4400 | 13000 | TBD | TBD | TBD | TBD | TBD | |
| | disabled | | 3.6 V | 74 | 340 | 1900 | 5650 | 16500 | TBD | TBD | TBD | TBD | TBD | |
| | | | 1.8 V | 365 | 505 | 1350 | 3450 | 9800 | - | - | - | - | - | |
| | | RTC clocked by LSE bypassed at | 2.4 V | 565 | 745 | 1750 | 4200 | 11500 | - | - | - | - | - | |
| | Supply current in | 32768 Hz | 3 V | 815 | 1050 | 2250 | 5250 | 14000 | - | - | - | - | - | |
| | | | 3.6 V | 1100 | 1400 | 2950 | 6700 | 17500 | - | - | - | - | - | nA |
| | | de RTC clocked by | 1.8 V | 475 | 640 | 1550 | 3800 | 10000 | - | - | - | - | - | IIA |
| IDD | Shutdown mode | | 2.4 V | 665 | 860 | 1900 | 4550 | 11500 | - | - | - | - | - | |
| (Shutdown with RTC) | (backup registers retained) RTC | Low-drive mode | 3 V | 905 | 1150 | 2450 | 5650 | 14000 | - | - | - | - | - | |
| | enabled | | 3.6 V | 1200 | 1500 | 3200 | 7200 | 17500 | - | - | - | - | - | |
| | | RTC clocked by | 1.8 V | 180 | - | - | - | - | - | - | - | - | - | |
| | | LSE quartz ⁽²⁾ in Low-drive mode | 2.4 V | 190 | - | - | - | - | - | - | - | - | - | |
| | | LPCAL = 1 | 3 V | 229 | - | - | - | - | ı | - | - | - | - | |
| | | LSESYSDIS =1 | 3.6 V | 293 | - | - | - | - | ı | - | _ | - | - | |
| IDD (wakeup from Shutdown) | Supply current during wakeup from Shutdown mode | Wakeup clock is MSI = 4 MHz ⁽³⁾ | 3 V | TBD | - | - | - | - | - | - | - | - | - | mA |



- . Guaranteed by characterization results, unless otherwise specified.
- 2. Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8 pF loading capacitors.



3. Wakeup with code execution from Flash. Average value given for a typical wakeup time as specified in *Table 43: Low-power mode wakeup timings*.

Table 41. Current consumption in VBAT mode

| Oh all | D | Conditions | | | | TYP | | | | | MAX | | | 11!4 |
|-----------|----------------|--------------------------------|--------------|------|------|------|-------|-------|------|------|------|-------|-------|------|
| Symbol | Parameter | - | V BAT | 25°C | 55°C | 85°C | 105°C | 125°C | 25°C | 55°C | 85°C | 105°C | 125°C | Unit |
| | | | 1.8 V | 3 | 24 | 155 | 475 | 1350 | - | - | - | - | - | |
| | | RTC disabled | 2.4 V | 3 | 28 | 180 | 540 | 1500 | - | - | - | - | - | |
| | | KTC disabled | 3 V | 4 | 36 | 220 | 665 | 1850 | - | - | - | - | - | |
| | | | 3.6 V | 12 | 78 | 465 | 1450 | 4050 | - | - | - | - | - | |
| | | DTC analysis and | 1.8 V | 345 | 375 | 525 | 865 | - | - | - | - | - | - | |
| | | RTC enabled and clocked by LSE | 2.4 V | 540 | 585 | 760 | 1150 | - | - | - | - | - | - | |
| | | bypassed at | 3 V | 780 | 835 | 1050 | 1550 | - | - | - | - | - | - | |
| IDD(VBAT) | Backup domain | 32768 Hz | 3.6 V | 1050 | 1100 | 1450 | 2400 | - | - | - | - | - | - | nA |
| IDD(VBAI) | supply current | | 1.8 V | 450 | - | - | - | - | - | - | - | - | - | IIA |
| | | RTC enabled and clocked by LSE | 2.4 V | 635 | - | - | - | - | - | - | - | - | - | |
| | | quartz ⁽¹⁾ | 3 V | 865 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 1150 | - | - | - | - | - | - | - | - | - | |
| | | RTC enabled and | 1.8 V | 150 | - | - | - | - | - | - | - | - | - | |
| | | clocked by LSE | 2.4 V | 165 | - | - | - | - | - | - | - | - | - | |
| | | quartz ⁽¹⁾ | 3 V | 195 | - | - | - | - | - | - | - | - | - | |
| | | | 3.6 V | 240 | - | - | - | - | ı | - | - | - | ı | |

^{1.} Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8 pF loading capacitors.

I/O system current consumption

The current consumption of the I/O system has two components: static and dynamic.

I/O static current consumption

All the I/Os used as inputs with pull-up generate current consumption when the pin is externally held low. The value of this current consumption can be simply computed by using the pull-up/pull-down resistors values given in *Table 62: I/O static characteristics*.

For the output pins, any external pull-down or external load must also be considered to estimate the current consumption.

Additional I/O current consumption is due to I/Os configured as inputs if an intermediate voltage level is externally applied. This current consumption is caused by the input Schmitt trigger circuits used to discriminate the input value. Unless this specific configuration is required by the application, this supply current consumption can be avoided by configuring these I/Os in analog mode. This is notably the case of ADC input pins which should be configured as analog inputs.

Caution:

Any floating input pin can also settle to an intermediate voltage level or switch inadvertently, as a result of external electromagnetic noise. To avoid current consumption related to floating pins, they must either be configured in analog mode, or forced internally to a definite digital value. This can be done either by using pull-up/down resistors or by configuring the pins in output mode.

I/O dynamic current consumption

In addition to the internal peripheral current consumption measured previously (see), the I/Os used by an application also contribute to the current consumption. When an I/O pin switches, it uses the current from the I/O supply voltage to supply the I/O pin circuitry and to charge/discharge the capacitive load (internal or external) connected to the pin:

$$I_{SW} = V_{DDIOx} \times f_{SW} \times C$$

where

 $I_{\mbox{SW}}$ is the current sunk by a switching I/O to charge/discharge the capacitive load

V_{DDIOx} is the I/O supply voltage

f_{SW} is the I/O switching frequency

C is the total capacitance seen by the I/O pin: $C = C_{INT} + C_{EXT} + C_{S}$

 $C_{\mbox{\scriptsize S}}$ is the PCB board capacitance including the pad pin.

The test pin is configured in push-pull output mode and is toggled by software at a fixed frequency.

On-chip peripheral current consumption

The current consumption of the on-chip peripherals is given in *Table 42*. The MCU is placed under the following conditions:

- All I/O pins are in Analog mode
- The given value is calculated by measuring the difference of the current consumptions:
 - when the peripheral is clocked on
 - when the peripheral is clocked off
- Ambient operating temperature and supply voltage conditions summarized in *Table 18: Voltage characteristics*
- The power consumption of the digital part of the on-chip peripherals is given in *Table 42*. The power consumption of the analog part of the peripherals (where applicable) is indicated in each related section of the datasheet.

Table 42. STM32L4Q5xx peripheral current consumption

| Range 1 Range 1 Low | | | | | | | | |
|---------------------|------------------------------|--------------------------|---------------------------|---------|--------------------------------|--------|--|--|
| | Peripheral | Range 1 Boost Mode | Range 1 Normal Mode | Range 2 | Low- power run and sleep | Unit | | |
| | Bus matrix | 3.361 | 3.144 | 2.626 | 2.772 | | | |
| | ADC independent clock domain | 0.254 | 0.241 | 0.125 | 0.750 | | | |
| | ADC AHB clock domain | 4.917 | 4.591 | 4.013 | 4.627 | | | |
| | AES | 3.000 | 2.750 | 2.150 | 3.000 | | | |
| | CRC | 0.534 | 0.498 | 0.426 | 0.405 | | | |
| | DMA1 | 2.556 | 2.386 | 1.945 | 2.203 | | | |
| | DMA2 | 2.644 | 2.463 | 2.030 | 2.179 | | | |
| | DMA2D | 3.322 | 3.099 | 2.525 | 2.853 | | | |
| | DMAMUX | 5.850 | 5.447 | 4.477 | 5.217 | | | |
| | DCMI | 8.498 | 7.948 | 6.563 | 7.503 | | | |
| AHB | PSSI | 8.498 | 7.948 | 6.563 | 7.503 | μΑ/MHz | | |
| | FLASH | 5.836 | 5.442 | 4.476 | 5.101 | | | |
| | FSMC | 10.215 | 9.485 | 7.807 | 9.043 | | | |
| | GPIOA | 0.158 | 0.141 | 0.142 | 0.153 | | | |
| | GPIOB | 0.173 | 0.150 | 0.160 | 0.108 | | | |
| | GPIOC | 0.189 | 0.179 | 0.164 | 0.090 | | | |
| | GPIOD | 0.181 | 0.171 | 0.159 | 0.134 | | | |
| | GPIOE | 0.157 | 0.143 | 0.146 | 0.151 | | | |
| | GPIOF | 0.178 | 0.151 | 0.153 | 0.340 | | | |
| | GPIOG | 0.171 | 0.164 | 0.164 | 0.162 | | | |
| | GPIOH | 0.202 | 0.193 | 0.176 | 0.157 | | | |



Table 42. STM32L4Q5xx peripheral current consumption (continued)

| | Peripheral | Range 1 Boost Mode | Range 1 Normal Mode | Range 2 | Low- power run and sleep | Unit |
|---------|---------------------------------|--------------------------|---------------------------|---------|--------------------------------|--------|
| | GPIOI | 0.155 | 0.136 | 0.134 | 0.095 | |
| | HASH1 | 1.808 | 1.682 | 1.400 | 1.530 | |
| | OTG_FS independent clock domain | 26.984 | 29.739 | NA | NA | |
| | OTG_FS AHB clock domain | 18.554 | 17.288 | NA | NA | |
| | OSPIM independent clock domain | 0.033 | 0.013 | 0.013 | 0.248 | |
| | OSPIM AHB clock domain | 0.120 | 0.115 | 0.099 | 0.087 | |
| | OSPI1 independent clock domain | 0.781 | 0.713 | 0.601 | 0.661 | |
| | OSPI1 AHB clock domain | 0.330 | 0.309 | 0.248 | 0.223 | |
| | OSPI2 independent clock domain | 1.043 | 0.995 | 0.799 | 0.761 | |
| | OSPI2 AHB clock domain | 0.334 | 0.295 | 0.249 | 0.218 | |
| AHB | PKA | 4.418 | 4.134 | 3.443 | 3.989 | |
| (Cont.) | RNG independent clock domain | 1.591 | 1.601 | NA | NA | µA/MHz |
| | RNG AHB clock domain | 1.278 | 1.203 | NA | NA | |
| | SDMMC1 independent clock domain | 18.306 | 17.327 | NA | NA | |
| | SDMMC1 AHB clock domain | 17.582 | 16.375 | NA | NA | |
| | SDMMC2 independent clock domain | 18.176 | 17.210 | NA | NA | |
| | SDMMC2 AHB clock domain | 17.517 | 16.300 | NA | NA | |
| | SRAM1 | 1.117 | 1.016 | 0.852 | 0.910 | |
| | SRAM2 | 3.976 | 3.709 | 3.113 | 3.292 | |
| | SRAM3 | 1.087 | 1.026 | 0.863 | 1.129 | |
| | TSC | 1.678 | 1.580 | 1.296 | 1.346 | |
| | All AHB peripherals | 114.236 | 106.366 | 87.640 | 98.866 | |

Table 42. STM32L4Q5xx peripheral current consumption (continued)

| | Peripheral | Range 1 Boost Mode | Range 1 Normal Mode | Range 2 | Low- power run and sleep | Unit |
|------|----------------------------------|--------------------------|---------------------------|---------|--------------------------------|--------|
| | AHB to APB1 bridge | 0.217 | 0.242 | 0.214 | 0.460 | |
| | CAN1 | 5.457 | 5.076 | 4.164 | 4.852 | |
| | CRS | 0.342 | 0.329 | 0.272 | 0.332 | |
| | DAC12 | 3.125 | 2.925 | 2.415 | 2.801 | |
| | I2C1 independent clock domain | 3.750 | 3.400 | 2.900 | 2.500 | |
| | I2C1 APB clock domain | 1.400 | 1.400 | 1.250 | 2.000 | |
| | I2C2 independent clock domain | 3.500 | 3.400 | 2.500 | 3.500 | |
| | I2C2 APB clock domain | 1.400 | 1.250 | 1.250 | 1.000 | |
| | I2C3 independent clock domain | 3.250 | 3.150 | 2.900 | 3.000 | |
| | I2C3 APB clock domain | 1.150 | 1.000 | 0.835 | 1.000 | |
| | I2C4 independent clock domain | 3.500 | 3.250 | 2.750 | 3.000 | |
| APB1 | I2C4 APB clock domain | 1.350 | 1.250 | 1.000 | 1.500 | µA/MHz |
| | LPUART1 independent clock domain | 3.150 | 3.000 | 2.450 | 3.000 | |
| | LPUART1 APB clock domain | 1.650 | 1.500 | 1.300 | 1.500 | |
| | LPTIM1 independent clock domain | 3.368 | 3.165 | 2.645 | 3.101 | |
| | LPTIM1 APB clock domain | 1.041 | 0.957 | 0.811 | 0.900 | |
| | LPTIM2 independent clock domain | 3.144 | 2.951 | 2.424 | 2.778 | |
| | LPTIM2 APB clock domain | 0.883 | 0.852 | 0.702 | 0.824 | |
| | OPAMP | 0.326 | 0.299 | 0.274 | 0.950 | |
| | PWR | 0.675 | 0.620 | 0.524 | 0.629 | |
| | RTCAPB | 2.126 | 1.968 | 1.629 | 1.953 | |
| | SPI2 | 2.062 | 1.934 | 1.602 | 1.936 | |



Table 42. STM32L4Q5xx peripheral current consumption (continued)

| | Peripheral | Range 1 Boost Mode | Range 1 Normal Mode | Range 2 | Low- power run and sleep | Unit |
|-----------------|---------------------------------|--------------------------|---------------------------|---------|--------------------------------|--------|
| | SPI3 | 2.022 | 1.891 | 1.561 | 1.925 | |
| | TIM2 | 6.192 | 5.769 | 4.755 | 5.751 | |
| | TIM3 | 5.414 | 5.051 | 4.178 | 5.031 | |
| | TIM4 | 5.104 | 4.748 | 3.901 | 4.575 | |
| | TIM5 | 6.204 | 5.759 | 4.769 | 5.413 | |
| | TIM6 | 1.111 | 1.026 | 0.854 | 0.911 | |
| | TIM7 | 1.146 | 1.070 | 0.882 | 1.055 | |
| | USART2 independent clock domain | 5.350 | 5.000 | 4.150 | 4.500 | |
| APB1 (Cont.) | USART2 APB clock domain | 3.000 | 2.750 | 2.500 | 2.500 | μΑ/MHz |
| (GOIII.) | USART3 independent clock domain | 6.350 | 6.000 | 5.000 | 5.500 | |
| | USART3 APB clock domain | 2.600 | 2.400 | 2.100 | 2.500 | |
| | UART4 independent clock domain | 5.150 | 4.900 | 3.750 | 4.500 | |
| | UART4 APB clock domain | 2.500 | 2.250 | 2.100 | 2.500 | |
| | UART5 independent clock domain | 5.400 | 5.000 | 4.150 | 5.000 | |
| | UART5 APB clock domain | 2.400 | 2.250 | 2.100 | 2.000 | |
| | WWDG | 0.438 | 0.410 | 0.352 | 0.494 | |
| | All APB1 on | 107.630 | 100.588 | 83.653 | 94.342 | |

Table 42. STM32L4Q5xx peripheral current consumption (continued)

| | Peripheral | Range 1 Boost Mode | Range 1 Normal Mode | Range 2 | Low- power run and sleep | Unit |
|------|---------------------------------|--------------------------|---------------------------|---------|--------------------------------|--------|
| | AHB to APB2 bridge | 0.136 | 0.157 | 0.143 | 0.565 | |
| | DFSDM | 5.432 | 5.045 | 4.229 | 5.355 | |
| | FW | 0.388 | 0.352 | 0.296 | 0.286 | |
| | LTDC independent clock domain | 39.542 | 38.367 | 42.248 | NA | |
| | LTDC APB clock domain | 10.490 | 9.803 | 8.138 | NA | |
| | SAI1 independent clock domain | 3.236 | 3.022 | 2.487 | 2.310 | |
| | SAI1 APB clock domain | 2.543 | 2.376 | 1.991 | 2.218 | |
| | SAI2 independent clock domain | 3.314 | 3.080 | 2.529 | 2.312 | |
| | SAI2 APB clock domain | 2.504 | 2.338 | 1.942 | 2.193 | |
| APB2 | SPI1 | 2.159 | 2.025 | 1.677 | 1.879 | |
| 7 | SYSCFG/VREFBUF/COMP | 0.698 | 0.662 | 0.546 | 0.370 | μΑ/MHz |
| | TIM1 | 8.846 | 8.259 | 6.781 | 7.915 | |
| | TIM8 | 9.126 | 8.479 | 6.980 | 7.966 | |
| | TIM15 | 4.544 | 4.226 | 3.510 | 3.928 | |
| | TIM16 | 3.158 | 2.935 | 2.448 | 2.825 | |
| | TIM17 | 3.180 | 2.950 | 2.452 | 2.959 | |
| | USART1 independent clock domain | 6.500 | 6.150 | 5.250 | 6.000 | |
| | USART1 APB clock domain | 2.900 | 2.750 | 2.250 | 2.000 | |
| | All APB2 on | 62.690 | 58.533 | 48.424 | 54.434 | |
| | ALL | 281.81 | 262.45 | 216.946 | 245.38 | |



6.3.6 Wakeup time from low-power modes and voltage scaling transition times

The wakeup times given in *Table 43* are the latency between the event and the execution of the first user instruction.

The device goes in low-power mode after the WFE (wait for event) instruction.

Table 43. Low-power mode wakeup timings⁽¹⁾

| Symbol | Parameter | Conditions | | Тур | Max | Unit |
|----------------------|---|---|--------------------------------|------|------|------------------------|
| t _{WUSLEEP} | Wakeup time from Sleep mode to Run mode | | - | 6 | TBD | NIIf |
| twulpsleep | Wakeup time from Lowpower sleep mode to Lowpower run mode | Wakeup in Flash with Flash in power-down during low-power sleep mode (SLEEP_PD=1 in FLASH_ACR) and with clock MSI = 2 MHz | | | TBD | Nb of CPU cycles |
| | | | Wakeup clock MSI = 48 MHz | 9 | 9.7 | |
| | Wake up time from Stop 0 mode to Run mode in Flash | range1 | Wakeup clock HSI16 = 16 MHz | 8.3 | 8.9 | |
| | | | Wakeup clock MSI = 24 MHz | 18.6 | 19.5 | |
| | | range2 | Wakeup clock HSI16 = 16 MHz | 17.5 | 18.2 | |
| t | | | Wakeup clock MSI = 4 MHz | 23.7 | 26.4 | μs |
| t _{WUSTOP0} | | | Wakeup clock MSI = 48 MHz | 1.8 | 2.5 | μδ |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 2.5 | 2.8 | |
| | from Stop 0 mode to Run | | Wakeup clock MSI = 24 MHz | 2.4 | 3.1 | |
| | mode in SRAM1 | range2 | Wakeup clock HSI16 = 16 MHz | 2.5 | 2.9 | |
| | | | Wakeup clock MSI = 4 MHz | 9.2 | 11.4 | |

Table 43. Low-power mode wakeup timings⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | | Тур | Max | Unit |
|----------------------|---|--|--------------------------------|------|------|------|
| | | | Wakeup clock MSI = 48 MHz | 12.6 | 13.8 | |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 12.0 | 13.0 | |
| | from Stop 1 mode to Run in | | Wakeup clock MSI = 24 MHz | 22.1 | 23.4 | |
| | Flash | range2 | Wakeup clock HSI16 = 16 MHz | 21.2 | 22.3 | |
| | | | Wakeup clock MSI = 4 MHz | 25.3 | 26.7 | |
| | | | Wakeup clock MSI = 48 MHz | 5.3 | 6.3 | |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 6.2 | 7.3 | |
| _ | from Stop 1 mode to Run | | Wakeup clock MSI = 24 MHz | 5.8 | 6.8 | |
| t _{WUSTOP1} | mode in SRAM1 | range2 | Wakeup clock HSI16 = 16 MHz | 6.2 | 7.3 | |
| | | | Wakeup clock MSI = 4 MHz | 10.4 | 11.6 | |
| | Wake up time from Stop 1 mode to Lowpower run mode in Flash | Regulator in lowpower mode (LPR=1 in | Wakeup clock MSI = 2 MHz | TBD | TBD | μs |
| | Wake up time fromStop1mode to Lowpower run mode in SRAM1 | PWR_CR1) | | 15.9 | 19.9 | |
| | | | Wakeup clock MSI = 48 MHz | 13.0 | 13.9 | |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 12.5 | 13.4 | |
| | from Stop 2 mode to Run | | Wakeup clock MSI = 24 MHz | 22.6 | 23.6 | |
| | mode in Flash | range2 | Wakeup clock HSI16 = 16 MHz | 21.7 | 22.6 | |
| turrozono | | | Wakeup clock MSI = 4 MHz | 25.9 | 27.2 | |
| t _{WUSTOP2} | | | Wakeup clock MSI = 48 MHz | 5.8 | 6.6 | |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 6.8 | 7.6 | |
| | from Stop 2 mode to Run | | Wakeup clock MSI = 24 MHz | 6.3 | 7.1 | |
| | mode in SRAM1 | range2 | Wakeup clock HSI16 = 16 MHz | 6.8 | 7.6 | |
| | | | Wakeup clock MSI = 4 MHz | 11.2 | 12.4 | |

Table 43. Low-power mode wakeup timings⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | | Тур | Max | Unit |
|-------------------------------|---|------------|--------------------------------|-------|-------|------|
| | | | Wakeup clock MSI = 48 MHz | 13.0 | 13.9 | |
| | Wake up time | range1 | Wakeup clock HSI16 = 16 MHz | 12.5 | 13.4 | |
| | from Stop 2 mode to Run | | Wakeup clock MSI = 24 MHz | 22.6 | 23.7 | |
| | mode in Flash | range2 | Wakeup clock HSI16 = 16 MHz | 21.6 | 22.7 | |
| t _{WUSTOP2} SRAM3 | | | Wakeup clock MSI = 4 MHz | 16.7 | 17.9 | |
| enabled | Wake up time from Stop 2 mode to Run mode in SRAM1 | | Wakeup clock MSI = 48 MHz | 5.8 | 6.6 | |
| | | range1 | Wakeup clock HSI16 = 16 MHz | | 7.6 | |
| | | | Wakeup clock MSI = 24 MHz | 6.3 | 7.1 | |
| | | range2 | Wakeup clock HSI16 = 16 MHz | 6.8 | 7.6 | μs |
| | | | Wakeup clock MSI = 4 MHz | 11.2 | 12.4 | |
| | Wakeup time | | Wakeup clock MSI = 8 MHz | TBD | TBD | |
| t _{WUSTBY} | from Standby mode to Run mode | range1 | Wakeup clock MSI = 4 MHz | TBD | TBD | |
| | Wakeup time | | Wakeup clock MSI = 8 MHz | TBD | TBD | |
| ^t WUSTBY SRAM2 | range | | Wakeup clock MSI = 4 MHz | TBD | TBD | |
| ^t wushdn | Wakeup time from Shutdown mode to Run mode | range1 | Wakeup clock MSI = 4 MHz | 262.6 | 323.5 | |

^{1.} Guaranteed by characterization results.

Table 44. Regulator modes transition times⁽¹⁾

| Symbol | Parameter | Conditions | Тур | Max | Unit |
|----------------------|--|--------------------------|-----|-----|------|
| t _{WULPRUN} | Wakeup time from Low- power run mode to Run mode ⁽²⁾ | Code run with MSI 2 MHz | 5 | 7 | |
| t _{VOST} | Regulator transition time from Range 2 to Range 1 or Range 1 to Range 2 ⁽³⁾ | Code run with MSI 24 MHz | 20 | 40 | μs |

^{1.} Guaranteed by characterization results.

^{2.} Time until REGLPF flag is cleared in PWR_SR2.

^{3.} Time until VOSF flag is cleared in PWR_SR2.

| | <u> </u> | | | | |
|----------------------|--|---------------|-----|-----|------|
| Symbol | Parameter | Conditions | Тур | Max | Unit |
| | Wakeup time needed to calculate | Stop mode 0 | - | 1.7 | |
| t _{WUUSART} | the maximum USART/LPUART baudrate allowing to wakeup up from stop mode when USART/LPUART clock source is HSI | Stop mode 1/2 | - | 8.5 | μs |

Table 45. Wakeup time using USART/LPUART⁽¹⁾

6.3.7 External clock source characteristics

High-speed external user clock generated from an external source

In bypass mode the HSE oscillator is switched off and the input pin is a standard GPIO.

The external clock signal has to respect the I/O characteristics in *Section 6.3.14*. However, the recommended clock input waveform is shown in *Figure 20: High-speed external clock source AC timing diagram*.

Table 46. High-speed external user clock characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|-------------------------------------|----------------------------|------------------------|-----|------------------------|-------------|
| f | User external clock | Voltage scaling Range 1 | - | 8 | 48 | MHz |
| | source frequency | Voltage scaling Range 2 | - | 8 | 26 | IVII IZ |
| V _{HSEH} | OSC_IN input pin high level voltage | - | 0.7 V _{DDIOx} | - | V_{DDIOx} | > |
| V _{HSEL} | OSC_IN input pin low level voltage | - | V _{SS} | - | 0.3 V _{DDIOx} | V |
| t _{w(HSEH)} | 000 INT: 1 1 1: | Voltage scaling Range 1 | 7 | - | - | ns |
| t _{w(HSEL)} | OSC_IN high or low time | Voltage scaling Range 2 | 18 | - | - | 115 |

^{1.} Guaranteed by design.

^{1.} Guaranteed by characterization results.

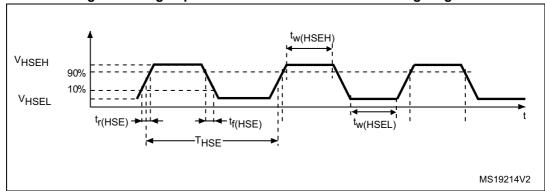


Figure 20. High-speed external clock source AC timing diagram

Low-speed external user clock generated from an external source

In bypass mode the LSE oscillator is switched off and the input pin is a standard GPIO.

The external clock signal has to respect the I/O characteristics in Section 6.3.14. However, the recommended clock input waveform is shown in Figure 21.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | | |
|----------------------|---------------------------------------|------------|------------------------|--------|------------------------|------|--|--|
| f _{LSE_ext} | User external clock source frequency | - | - | 32.768 | 1000 | kHz | | |
| V _{LSEH} | OSC32_IN input pin high level voltage | - | 0.7 V _{DDIOx} | - | V _{DDIOx} | V | | |
| V _{LSEL} | OSC32_IN input pin low level voltage | - | V_{SS} | - | 0.3 V _{DDIOx} | - | | |
| t _{w(LSEH)} | OSC32_IN high or low time | - | 250 | - | - | ns | | |

Table 47. Low-speed external user clock characteristics⁽¹⁾

Guaranteed by design.

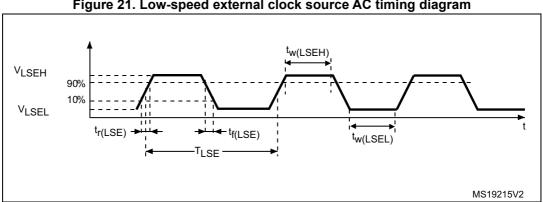


Figure 21. Low-speed external clock source AC timing diagram

High-speed external clock generated from a crystal/ceramic resonator

The high-speed external (HSE) clock can be supplied with a 4 to 48 MHz crystal/ceramic resonator oscillator. All the information given in this paragraph are based on design simulation results obtained with typical external components specified in *Table 48*. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

Conditions⁽²⁾ **Symbol** Min Unit **Parameter** Typ Max 4 8 48 MHz Oscillator frequency fosc in R_F 200 Feedback resistor _ kΩ _ During startup⁽³⁾ 5.5 $V_{DD} = 3 V$ $Rm = 30 \Omega$, 0.44 CL = 10 pF@8 MHz $V_{DD} = 3 V$ $Rm = 45 \Omega$ 0.45 CL = 10 pF@8 MHz $V_{DD} = 3 V$ HSE current consumption mΑ IDD(HSE) $Rm = 30 \Omega$ 0.68 CL = 5 pF@48 MHz $V_{DD} = 3 V$ $Rm = 30 \Omega$. 0.94 CL = 10 pF@48 MHz $V_{DD} = 3 V$ $Rm = 30 \Omega$ 1.77 CL = 20 pF@48 MHz Maximum critical crystal G_{m} mA/V Startup 1.5 transconductance t_{SU(HSE)}(4) V_{DD} is stabilized Startup time 2 ms

Table 48. HSE oscillator characteristics⁽¹⁾

For C_{L1} and C_{L2} , it is recommended to use high-quality external ceramic capacitors in the 5 pF to 20 pF range (typ.), designed for high-frequency applications, and selected to match the requirements of the crystal or resonator (see *Figure 22*). C_{L1} and C_{L2} are usually the same size. The crystal manufacturer typically specifies a load capacitance which is the series combination of C_{L1} and C_{L2} . PCB and MCU pin capacitance must be included (10 pF can be used as a rough estimate of the combined pin and board capacitance) when sizing C_{L1} and C_{L2} .



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^{1.} Guaranteed by design.

^{2.} Resonator characteristics given by the crystal/ceramic resonator manufacturer.

^{3.} This consumption level occurs during the first 2/3 of the $t_{\text{SU(HSE)}}$ startup time

^{4.} t_{SU(HSE)} is the startup time measured from the moment it is enabled (by software) to a stabilized 8 MHz oscillation is reached. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer

Note:

For information on selecting the crystal, refer to the application note AN2867 "Oscillator design guide for ST microcontrollers" available from the ST website www.st.com.

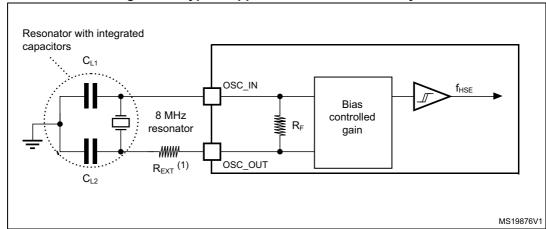


Figure 22. Typical application with an 8 MHz crystal

1. R_{EXT} value depends on the crystal characteristics.

Low-speed external clock generated from a crystal resonator

The low-speed external (LSE) clock can be supplied with a 32.768 kHz crystal resonator oscillator. All the information given in this paragraph are based on design simulation results obtained with typical external components specified in *Table 49*. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

| Symbol | Parameter | Conditions ⁽²⁾ | Min | Тур | Max | Unit |
|-------------------------------------|-----------------------------|--|-----|-----|------|------|
| | | LSEDRV[1:0] = 00 Low drive capability | - | 250 | - | |
| | LSE current consumption | LSEDRV[1:0] = 01 Medium low drive capability | - | 315 | - | nA |
| I _{DD(LSE)} | Loc current consumption | LSEDRV[1:0] = 10 Medium high drive capability | - | 500 | - | IIA |
| | | LSEDRV[1:0] = 11 High drive capability | - | 630 | - | |
| | | LSEDRV[1:0] = 00 Low drive capability | - | - | 0.5 | |
| Cm | Maximum critical crystal gm | LSEDRV[1:0] = 01 Medium low drive capability | - | - | 0.75 | μΑ/V |
| Gm _{critmax} | | LSEDRV[1:0] = 10 Medium high drive capability | - | - | 1.7 | μΑνν |
| | | LSEDRV[1:0] = 11 High drive capability | - | - | 2.7 | |
| t _{SU(LSE)} ⁽³⁾ | Startup time | V _{DD} is stabilized | - | 2 | - | S |

Table 49. LSE oscillator characteristics $(f_{LSE} = 32.768 \text{ kHz})^{(1)}$

Note: For information on selecting the crystal, refer to the application note AN2867 "Oscillator design guide for ST microcontrollers" available from the ST website www.st.com.

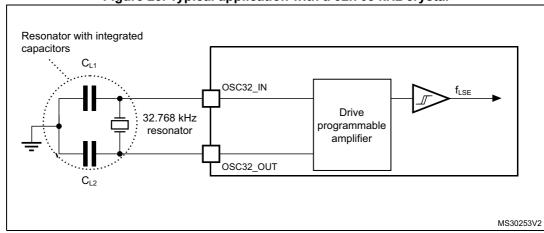


Figure 23. Typical application with a 32.768 kHz crystal

Note:

An external resistor is not required between OSC32_IN and OSC32_OUT and it is forbidden to add one.



^{1.} Guaranteed by design.

Refer to the note and caution paragraphs below the table, and to the application note AN2867 "Oscillator design guide for ST microcontrollers".

t_{SU(LSE)} is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation is reached. This value is measured for a standard crystal and it can vary significantly with the crystal manufacturer

6.3.8 Internal clock source characteristics

The parameters given in *Table 50* are derived from tests performed under ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*. The provided curves are characterization results, not tested in production.

High-speed internal (HSI16) RC oscillator

Table 50. HSI16 oscillator characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|---|---|-------|-----|-------|------|
| f _{HSI16} | HSI16 Frequency | V _{DD} =3.0 V, T _A =30 °C | 15.88 | - | 16.08 | MHz |
| TPIM | HSI16 user trimming step | Trimming code is not a multiple of 64 | 0.2 | 0.3 | 0.4 | % |
| TRIM | Thomas dep | Trimming code is a multiple of 64 | -4 | -6 | -8 | 76 |
| DuCy(HSI16) ⁽²⁾ | Duty Cycle | - | 45 | - | 55 | % |
| A (HCI46) | HSI16 oscillator frequency | T _A = 0 to 85 °C | -1 | - | 1 | % |
| $\Delta_{Temp}(HSI16)$ | drift over temperature | T _A = -40 to 125 °C | -2 | - | 1.5 | % |
| Δ _{VDD} (HSI16) | HSI16 oscillator frequency drift over V _{DD} | V _{DD} =1.62 V to 3.6 V | -0.1 | - | 0.05 | % |
| t _{su} (HSI16) ⁽²⁾ | HSI16 oscillator start-up time | - | - | 0.8 | 1.2 | μs |
| t _{stab} (HSI16) ⁽²⁾ | HSI16 oscillator stabilization time | - | - | 3 | 5 | μs |
| I _{DD} (HSI16) ⁽²⁾ | HSI16 oscillator power consumption | - | - | 155 | 190 | μΑ |

^{1.} Guaranteed by characterization results.

^{2.} Guaranteed by design.

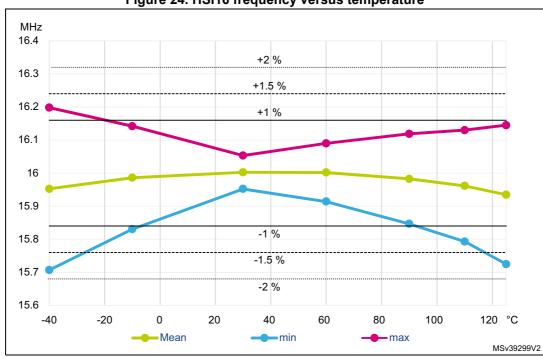


Figure 24. HSI16 frequency versus temperature

Multi-speed internal (MSI) RC oscillator

Table 51. MSI oscillator characteristics⁽¹⁾

| Symbol | Parameter | | Conditions | Min | Тур | Max | Unit |
|----------------------------|--|-------------------|--------------------------------|-------|---------|-------|------------|
| | | | Range 0 | 98.7 | 100 | 101.3 | |
| | | | Range 1 | 197.4 | 200 | 202.6 | kHz |
| | | | Range 2 | 394.8 | 400 | 405.2 | KIIZ |
| | | | Range 3 | 7896 | 800 | 810.4 | |
| | | | Range 4 | 0.987 | 1 | 1.013 | |
| | | MSI mode | Range 5 | 1.974 | 2 | 2.026 | |
| | | IVISI Mode | Range 6 | 3.948 | 4 | 4.052 | |
| | | | Range 7 | 7.896 | 8 | 8.104 | NALI |
| | | | Range 8 | 15.79 | 16 | 16.21 | MHz |
| | | | Range 9 | 23.69 | 24 | 24.31 | |
| | MSI frequency | | Range 10 | 31.58 | 32 | 32.42 | - |
| after factory | after factory | | Range 11 | 47.38 | 48 | 48.62 | |
| ^I MSI | f _{MSI} calibration, done at V _{DD} =3 V and | | Range 0 | - | 98.304 | - | - kHz |
| | T _A =30 °C | | Range 1 | - | 196.608 | - | |
| | | | Range 2 | - | 393.216 | - | |
| | | | Range 3 | - | 786.432 | - | |
| | | | Range 4 | - | 1.016 | - | |
| | | PLL mode XTAL= | Range 5 | - | 1.999 | - | |
| | | 32.768 kHz | Range 6 | - | 3.998 | - | |
| | | | Range 7 | - | 7.995 | - | MHz |
| | | | Range 8 | - | 15.991 | - | IVITZ |
| | | | Range 9 | - | 23.986 | - | |
| | | | Range 10 | - | 32.014 | - | |
| | | | Range 11 | - | 48.005 | - | |
| | MSI oscillator | | T _A = -0 to 85 °C | -3.5 | - | 3 | |
| $\Delta_{TEMP}(MSI)^{(2)}$ | frequency drift over temperature | MSI mode | T _A = -40 to 125 °C | -8 | - | 6 | % |

Table 51. MSI oscillator characteristics⁽¹⁾ (continued)

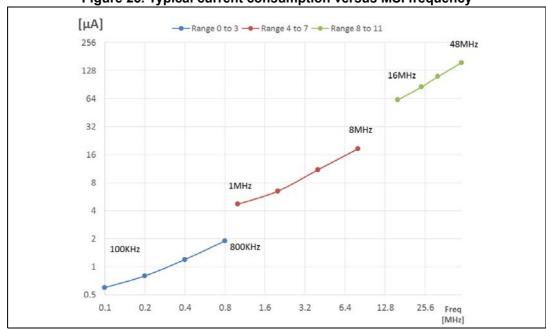
| Symbol | Parameter | | Conditions | 33.22 (30) | Min | Тур | Max | Unit |
|--|---|-------------------------------|----------------------------------|-------------------------------------|------|------|-------|------|
| | | | Dange 0 to 0 | V _{DD} =1.62 V to 3.6 V | -1.2 | - | 0.5 | |
| | | | Range 0 to 3 | V _{DD} =2.4 V to 3.6 V | -0.5 | - | - 0.5 | |
| $\Delta_{VDD}(MSI)^{(2)}$ | MSI oscillator frequency drift over V _{DD} | MSI mode | Range 4 to 7 | V _{DD} =1.62 V to 3.6 V | -2.5 | ı | 0.7 | % |
| Δγ _{DD} (MOI) | (reference is 3 V) | Wormode | V_{DD} | V _{DD} =2.4 V to 3.6 V | -0.8 | - | 0.7 | 70 |
| | | | | V _{DD} =1.62 V to 3.6 V | -5 | - | 1 | |
| | | | V _D | V _{DD} =2.4 V to 3.6 V | -1.6 | - | · | |
| 4.5 | Frequency | | $T_A = -40 \text{ to } 85^\circ$ | °C | - | 1 | 2 | |
| ΔF _{SAMPLING} (MSI) ⁽²⁾⁽⁶⁾ | variation in sampling mode ⁽³⁾ | MSI mode | T _A = -40 to 125 | 5°C | - | 2 | 4 | % |
| P_USB | Period jitter for USB clock ⁽⁴⁾ | PLL mode | for next transition | - | - | - | 3.458 | ns |
| Jitter(MSI) ⁽⁶⁾ | | clock ⁽⁴⁾ Range 11 | for paired transition | - | - | - | 3.916 | 113 |
| MT_USB | Medium term jitter for USB clock ⁽⁵⁾ | PLL mode | for next transition | - | - | - | 2 | ns |
| Jitter(MSI) ⁽⁶⁾ | | Range 11 | for paired transition | - | - | - | 1 | 113 |
| CC jitter(MSI) ⁽⁶⁾ | RMS cycle-to- cycle jitter | PLL mode R | ange 11 | - | - | 60 | - | ps |
| P jitter(MSI) ⁽⁶⁾ | RMS Period jitter | PLL mode R | ange 11 | - | - | 50 | - | ps |
| | | Range 0 | | - | - | 10 | 20 | |
| | | Range 1 | | - | - | 5 | 10 | |
| t _{SU} (MSI) ⁽⁶⁾ | MSI oscillator | Range 2 | | - | - | 4 | 8 | us |
| tgu(MOI)** | start-up time | Range 3 | | - | - | 3 | 7 | us |
| | | Range 4 to 7 | 7 | - | - | 3 | 6 | |
| | | Range 8 to 11 | | - | - | 2.5 | 6 | |
| | MSI oscillator stabilization time | | 10 % of final frequency | - | - | 0.25 | 0.5 | |
| t _{STAB} (MSI) ⁽⁶⁾ | | | 5 % of final frequency | - | - | 0.5 | 1.25 | ms |
| | | | | 1 % of final frequency | - | - | - | 2.5 |



| Symbol | Parameter | | Conditions | | Min | Тур | Max | Unit |
|--------------------------------------|-------------------|---------------------|------------|---|-----|------|-----|------|
| | | | Range 0 | - | - | 0.6 | 1 | |
| | | | Range 1 | - | - | 0.8 | 1.2 | |
| | | | Range 2 | - | - | 1.2 | 1.7 | |
| | | | Range 3 | - | - | 1.9 | 2.5 | |
| | | MSI and PLL mode | Range 4 | - | - | 4.7 | 6 | |
| 1 (MCI)(6) | MSI oscillator | | Range 5 | - | - | 6.5 | 9 | |
| I _{DD} (MSI) ⁽⁶⁾ | power consumption | | Range 6 | - | - | 11 | 15 | μA |
| | | | Range 7 | - | - | 18.5 | 25 | 5 |
| | | Range 8 | - | - | 62 | 80 | | |
| | | | Range 9 | - | - | 85 | 110 | |
| | | | Range 10 | - | - | 110 | 130 | |
| | | | Range 11 | - | - | 155 | 190 | |

- 1. Guaranteed by characterization results.
- 2. This is a deviation for an individual part once the initial frequency has been measured.
- 3. Sampling mode means Low-power run/Low-power sleep modes with Temperature sensor disable.
- 4. Average period of MSI @48 MHz is compared to a real 48 MHz clock over 28 cycles. It includes frequency tolerance + jitter of MSI @48 MHz clock.
- Only accumulated jitter of MSI @48 MHz is extracted over 28 cycles.
 For next transition: min. and max. jitter of 2 consecutive frame of 28 cycles of the MSI @48 MHz, for 1000 captures over 28 cycles.
 For paired transitions: min. and max. jitter of 2 consecutive frame of 56 cycles of the MSI @48 MHz, for 1000 captures over 56 cycles.
- 6. Guaranteed by design.

Figure 25. Typical current consumption versus MSI frequency



High-speed internal 48 MHz (HSI48) RC oscillator

Table 52. HSI48 oscillator characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---|---|--|-------------------|------------------------|---------------------|------|
| f _{HSI48} | HSI48 Frequency | V _{DD} =3.0V, T _A =30°C | - | 48 | - | MHz |
| TRIM | HSI48 user trimming step | - | - | 0.11 ⁽²⁾ | 0.18 ⁽²⁾ | % |
| USER TRIM COVERAGE | HSI48 user trimming coverage | ±32 steps | ±3 ⁽³⁾ | ±3.5 ⁽³⁾ | - | % |
| DuCy(HSI48) | Duty Cycle | - | 45 ⁽²⁾ | - | 55 ⁽²⁾ | % |
| ACC | Accuracy of the HSI48 oscillator over temperature | V _{DD} = 3.0 V to 3.6 V, T _A = -15 to 85 °C | - | - | ±3 ⁽³⁾ | % |
| ACC _{HSI48_REL} | (factory calibrated) | V_{DD} = 1.65 V to 3.6 V, T_A = -40 to 125 °C | - | - | ±4.5 ⁽³⁾ | 70 |
| D _{VDD} (HSI48) | HSI48 oscillator frequency | V _{DD} = 3 V to 3.6 V | - | 0.025 ⁽³⁾ | 0.05 ⁽³⁾ | % |
| DVDD(113146) | drift with V _{DD} | V _{DD} = 1.65 V to 3.6 V | - | 0.05 ⁽³⁾ | 0.1 ⁽³⁾ | 70 |
| t _{su} (HSI48) | HSI48 oscillator start-up time | - | - | 2.5 ⁽²⁾ | 6 ⁽²⁾ | μs |
| I _{DD} (HSI48) | HSI48 oscillator power consumption | - | - | 340 ⁽²⁾ | 380 ⁽²⁾ | μA |
| Next transition jitter N _T jitter Accumulated jitter on 28 cycles ⁽⁴⁾ | | - | - | +/-0.15 ⁽²⁾ | - | ns |
| P _T jitter | Paired transition jitter Accumulated jitter on 56 cycles ⁽⁴⁾ | - | - | +/-0.25 ⁽²⁾ | - | ns |

^{1.} $V_{DD} = 3 \text{ V}$, $T_A = -40 \text{ to } 125^{\circ}\text{C}$ unless otherwise specified.

^{2.} Guaranteed by design.

^{3.} Guaranteed by characterization results.

^{4.} Jitter measurement are performed without clock source activated in parallel.

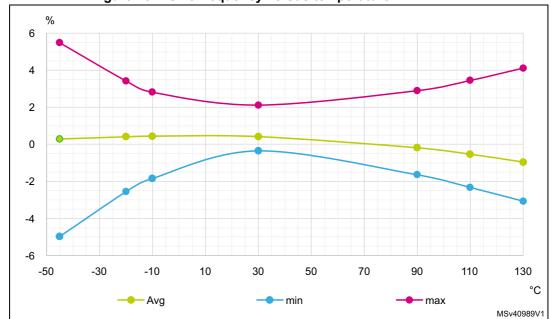


Figure 26. HSI48 frequency versus temperature

Low-speed internal (LSI) RC oscillator

Table 53. LSI oscillator characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|-----------------------------------|--|-------|-----|-------|------|
| f _{LSI} | I SI Eraguanov | V _{DD} = 3.0 V, T _A = 30 °C | 31.04 | - | 32.96 | kHz |
| | LSI Frequency | V _{DD} = 1.62 to 3.6 V, T _A = -40 to 125 °C | 29.5 | - | 34 | KIIZ |
| t _{SU} (LSI) ⁽²⁾ | LSI oscillator start-up time | - | - | 80 | 130 | μs |
| t _{STAB} (LSI) ⁽²⁾ | LSI oscillator stabilization time | 5% of final frequency | - | 125 | 180 | μs |
| I _{DD} (LSI) ⁽²⁾ | LSI oscillator power consumption | - | - | 110 | 180 | nA |

^{1.} Guaranteed by characterization results.

^{2.} Guaranteed by design.

6.3.9 PLL characteristics

The parameters given in *Table 54* are derived from tests performed under temperature and V_{DD} supply voltage conditions summarized in *Table 21: General operating conditions*.

Table 54. PLL, PLLSAI1, PLLSAI2 characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
|------------------------|--------------------------------|--|--------|-----|-----|--------|--|
| f | PLL input clock ⁽²⁾ | - | 2.66 | - | 16 | MHz | |
| f _{PLL_IN} | PLL input clock duty cycle | - | 45 | - | 55 | % | |
| | | Voltage scaling Range 1 Normal mode | 2.0645 | - | 80 | | |
| f _{PLL_P_OUT} | PLL multiplier output clock P | Voltage scaling Range 1 Boost mode | 2.0645 | - | 120 | | |
| | | Voltage scaling Range 2 | 2.0645 | - | 26 | | |
| | | Voltage scaling Range 1 Normal mode | 8 | - | 80 | | |
| f _{PLL_Q_OUT} | PLL multiplier output clock Q | Voltage scaling Range 1 Boost mode | 8 | - | 120 | MHz | |
| | | Voltage scaling Range 2 | 8 | - | 26 | IVIIIZ | |
| | | Voltage scaling Range 1 Normal mode | 8 | - | 80 | | |
| f _{PLL_R_OUT} | PLL multiplier output clock R | Voltage scaling Range 1 Boost mode | 8 | - | 120 | | |
| | | Voltage scaling Range 2 | 8 | - | 26 | | |
| £ | DLL VCO autaut | Voltage scaling Range 1 | 64 | - | 344 | | |
| f _{VCO_OUT} | PLL VCO output | Voltage scaling Range 2 | 64 | - | 128 | | |
| t _{LOCK} | PLL lock time | - | - | 15 | 40 | μs | |
| Jitter | RMS cycle-to-cycle jitter | System sleek 90 MHz | - | 40 | - | Lno | |
| Jiller | RMS period jitter | System clock 80 MHz | - | 30 | - | ±ps | |
| | | VCO freq = 64 MHz | - | 150 | 200 | | |
| I (DII) | PLL power consumption on | VCO freq = 96 MHz | - | 200 | 260 | μA | |
| I _{DD} (PLL) | V _{DD} ⁽¹⁾ | VCO freq = 192 MHz | - | 300 | 380 | | |
| | | VCO freq = 344 MHz | - | 520 | 650 | | |

^{1.} Guaranteed by design.

Take care of using the appropriate division factor M to obtain the specified PLL input clock values. The M factor is shared between the 3 PLLs.

6.3.10 Flash memory characteristics

Table 55. Flash memory characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Тур | Max | Unit | |
|------------------------|---------------------------------------|--------------------|-------|-------|------|--|
| t _{prog} | 64-bit programming time | - | 81.69 | 83.35 | μs | |
| | One row (64 double | Normal programming | 5.23 | 5.33 | | |
| t _{prog_row} | word) programming time | Fast programming | 3.80 | 3.88 | | |
| • | One page (4 Kbytes) | Normal programming | 41.82 | 42.68 | ms | |
| t _{prog_page} | programming time | Fast programming | 30.39 | 31.01 | | |
| t _{ERASE} | Page (4 Kbytes) erase time | - | 22.02 | 24.47 | | |
| 4 | One bank (512 Kbytes) | Normal programming | 5.35 | 5.46 | | |
| t _{prog_bank} | programming time | Fast programming | 3.89 | 3.97 | S | |
| t _{ME} | Mass erase time (one or two banks) | - | 22.13 | 24.59 | ms | |
| | Average consumption | Write mode | TBD | TBD | | |
| | from V _{DD} | Erase mode | TBD | TBD | - mA | |
| I _{DD} | Maximum current (pook) | Write mode | TBD | TBD | | |
| | Maximum current (peak) | Erase mode | TBD | TBD | | |

^{1.} Guaranteed by design.

Table 56. Flash memory endurance and data retention

| Symbol | Parameter | Conditions | Min ⁽¹⁾ | Unit | |
|------------------|----------------|--|--------------------|---------|--|
| N _{END} | Endurance | $T_A = -40 \text{ to } +105 ^{\circ}\text{C}$ | 10 | kcycles | |
| | | 1 kcycle ⁽²⁾ at T _A = 85 °C | 30 | | |
| | Data vatantian | 1 kcycle ⁽²⁾ at T _A = 105 °C | 15 | V | |
| | | 1 kcycle ⁽²⁾ at T _A = 125 °C | 7 | | |
| t _{RET} | Data retention | 10 kcycles ⁽²⁾ at T _A = 55 °C | 30 | Years | |
| | | 10 kcycles ⁽²⁾ at T _A = 85 °C | 15 | | |
| | | 10 kcycles ⁽²⁾ at T _A = 105 °C | 10 | | |

^{1.} Guaranteed by characterization results.

^{2.} Cycling performed over the whole temperature range.

6.3.11 EMC characteristics

Susceptibility tests are performed on a sample basis during device characterization.

Functional EMS (electromagnetic susceptibility)

While a simple application is executed on the device (toggling 2 LEDs through I/O ports). the device is stressed by two electromagnetic events until a failure occurs. The failure is indicated by the LEDs:

- Electrostatic discharge (ESD) (positive and negative) is applied to all device pins until a functional disturbance occurs. This test is compliant with the IEC 61000-4-2 standard.
- FTB: A Burst of Fast Transient voltage (positive and negative) is applied to V_{DD} and V_{SS} through a 100 pF capacitor, until a functional disturbance occurs. This test is compliant with the IEC 61000-4-4 standard.

A device reset allows normal operations to be resumed.

The test results are given in *Table 57*. They are based on the EMS levels and classes defined in application note AN1709.

Level/ **Symbol Parameter Conditions** Class $V_{DD} = 3.3 \text{ V}, T_A = +25 ^{\circ}\text{C},$ Voltage limits to be applied on any I/O pin $f_{HCLK} = 120 \text{ MHz}.$ 3B V_{FESD} to induce a functional disturbance conforming to IEC 61000-4-2 Fast transient voltage burst limits to be $V_{DD} = 3.3 \text{ V}, T_A = +25 ^{\circ}\text{C},$ $f_{HCLK} = 120 \text{ MHz},$ applied through 100 pF on V_{DD} and V_{SS} 5A V_{EFTB} pins to induce a functional disturbance conforming to IEC 61000-4-4

Table 57. EMS characteristics

Designing hardened software to avoid noise problems

EMC characterization and optimization are performed at component level with a typical application environment and simplified MCU software. It should be noted that good EMC performance is highly dependent on the user application and the software in particular.

Therefore it is recommended that the user applies EMC software optimization and prequalification tests in relation with the EMC level requested for his application.

Software recommendations

The software flowchart must include the management of runaway conditions such as:

- · Corrupted program counter
- Unexpected reset
- Critical Data corruption (control registers...)



Prequalification trials

Most of the common failures (unexpected reset and program counter corruption) can be reproduced by manually forcing a low state on the NRST pin or the Oscillator pins for 1 second.

To complete these trials, ESD stress can be applied directly on the device, over the range of specification values. When unexpected behavior is detected, the software can be hardened to prevent unrecoverable errors occurring (see application note AN1015).

Electromagnetic Interference (EMI)

The electromagnetic field emitted by the device are monitored while a simple application is executed (toggling 2 LEDs through the I/O ports). This emission test is compliant with IEC 61967-2 standard which specifies the test board and the pin loading.

| Symbol Parameter | | Parameter Conditions Monitored frequency band | | Max vs. [f _{HSE} /f _{HCLK}] | Unit |
|------------------|--------------------------|---|-------------------|--|------|
| | | | | 8 MHz/120 MHz | |
| | | 0.1 MHz to 30 MHz | 16 | | |
| | | Vdd=3.6 V, T _A =25°C, | 30 MHz to 130 MHz | 16 | dBµV |
| S_{EMI} | Peak level | LQFP144 package, | 130 MHz to 1 GHz | 19 | чоμν |
| | conforming to IEC61967-2 | 1 GHz to 2 GHz | 12 | | |
| | | | EMI Level | 3.5 | - |

Table 58. EMI characteristics

6.3.12 Electrical sensitivity characteristics

Based on three different tests (ESD, LU) using specific measurement methods, the device is stressed in order to determine its performance in terms of electrical sensitivity.

Electrostatic discharge (ESD)

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts × (n+1) supply pins). This test conforms to the ANSI/JEDEC standard.

| Symbol | Ratings | Conditions | Packages | Class | Maximum value ⁽¹⁾ | Unit | |
|-----------------------|--|---|---------------------------|-------|---------------------------------|------|--|
| V _{ESD(HBM)} | Electrostatic discharge voltage (human body model) | T _A = +25 °C, conforming to ANSI/ESDA/JEDEC JS-001 | All | 2 | 2000 | V | |
| ., | Electrostatic discharge | T _A = +25 °C, | LQFP144 | C1 | 250 | ., | |
| V _{ESD(CDM)} | voltage (charge device model) | conforming to ANSI/ESDA/JEDEC JS-002 | All others ⁽²⁾ | C2a | 500 | V | |

Table 59. ESD absolute maximum ratings

Guaranteed by characterization results.

^{2.} For all other packages except WLCSP100.

Static latch-up

Two complementary static tests are required on six parts to assess the latch-up performance:

- A supply overvoltage is applied to each power supply pin.
- A current injection is applied to each input, output and configurable I/O pin.

These tests are compliant with EIA/JESD78 IC latch-up standard.

Table 60. Electrical sensitivities

| Symbol | Parameter | Conditions | Class |
|--------|-----------------------|---|------------|
| LU | Static latch-up class | T _A = +105 °C conforming to JESD78 | II level A |

6.3.13 I/O current injection characteristics

As a general rule, current injection to the I/O pins, due to external voltage below V_{SS} or above V_{DDIOx} (for standard, 3.3 V-capable I/O pins) should be avoided during normal product operation. However, in order to give an indication of the robustness of the microcontroller in cases when abnormal injection accidentally happens, susceptibility tests are performed on a sample basis during device characterization.

Functional susceptibility to I/O current injection

While a simple application is executed on the device, the device is stressed by injecting current into the I/O pins programmed in floating input mode. While current is injected into the I/O pin, one at a time, the device is checked for functional failures.

The failure is indicated by an out of range parameter: ADC error above a certain limit (higher than 5 LSB TUE), out of conventional limits of induced leakage current on adjacent pins (out of the -5 μ A/+0 μ A range) or other functional failure (for example reset occurrence or oscillator frequency deviation).

The characterization results are given in *Table 61*.

Negative induced leakage current is caused by negative injection and positive induced leakage current is caused by positive injection.

Table 61. I/O current injection susceptibility

| Symbol | Description | Func susce | Unit | |
|---------------------------------|--|---------------|--------------------|-------|
| | Description | | Positive injection | Oille |
| | Injected current on all pins except TT_x | -5 | NA | |
| I _{INJ} ⁽¹⁾ | Injected current on pins PD7, OPAMP1_VINM, OPAMP2_VINM | | NA | mA |
| | Injected current on TT_ax pins | -5 | 0 | |

1. Guaranteed by characterization.



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6.3.14 I/O port characteristics

General input/output characteristics

Unless otherwise specified, the parameters given in *Table 62* are derived from tests performed under the conditions summarized in *Table 21: General operating conditions*. All I/Os are designed as CMOS- and TTL-compliant.

Table 62. I/O static characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------------------|---|---------------------------------------|--------------------------------------|-----|------------------|------|
| | I/O input low level voltage | 1.62 V <v<sub>DDIOx<3.6 V</v<sub> | - | - | 0.3xVDDIOX | |
| V _{IL} ⁽¹⁾ | I/O input low level voltage | 1.62 V <v<sub>DDIOx<3.6 V</v<sub> | - | - | 0.39xVDDIOX-0.06 | V |
| | I/O input low level voltage | 1.08 V <v<sub>DDIOx<1.62 V</v<sub> | - | - | 0.43xVDDIOX-0.1 | |
| | I/O input high level voltage | 1.62 V <v<sub>DDIOx<3.6 V</v<sub> | 0.7xVDDIOX | - | - | |
| $V_{IH}^{(1)}$ | I/O input high level voltage | 1.62 V <v<sub>DDIOX<3.6 V</v<sub> | 0.49x VDDIOX +0.26 ⁽³⁾ | - | - | V |
| | I/O input high level voltage | 1.08 V <v<sub>DDIOx<1.62 V</v<sub> | 0.61x VDDIOX +0.05 ⁽³⁾ | - | - | |
| V _{hys} ⁽³⁾ | TT_xx, FT_xxx and NRST I/O input hysteresis | 1.62 V <v<sub>DDIOx<3.6 V</v<sub> | - | 200 | - | mV |
| - | FT_sx | 1.08 V <v<sub>DDIOx<1.62 V</v<sub> | - | 150 | - | |

Table 62. I/O static characteristics (continued)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------|--|--|-----|-----|------------------------|------|
| | | $V_{IN} \le Max(V_{DDXXX})^{(4)}$ | - | - | +/- 100 | |
| | FT_xx input leakage current ⁽³⁾ | $\begin{aligned} & Max(V_{DDXXX}) \leq V_{IN} \leq \\ & Max(V_{DDXXX}) + 1 \ V^{(4)(5)} \end{aligned}$ | - | - | 650 ⁽³⁾⁽⁶⁾ | |
| | | $Max(V_{DDXXX})+1 V < VIN ≤ 5.5 V(3)(5)$ | - | - | 200 ⁽⁶⁾ | |
| | | $V_{IN} \le Max(V_{DDXXX})^{(4)}$ | - | - | +/- 150 | |
| | FT_lu, FT_u, PB2 and PC3 IO | $\begin{aligned} &Max(V_{DDXXX}) \leq V_{IN} \leq \\ &Max(V_{DDXXX}) + 1 \ V^{(4)} \end{aligned}$ | - | - | 2500 ⁽³⁾⁽⁷⁾ | |
| I _{Ikg} | | $Max(V_{DDXXX})+1 V < VIN ≤ 5.5 V^{(4)(5)(7)}$ | - | - | 250 ⁽⁷⁾ | nA |
| | TT xx input | $V_{IN} \le Max(V_{DDXXX})^{(6)}$ | - | - | +/-150 | |
| | leakage current | | - | - | 2000 ⁽³⁾ | |
| | OPAMPx_VINM (x=1,2) dedicated input leakage current | - | - | - | (8) | |
| R _{PU} | Weak pull-up equivalent resistor | V _{IN} = V _{SS} | 25 | 40 | 55 | kΩ |
| R _{PD} | Weak pull-down equivalent resistor ⁽⁹⁾ | V _{IN} = V _{DDIOx} | 25 | 40 | 55 | kΩ |
| C _{IO} | I/O pin capacitance | - | - | 5 | - | pF |

- 1. Refer to Figure 27: I/O input characteristics.
- 2. Tested in production.
- 3. Guaranteed by design.
- 4. Max(V_{DDXXX}) is the maximum value of all the I/O supplies. Refer to Table: Legend/Abbreviations used in the pinout table.
- 5. All TX_xx IO except FT_lu, FT_u, PB2 and PC3.
- 6. This value represents the pad leakage of the IO itself. The total product pad leakage is provided by this formula: $I_{Total_lleak_max} = 10 \ \mu A + [number of IOs where V_{IN} is applied on the pad] x I_{lkg}(Max)$.
- To sustain a voltage higher than MIN(V_{DD}, V_{DDA}, V_{DDUSB}, V_{DDIO2}) +0.3 V, the internal Pull-up and Pull-Down resistors must be disabled.
- 8. Refer to I_{bias} in Table 78: OPAMP characteristics for the values of the OPAMP dedicated input leakage current.
- Pull-up and pull-down resistors are designed with a true resistance in series with a switchable PMOS/NMOS. This PMOS/NMOS contribution to the series resistance is minimal (~10% order).

All I/Os are CMOS- and TTL-compliant (no software configuration required). Their characteristics cover more than the strict CMOS-technology or TTL parameters. The coverage of these requirements is shown in *Figure 27* for standard I/Os, and in *Figure 27* for 5 V tolerant I/Os.

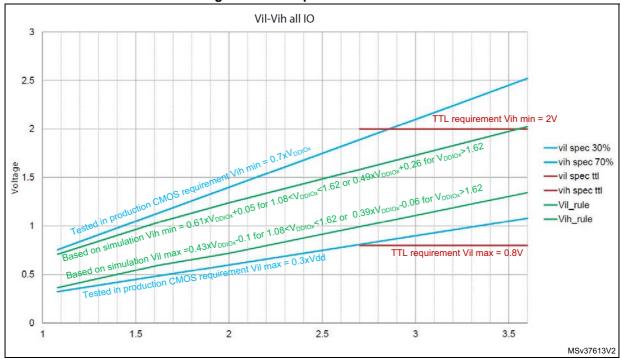


Figure 27. I/O input characteristics

Output driving current

The GPIOs (general purpose input/outputs) can sink or source up to ± 8 mA, and sink or source up to ± 20 mA (with a relaxed V_{OL}/V_{OH}).

In the user application, the number of I/O pins which can drive current must be limited to respect the absolute maximum rating specified in *Section 6.2*:

- The sum of the currents sourced by all the I/Os on V_{DDIOx}, plus the maximum consumption of the MCU sourced on V_{DD}, cannot exceed the absolute maximum rating ΣI_{VDD} (see *Table 18: Voltage characteristics*).
- The sum of the currents sunk by all the I/Os on V_{SS}, plus the maximum consumption of the MCU sunk on V_{SS}, cannot exceed the absolute maximum rating ΣI_{VSS} (see Table 18: Voltage characteristics).

Output voltage levels

Unless otherwise specified, the parameters given in the table below are derived from tests performed under the ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*. All I/Os are CMOS- and TTL-compliant (FT OR TT unless otherwise specified).



| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------------------|--|--|---------------------------|--------------------------|------|
| V _{OL} | Output low level voltage for an I/O pin | CMOS port ⁽²⁾ I _{IO} = 8 mA | - | 0.4 | |
| V _{OH} | Output high level voltage for an I/O pin | $V_{\text{DDIOx}} \ge 2.7 \text{ V}$ | V _{DDIOx} -0.4 | - | |
| V _{OL} ⁽³⁾ | Output low level voltage for an I/O pin | TTL port ⁽²⁾ | - | 0.4 | |
| V _{OH} ⁽³⁾ | Output high level voltage for an I/O pin | $\begin{cases} I_{IO} = 8 \text{ mA} \\ V_{DDIOX} \ge 2.7 \text{ V} \end{cases}$ | 2.4 | - | |
| V _{OL} ⁽³⁾ | Output low level voltage for an I/O pin | I _{IO} = 20 mA | - | 1.3 | |
| V _{OH} ⁽³⁾ | Output high level voltage for an I/O pin | V _{DDIOX} ≥ 2.7 V | V _{DDIOx} -1.3 | - | |
| V _{OL} ⁽³⁾ | Output low level voltage for an I/O pin | I _{IO} = 4 mA | - | 0.45 | V |
| V _{OH} ⁽³⁾ | Output high level voltage for an I/O pin | V _{DDIOx} ≥ 1.62 V | V _{DDIOx} -0.45 | - | |
| V _{OL} ⁽³⁾ | Output low level voltage for an I/O pin | I _{IO} = 2 mA | - | 0.35 x _{VDDIOx} | |
| V _{OH} ⁽³⁾ | Output high level voltage for an I/O pin | 1.62 V ≥ V _{DDIOX} ≥ 1.08 V | 0.65 x V _{DDIOx} | - | |
| | | I _{IO} = 20 mA V _{DDIOx} ≥ 2.7 V | - | 0.4 | |
| V _{OLFM+} | Output low level voltage for an FT I/O pin in FM+ mode | I _{IO} = 10 mA V _{DDIOx} ≥ 1.62 V | - | 0.4 | |
| (3) | (FT I/O with "f" option) | I _{IO} = 2 mA 1.62 V ≥ V _{DDIOx} ≥ 1.08 V | - | 0.4 | |

Table 63. Output voltage characteristics⁽¹⁾

Input/output AC characteristics

The definition and values of input/output AC characteristics are given in *Figure 28* and *Table 64*, respectively.

Unless otherwise specified, the parameters given are derived from tests performed under the ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*.



The I_{IO} current sourced or sunk by the device must always respect the absolute maximum rating specified in Table 18:
 Voltage characteristics, and the sum of the currents sourced or sunk by all the I/Os (I/O ports and control pins) must always respect the absolute maximum ratings ΣI_{IO}.

^{2.} TTL and CMOS outputs are compatible with JEDEC standards JESD36 and JESD52.

^{3.} Guaranteed by design.

Table 64. I/O AC characteristics⁽¹⁾⁽²⁾

| Speed | Symbol | Parameter | Conditions | Min | Max | Unit | | |
|-------|--------|-------------------|--|-----|-----|---------|--|--|
| | | | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 5 | | | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 1 | | | |
| | Fmax | Maximum frequency | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 0.1 | MHz | | |
| | ГШах | | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 10 | IVITZ | | |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 1.5 | | | |
| 00 | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 0.1 | | | |
| 00 | | Tr/Tf Gall time | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 25 | | | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 52 | | | |
| | Tr/Tf | | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 140 | ns | | |
| | 11/11 | | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 17 | 113 | | |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 37 | | | |
| | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 110 | | | |
| | | Maximum | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 25 | | | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 10 | MHz | | |
| | Fmax | | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 1 | | | |
| | ГШах | frequency | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 50 | IVII IZ | | |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 15 | | | |
| 01 | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 1 | | | |
| 01 | | | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 9 | | | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 16 | | | |
| | Tr/Tf | Output rise and | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 40 | no | | |
| | 11/11 | fall time | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 4.5 | ns | | |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 9 | 1 | | |
| | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 21 | | | |

Table 64. I/O AC characteristics⁽¹⁾⁽²⁾ (continued)

| Speed | Symbol | Parameter | Conditions | Min | Max | Unit |
|-------|--------|---------------------------------|--|-----|--------------------|-------|
| | | | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 50 | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 25 | |
| | Fmax | Maximum | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 5 | MHz |
| | rillax | frequency | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 100 | IVITZ |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 37.5 | |
| 10 | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 5 | |
| 10 | | Output rise and fall time | C=50 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 5.8 | |
| | | | C=50 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 11 | |
| | Tr/Tf | | C=50 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 28 | ns |
| | 11/11 | | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 2.5 | |
| | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 5 | |
| | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 12 | |
| | | Maximum | C=30 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 120 | |
| | | | C=30 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 50 | |
| | Fmax | | C=30 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 10 | MHz |
| | ГШах | frequency | C=10 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 180 ⁽³⁾ | IVITZ |
| 11 | | | C=10 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 75 | |
| | | | C=10 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 10 | |
| | | | C=30 pF, 2.7 V≤V _{DDIOx} ≤3.6 V | - | 3.3 | |
| | Tr/Tf | Output rise and fall time | C=30 pF, 1.62 V≤V _{DDIOx} ≤2.7 V | - | 6 | ns |
| | | | C=30 pF, 1.08 V≤V _{DDIOx} ≤1.62 V | - | 16 | |
| Fm+ | Fmax | Maximum frequency | C-50 pE 16 V/sV/ <3 6 V | - | 1 | MHz |
| FIIIT | Tf | Output fall time ⁽⁴⁾ | C=50 pF, 1.6 V≤V _{DDIOx} ≤3.6 V | - | 5 | ns |

The I/O speed is configured using the OSPEEDRy[1:0] bits. The Fm+ mode is configured in the SYSCFG_CFGR1 register. Refer to the RM0432 reference manual for a description of GPIO Port configuration register.

^{2.} Guaranteed by design.

^{3.} This value represents the I/O capability but the maximum system frequency is limited to 120 MHz.

^{4.} The fall time is defined between 70% and 30% of the output waveform accordingly to I^2C specification.

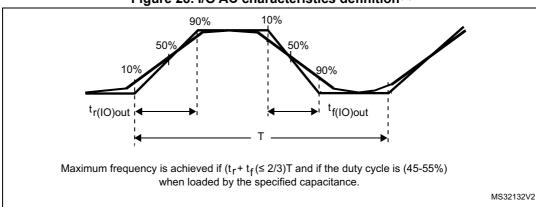


Figure 28. I/O AC characteristics definition⁽¹⁾

1. Refer to Table 64: I/O AC characteristics.

6.3.15 NRST pin characteristics

The NRST pin input driver uses the CMOS technology. It is connected to a permanent pull-up resistor, R_{PU} .

Unless otherwise specified, the parameters given in the table below are derived from tests performed under the ambient temperature and supply voltage conditions summarized in *Table 21: General operating conditions*.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|---|-------------------------------------|--------------------------|-----|--------------------------|----------|
| V _{IL(NRST)} | NRST input low level voltage | - | - | - | 0.3 x V _{DDIOX} | V |
| V _{IH(NRST)} | NRST input high level voltage | - | 0.7 x V _{DDIOX} | - | - | v |
| V _{hys(NRST)} | NRST Schmitt trigger voltage hysteresis | - | - | 200 | - | mV |
| R _{PU} | Weak pull-up equivalent resistor ⁽²⁾ | V _{IN} = V _{SS} | 25 | 40 | 55 | kΩ |
| V _{F(NRST)} | NRST input filtered pulse | - | - | - | 70 | ns |
| V _{NF(NRST)} | NRST input not filtered pulse | 1.71 V ≤ V _{DD} ≤ 3.6 V | 350 | - | - | ns |

Table 65. NRST pin characteristics⁽¹⁾

^{1.} Guaranteed by design.

The pull-up is designed with a true resistance in series with a switchable PMOS. This PMOS contribution to the series resistance is minimal (~10% order).

External reset circuit⁽¹⁾

NRST⁽²⁾

NRST⁽²⁾

Filter

Internal reset

MS19878V3

Figure 29. Recommended NRST pin protection

- 1. The reset network protects the device against parasitic resets.
- 2. The user must ensure that the level on the NRST pin can go below the V_{IL(NRST)} max level specified in *Table 65: NRST pin characteristics*. Otherwise the reset is not taken into account by the device.
- 3. The external capacitor on NRST must be placed as close as possible to the device.

6.3.16 Extended interrupt and event controller input (EXTI) characteristics

The pulse on the interrupt input must have a minimal length in order to guarantee that it is detected by the event controller.

Table 66. EXTI input characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------|----------------------------------|------------|-----|-----|-----|------|
| PLEC | Pulse length to event controller | - | 20 | - | - | ns |

^{1.} Guaranteed by design.

6.3.17 Analog switches booster

Table 67. Analog switches booster characteristics⁽¹⁾

| Symbol | Parameter | Min | Тур | Max | Unit |
|------------------------|--|------|-----|-----|------|
| V_{DD} | Supply voltage | 1.62 | - | 3.6 | V |
| t _{SU(BOOST)} | Booster startup time | - | - | 240 | μs |
| I _{DD(BOOST)} | Booster consumption for 1.62 V ≤ V _{DD} ≤ 2.0 V | - | - | 250 | |
| | Booster consumption for 2.0 V ≤ V _{DD} ≤ 2.7 V | - | - | 500 | μΑ |
| | Booster consumption for $2.7 \text{ V} \leq \text{V}_{\text{DD}} \leq 3.6 \text{ V}$ | - | - | 900 | |

^{1.} Guaranteed by design.

6.3.18 Analog-to-digital converter characteristics

Unless otherwise specified, the parameters given in *Table 68* are preliminary values derived from tests performed under ambient temperature, f_{PCLK} frequency and V_{DDA} supply voltage conditions summarized in *Table 21: General operating conditions*.

Note: It is recommended to perform a calibration after each power-up.

Table 68. ADC characteristics⁽¹⁾ (2)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | | |
|----------------------|--|---|-----------------|------------------|----------------------|--------------------|--|--|
| V _{DDA} | Analog supply voltage | - | 1.62 | - | 3.6 | V | | |
| ., | Positive | V _{DDA} ≥ 2 V | 2 | - | V_{DDA} | V | | |
| V _{REF+} | reference voltage | V _{DDA} < 2 V | V_{DDA} | | | V | | |
| V _{REF-} | Negative reference voltage | - | | V _{SSA} | | V | | |
| f | ADC clock | Range 1 | - | - | 80 | MHz | | |
| f _{ADC} | frequency | Range 2 | - | - | 26 | IVII IZ | | |
| | | Resolution = 12 bits | - | - | 5.33 | | | |
| | Sampling rate for FAST | Resolution = 10 bits | - | - | 6.15 | | | |
| | channels | Resolution = 8 bits | - | - | 7.27 | | | |
| £ | | Resolution = 6 bits | - | - | 8.88 | N4 | | |
| f_s | | Resolution = 12 bits | - | - | 4.21 | Msps | | |
| | Sampling rate for SLOW channels | Resolution = 10 bits | - | - | 4.71 | | | |
| | | Resolution = 8 bits | - | - | 5.33 | | | |
| | | Resolution = 6 bits | - | - | 6.15 | | | |
| f _{TRIG} | External trigger | f _{ADC} = 80 MHz Resolution = 12 bits | - | - | 5.33 | MHz | | |
| 11110 | frequency | Resolution = 12 bits | - | - | 15 | 1/f _{ADC} | | |
| V _{AIN} (3) | Conversion voltage range(2) | - | 0 | - | V _{REF+} | V | | |
| R _{AIN} | External input impedance | - | - | - | 50 | kΩ | | |
| C _{ADC} | Internal sample and hold capacitor | - | - | 5 | - | pF | | |
| t _{STAB} | Power-up time | - | 1 | | conversi on cycle | | | |
| t | Calibration time | f _{ADC} = 80 MHz | c = 80 MHz 1.45 | | | μs | | |
| t _{CAL} | Calibration tille | - | | 116 | | | | |

Table 68. ADC characteristics^{(1) (2)} (continued)

| | | | <u> </u> | liucu, | l | | |
|------------------------------|--|---|----------|---|---------|--------------------|--|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
| | Trigger . | CKMODE = 00 | 1.5 | 2 | 2.5 | | |
| | conversion latency Regular | CKMODE = 01 | - | - | 2.0 | | |
| t _{LATR} | and injected | CKMODE = 10 | - | - | 2.25 | 1/f _{ADC} | |
| Z.iii | channels without conversion abort | CKMODE = 11 | - | - | 2.125 | 7.50 | |
| | Trigger | CKMODE = 00 | 2.5 | 3 | 3.5 | | |
| | conversion latency Injected | CKMODE = 01 | - | - | 3.0 | | |
| t _{LATRINJ} | channels | CKMODE = 10 | - | - | 3.25 | 1/f _{ADC} | |
| | aborting a regular conversion | CKMODE = 11 | - | - | 3.125 | | |
| | Commission of time of | f _{ADC} = 80 MHz | 0.03125 | - | 8.00625 | μs | |
| t _s Sampling time | | - | 2.5 | - | 640.5 | 1/f _{ADC} | |
| t _{ADCVREG_STU} | ADC voltage regulator start-up time | - | - | - | 20 | μs | |
| | Total conversion time | f _{ADC} = 80 MHz Resolution = 12 bits | 0.1875 | - | 8.1625 | μs | |
| t _{CONV} | (including sampling time) | Resolution = 12 bits | successi | ts + 12.5 cycles for successive approximation = 15 to 653 | | | |
| | ADC | fs = 5 Msps | - | 730 | 830 | | |
| I _{DDA} (ADC) | consumption from the V _{DDA} | fs = 1 Msps | - | 160 | 220 | μΑ | |
| | supply | fs = 10 ksps | - | 16 | 50 | | |
| | ADC | fs = 5 Msps | - | 130 | 160 | | |
| I _{DDV_S} (ADC) | consumption from the V _{REF+} | fs = 1 Msps | - | 30 | 40 | μA | |
| IDDV_S(ADC) | single ended mode | fs = 10 ksps | - | 0.6 | 2 | μ/\ | |
| | ADC | fs = 5 Msps | - | 260 | 310 | | |
| I _{DDV_D} (ADC) | consumption from the V _{REF+} differential mode | fs = 1 Msps | - | 60 | 70 | μΑ | |
| | | fs = 10 ksps | - | 1.3 | 3 | | |

^{1.} Guaranteed by design

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^{2.} The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4 V.

V_{REF+} can be internally connected to V_{DDA} and V_{REF-} can be internally connected to V_{SSA}, depending on the package.
 Refer to Section 4: Pinouts and pin description for further details.

The maximum value of R_{AIN} can be found in *Table 69: Maximum ADC RAIN*.

Table 69. Maximum ADC R_{AIN}⁽¹⁾⁽²⁾

| Deceleties. | Sampling cycle | Sampling time | R _{AIN} n | nax (Ω) |
|-------------|----------------|---------------|------------------------------|------------------------------|
| Resolution | @80 MHz | [ns] @80 MHz | Fast channels ⁽³⁾ | Slow channels ⁽⁴⁾ |
| | 2.5 | 31.25 | 100 | N/A |
| | 6.5 | 81.25 | 330 | 100 |
| | 12.5 | 156.25 | 680 | 470 |
| 12 bits | 24.5 | 306.25 | 1500 | 1200 |
| 12 DILS | 47.5 | 593.75 | 2200 | 1800 |
| | 92.5 | 1156.25 | 4700 | 3900 |
| | 247.5 | 3093.75 | 12000 | 10000 |
| | 640.5 | 8006.75 | 39000 | 33000 |
| | 2.5 | 31.25 | 120 | N/A |
| | 6.5 | 81.25 | 390 | 180 |
| | 12.5 | 156.25 | 820 | 560 |
| 40 hita | 24.5 | 306.25 | 1500 | 1200 |
| 10 bits | 47.5 | 593.75 | 2200 | 1800 |
| | 92.5 | 1156.25 | 5600 | 4700 |
| | 247.5 | 3093.75 | 12000 | 10000 |
| | 640.5 | 8006.75 | 47000 | 39000 |
| | 2.5 | 31.25 | 180 | N/A |
| | 6.5 | 81.25 | 470 | 270 |
| | 12.5 | 156.25 | 1000 | 680 |
| 8 bits | 24.5 | 306.25 | 1800 | 1500 |
| o bits | 47.5 | 593.75 | 2700 | 2200 |
| | 92.5 | 1156.25 | 6800 | 5600 |
| | 247.5 | 3093.75 | 15000 | 12000 |
| | 640.5 | 8006.75 | 50000 | 50000 |
| | 2.5 | 31.25 | 220 | N/A |
| | 6.5 | 81.25 | 560 | 330 |
| | 12.5 | 156.25 | 1200 | 1000 |
| 6 bits | 24.5 | 306.25 | 2700 | 2200 |
| O DILS | 47.5 | 593.75 | 3900 | 3300 |
| | 92.5 | 1156.25 | 8200 | 6800 |
| | 247.5 | 3093.75 | 18000 | 15000 |
| | 640.5 | 8006.75 | 50000 | 50000 |

- 1. Guaranteed by design.
- 2. The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4V). It is disable when $V_{DDA} \ge 2.4$ V.
- 3. Fast channels are: PC0, PC1, PC2, PC3, PA0.
- 4. Slow channels are: all ADC inputs except the fast channels.



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Table 70. ADC accuracy - limited test conditions $\mathbf{1}^{(1)(2)(3)}$

| Sym- | | | - | test conditions 1(1)(2)(3) | | | | |
|------------------------------|---------------------------------------|--|--------------------------|----------------------------|------|------|-----|------|
| bol | Parameter | (| Conditions ⁽⁴ |) | Min | Тур | Max | Unit |
| | | | Single | Fast channel (max speed) | - | 4 | 5 | |
| | Total | | ended | Slow channel (max speed) | - | 4 | 5 | |
| ET | unadjusted error | | Differential | Fast channel (max speed) | - | 3.5 | 4.5 | |
| | | | Differential | Slow channel (max speed) | - | 3.5 | 4.5 | |
| | | | Single | Fast channel (max speed) | _ | 1 | 2.5 | |
| EO | Offset | | ended | Slow channel (max speed) | - | 1 | 2.5 | |
| | error | | Differential | Fast channel (max speed) | - | 1.5 | 2.5 | |
| | | | Dillerential | Slow channel (max speed) | _ | 1.5 | 2.5 | |
| | | | Single | Fast channel (max speed) | - | 2.5 | 4.5 | |
| EG | Gain error | | ended | Slow channel (max speed) | - | 2.5 | 4.5 | LSB |
| LG | Gain enoi | | Differential | Fast channel (max speed) | - | 2.5 | 3.5 | LOD |
| | | | Differential | Slow channel (max speed) | - | 2.5 | 3.5 | |
| | | | Single | Fast channel (max speed) | - | 1 | 1.5 | |
| Differential linearity error | | | ended | Slow channel (max speed) | - | 1 | 1.5 | |
| | _ | ADC clock frequency ≤ | Differential | Fast channel (max speed) | - | 1 | 1.2 | |
| | 80 MHz, Sampling rate ≤ 5.33 Msps, | Dillerential | Slow channel (max speed) | - | 1 | 1.2 | | |
| | | $V_{DDA} = VREF + = 3 V$, TA = 25 °C | Single ended | Fast channel (max speed) | - | 1.5 | 2.5 | |
| EL | Integral linearity | | | Slow channel (max speed) | - | 1.5 | 2.5 | |
| LL | error | | Differential | Fast channel (max speed) | - | 1 | 2 | |
| | | | Dillerential | Slow channel (max speed) | - | 1 | 2 | |
| | | | Single | Fast channel (max speed) | 10.4 | 10.5 | - | |
| ENOB | Effective number of | | ended | Slow channel (max speed) | 10.4 | 10.5 | • | bits |
| LINOD | bits | | Differential | Fast channel (max speed) | 10.8 | 10.9 | - | Dita |
| | | | Dilicicitiai | Slow channel (max speed) | 10.8 | 10.9 | - | |
| | Signal-to- | | Single | Fast channel (max speed) | 64.4 | 65 | • | |
| SINAD | noise and | | ended | Slow channel (max speed) | 64.4 | 65 | - | |
| SINAD | distortion | | Differential | Fast channel (max speed) | 66.8 | 67.4 | - | |
| | ratio | | Dillerential | Slow channel (max speed) | 66.8 | 67.4 | - | dB |
| | | | Single | Fast channel (max speed) | 65 | 66 | - | uБ |
| SNR | Signal-to- | | ended | Slow channel (max speed) | 65 | 66 | - |] |
| CINIX | noise ratio | | Differential | Fast channel (max speed) | 67 | 68 | - | |
| | | וויכופווומו | Slow channel (max speed) | 67 | 68 | - | | |

Table 70. ADC accuracy - limited test conditions $1^{(1)(2)(3)}$ (continued)

| Sym- bol | Parameter | Conditions ⁽⁴⁾ | | | | | Max | Unit |
|-------------------------------|-------------------------------------|---------------------------------------|--------------------------|--------------------------|-----|-----|-----|------|
| | | ADC clock frequency ≤ | Single | Fast channel (max speed) | - | -74 | -73 | |
| THD Total harmonic distortion | | 80 MHz, Sampling rate ≤ 5.33 Msps, | ended | Slow channel (max speed) | - | -74 | -73 | dB |
| | $V_{DDA} = V_{REF+} = 3 \text{ V},$ | Differential | Fast channel (max speed) | - | -79 | -76 | uБ | |
| | TA = 25 °C | Dillerential | Slow channel (max speed) | - | -79 | -76 | | |

- 1. Guaranteed by design.
- 2. ADC DC accuracy values are measured after internal calibration.
- ADC accuracy vs. negative Injection Current: Injecting negative current on any analog input pins should be avoided as this
 significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a
 Schottky diode (pin to ground) to analog pins which may potentially inject negative current.
- 4. The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4 V). It is disable when $V_{DDA} \ge 2.4$ V. No oversampling.



Table 71. ADC accuracy - limited test conditions $2^{(1)(2)(3)}$

| Sym- bol | Parameter | | Conditions ⁽⁴ |) | Min | Тур | Max | Unit |
|-----------------------|-------------------------|--|--------------------------|--------------------------|------|------|-----|------|
| | | | Single | Fast channel (max speed) | - | 4 | 6.5 | |
| | Total | | ended | Slow channel (max speed) | - | 4 | 6.5 | |
| ET | unadjusted error | | Differential | Fast channel (max speed) | - | 3.5 | 5.5 | |
| | | | Dillerential | Slow channel (max speed) | _ | 3.5 | 5.5 | |
| | | | Single | Fast channel (max speed) | - | 1 | 4.5 | |
| EO | Offset | | ended | Slow channel (max speed) | - | 1 | 5 | |
| | error | | Differential | Fast channel (max speed) | - | 1.5 | 3 | |
| | | | Dillerential | Slow channel (max speed) | - | 1.5 | 3 | |
| | | Sin | Single | Fast channel (max speed) | - | 2.5 | 6 | |
| EG | Gain error | | ended | Slow channel (max speed) | - | 2.5 | 6 | LSB |
| LG | Gain enoi | | Differential - | Fast channel (max speed) | - | 2.5 | 3.5 | LOD |
| | | | | Slow channel (max speed) | - | 2.5 | 3.5 | |
| | | | Single | Fast channel (max speed) | - | 1 | 1.5 | |
| ED | Differential | | ended | Slow channel (max speed) | - | 1 | 1.5 | |
| ED linearity error | | ADC clock frequency ≤ | Differential | Fast channel (max speed) | - | 1 | 1.2 | |
| | 80 MHz, | Sinoroniai | Slow channel (max speed) | - | 1 | 1.2 |] | |
| | | Sampling rate ≤ 5.33 Msps, 2 V ≤ V _{DDA} | Single ended | Fast channel (max speed) | - | 1.5 | 3.5 | - |
| EL | Integral linearity | | | Slow channel (max speed) | - | 1.5 | 3.5 | |
| | error | | Differential | Fast channel (max speed) | - | 1 | 3 | |
| | | | Dillerential | Slow channel (max speed) | - | 1 | 2.5 | |
| | | | Single | Fast channel (max speed) | 10 | 10.5 | ı | |
| ENOB | Effective number of | | ended | Slow channel (max speed) | 10 | 10.5 | ı | bits |
| LINOB | bits | | Differential | Fast channel (max speed) | 10.7 | 10.9 | ı | Dita |
| | | | Dillerential | Slow channel (max speed) | 10.7 | 10.9 | - | |
| | Cianal to | | Single | Fast channel (max speed) | 62 | 65 | - | |
| SINAD | Signal-to- noise and | | ended | Slow channel (max speed) | 62 | 65 | - | |
| SINAD | distortion | | Differential | Fast channel (max speed) | 66 | 67.4 | - | |
| | ratio | | Dillerential | Slow channel (max speed) | 66 | 67.4 | - | dB |
| | | | Single ended | Fast channel (max speed) | 64 | 66 | - | иБ |
| CNID | Signal-to- | | | Slow channel (max speed) | 64 | 66 | - |] |
| SIMP | noise ratio | | | Fast channel (max speed) | 66.5 | 68 | • | |
| | | | Differential | Slow channel (max speed) | 66.5 | 68 | - | |

Table 71. ADC accuracy - limited test conditions $2^{(1)(2)(3)}$ (continued)

| Sym- bol | Parameter | C | Conditions ⁽⁴⁾ | | | | | | |
|-------------|----------------------------|------------------------|---------------------------|--------------------------|-----|-----|-----|----|--|
| | | ADC clock frequency ≤ | Single | Fast channel (max speed) | - | -74 | -65 | | |
| THD | Total harmonic | 80 MHz, | ended | Slow channel (max speed) | • | -74 | -67 | dB | |
| distortion | Sampling rate ≤ 5.33 Msps, | Differential | Fast channel (max speed) | • | -79 | -70 | uБ | | |
| | | 2 V ≤ V _{DDA} | Differential | Slow channel (max speed) | - | -79 | -71 | | |

- 1. Guaranteed by design.
- 2. ADC DC accuracy values are measured after internal calibration.
- ADC accuracy vs. negative Injection Current: Injecting negative current on any analog input pins should be avoided as this
 significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a
 Schottky diode (pin to ground) to analog pins which may potentially inject negative current.
- 4. The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4 V). It is disable when $V_{DDA} \ge 2.4$ V. No oversampling.



Table 72. ADC accuracy - limited test conditions 3⁽¹⁾⁽²⁾⁽³⁾

| Sym- bol | Parameter | (| Conditions ⁽⁴ |) | Min | Тур | Max | Unit |
|---------------------------|--------------------------|---|----------------------------|--------------------------|------|------|-----|------|
| | | | Single | Fast channel (max speed) | - | 5.5 | 7.5 | |
| | Total | | ended | Slow channel (max speed) | - | 4.5 | 6.5 | |
| ET | unadjusted error | | Differential | Fast channel (max speed) | - | 4.5 | 7.5 | |
| | | | Differential | Slow channel (max speed) | _ | 4.5 | 5.5 | |
| | | | Single | Fast channel (max speed) | - | 2 | 5 | |
| EO | Offset | | ended | Slow channel (max speed) | - | 2.5 | 5 | |
| | error | | Differential | Fast channel (max speed) | - | 2 | 3.5 | |
| | | | Dillerential | Slow channel (max speed) | - | 2.5 | 3 | |
| | | | Single | Fast channel (max speed) | - | 4.5 | 7 | |
| EG | Gain error | | ended | Slow channel (max speed) | - | 3.5 | 6 | LSB |
| EG Gaill elloi | | al | Differential | Fast channel (max speed) | - | 3.5 | 4 | LOD |
| | | | Dillerential | Slow channel (max speed) | - | 3.5 | 5 | |
| | | | Single ended | Fast channel (max speed) | - | 1.2 | 1.5 | |
| Differential ED linearity | Slow channel (max speed) | | | - | 1.2 | 1.5 | | |
| | error | ADC clock frequency ≤ 80 MHz, Sampling rate ≤ 5.33 Msps, 1.65 V ≤ V _{DDA} = V _{REF+} ≤ 3.6 V, Voltage scaling Range 1 | Differential - | Fast channel (max speed) | - | 1 | 1.2 | - |
| | | | Dillerential | Slow channel (max speed) | - | 1 | 1.2 | |
| | | | Single ended Differential | Fast channel (max speed) | - | 3 | 3.5 | |
| EL | Integral linearity | | | Slow channel (max speed) | - | 2.5 | 3.5 | |
| | error | | | Fast channel (max speed) | - | 2 | 2.5 | |
| | | | | Slow channel (max speed) | - | 2 | 2.5 | |
| | | | Single | Fast channel (max speed) | 10 | 10.4 | - | |
| ENOB | Effective number of | | ended | Slow channel (max speed) | 10 | 10.4 | - | bits |
| LINOD | bits | | Differential | Fast channel (max speed) | 10.6 | 10.7 | ı | טונס |
| | | | Dillerential | Slow channel (max speed) | 10.6 | 10.7 | - | |
| | Signal-to- | | Single | Fast channel (max speed) | 62 | 64 | - | |
| SINAD | noise and | | ended | Slow channel (max speed) | 62 | 64 | - | |
| SINAD | distortion | | Differential | Fast channel (max speed) | 65 | 66 | - | |
| ratio | | Dillerential | Slow channel (max speed) | 65 | 66 | - | dB | |
| | | | Single | Fast channel (max speed) | 63 | 65 | - | ub |
| SNR | Signal-to- | | ended | Slow channel (max speed) | 63 | 65 | - | _ |
| SINIX | noise ratio | | Differential | Fast channel (max speed) | 66 | 67 | - | |
| | | | Dilletetilial | Slow channel (max speed) | 66 | 67 | - | |

Table 72. ADC accuracy - limited test conditions $3^{(1)(2)(3)}$ (continued)

| Sym- bol | Parameter | C | Min | Тур | Max | Unit | | |
|-------------|------------|------------------------------------|--------------|--------------------------|-----|------|-----|----|
| | | ADC clock frequency ≤ | Single | Fast channel (max speed) | - | -69 | -67 | |
| | Total | monic Sampling rate ≤ 5.33 Msps, _ | ended | Slow channel (max speed) | - | -71 | -67 | |
| THD | harmonic | | | Fast channel (max speed) | - | -72 | -71 | dB |
| | distortion | 3.6 V, Voltage scaling Range 1 | Differential | Slow channel (max speed) | - | -72 | -71 | |

- 1. Guaranteed by design.
- 2. ADC DC accuracy values are measured after internal calibration.
- ADC accuracy vs. negative Injection Current: Injecting negative current on any analog input pins should be avoided as this
 significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a
 Schottky diode (pin to ground) to analog pins which may potentially inject negative current.
- 4. The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4 V). It is disable when $V_{DDA} \ge 2.4$ V. No oversampling.



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Table 73. ADC accuracy - limited test conditions 4⁽¹⁾⁽²⁾⁽³⁾

| Sym- bol | Parameter | | Conditions ⁽⁴ |) | Min | Тур | Max | Unit |
|------------------------------|------------------------|---|--------------------------|--------------------------|------|------|-----|------|
| | | | Single | Fast channel (max speed) | - | 5 | 5.4 | |
| | Total | | ended | Slow channel (max speed) | - | 4 | 5 | |
| ET | unadjusted error | | Differential | Fast channel (max speed) | - | 4 | 5 | |
| | | | Dillerential | Slow channel (max speed) | - | 3.5 | 4.5 | |
| | | | Single | Fast channel (max speed) | - | 2 | 4 | |
| EO | Offset | | ended | Slow channel (max speed) | - | 2 | 4 | |
| | error | | Differential | Fast channel (max speed) | - | 2 | 3.5 | |
| | | | Dilleteritial | Slow channel (max speed) | - | 2 | 3.5 | |
| | | | Single | Fast channel (max speed) | - | 4 | 4.5 | |
| EG | Gain error | | ended | Slow channel (max speed) | - | 4 | 4.5 | LSB |
| LG | Gain enoi | | Differential | Fast channel (max speed) | - | 3 | 4 | LOD |
| | | | Dillerential | Slow channel (max speed) | - | 3 | 4 | |
| Differential ED linearity | Single | | Fast channel (max speed) | - | 1 | 1.5 | | |
| | Differential linearity | | ended | Slow channel (max speed) | _ | 1 | 1.5 | |
| | error | ADC clock frequency ≤ | Differential | Fast channel (max speed) | - | 1 | 1.2 | |
| | | 26 MHz, - 1.65 V ≤ V _{DDA} = VREF+ ≤ 3.6 V, Voltage scaling Range 2 | Dillerential | Slow channel (max speed) | - | 1 | 1.2 | |
| | | | Single ended | Fast channel (max speed) | - | 2.5 | 3 | |
| EL | Integral linearity | | | Slow channel (max speed) | - | 2.5 | 3 | |
| | error | | Differential | Fast channel (max speed) | - | 2 | 2.5 | |
| | | | | Slow channel (max speed) | - | 2 | 2.5 | |
| | | 1 | Single | Fast channel (max speed) | 10.2 | 10.5 | ı | |
| ENOB | Effective number of | | ended | Slow channel (max speed) | 10.2 | 10.5 | ı | bits |
| LINOB | bits | | Differential | Fast channel (max speed) | 10.6 | 10.7 | ı | Dita |
| | | | Dillerential | Slow channel (max speed) | 10.6 | 10.7 | ı | |
| | Signal-to- | | Single | Fast channel (max speed) | 63 | 65 | ı | |
| SINAD | noise and | | ended | Slow channel (max speed) | 63 | 65 | - | |
| SINAD | distortion | | Differential | Fast channel (max speed) | 65 | 66 | - | |
| | ratio | | Dillerential | Slow channel (max speed) | 65 | 66 | - | dB |
| | | | Single | Fast channel (max speed) | 64 | 65 | ı | uD |
| SNR | Signal-to- | | Olligic | Slow channel (max speed) | 64 | 65 | ı | |
| SINK | noise ratio | | Differential | Fast channel (max speed) | 66 | 67 | ı | |
| | | | Dilletetilial | Slow channel (max speed) | 66 | 67 | - | |



Table 73. ADC accuracy - limited test conditions $4^{(1)(2)(3)}$ (continued)

| Sym- bol | Parameter | (| Min | Тур | Max | Unit | | |
|----------------------------|------------|--|---------------|--------------------------|-----|------|-----|----|
| | | ADC clock frequency ≤ | Single | Fast channel (max speed) | - | -71 | -69 | _ |
| Total THD harm disto | | · · · · · · · · · · · · · · · · · · · | ended | Slow channel (max speed) | - | -71 | -69 | dB |
| | distortion | $1.65 \text{ V} \le \text{V}_{\text{DDA}} = \text{VREF+} \le$ $3.6 \text{ V},$ | Differential | Fast channel (max speed) | - | -73 | -72 | uБ |
| | | Voltage scaling Range 2 | Dilleterillar | Slow channel (max speed) | - | -73 | -72 | |

- 1. Guaranteed by design.
- 2. ADC DC accuracy values are measured after internal calibration.
- ADC accuracy vs. negative Injection Current: Injecting negative current on any analog input pins should be avoided as this
 significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a
 Schottky diode (pin to ground) to analog pins which may potentially inject negative current.
- 4. The I/O analog switch voltage booster is enable when V_{DDA} < 2.4 V (BOOSTEN = 1 in the SYSCFG_CFGR1 when V_{DDA} < 2.4 V). It is disable when $V_{DDA} \ge 2.4$ V. No oversampling.



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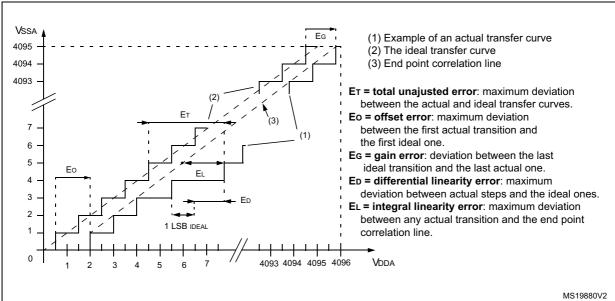
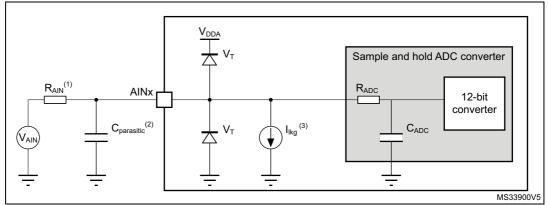


Figure 30. ADC accuracy characteristics





- 1. Refer to Table 68: ADC characteristics for the values of R_{AIN} and C_{ADC}.
- 2. C_{parasitic} represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (refer to *Table 62: I/O static characteristics* for the value of the pad capacitance). A high C_{parasitic} value downgrades the conversion accuracy. To remedy this, f_{ADC} should be reduced.
- 3. Refer to *Table 62: I/O static characteristics* for the values of I_{lkq}.

General PCB design guidelines

Power supply decoupling should be performed as shown in *Figure 17: STM32L4Q5xx* power supply scheme. The 10 nF capacitor should be ceramic (good quality) and it should be placed as close as possible to the chip.



6.3.19 Digital-to-Analog converter characteristics

Table 74. DAC characteristics⁽¹⁾

| Symbol | Parameter | Co | onditions | Min | Тур | Max | Unit |
|-----------------------|---|---|--|------|------------------|----------------------------|------|
| V_{DDA} | Analog supply voltage for DAC ON | DAC output bu pin not connec connection only | | 1.71 | - | 3.6 | |
| | | Other modes | | 1.80 | - | | |
| V _{REF+} | Positive reference voltage | DAC output buffer OFF, DAC_OUT pin not connected (internal connection only) | | 1.71 | - | V _{DDA} | V |
| | | Other modes | Other modes 1.8 | | - | | |
| V _{REF-} | Negative reference voltage | - | | | V _{SSA} | | |
| R _L | Resistive load | DAC output connected to V _{SSA} | | 5 | - | - | kΩ |
| IVL | Tresistive load | buffer ON connected to V _{DDA} | | 25 | - | ı | K22 |
| R_{O} | Output Impedance | DAC output bu | DAC output buffer OFF | | 11.7 | 13.8 | kΩ |
| | Output impedance sample | V _{DD} = 2.7 V | V _{DD} = 2.7 V | | - | 2 | |
| R _{BON} | and hold mode, output buffer ON | V _{DD} = 2.0 V | | - | - | 3.5 | kΩ |
| | Output impedance sample | V _{DD} = 2.7 V | | - | - | 16.5 | |
| R _{BOFF} | and hold mode, output buffer OFF | V _{DD} = 2.0 V | V _{DD} = 2.0 V | | - | 18.0 | kΩ |
| C _L | 0 11 1 | DAC output bu | ffer ON | - | - | 50 | pF |
| C _{SH} | - Capacitive load | Sample and ho | old mode | - | 0.1 | 1 | μF |
| V _{DAC_OUT} | Voltage on DAC_OUT | DAC output bu | ffer ON | 0.2 | - | V _{REF+} - 0.2 | V |
| 27.0_00. | output | DAC output bu | ffer OFF | 0 | - | V _{REF+} | |
| | | | ±0.5 LSB | - | 1.7 | 3 | |
| | Settling time (full scale: for a 12-bit code transition | Normal mode DAC output | ±1 LSB | - | 1.6 | 2.9 | |
| | between the lowest and the | buffer ON | ±2 LSB | - | 1.55 | 2.85 | |
| t _{SETTLING} | highest input codes when DAC_OUT reaches final | CL ≤ 50 pF, RL ≥ 5 kΩ | ±4 LSB | - | 1.48 | 2.8 | μs |
| | value ±0.5LSB, ±1 LSB, | | ±8 LSB | - | 1.4 | 2.75 | |
| | ±2 LSB, ±4 LSB, ±8 LSB) | Normal mode [OFF, ±1LSB, C | DAC output buffer CL = 10 pF | - | 2 | 2.5 | |
| . (2) | Wakeup time from off state (setting the ENx bit in the | Normal mode DAC output buffer ON CL \leq 50 pF, RL \geq 5 k Ω | | - | 4.2 | 7.5 | |
| WAKEUP'-' | DAC Control register) until | | Normal mode DAC output buffer OFF, CL ≤ 10 pF | | 2 | 5 | μs |
| PSRR | V _{DDA} supply rejection ratio | Normal mode [CL ≤ 50 pF, RL | DAC output buffer ON . = 5 kΩ, DC | - | -80 | -28 | dB |



Table 74. DAC characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Co | onditions | Min | Тур | Max | Unit |
|------------------------|---|---|--|-------|------------------------------------|------------------------------------|------|
| T _{W_to_W} | Minimal time between two consecutive writes into the DAC_DORx register to guarantee a correct DAC_OUT for a small variation of the input code (1 LSB) DAC_MCR:MODEx[2:0] = 000 or 001 DAC_MCR:MODEx[2:0] = 010 or 011 | CL ≤ 50 pF, RL ≥ 5 kΩ CL ≤ 10 pF | | 1 1.4 | - | - | μs |
| | | DAC_OUT | , , | | 0.7 | 3.5 | me |
| | Sampling time in sample and hold mode (code transition between the | pin connected | DAC output buffer OFF, C _{SH} = 100 nF | - | 10.5 | 18 | ms |
| t _{SAMP} | lowest input code and the highest input code when DACOUT reaches final value ±1LSB) | DAC_OUT pin not connected (internal connection only) | DAC output buffer OFF | - | 2 | 3.5 | μs |
| I _{leak} | Output leakage current | Sample and ho DAC_OUT pin | | - | - | _(3) | nA |
| Cl _{int} | Internal sample and hold capacitor | | - | 5.2 | 7 | 8.8 | pF |
| t _{TRIM} | Middle code offset trim time | DAC output bu | ffer ON | 50 | - | - | μs |
| V | Middle code offset for 1 trim | V _{REF+} = 3.6 V | | - | 1500 | - | μV |
| $V_{ m offset}$ | code step | V _{REF+} = 1.8 V | | - | 750 | - | μν |
| | | DAC output | No load, middle code (0x800) | - | 315 | 500 | |
| | | buffer ON | No load, worst code (0xF1C) | - | 450 | 670 | |
| I _{DDA} (DAC) | DAC consumption from V _{DDA} | DAC output buffer OFF | No load, middle code (0x800) | - | - | 0.2 | μA |
| | | Sample and hold mode, C _{SH} = 100 nF | | - | 315 x Ton/(Ton +Toff) (4) | 670 x Ton/(Ton +Toff) (4) | |

| Symbol | Parameter | Co | onditions | Min | Тур | Max | Unit |
|------------------------|--|---|-------------------------------------|-----|---|---|------|
| | DAC consumption from V _{REF+} | DAC output | No load, middle code (0x800) | - | 185 | 240 | |
| | | buffer ON | No load, worst code (0xF1C) | - | 340 400 | | |
| | | DAC output buffer OFF | No load, middle code (0x800) | - | 155 | 205 | |
| I _{DDV} (DAC) | | Sample and hold mode, buffer ON, C _{SH} = 100 nF, worst case | | - | 185 _x Ton/(Ton +Toff) (4) | 400 x Ton/(Ton +Toff) (4) | μА |
| | | Sample and ho C _{SH} = 100 nF, | old mode, buffer OFF, worst case | - | 155 _x Ton/(Ton +Toff) (4) | 205 _x Ton/(Ton +Toff) (4) | |

Table 74. DAC characteristics⁽¹⁾ (continued)

- Guaranteed by design.
- 2. In buffered mode, the output can overshoot above the final value for low input code (starting from min value).
- 3. Refer to Table 62: I/O static characteristics.
- 4. Ton is the Refresh phase duration. Toff is the Hold phase duration. Refer to RM0432 reference manual for more details.

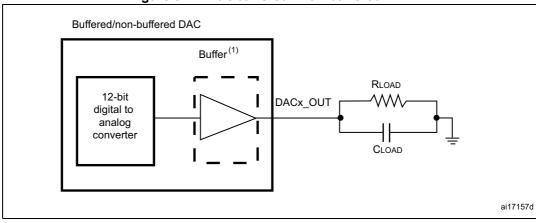


Figure 32. 12-bit buffered / non-buffered DAC

 The DAC integrates an output buffer that can be used to reduce the output impedance and to drive external loads directly without the use of an external operational amplifier. The buffer can be bypassed by configuring the BOFFx bit in the DAC_CR register.

STM32L4Q5xx **Electrical characteristics**

Table 75. DAC accuracy⁽¹⁾

| Symbol | Parameter | Conditio | ns | Min | Тур | Max | Unit |
|-----------|---|---|---------------------------|-----|-----------|------|------|
| DNL | Differential non | DAC output buffer ON | | - | - | ±2 | |
| DINL | linearity ⁽²⁾ | DAC output buffer OFF | | - | - | ±2 | |
| - | monotonicity | 10 bits | | (| guarantee | d | |
| INL | Integral non | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ | | - | - | ±4 | |
| INC | linearity ⁽³⁾ | DAC output buffer OFF CL ≤ 50 pF, no RL | | - | - | ±4 | |
| | | DAC output buffer ON | V _{REF+} = 3.6 V | - | - | ±12 | |
| Offset | Offset error at code 0x800 ⁽³⁾ | CL ≤ 50 pF, RL ≥ 5 kΩ | V _{REF+} = 1.8 V | - | - | ±25 | LSB |
| | | DAC output buffer OFF CL ≤ 50 pF, no RL | | - | - | ±8 | |
| Offset1 | Offset error at code 0x001 ⁽⁴⁾ | DAC output buffer OFF CL ≤ 50 pF, no RL | | - | - | ±5 | |
| OffsetCal | Offset Error at code 0x800 | DAC output buffer ON | V _{REF+} = 3.6 V | - | - | ±5 | |
| OlisetCai | after calibration | CL ≤ 50 pF, RL ≥ 5 kΩ | V _{REF+} = 1.8 V | - | - | ±7 | |
| Coin | Gain error ⁽⁵⁾ | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ | | - | - | ±0.5 | % |
| Gain | Gain enor | DAC output buffer OFF CL ≤ 50 pF, no RL | | - | - | ±0.5 | 70 |
| TUE | Total | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ | | - | - | ±30 | LSB |
| TOE | unadjusted error | DAC output buffer OFF CL ≤ 50 pF, no RL | | - | - | ±12 | LOD |
| TUECal | Total unadjusted error after calibration | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ | | - | - | ±23 | LSB |
| SNR | Signal-to-noise | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ 1 kHz, BW 500 kHz | | - | 71.2 | - | dB |
| NIC | ratio | DAC output buffer OFF CL ≤ 50 pF, no RL, 1 kHz BW 500 kHz | | - | 71.6 | - | uБ |
| TUD | Total harmonic | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ, 1 | kHz | - | -78 | - | ٩D |
| THD | distortion | DAC output buffer OFF CL ≤ 50 pF, no RL, 1 kHz | | - | -79 | - | dB |



| Table 75. DAC accura | cv ⁽¹⁾ (continued) |
|----------------------|-------------------------------|
|----------------------|-------------------------------|

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------|--|--|-----|------|-----|------|
| SINAD | Signal-to-noise and distortion ratio | DAC output buffer ON CL \leq 50 pF, RL \geq 5 k Ω , 1 kHz | - | 70.4 | - | dB |
| | | DAC output buffer OFF CL ≤ 50 pF, no RL, 1 kHz | - | 71 | - | - ub |
| ENOR | Effective | DAC output buffer ON CL ≤ 50 pF, RL ≥ 5 kΩ, 1 kHz | - | 11.4 | - | hita |
| ENOB | number of bits | DAC output buffer OFF CL ≤ 50 pF, no RL, 1 kHz | - | 11.5 | - | bits |

- 1. Guaranteed by design.
- 2. Difference between two consecutive codes 1 LSB.
- 3. Difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 4095.
- 4. Difference between the value measured at Code (0x001) and the ideal value.
- Difference between ideal slope of the transfer function and measured slope computed from code 0x000 and 0xFFF when buffer is OFF, and from code giving 0.2 V and (V_{REF+} – 0.2) V when buffer is ON.



6.3.20 Voltage reference buffer characteristics

Table 76. VREFBUF characteristics⁽¹⁾

| Symbol | Parameter | Condition | ons | Min | Тур | Max | Unit |
|-----------------------|---|---|----------------------------|--------------------------|-------------------------------|----------------------------------|---------|
| | | Normal mode | V _{RS} = 0 | 2.4 | - | 3.6 | |
| | Analog supply | Normal mode | V _{RS} = 1 | 2.8 | - | 3.6 | |
| V_{DDA} | voltage | Degraded mode ⁽²⁾ | V _{RS} = 0 | 1.65 | - | 2.4 | |
| | | Degraded mode | V _{RS} = 1 | 1.65 | - | 2.8 | V |
| | | Normal mode | V _{RS} = 0 | TBD | TBD | TBD | V |
| V _{REFBUF_} | Voltage reference | Normal mode | V _{RS} = 1 | 2.498 ⁽³⁾ | 2.5 | 2.502 ⁽³⁾ | |
| OUT | output | Degraded mode ⁽²⁾ | V _{RS} = 0 | V _{DDA} -150 mV | - | V_{DDA} | |
| | | Degraded mode. | V _{RS} = 1 | V _{DDA} -150 mV | - | V_{DDA} | |
| TRIM | Trim step resolution | - | - | - | ±0.05 | ±0.1 | % |
| CL | Load capacitor | - | - | 0.5 | 1 | 1.5 | μF |
| esr | Equivalent Serial Resistor of Cload | - | - | - | - | 2 | Ω |
| I _{load} | Static load current | - | - | - | - | 4 | mA |
| 1 | Line regulation | 201/61/ 6261/ | I _{load} = 500 μA | - | 200 | 1000 | nnm/\/ |
| I _{line_reg} | Line regulation | $2.8 \text{ V} \le \text{V}_{\text{DDA}} \le 3.6 \text{ V}$ | I _{load} = 4 mA | - | 100 | 500 | ppm/V |
| l _{load_reg} | Load regulation | 500 μA ≤ I _{load} ≤4 mA | Normal mode | - | 50 | 500 | ppm/mA |
| т | Temperature | -40 °C < TJ < +125 °C | - | - | T _{coeff_} vrefint + | ppm/ °C | |
| T _{Coeff} | coefficient | 0 °C < TJ < +50 °C | | - | - | T _{coeff_} vrefint + 50 | ррпі/ С |
| PSRR | Power supply | DC | | 40 | 60 | - | dB |
| 1 OIXIX | rejection | 100 kHz | | 25 | 40 | - | uБ |
| | | $CL = 0.5 \mu F^{(4)}$ | | - | 300 | 350 | |
| t _{START} | Start-up time | $CL = 1.1 \mu F^{(4)}$ | | - | 500 | 650 | μs |
| | | $CL = 1.5 \mu F^{(4)}$ | | - | 650 | 800 | |
| I _{INRUSH} | Control of maximum DC current drive on VREFBUF_ OUT during start-up phase (5) | - | - | - | 8 | - | mA |

Table 76. VREFBUF characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|---|----------------------------|-----|-----|-----|------|
| I _{DDA} (VREF | VREFBUF consumption from V _{DDA} | I _{load} = 0 μA | - | 16 | 25 | |
| | | I _{load} = 500 μA | - | 18 | 30 | μΑ |
| | | I _{load} = 4 mA | - | 35 | 50 | |

- 1. Guaranteed by design, unless otherwise specified.
- In degraded mode, the voltage reference buffer can not maintain accurately the output voltage which follows (V_{DDA} drop voltage).
- 3. Guaranteed by test in production.
- 4. The capacitive load must include a 100 nF capacitor in order to cut-off the high frequency noise.
- 5. To correctly control the VREFBUF inrush current during start-up phase and scaling change, the V_{DDA} voltage must be in the range [2.4 V to 3.6 V] and [2.8 V to 3.6 V] respectively for $V_{RS} = 0$ and $V_{RS} = 1$.



6.3.21 Comparator characteristics

Table 77. COMP characteristics⁽¹⁾

| Symbol | Parameter | Co | onditions | Min | Тур | Max | Unit |
|--------------------------------|--------------------------------|------------------------|--------------------------|------|---------------------|-----------|------|
| V _{DDA} | Analog supply voltage | | - | 1.62 | - | 3.6 | |
| V _{IN} | Comparator input voltage range | | - | 0 | - | V_{DDA} | V |
| V _{BG} ⁽²⁾ | Scaler input voltage | | - | | V _{REFINT} | - | |
| V _{SC} | Scaler offset voltage | | - | - | ±5 | ±10 | mV |
| I _{DDA} (SCALER) | Scaler static consumption | BRG_EN=0 (bi | ridge disable) | - | 200 | 300 | nA |
| IDDA(SCALER) | from V _{DDA} | BRG_EN=1 (bi | ridge enable) | - | 0.8 | 1 | μA |
| t _{START_SCALER} | Scaler startup time | - | | - | 100 | 200 | μs |
| | | High-speed | V _{DDA} ≥ 2.7 V | - | - | 5 | |
| | Comparator startup time to | mode | V _{DDA} < 2.7 V | - | - | 7 | μs |
| ^t START | reach propagation delay | Medium mode | V _{DDA} ≥ 2.7 V | - | - | 15 | |
| | specification | | V _{DDA} < 2.7 V | - | - | 25 | |
| | | Ultra-low-powe | r mode | - | - | 80 | |
| | | High-speed mode | V _{DDA} ≥ 2.7 V | - | 55 | 80 ns | 20 |
| | Propagation delay for | | V _{DDA} < 2.7 V | - | 65 | 100 | ns |
| t _D ⁽³⁾ | 200 mV step | Maraliana na ada | V _{DDA} ≥ 2.7 V | - | 0.55 | 0.9 | μs |
| | with 100 mV overdrive | Medium mode | V _{DDA} < 2.7 V | - | 0.65 | 1 | |
| | | Ultra-low-powe | r mode | - | 5 | 12 | |
| V _{offset} | Comparator offset error | Full common mode range | - | - | ±5 | ±20 | mV |
| | | No hysteresis | | - | 0 | - | |
| | 0 | Low hysteresis | Low hysteresis | | 8 | - | mV |
| V_{hys} | Comparator hysteresis | Medium hysteresis | | - | 15 | - | |
| | | High hysteresis | - | 27 | - | | |

| Symbol | Parameter | Co | onditions | Min | Тур | Max | Unit | | |
|-------------------------|--|--------------------------|---|-----|------|------|------|--|--|
| | | | Static | - | 400 | 600 | | | |
| I _{DDA} (COMP) | Comparator consumption from V _{DDA} | Ultra-low- power mode | With 50 kHz ±100 mV overdrive square signal | - | 1200 | - | nA | | |
| | | | Static | - | 5 | 7 | | | |
| | | Medium mode | With 50 kHz ±100 mV overdrive square signal | - | 6 | 1 | | | |
| | | | Static | - | 70 | 100 | μA | | |
| | | High-speed mode | With 50 kHz ±100 mV overdrive square signal | - | 75 | - | | | |
| I _{bias} | Comparator input bias current | | - | - | - | _(4) | nA | | |

Table 77. COMP characteristics⁽¹⁾ (continued)

6.3.22 Operational amplifiers characteristics

Table 78. OPAMP characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
|------------------------------|--|-----------------------------|-----|-----|------------------|-------|--|
| V _{DDA} | Analog supply voltage | - | 1.8 | - | 3.6 | V | |
| CMIR | Common mode input range | - | 0 | - | V _{DDA} | V | |
| VI | Input offset | t 25 °C, No Load on output. | | - | ±1.5 | mV | |
| VI _{OFFSET} | voltage | All voltage/Temp. | - | - | ±3 | IIIV | |
| A\/I | Input offset | Normal mode | | ±5 | - | μV/°C | |
| ΔVI _{OFFSET} | voltage drift | Low-power mode | - | ±10 | - | μν/ Ο | |
| TRIMOFFSETP TRIMLPOFFSETP | Offset trim step at low common input voltage (0.1 x V _{DDA}) | - | - | 0.8 | 1.1 | mV | |
| TRIMOFFSETN TRIMLPOFFSETN | Offset trim step at high common input voltage (0.9 x V _{DDA}) | - | - | 1 | 1.35 | IIIV | |

^{1.} Guaranteed by design, unless otherwise specified.

^{2.} Refer to Table 24: Embedded internal voltage reference.

^{3.} Guaranteed by characterization results.

^{4.} Mostly I/O leakage when used in analog mode. Refer to I_{lkg} parameter in Table 62: I/O static characteristics.

Table 78. OPAMP characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Con | ditions | Min | Тур | Max | Unit |
|-----------------------------------|---|----------------|---|---------------------------|------|------|--------|
| | Duite accument | Normal mode | V > 2 V | - | - | 500 | |
| I _{LOAD} | Drive current | Low-power mode | - V _{DDA} ≥ 2 V | - | - | 100 | |
| | Drive current in | Normal mode | V > 2 V | - | - | 450 | μA |
| I _{LOAD_PGA} | PGA mode | Low-power mode | V _{DDA} ≥ 2 V | - | - | 50 | |
| P | Resistive load (connected to | Normal mode | - V _{DDA} < 2 V | 4 | ı | ı | |
| R _{LOAD} | VSSA or to VDDA) | Low-power mode | T VDDA NZ V | 20 | - | - | kΩ |
| D | Resistive load in PGA mode | Normal mode | V | 4.5 | - | - | K77 |
| R _{LOAD_PGA} | (connected to VSSA or to V _{DDA}) | Low-power mode | - V _{DDA} < 2 V | 40 | - | - | |
| C _{LOAD} | Capacitive load | | - | - | - | 50 | pF |
| CMRR | Common mode | Normal mode | | - | -85 | - | dB |
| CIVILLY | rejection ratio | Low-power mode | | - | -90 | - | uБ |
| Debb | Power supply rejection ratio | Normal mode | $C_{LOAD} \le 50 \text{ pf},$ $R_{LOAD} \ge 4 \text{ k}\Omega \text{ DC}$ | 70 | 85 | - | dB |
| PSRR | | Low-power mode | $C_{LOAD} \le 50 \text{ pf},$ $R_{LOAD} \ge 20 \text{ k}\Omega \text{ DC}$ | 72 | 90 | - | |
| | | Normal mode | $V_{DDA} \ge 2.4 \text{ V}$ $(OPA_RANGE = 1)$ $V_{DDA} < 2.4 \text{ V}$ | 550 | 1600 | 2200 | - kHz |
| GBW | Gain Bandwidth Product | Low-power mode | | 100 | 420 | 600 | |
| OBW | | Normal mode | | 250 | 700 | 950 | |
| | | Low-power mode | (OPA_RANGE = 0) | 40 | 180 | 280 | |
| | Slew rate | Normal mode | - V _{DDA} ≥ 2.4 V | - | 700 | ı | |
| SR ⁽²⁾ | (from 10 and | Low-power mode | VDDA = 2.4 V | - | 180 | - | V/ms |
| OIX * | 90% of output voltage) | Normal mode | - V _{DDA} < 2.4 V | - | 300 | - | V/IIIO |
| | voltago) | Low-power mode | VDDA 12.4 V | - | 80 | - | |
| AO | Open loop gain | Normal mode | | 55 | 110 | - | dB |
| 7.0 | Open loop gain | Low-power mode | | 45 | 110 | - | ub |
| V _{OHSAT} ⁽²⁾ | High saturation | Normal mode | I _{load} = max or R _{load} = | V _{DDA} - 100 | - | - | |
| VOHSAT | voltage | Low-power mode | min Input at V _{DDA} . | V _{DDA} - 50 | - | - | mV |
| V _{OLSAT} ⁽²⁾ | Low saturation | Normal mode | I _{load} = max or R _{load} = | - | ı | 100 | |
| VOLSAT` ′ | voltage | Low-power mode | min Input at 0. | - | - | 50 | |
| <u> </u> | Phase margin | Normal mode | | - | 74 | - | 0 |
| Φ_{m} | i nase maryin | Low-power mode | | - | 66 | - | |

Table 78. OPAMP characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Con | ditions | Min | Тур | Max | Unit | |
|-------------------------|--|------------------------------------|--|-----|------------|-----|-------|--|
| 014 | | Normal mode | | - | 13 | - | in. | |
| GM | Gain margin | Low-power mode | | - | 20 | - | dB | |
| | Wake up time | Normal mode | $C_{LOAD} \le 50 \text{ pf},$ $R_{LOAD} \ge 4 \text{ k}\Omega$ follower configuration | - | 5 | 10 | | |
| ^t WAKEUP | from OFF state. | Low-power mode | $C_{LOAD} \le 50 \text{ pf},$ $R_{LOAD} \ge 20 \text{ k}\Omega$ follower configuration | - | 10 | 30 | · µs | |
| | | General purpose in except UFBGA132 | put (all packages and UFBGA169 only) | - | - | (3) | | |
| | OPAMP input | | T _J ≤ 75 °C | - | - | 1 | | |
| l _{bias} | bias current | Dedicated input | T _J ≤ 85 °C | - | - | 3 | nA | |
| | | (UFBGA132 and UFBGA169 only) | T _J ≤ 105 °C | - | - | 8 | | |
| | | | T _J ≤ 125 °C | - | - | 15 | | |
| | | | | - | 2 | - | | |
| PGA gain ⁽²⁾ | Non inverting | | | - | 4 | - | | |
| | gain value | | - | - | 8 | - | | |
| | | | | - | 16 | - | | |
| | | PGA Gain = 2 | | - | 80/80 | - | kΩ/kΩ | |
| | R2/R1 internal | PGA Gain = 4 | | - | 120/ 40 | - | | |
| R _{network} | resistance values in PGA mode ⁽⁴⁾ | PGA Gain = 8 | | - | 140/ 20 | - | | |
| | | PGA Gain = 16 | PGA Gain = 16 | | 150/ 10 | - | | |
| Delta R | Resistance variation (R1 or R2) | | - | -15 | - | 15 | % | |
| PGA gain error | PGA gain error | | - | -1 | - | 1 | % | |
| | | Gain = 2 | - | - | GBW/ 2 | - | | |
| DCA DVA | PGA bandwidth for different non inverting gain Gain = 4 Gain = 8 | Gain = 4 | - | - | GBW/ | - | | |
| L GA BM | | | | - | GBW/ | - | MHz | |
| | | Gain = 16 | - | - | GBW/ 16 | - | | |

Table 78. OPAMP characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Con | ditions | Min | Тур | Max | Unit | |
|---|--------------------------------------|----------------|---|-----|-----|-----------|--------|--|
| | Voltage noise density | Normal mode | at 1 kHz, Output loaded with 4 kΩ | - | 500 | - | | |
| en | | Low-power mode | at 1 kHz, Output loaded with 20 kΩ | - | 600 | - | nV/√Hz | |
| | | Normal mode | mode at 10 kHz, Output loaded with 4 kΩ - 180 | | - | 110/ 1112 | | |
| | | Low-power mode | at 10 kHz, Output loaded with 20 kΩ | - | 290 | - | | |
| I _{DDA} (OPAMP) ⁽²⁾ | OPAMP | Normal mode | no Load, quiescent | - | 120 | 260 | ^ | |
| | consumption from V _{DDA} | Low-power mode | mode | - | 45 | 100 | μΑ | |

- 1. Guaranteed by design, unless otherwise specified.
- 2. Guaranteed by characterization results.
- 3. Mostly I/O leakage, when used in analog mode. Refer to I_{lkg} parameter in Table 62: I/O static characteristics.
- 4. R2 is the internal resistance between OPAMP output and OPAMP inverting input. R1 is the internal resistance between OPAMP inverting input and ground. The PGA gain =1+R2/R1

6.3.23 Temperature sensor characteristics

Table 79. TS characteristics

| Symbol | Parameter | Min | Тур | Max | Unit |
|--|---|-------|------|-------|-------|
| T _L ⁽¹⁾ | V _{TS} linearity with temperature | - | ±1 | ±2 | °C |
| Avg_Slope ⁽²⁾ | Average slope | 2.3 | 2.5 | 2.7 | mV/°C |
| V ₃₀ | Voltage at 30°C (±5 °C) ⁽³⁾ | 0.742 | 0.76 | 0.785 | V |
| t _{START} (TS_BUF) ⁽¹⁾ | Sensor Buffer Start-up time in continuous mode ⁽⁴⁾ | - | 8 | 15 | μs |
| t _{START} ⁽¹⁾ | Start-up time when entering in continuous mode ⁽⁴⁾ | | 70 | 120 | μs |
| t _{S_temp} ⁽¹⁾ | ADC sampling time when reading the temperature | 5 | - | - | μs |
| I _{DD} (TS) ⁽¹⁾ | Temperature sensor consumption from V_{DD} , when selected by ADC | - | 4.7 | 7 | μΑ |

^{1.} Guaranteed by design.

6.3.24 V_{BAT} monitoring characteristics

Table 80. V_{BAT} monitoring characteristics⁽¹⁾

| Symbol | Parameter | Min | Тур | Max | Unit |
|------------------------------------|---|-----|-----|-----|------|
| R | Resistor bridge for V _{BAT} | - | 39 | - | kΩ |
| Q | Ratio on V _{BAT} measurement | - | 3 | - | - |
| Er ⁽²⁾ | Error on Q | -10 | - | 10 | % |
| t _{S_vbat} ⁽²⁾ | ADC sampling time when reading the VBAT | 12 | - | - | μs |

^{1. 1.55} V < VBAT < 3.6 V

Table 81. V_{BAT} charging characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
|-----------------|----------------------|------------|-----|-----|-----|------|--|
| R _{BC} | Battery | VBRS = 0 | - | 5 | - | kΩ | |
| | charging resistor | VBRS = 1 | - | 1.5 | - | | |



^{2.} Guaranteed by characterization results.

^{3.} Measured at V_{DDA} = 3.0 V ±10 mV. The V_{30} ADC conversion result is stored in the TS_CAL1 byte. Refer to Table 8: Temperature sensor calibration values.

Continuous mode means Run/Sleep modes, or temperature sensor enable in Low-power run/Low-power sleep modes.

^{2.} Guaranteed by design.

6.3.25 DFSDM characteristics

Unless otherwise specified, the parameters given in *Table 82* for DFSDM are derived from tests performed under the ambient temperature, f_{APB2} frequency and V_{DD} supply voltage conditions summarized in *Table 21: General operating conditions*.

- Output speed is set to OSPEEDRy[1:0] = 10
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics (DFSDM1_CKINy, DFSDM1_DATINy, DFSDM1_CKOUT for DFSDM).

Table 82. DFSDM characteristics⁽¹⁾

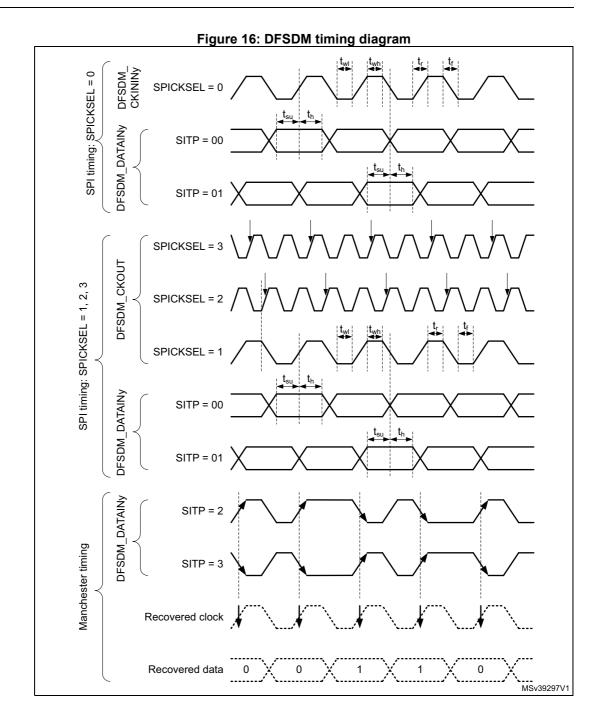
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---|---|--|----------------------|-----|---------------------|------|
| f _{DFSDMCLK} | DFSDM clock | 1.71 < V _{DD} < 3.6 V | - | - | f _{SYSCLK} | |
| f _{CKIN} Input clock (1/T _{CKIN}) frequency | | SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.71 < V _{DD} < 3.6 V | - | - | 20 | |
| | Input clock | SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 2.7 < V _{DD} < 3.6 V | ck mode [1:0]=0), | | 20 | |
| | irequency | SPI mode (SITP[1:0]=0,1), Internal clock mode (SPICKSEL[1:0]≠0), 1.71 < V _{DD} < 3.6 V | - | - | 20 | MHz |
| | | SPI mode (SITP[1:0]=0,1), Internal clock mode (SPICKSEL[1:0] \neq 0), 2.7 < V _{DD} < 3.6 V | - | - | 20 | |
| f _{CKOUT} | Output clock frequency | 1.71 < V _{DD} < 3.6 V | - | 20 | | |
| DuCy _{CKOUT} | Output clock frequency duty cycle | 1.71 < V _{DD} < 3.6 V | 45 | 50 | 55 | % |

Table 82. DFSDM characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|--|--|--------------------------------------|----------------------|---|------|
| t _{wh(CKIN)} t _{wl(CKIN)} | Input clock high and low time | SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.71 < V _{DD} < 3.6 V | TCKIN/2-0.5 | T _{CKIN} /2 | - | |
| t _{su} | Data input setup time | SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.71 < V _{DD} < 3.6 V | 2 | - | - | |
| t _h | Data input hold time | SPI mode (SITP[1:0]=0,1), External clock mode (SPICKSEL[1:0]=0), 1.71 < V _{DD} < 3.6 V | 0.5 | - | - | ns |
| T _{Manchester} | Manchester data period (recovered clock period) | Manchester mode (SITP[1:0]=2,3), Internal clock mode (SPICKSEL[1:0]≠0), 1.71 < V _{DD} < 3.6 V | (CKOUTDIV+1) * T _{DFSDMCLK} | - | (2*CKOUTDIV) * T _{DFSDMCLK} | |

^{1.} Guaranteed by characterization results.





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6.3.26 Timer characteristics

The parameters given in the following tables are guaranteed by design.

Refer to Section 6.3.14: I/O port characteristics for details on the input/output alternate function characteristics (output compare, input capture, external clock, PWM output).

Table 83. TIMx⁽¹⁾ characteristics

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-------------------------|--|--------------------------------|---------|-------------------------|----------------------|
| t _{res(TIM)} | Timer resolution time | - | 1 | - | t _{TIMxCLK} |
| | | f _{TIMxCLK} = 120 MHz | 8.33 | - | ns |
| f _{EXT} | Timer external clock frequency on CH1 to CH4 | - | 0 | f _{TIMxCLK} /2 | MHz |
| | | f _{TIMxCLK} = 120 MHz | 0 | 60 | MHz |
| Res _{TIM} | Timer resolution | TIMx (except TIM2 and TIM5) | - | 16 | bit |
| | | TIM2 and TIM5 | - | 32 | |
| tcounter | 16-bit counter clock period | - | 1 | 65536 | t _{TIMxCLK} |
| | | f _{TIMxCLK} = 120 MHz | 0.00833 | 546.13 | μs |
| t _{MAX_} COUNT | Maximum possible count with 32-bit counter | - | - | 65536 × 65536 | t _{TIMxCLK} |
| | | f _{TIMxCLK} = 120 MHz | - | 35.77 | S |

^{1.} TIMx is used as a general term in which x stands for 1,2,3,4,5,6,7,8,15,16 or 17.

Table 84. IWDG min/max timeout period at 32 kHz (LSI)⁽¹⁾

| Prescaler divider | PR[2:0] bits | Min timeout RL[11:0]= 0x000 | Max timeout RL[11:0]= 0xFFF | Unit |
|-------------------|--------------|--------------------------------|--------------------------------|------|
| /4 | 0 | 0.125 | 512 | |
| /8 | 1 | 0.250 | 1024 | |
| /16 | 2 | 0.500 | 2048 | |
| /32 | 3 | 1.0 | 4096 | ms |
| /64 | 4 | 2.0 | 8192 | |
| /128 | 5 | 4.0 | 16384 | |
| /256 | 6 or 7 | 8.0 | 32768 | |

^{1.} The exact timings still depend on the phasing of the APB interface clock versus the LSI clock so that there is always a full RC period of uncertainty.

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Table 85. WWDG min/max timeout value at 120 MHz (PCLK)

| Prescaler | WDGTB | Min timeout value | Max timeout value | Unit |
|-----------|-------|-------------------|-------------------|------|
| 1 | 0 | 0.0341 | 2.1845 | |
| 2 | 1 | 0.0683 | 4.3691 | ma |
| 4 | 2 | 0.1356 | 8.7381 | ms |
| 8 | 3 | 0.2731 | 17.4763 | |

6.3.27 Communication interfaces characteristics

I²C interface characteristics

The I2C interface meets the timings requirements of the I²C-bus specification and user manual rev. 03 for:

- Standard-mode (Sm): with a bit rate up to 100 kbit/s
- Fast-mode (Fm): with a bit rate up to 400 kbit/s
- Fast-mode Plus (Fm+): with a bit rate up to 1 Mbit/s.

The I2C timings requirements are guaranteed by design when the I2C peripheral is properly configured (refer to RM0432 reference manual).

The SDA and SCL I/O requirements are met with the following restrictions: the SDA and SCL I/O pins are not "true" open-drain. When configured as open-drain, the PMOS connected between the I/O pin and V_{DDIOx} is disabled, but is still present. Only FT_f I/O pins support Fm+ low level output current maximum requirement. Refer to Section 6.3.14: I/O port characteristics for the I2C I/Os characteristics.

All I2C SDA and SCL I/Os embed an analog filter. Refer to *Table 86* below for the analog filter characteristics:

Table 86. I2C analog filter characteristics⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|-----------------|--|-------------------|--------------------|------|
| t _{AF} | Maximum pulse width of spikes that are suppressed by the analog filter | 50 ⁽²⁾ | 260 ⁽³⁾ | ns |

- 1. Guaranteed by design.
- 2. Spikes with widths below $t_{AF(min)}$ are filtered.
- 3. Spikes with widths above $t_{AF(max)}$ are not filtered.

SPI characteristics

Unless otherwise specified, the parameters given in *Table 87* for SPI are derived from tests performed under the ambient temperature, f_{PCLKx} frequency and supply voltage conditions summarized in *Table 21: General operating conditions*.

- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO for SPI).

Table 87. SPI characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max ⁽²⁾ | Unit |
|--|-------------------------|--|----------------------------------|-------------------|----------------------|------|
| | | Master mode 2.7 V < V _{DD} < 3.6 V Voltage Range V1 | | | 60 | |
| | | Master mode 1.71 V < V _{DD} < 3.6 V Voltage Range V1 | | | 45 | |
| | | Master transmitter mode 1.71 V < V _{DD} < 3.6 V Voltage Range V1 | | | 60 | |
| f _{SCK} 1/t _{c(SCK)} | SPI clock frequency | Slave receiver mode 1.71 V < V _{DD} < 3.6 V Voltage Range V1 | | - | 60 | MHz |
| | | Slave mode transmitter/full duplex 2.7 V < V _{DD} < 3.6 V Voltage Range V1 | | | 32 | |
| | | Slave mode transmitter/full duplex 1.71 V < V _{DD} < 3.6 V Voltage Range V1 | | | 22 | |
| | | 1.71 V < V _{DD} < 3.6 V Voltage Range V2 | | | 13 | |
| | | 1.08 V < V _{DD} < 1.32 V ⁽³⁾ | | | 12 | |
| t _{su(NSS)} | NSS setup time | Slave mode, SPI prescaler = 2 | 4 _x T _{PCLK} | - | - | |
| t _{h(NSS)} | NSS hold time | Slave mode, SPI prescaler = 2 | 2 _x T _{PCLK} | - | - | |
| $\begin{matrix} t_{w(SCKH)} \\ t_{w(SCKL)} \end{matrix}$ | SCK high and low time | Master mode | T _{PCLK} -1 | T _{PCLK} | T _{PCLK} +1 | |
| t _{su(MI)} | Data input setup time | Master mode | 1.5 | - | - | ns |
| t _{su(SI)} | Data input sotup time | Slave mode | 2 | - | - | |
| t _{h(MI)} | Data input hold time | Master mode | 5.5 | - | - | |
| t _{h(SI)} | Data input noid time | Slave mode | 5 | - | - | |
| t _{a(SO)} | Data output access time | Slave mode | 9 | - | 34 | |



Table 87. SPI characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | Min | Тур | Max ⁽²⁾ | Unit |
|----------------------|---|---|-----|-----|--------------------|------|
| t _{dis(SO)} | Data output disable time | Slave mode | 9 | - | 16 | |
| | t _{v(SO)} Data output valid time | Slave mode 2.7 V < V _{DD} < 3.6 V Voltage Range V1 | - | 13 | 15.5 | |
| | | Slave mode 1.71 V < V _{DD} < 3.6 V Voltage Range V1 | - | 11 | 23 | |
| [[] v(SO) | | Slave mode 1.71 V < V _{DD} < 3.6 V Voltage Range V2 | - | 13 | 22 | |
| | | Slave mode ⁽³⁾ 1.08 V < V _{DD} < 1.32 V | - | 27 | 30 | ns |
| t _{v(MO)} | | Master mode | - | 2 | 4 | |
| | | Slave mode 1.71 V < V _{DD} < 3.6 V | 9 | - | - | |
| t _{h(SO)} | Data output hold time | Slave mode ⁽³⁾ 1.08 < V _{DD} < 1.32 V | 24 | - | - | |
| t _{h(MO)} | | Master mode | 1 | - | - | |

- 1. Guaranteed by characterization results.
- The maximum frequency in Slave transmitter mode is determined by the sum of tv(SO) and tsu(MI) which has to fit into SCK low or high-phase preceding the SCK sampling edge. This value can be achieved when the SPI communicates with a master having tsu(MI) = 0 while Duty(SCK) = 50%.
- 3. SPI mapped on GPIOG port which is supplied by VDDIO2 specified down to 1.08V. SPI is tested in this voltage.

NSS input ·t_{c(SCK)}· $t_{\mathsf{h}(\mathsf{NSS})}$ ·t_{su(NSS)}-► −tw(SCKH)
→ <-t_{r(SCK)}-CPHA=0 SCK input CPOL=0 CPHA=0 CPOL=1 -t_{w(SCKL)}- $\vdash t_{f(SCK)}$ t_{dis(SO)} MISO output First bit OUT Next bits OUT Last bit OUT $\mathsf{t}_{\mathsf{h}(\mathsf{SI})}$ MOSI input First bit IN Next bits IN Last bit IN MSv41658V1

Figure 33. SPI timing diagram - slave mode and CPHA = 0

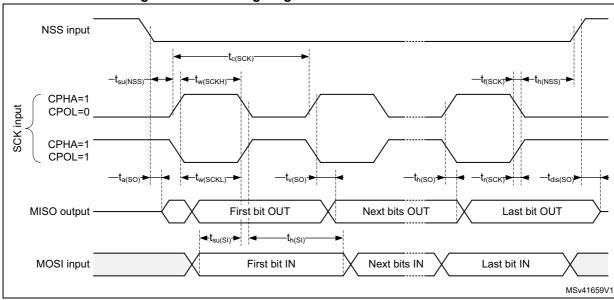


Figure 34. SPI timing diagram - slave mode and CPHA = 1

1. Measurement points are done at CMOS levels: 0.3 $\rm V_{DD}$ and 0.7 $\rm V_{DD}$.

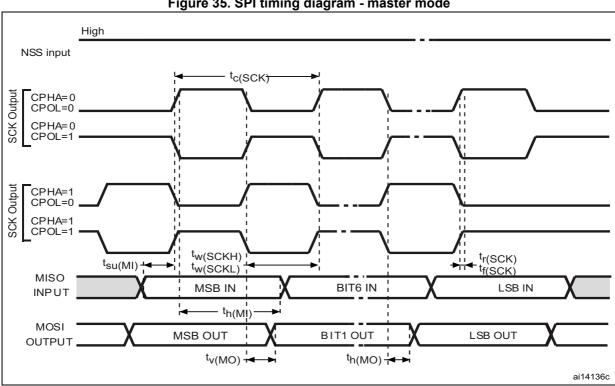


Figure 35. SPI timing diagram - master mode

1. Measurement points are done at CMOS levels: 0.3 $\rm V_{DD}$ and 0.7 $\rm V_{DD}$

SAI characteristics

Unless otherwise specified, the parameters given in *Table 88* for SAI are derived from tests performed under the ambient temperature, f_{PCLKx} frequency and V_{DD} supply voltage conditions summarized in *Table 21: General operating conditions*, with the following configuration:

- Output speed is set to OSPEEDRy[1:0] = 10
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics (CK,SD,FS).

Table 88. SAI characteristics⁽¹⁾

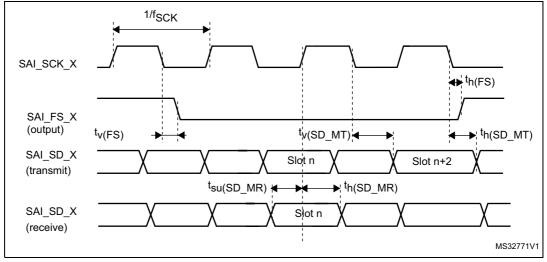
| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------------|------------------------------------|---|-----|-----|------|
| f _{MCLK} | SAI Main clock output | - | ı | 50 | |
| | | Master transmitter 2.7 ≤ V _{DD} ≤ 3.6 Voltage Range V1 | - | 30 | |
| | | Master transmitter $1.71 \le V_{DD} \le 3.6$ Voltage Range V1 | - | 20 | |
| | | Master receiver Voltage Range V1 | - | 15 | |
| f _{CK} | SAI clock frequency ⁽²⁾ | Slave transmitter 2.7 ≤ V _{DD} ≤ 3.6 Voltage Range V1 | - | 38 | MHz |
| | | Slave transmitter 1.71 ≤ V _{DD} ≤ 3.6 Voltage Range V1 | - | 26 | - |
| | | Slave receiver Voltage Range V1 | - | 50 | |
| | | Voltage Range V2 | - | 13 | |
| | | 1.08V <vdd< 1.32v<="" td=""><td>-</td><td>8</td><td></td></vdd<> | - | 8 | |
| | FS valid time | Master mode 2.7 ≤ V _{DD} ≤ 3.6 | - | 15 | |
| t _{v(FS)} | ro valid tillle | Master mode 1.71 ≤ V _{DD} ≤ 3.6 | - | 22 | |
| t _{h(FS)} | FS hold time | Master mode | 22 | - | |
| t _{su(FS)} | FS setup time | Slave mode | 2.5 | - | ns |
| t _{h(FS)} | FS hold time | Slave mode | 1 | ı | |
| t _{su(SD_A_MR)} | Data input setup time | Master receiver | 3 | - | |
| t _{su(SD_B_SR)} | Data Iliput Setup tillie | Slave receiver | 1 | - | |
| t _{h(SD_A_MR)} | Data input hold time | Master receiver | 3.5 | ı | |
| t _{h(SD_B_SR)} | Data input noid time | Slave receiver | 1.5 | • | |

Table 88. SAI characteristics⁽¹⁾ (continued)

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------------|------------------------|--|-----|------|------|
| | | Slave transmitter (after enable edge) 2.7 ≤ V _{DD} ≤ 3.6 | - | 13 | |
| | | Slave transmitter (after enable edge) 1.71 ≤ V _{DD} ≤ 3.6 | - | 19 | |
| t _v (SD_B_ST) | Data output valid time | Slave transmitter (after enable edge) 1.08V <vdd< 1.32v<="" td=""><td>-</td><td>52</td><td></td></vdd<> | - | 52 | |
| | | Slave transmitter Voltage Range V2 | - | 23.5 | |
| t _{h(SD_B_ST)} | Data output hold time | Slave transmitter (after enable edge) | 10 | - | ns |
| | Data output valid time | Master transmitter (after enable edge) $2.7 \le V_{DD} \le 3.6$ | - | 16.5 | |
| t _{v(SD_A_MT)} | | Master transmitter (after enable edge) 1.71 ≤ V _{DD} ≤ 3.6 | - | 24 | |
| | | Master transmitter (after enable edge) 1.08V <vdd< 1.32v<="" td=""><td>-</td><td>58</td><td></td></vdd<> | - | 58 | |
| t _{h(SD_A_MT)} | Data output hold time | Master transmitter (after enable edge) | 10 | - | |

- 1. Guaranteed by characterization results.
- 2. APB clock frequency must be at least twice SAI clock frequency.

Figure 36. SAI master timing waveforms



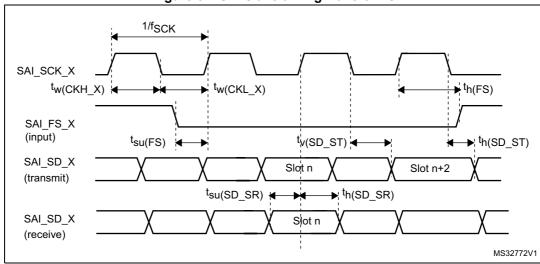


Figure 37. SAI slave timing waveforms

USB OTG full speed (FS) characteristics

The device's USB interface is fully compliant with the USB specification version 2.0 and is USB-IF certified (for Full-speed device operation).

| Table 69. USB electrical characteristics | | | | | | | |
|--|--|---|--------------------|------|--------------------|------|--|
| Symbol | Parameter | Conditions | Min ⁽¹⁾ | Тур | Max ⁽¹⁾ | Unit | |
| V _{DDUSB} | USB OTG full speed transceiver operating voltage | - | 3.0 ⁽²⁾ | - | 3.6 | | |
| V _{DI} ⁽³⁾ | Differential input sensitivity | Over VCM range | 0.2 | - | - | | |
| V _{CM} ⁽³⁾ | Differential input common mode range | Includes V _{DI} range | 0.8 | - | 2.5 | | |
| V _{SE} ⁽³⁾ | Single ended receiver input threshold | - | 0.8 | - | 2.0 | V | |
| V_{OL} | Static output level low | R_L of 1.5 kΩ to 3.6 $V^{(4)}$ | - | - | 0.3 | | |
| V_{OH} | Static output level high | R _L of 15 kΩ to 3.6 V ⁽⁴⁾ | 2.8 | - | 3.6 | | |
| R _{PD} ⁽³⁾ | Pull down resistor on PA11, PA12 (USB_FS_DP/DM) | $V_{IN} = V_{DD}$ | 14.25 | - | 24.8 | | |
| | Pull Up Resistor on PA12 (USB_FS_DP) | V _{IN} = V _{SS} during idle | 0.9 | 1.25 | 1.575 | kΩ | |
| R _{PU} ⁽³⁾ | Pull Up Resistor on PA12 (USB_FS_DP) | V _{IN} = V _{SS} during reception | 1.425 | 2.25 | 3.09 | K77 | |
| | Pull Up Resistor on PA10 (OTG_FS_ID) | - | - | - | 14.5 | | |

Table 89. USB electrical characteristics

^{1.} All the voltages are measured from the local ground potential.

- The STM32L4Q5xx USB OTG full speed transceiver functionality is ensured down to 2.7 V but not the full USB full speed electrical characteristics which are degraded in the 2.7-to-3.0 V V_{DD} voltage range.
- 3. Guaranteed by design.
- 4. R_L is the load connected on the USB OTG full speed drivers.

Note:

When VBUS sensing feature is enabled, PA9 should be left at its default state (floating input), not as alternate function. A typical 200 μ A current consumption of the sensing block (current to voltage conversion to determine the different sessions) can be observed on PA9 when the feature is enabled.

Figure 38. USB OTG timings - definition of data signal rise and fall time

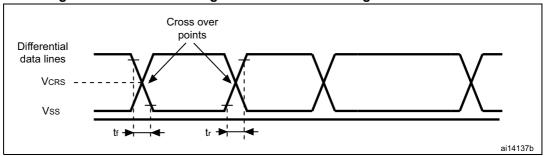


Table 90. USB OTG electrical characteristics⁽¹⁾

| Driver characteristics | | | | | | | |
|------------------------|---|---------------------------------|-----|-----|------|--|--|
| Symbol | Parameter | Conditions | Min | Max | Unit | | |
| t _{rLS} | Rise time in LS ⁽²⁾ | O 000 to 000 mF | | 300 | no | | |
| t _{fLS} | Fall time in LS ⁽²⁾ | C _L = 200 to 600 pF | 75 | 300 | ns | | |
| t _{rfmLS} | Rise/ fall time matching in LS | t _r / t _f | 80 | 125 | % | | |
| t _{rFS} | Rise time in FS ⁽²⁾ | C _L = 50 pF | 4 | 20 | ns | | |
| t _{fFS} | Fall time in FS ⁽²⁾ | C _L = 50 pF | 4 | 20 | 115 | | |
| t _{rfmFS} | Rise/ fall time matching in FS | t _r / t _f | 90 | 111 | % | | |
| V _{CRS} | Output signal crossover voltage (LS/FS) | - | 1.3 | 2.0 | V | | |
| Z _{DRV} | Output driver impedance ⁽³⁾ | Driving high or low | 28 | 44 | Ω | | |

- 1. Guaranteed by design
- Measured from 10% to 90% of the data signal. For more detailed informations, please refer to USB Specification - Chapter 7 (version 2.0).
- 3. No external termination series resistors are required on DP (D+) and DM (D-) pins since the matching impedance is included in the embedded driver.

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Driver characteristics Symbol Conditions Min Max Unit **Parameter** Тур Primary detection mode consumption 300 μΑ I_{DD(USBBCD)} Secondary detection mode consumption RDAT LKG Data line leakage resistance 300 kΩ VDAT_LKG ٧ Data line leakage voltage 0.0 3.6 Dedicated charging port RDCP DAT 200 Ω resistance across D+/D-VLGC_HI 3.6 ٧ Logic high 2.0 VLGC LOW 8.0 ٧ Logic low **VLGC** ٧ 2.0 Logic threshold 8.0 VDAT REF ٧ Data detect voltage 0.25 0.4 VDP SRC ٧ 0.5 0.7 D+ source voltage ٧ VDM_SRC D- source voltage 0.5 0.7 IDP SINK 25 D+ sink current 175 μΑ **IDM SINK** D- sink current 175 μΑ

Table 91. USB BCD DC electrical characteristics⁽¹⁾

CAN (controller area network) interface

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics (CAN_TX and CAN_RX).

6.3.28 FSMC characteristics

Unless otherwise specified, the parameters given in *Table 92* to *Table 105* for the FMC interface are derived from tests performed under the ambient temperature, f_{HCLK} frequency and V_{DD} supply voltage conditions summarized in *Table 21*, with the following configuration:

- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output characteristics.



^{1.} Guaranteed by design

Asynchronous waveforms and timings

Figure 39 through Figure 42 represent asynchronous waveforms and Table 92 through Table 99 provide the corresponding timings. The results shown in these tables are obtained with the following FMC configuration:

- AddressSetupTime(ADDSET) = 0x1
- AddressHoldTime(ADDHLD) = 0x1
- DataHoldTime(DATAHLD) = 0x1 (1THCLK for read operations and 2THCLK for write operations)
- ByteLaneSetup(NBLSET)=0x1
- DataSetupTime(DATAST) = 0x1 (except for asynchronous NWAIT mode, DataSetupTime = 0x5)
- BusTurnAroundDuration = 0x0

In all timing tables, the THCLK is the HCLK clock period.

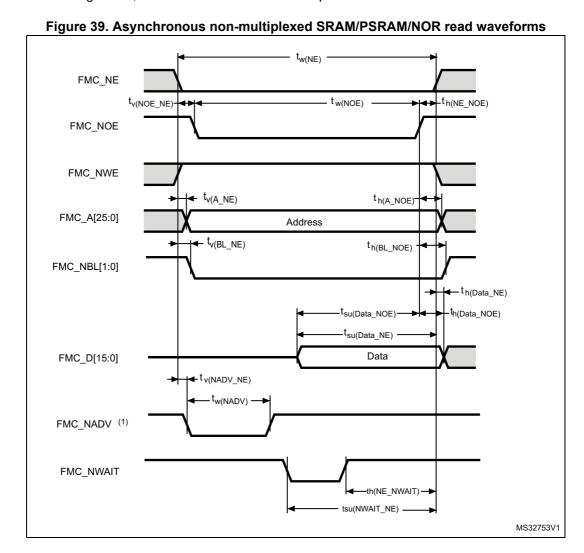


Table 92. Asynchronous non-multiplexed SRAM/PSRAM/NOR read timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|---------------------------------------|-------------------------|------------------------|------|
| t _{w(NE)} | FMC_NE low time | 3T _{HCLK} -0.5 | 3T _{HCLK} +1 | |
| t _{v(NOE_NE)} | FMC_NEx low to FMC_NOE low | 0 | 1 | |
| t _{w(NOE)} | FMC_NOE low time | 2T _{HCLK} -0.5 | 2T _{HCLK} +1 | |
| t _{h(NE_NOE)} | FMC_NOE high to FMC_NE high hold time | T _{HCLK} | - | |
| t _{v(A_NE)} | FMC_NEx low to FMC_A valid | - | 1 | |
| t _{h(A_NOE)} | Address hold time after FMC_NOE high | 2T _{HCLK} -1 | - | ns |
| t _{su(Data_NE)} | Data to FMC_NEx high setup time | T _{HCLK} +14 | - | 113 |
| t _{su(Data_NOE)} | Data to FMC_NOEx high setup time | 14 | - | |
| t _{h(Data_NOE)} | Data hold time after FMC_NOE high | 0 | - | |
| t _{h(Data_NE)} | Data hold time after FMC_NEx high | 0 | - | |
| t _{v(NADV_NE)} | FMC_NEx low to FMC_NADV low | - | 0 | |
| t _{w(NADV)} | FMC_NADV low time | - | T _{HCLK} +1.5 | |

^{1.} Guaranteed by characterization results.

Table 93. Asynchronous non-multiplexed SRAM/PSRAM/NOR read-NWAIT timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|---|--------------------------|-------------------------|------|
| t _{w(NE)} | FMC_NE low time | 8T _{HCLK} -0.5 | 8T _{HCLK} +1 | |
| t _{w(NOE)} | FMC_NWE low time | 7T _{HCLK} -0.5 | 7T _{HCLK} +0.5 | |
| t _{w(NWAIT)} | FMC_NWAIT low time | T _{HCLK} | - | ns |
| t _{su(NWAIT_NE)} | FMC_NWAIT valid before FMC_NEx high | 5T _{HCLK} +12.5 | - | |
| t _{h(NE_NWAIT)} | FMC_NEx hold time after FMC_NWAIT invalid | 4T _{HCLK} +12 | - | |

^{1.} Guaranteed by characterization results.

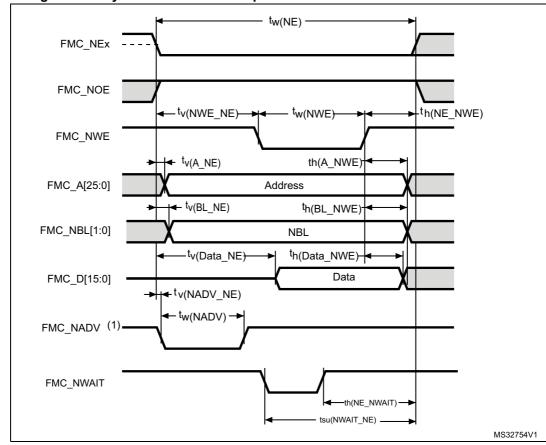


Figure 40. Asynchronous non-multiplexed SRAM/PSRAM/NOR write waveforms

Table 94. Asynchronous non-multiplexed SRAM/PSRAM/NOR write timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|--------------------------|---------------------------------------|-------------------------|------------------------|------|
| t _{w(NE)} | FMC_NE low time | 4T _{HCLK} -0.5 | 4T _{HCLK} +1 | |
| t _{v(NWE_NE)} | FMC_NEx low to FMC_NWE low | T _{HCLK} -0.5 | T _{HCLK} +1 | |
| t _{w(NWE)} | FMC_NWE low time | T _{HCLK} -0.5 | T _{HCLK} +1 | |
| t _{h(NE_NWE)} | FMC_NWE high to FMC_NE high hold time | 2T _{HCLK} -0.5 | - | |
| t _{v(A_NE)} | FMC_NEx low to FMC_A valid | - | 0 | |
| t _{h(A_NWE)} | Address hold time after FMC_NWE high | 2T _{HCLK} -1 | - | ns |
| t _{v(BL_NE)} | FMC_NEx low to FMC_BL valid | - | T _{HCLK} | 115 |
| t _{h(BL_NWE)} | FMC_BL hold time after FMC_NWE high | 2T _{HCLK} -0.5 | - | |
| t _{v(Data_NE)} | Data to FMC_NEx low to Data valid | - | T _{HCLK} +3 | |
| t _{h(Data_NWE)} | Data hold time after FMC_NWE high | 2T _{HCLK} +1 | - | |
| t _{v(NADV_NE)} | FMC_NEx low to FMC_NADV low | - | 1 | |
| t _{w(NADV)} | FMC_NADV low time | - | T _{HCLK} +1.5 | |

^{1.} Guaranteed by characterization results.



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Table 95. Asynchronous non-multiplexed SRAM/PSRAM/NOR write-NWAIT timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|---|-------------------------|-------------------------|------|
| t _{w(NE)} | FMC_NE low time | 9T _{HCLK} -0.5 | 9T _{HCLK} +1.5 | |
| t _{w(NWE)} | FMC_NWE low time | 6T _{HCLK} -0.5 | 6T _{HCLK} +1 | no |
| t _{su(NWAIT_NE)} | FMC_NWAIT valid before FMC_NEx high | 7T _{HCLK} -13 | - | ns |
| t _{h(NE_NWAIT)} | FMC_NEx hold time after FMC_NWAIT invalid | 5T _{HCLK} +13 | - | |

^{1.} Guaranteed by characterization results.

Figure 41. Asynchronous multiplexed PSRAM/NOR read waveforms

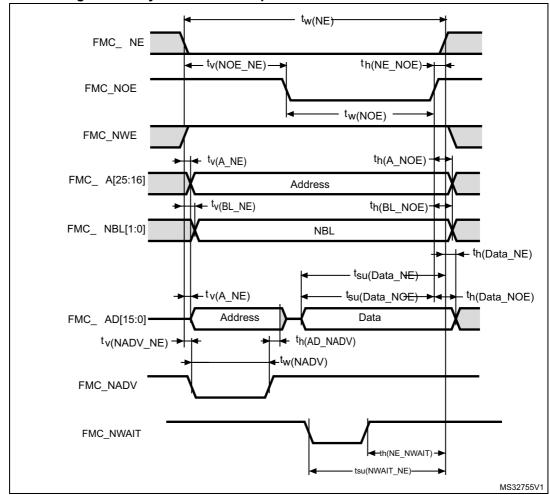


Table 96. Asynchronous multiplexed PSRAM/NOR read timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|---|---|------------------------|------|
| t _{w(NE)} | FMC_NE low time | 4T _{HCLK} -0.5 | 4T _{HCLK} +1 | |
| t _{v(NOE_NE)} | FMC_NEx low to FMC_NOE low | 2T _{HCLK} -0.5 | 2T _{HCLK} +1 | |
| t _{w(NOE)} | FMC_NOE low time | T _{HCLK} -0.5 | T _{HCLK} +0.5 | |
| t _{h(NE_NOE)} | FMC_NOE high to FMC_NE high hold time | T _{HCLK} -1 | - | |
| t _{v(A_NE)} | FMC_NEx low to FMC_A valid | - | 3 | |
| t _{v(NADV_NE)} | FMC_NEx low to FMC_NADV low | 0.5 | 1.5 | |
| t _{w(NADV)} | FMC_NADV low time | T _{HCLK} | T _{HCLK} +1.5 | |
| t _{h(AD_NADV)} | FMC_AD(address) valid hold time after FMC_NADV high | T _{HCLK} -3 | - | ns |
| t _{h(A_NOE)} | Address hold time after FMC_NOE high | Address holded until next read operation | - | |
| t _{su(Data_NE)} | Data to FMC_NEx high setup time | T _{HCLK} +14 | ı | |
| t _{su(Data_NOE)} | Data to FMC_NOE high setup time | 14 | - | |
| t _{h(Data_NE)} | Data hold time after FMC_NEx high | 0 | - | |
| t _{h(Data_NOE)} | Data hold time after FMC_NOE high | 0 | - | |

^{1.} Guaranteed by characterization results.

Table 97. Asynchronous multiplexed PSRAM/NOR read-NWAIT timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|---|-------------------------|------------------------|------|
| t _{w(NE)} | FMC_NE low time | 8T _{HCLK} -0.5 | 9T _{HCLK} + 1 | |
| t _{w(NOE)} | FMC_NOE low time | 5T _{HCLK} -0.5 | 6T _{HCLK} +1 | ns |
| t _{su(NWAIT_NE)} | FMC_NWAIT valid before FMC_NEx high | 5T _{HCLK} +12 | - | 113 |
| t _{h(NE_NWAIT)} | FMC_NEx hold time after FMC_NWAIT invalid | 4T _{HCLK} +11 | - | |

^{1.} Guaranteed by characterization results.

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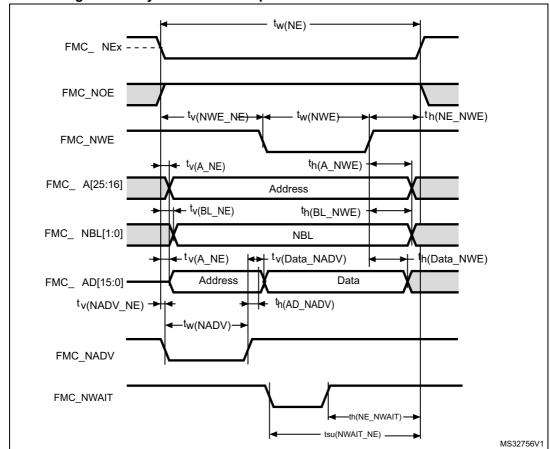


Figure 42. Asynchronous multiplexed PSRAM/NOR write waveforms



| Symbol | Parameter | Min | Max | Unit |
|---------------------------|--|--|-------------------------|------|
| t _{w(NE)} | FMC_NE low time | 5T _{HCLK} -0.5 | 5T _{HCLK} +1 | |
| t _{v(NWE_NE)} | FMC_NEx low to FMC_NWE low | T _{HCLK} -0.5 | T _{HCLK} +1 | |
| t _{w(NWE)} | FMC_NWE low time | 2T _{HCLK} -0.5 | 2T _{HCLK} +0.5 | |
| t _{h(NE_NWE)} | FMC_NWE high to FMC_NE high hold time | 2T _{HCLK} -0.5 | - | |
| t _{v(A_NE)} | FMC_NEx low to FMC_A valid | - | 3 | |
| t _{v(NADV_NE)} | FMC_NEx low to FMC_NADV low | 0 | 1 | |
| t _{w(NADV)} | FMC_NADV low time | T _{HCLK} +0.5 | T _{HCLK} +1.5 | |
| t _{h(AD_NADV)} | FMC_AD(adress) valid hold time after FMC_NADV high | T _{HCLK} -3 | - | ns |
| t _{h(A_NWE)} | Address hold time after FMC_NWE high | Address holded until next write operation | - | |
| t _{h(BL_NWE)} | FMC_BL hold time after FMC_NWE high | 2T _{HCLK} -0.5 | - | |
| t _{v(BL_NE)} | FMC_NEx low to FMC_BL valid | - | T _{HCLK} | |
| t _{v(Data_NADV)} | FMC_NADV high to Data valid | - | T _{HCLK} +2 | |
| t _{h(Data_NWE)} | Data hold time after FMC_NWE high | 2T _{HCLK} +0.5 | - | |

Table 98. Asynchronous multiplexed PSRAM/NOR write timings⁽¹⁾

Table 99. Asynchronous multiplexed PSRAM/NOR write-NWAIT timings⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|---------------------------|--|--------------------------|-------------------------|------|
| t _{w(NE)} | FMC_NE low time | 10T _{HCLK} -0.5 | 10T _{HCLK} +1 | |
| t _{w(NWE)} | FMC_NWE low time 7T _{HCLK} -0.5 7T _{HCLK} +0 | | 7T _{HCLK} +0.5 | ns |
| t _{su(NWAIT_NE)} | FMC_NWAIT valid before FMC_NEx high | 7T _{HCLK} +12.5 | - | |
| t _{h(NE_NWAIT)} | FMC_NEx hold time after FMC_NWAIT invalid | 5T _{HCLK} +13 | - | |

^{1.} Guaranteed by characterization results.

Synchronous waveforms and timings

Figure 43 through Figure 46 represent synchronous waveforms and Table 100 through Table 103 provide the corresponding timings. The results shown in these tables are obtained with the following FMC configuration:

- BurstAccessMode = FMC_BurstAccessMode_Enable
- MemoryType = FMC_MemoryType_CRAM
- WriteBurst = FMC_WriteBurst_Enable
- CLKDivision = 1
- DataLatency = 1 for NOR Flash; DataLatency = 0 for PSRAM



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^{1.} Guaranteed by characterization results.

In all timing tables, the T_{HCLK} is the HCLK clock period.

• For 2.7 V \leq V_{DD} \leq 3.6 V, maximum FMC_CLK = 60 MHz for CLKDIV = 0x1 and 54 MHz for CLKDIV = 0x0 at CL = 30 pF (on FMC_CLK).

• For 1.71 V \leq V_{DD} \leq 2.7 V, maximum FMC_CLK = 60 MHz for CLKDIV = 0x1 and 32 MHz for CLKDIV = 0x0 at CL= 20 pF (on FMC_CLK).

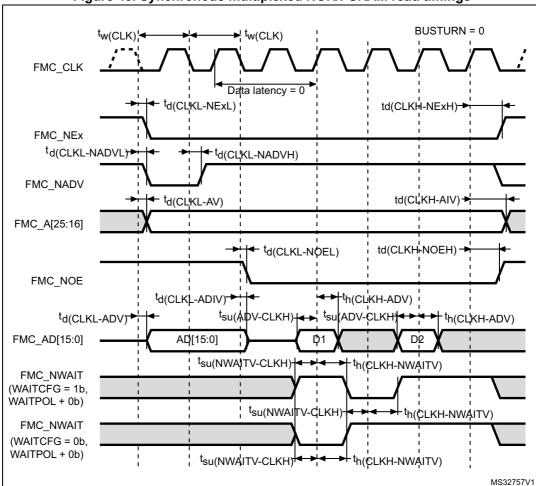


Figure 43. Synchronous multiplexed NOR/PSRAM read timings

Table 100. Synchronous multiplexed NOR/PSRAM read timings⁽¹⁾⁽²⁾

| Symbol | Parameter | Min | Max | Unit |
|-----------------------------|--|--|-----|------|
| t _{w(CLK)} | FMC_CLK period | RxT _{HCLK} -0.5 ⁽²⁾ | - | |
| t _{d(CLKL-NExL)} | FMC_CLK low to FMC_NEx low (x=02) | - | 2.5 | |
| t _{d(CLKH_NExH)} | FMC_CLK high to FMC_NEx high (x= 02) | RxT _{HCLK} /2 +1 ⁽²⁾ | - | |
| t _{d(CLKL-NADVL)} | FMC_CLK low to FMC_NADV low | - | 2.5 | |
| t _{d(CLKL-NADVH)} | FMC_CLK low to FMC_NADV high | 2 | - | |
| t _{d(CLKL-AV)} | FMC_CLK low to FMC_Ax valid (x=1625) | - | 5.5 | |
| t _{d(CLKH-AIV)} | FMC_CLK high to FMC_Ax invalid (x=1625) | RxT _{HCLK} /2 +1 ⁽²⁾ | - | |
| t _{d(CLKL-NOEL)} | FMC_CLK low to FMC_NOE low | - | 2 | ns |
| t _{d(CLKH-NOEH)} | FMC_CLK high to FMC_NOE high | RxT _{HCLK} /2 +1 ⁽²⁾ | - | |
| t _{d(CLKL-ADV)} | FMC_CLK low to FMC_AD[15:0] valid | - | 3 | |
| t _{d(CLKL-ADIV)} | FMC_CLK low to FMC_AD[15:0] invalid | 0 | - | |
| t _{su(ADV-CLKH)} | FMC_A/D[15:0] valid data before FMC_CLK high | 2 | - | |
| t _{h(CLKH-ADV)} | FMC_A/D[15:0] valid data after FMC_CLK high | 4 | - | |
| t _{su(NWAIT-CLKH)} | FMC_NWAIT valid before FMC_CLK high | 1.5 | - | |
| t _{h(CLKH-NWAIT)} | FMC_NWAIT valid after FMC_CLK high | 4 | - | |

^{1.} Guaranteed by characterization results.

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^{2.} Clock ratio R = (HCLK period /FMC_CLK period).

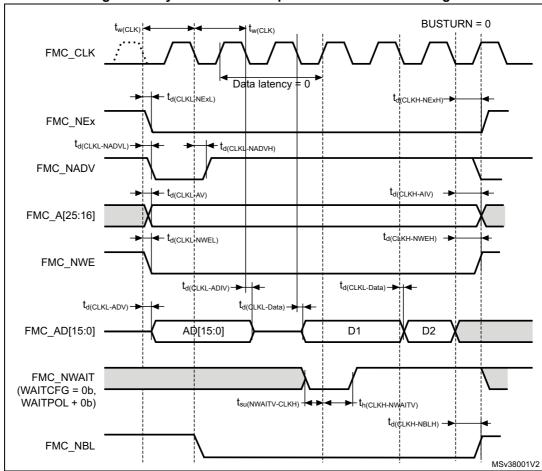


Figure 44. Synchronous multiplexed PSRAM write timings



Table 101. Synchronous multiplexed PSRAM write timings⁽¹⁾⁽²⁾

| Symbol | Parameter | Min | Max | Unit |
|-----------------------------|--|--|-----|------|
| t _{w(CLK)} | FMC_CLK period,VDD range= 2.7 to 3.6 V | RxT _{HCLK} - 0.5 ⁽²⁾ | - | |
| t _{d(CLKL-NExL)} | FMC_CLK low to FMC_NEx low (x=02) | - | 2.5 | |
| t _{d(CLKH-NExH)} | FMC_CLK high to FMC_NEx high (x= 02) | RxT _{HCLK} /2 +1 ⁽²⁾ | - | |
| t _{d(CLKL-NADVL)} | FMC_CLK low to FMC_NADV low | - | 2.5 | |
| t _{d(CLKL-NADVH)} | FMC_CLK low to FMC_NADV high | 2 | - | |
| t _{d(CLKL-AV)} | FMC_CLK low to FMC_Ax valid (x=1625) | - | 5.5 | |
| t _{d(CLKH-AIV)} | FMC_CLK high to FMC_Ax invalid (x=1625) RxT _{HCLK} /2 +1 ⁽²⁾ | | - | |
| t _{d(CLKL-NWEL)} | FMC_CLK low to FMC_NWE low | - | 2 | ns |
| t _{d(CLKH-NWEH)} | FMC_CLK high to FMC_NWE high | RxT _{HCLK} /2 +1 ⁽²⁾ | - | 115 |
| t _{d(CLKL-ADV)} | FMC_CLK low to FMC_AD[15:0] valid | - | 3 | |
| t _{d(CLKL-ADIV)} | FMC_CLK low to FMC_AD[15:0] invalid | 0 | - | |
| t _{d(CLKL-DATA)} | FMC_A/D[15:0] valid data after FMC_CLK low | - | 3.5 | |
| t _{d(CLKL-NBLL)} | FMC_CLK low to FMC_NBL low | 1 | - | |
| t _{d(CLKH-NBLH)} | FMC_CLK high to FMC_NBL high | RxT _{HCLK} /2 +1.5 ⁽²⁾ | - | |
| t _{su(NWAIT-CLKH)} | FMC_NWAIT valid before FMC_CLK high | 1.5 | - | |
| t _{h(CLKH-NWAIT)} | FMC_NWAIT valid after FMC_CLK high | 4 | - | |

^{1.} Guaranteed by characterization results.

^{2.} Clock ratio R = (HCLK period /FMC_CLK period).

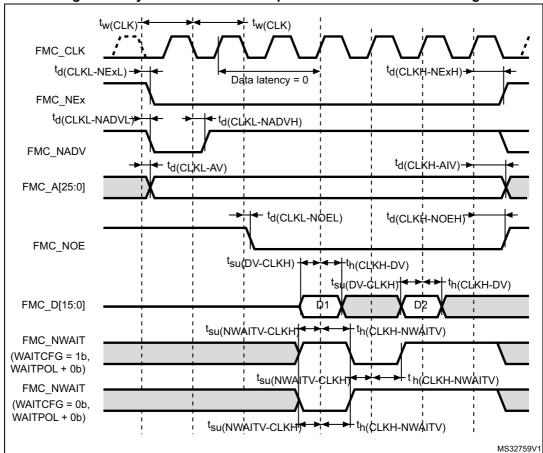


Figure 45. Synchronous non-multiplexed NOR/PSRAM read timings

Table 102. Synchronous non-multiplexed NOR/PSRAM read timings⁽¹⁾⁽²⁾

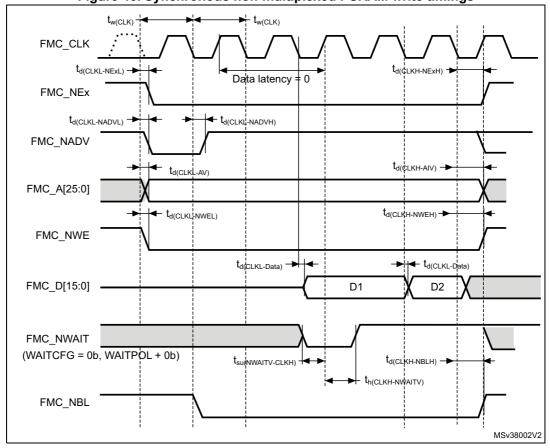
| Symbol | Parameter | Min | Max | Unit |
|----------------------------|--|--|-----|------|
| t _{w(CLK)} | FMC_CLK period | RxT _{HCLK} -0.5 ⁽²⁾ | - | |
| t _{d(CLKL-NExL)} | FMC_CLK low to FMC_NEx low (x=02) | - | 2.5 | |
| t _{d(CLKH-NExH)} | FMC_CLK high to FMC_NEx high (x= 02) | RxT _{HCLK} /2 +1 ⁽²⁾ | ı | |
| t _{d(CLKL-NADVL)} | FMC_CLK low to FMC_NADV low | - | 2.5 | |
| t _{d(CLKL-NADVH)} | FMC_CLK low to FMC_NADV high | 2 | ı | |
| t _{d(CLKL-AV)} | FMC_CLK low to FMC_Ax valid (x=1625) | - | 5.5 | ns |
| t _{d(CLKH-AIV)} | FMC_CLK high to FMC_Ax invalid (x=1625) | $RxT_{HCLK}/2 + 0.5^{(2)}$ | ı | |
| t _{d(CLKL-NOEL)} | FMC_CLK low to FMC_NOE low | - | 2 | |
| t _{d(CLKH-NOEH)} | FMC_CLK high to FMC_NOE high | RxT _{HCLK} /2 +1 ⁽²⁾ | - | |
| t _{su(DV-CLKH)} | FMC_D[15:0] valid data before FMC_CLK high | 2 | 1 | |
| t _{h(CLKH-DV)} | FMC_D[15:0] valid data after FMC_CLK high | 4 | - | |

Table 102. Synchronous non-multiplexed NOR/PSRAM read timings⁽¹⁾⁽²⁾ (continued)

| Symbol | Parameter | Min | Max | Unit |
|-----------------------------|-------------------------------------|-----|-----|------|
| t _{su(NWAIT-CLKH)} | FMC_NWAIT valid before FMC_CLK high | 1.5 | - | ns |
| t _{h(CLKH-NWAIT)} | FMC_NWAIT valid after FMC_CLK high | 4 | - | 113 |

- 1. Guaranteed by characterization results.
- 2. Clock ratio R = (HCLK period /FMC_CLK period).

Figure 46. Synchronous non-multiplexed PSRAM write timings



| Symbol | Parameter | Min | Max | Unit | | |
|-----------------------------|--|--|-----|------|--|--|
| t _{w(CLK)} | FMC_CLK period | RxT _{HCLK} -0.5 ⁽²⁾ | - | | | |
| t _{d(CLKL-NExL)} | FMC_CLK low to FMC_NEx low (x=02) | - | 2.5 | , | | |
| t _{d(CLKH-NExH)} | FMC_CLK high to FMC_NEx high (x= 02) | RxT _{HCLK} /2 +1 ⁽²⁾ | - | | | |
| t _{d(CLKL-NADVL)} | FMC_CLK low to FMC_NADV low | - | 2.5 | | | |
| t _{d(CLKL-NADVH)} | FMC_CLK low to FMC_NADV high | 2 | - | | | |
| t _{d(CLKL-AV)} | FMC_CLK low to FMC_Ax valid (x=1625) | | 5.5 | | | |
| t _{d(CLKH-AIV)} | FMC_CLK high to FMC_Ax invalid (x=1625) | RxT _{HCLK} /2 +0.5 ⁽²⁾ | - | no | | |
| t _{d(CLKL-NWEL)} | FMC_CLK low to FMC_NWE low | - | 2 | ns | | |
| t _{d(CLKH-NWEH)} | FMC_CLK high to FMC_NWE high | RxT _{HCLK} /2 +1 ⁽²⁾ | - | • | | |
| t _{d(CLKL-Data)} | FMC_D[15:0] valid data after FMC_CLK low | - | 3.5 | | | |
| t _{d(CLKL-NBLL)} | FMC_CLK low to FMC_NBL low | 1 | - | • | | |
| t _{d(CLKH-NBLH)} | FMC_CLK high to FMC_NBL high | RxT _{HCLK} /2 +1.5 ⁽²⁾ | - | | | |
| t _{su(NWAIT-CLKH)} | FMC_NWAIT valid before FMC_CLK high | 1.5 | - | , | | |
| t _{h(CLKH-NWAIT)} | FMC_NWAIT valid after FMC_CLK high | 4 | - | • | | |

Table 103. Synchronous non-multiplexed PSRAM write timings⁽¹⁾⁽²⁾

NAND controller waveforms and timings

Figure 47 through Figure 50 represent synchronous waveforms, and Table 104 and Table 105 provide the corresponding timings. The results shown in these tables are obtained with the following FMC configuration:

- COM.FMC_SetupTime = 0x01
- COM.FMC_WaitSetupTime = 0x03
- COM.FMC_HoldSetupTime = 0x02
- COM.FMC_HiZSetupTime = 0x01
- ATT.FMC_SetupTime = 0x01
- ATT.FMC WaitSetupTime = 0x03
- ATT.FMC HoldSetupTime = 0x02
- ATT.FMC_HiZSetupTime = 0x01
- Bank = FMC Bank NAND
- MemoryDataWidth = FMC_MemoryDataWidth_16b
- ECC = FMC ECC Enable
- ECCPageSize = FMC_ECCPageSize_512Bytes
- TCLRSetupTime = 0
- TARSetupTime = 0

In all timing tables, the T_{HCLK} is the HCLK clock period.

^{1.} Guaranteed by characterization results.

^{2.} Clock ratio R = (HCLK period /FMC_CLK period).

FMC_NCEX

ALE (FMC_A17)
CLE (FMC_A16)

FMC_NWE

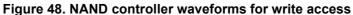
FMC_NOE (NRE)

Th(NOE-ALE)

FMC_D[15:0]

MSv38003V1

Figure 47. NAND controller waveforms for read access



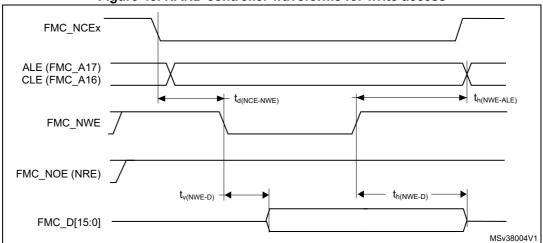
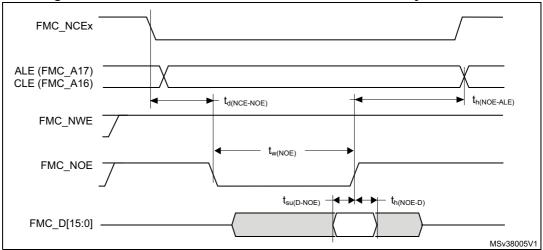


Figure 49. NAND controller waveforms for common memory read access



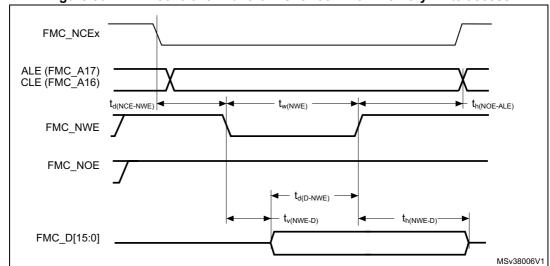


Figure 50. NAND controller waveforms for common memory write access

Table 104. Switching characteristics for NAND Flash read cycles⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|-------------------------|--|-------------------------|-------------------------|------|
| T _{w(N0E)} | FMC_NOE low width | 4T _{HCLK} -0.5 | 4T _{HCLK} +0.5 | |
| T _{su(D-NOE)} | FMC_D[15-0] valid data before FMC_NOE high | 14 | - | |
| T _{h(NOE-D)} | FMC_D[15-0] valid data after FMC_NOE high | 0 | - | ns |
| T _{d(ALE-NOE)} | FMC_ALE valid before FMC_NOE low | - | 3T _{HCLK} -1 | |
| T _{h(NOE-ALE)} | FMC_NOE high to FMC_ALE invalid | 3T _{HCLK} -0.5 | - | |

^{1.} Guaranteed by characterization results.

Table 105. Switching characteristics for NAND Flash write cycles⁽¹⁾

| Symbol | Parameter | Min | Max | Unit |
|-------------------------|--|-------------------------|-------------------------|------|
| T _{w(NWE)} | FMC_NWE low width | 4T _{HCLK} -0.5 | 4T _{HCLK} +0.5 | |
| T _{v(NWE-D)} | FMC_NWE low to FMC_D[15-0] valid | 5 | - | |
| T _{h(NWE-D)} | FMC_NWE high to FMC_D[15-0] invalid 2T _{HCLK} | | - | ns |
| T _{d(D-NWE)} | (D-NWE) FMC_D[15-0] valid before FMC_NWE high 5 | | - | 115 |
| T _{d(ALE_NWE)} | FMC_ALE valid before FMC_NWE low | - | 3T _{HCLK} -1 | |
| T _{h(NWE-ALE)} | FMC_NWE high to FMC_ALE invalid | 3T _{HCLK} -0.5 | - | |

^{1.} Guaranteed by characterization results.

6.3.29 OCTOSPI characteristics

Unless otherwise specified, the parameters given in *Table 106* and *Table 107* for OCTOSPI are derived from tests performed under the ambient temperature, f_{AHB} frequency and V_{DD} supply voltage conditions summarized in *Table 21: General operating conditions*, with the following configuration:

- Output speed is set to OSPEEDRy[1:0] = 11
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics.

Table 106. OCTOSPI⁽¹⁾ characteristics in SDR mode⁽²⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|----------------------------|---|--------------------------|-----|----------------------|------|
| | | 1.71 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 20 pF | - | 1 | 54 | |
| F(QCK) | OCTOSPI clock frequency | 2.7 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 20 pF | - | 1 | 92 | MHz |
| | inequency | 1.71 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 15 pF | - | - | 58 | |
| | | 1.71 V < V _{DD} < 3.6 V Voltage Range 2 C _{LOAD} = 20 pF | - | - | 26 | |
| t _{w(CKH)} | OCTOSPI clock high | Prescaler[7:0] = | t _(CK) /2-0.5 | - | t _(CK) /2 | |
| t _{w(CKL)} | and low time Even division | n = 0,1,3,5 | t _(CK) /2-0.5 | - | t _(CK) /2 | |
| t _{w(CKH)} | OCTOSPI clock high | Prescaler[7:0] = | (n/2)*t(CK)/(n+1)- 0.5 | - | (n/2)*t(CK)/(n+1) | |
| t _{w(CKL)} | and low time Odd division | n = 2,4,6,8 | (n/2+1)*t(CK)/(n+1) -0.5 | - | (n/2+1)*t(CK)/(n+1) | |
| | Data input actus time | Voltage Range V1 | 1 | - | - | |
| t _{s(IN)} | Data input setup time | Voltage Range V2 | 0.5 | - | - | ns |
| + | Data input hold time | Voltage Range V1 | 4.5 | - | - | |
| t _{h(IN)} | Data input noid time | Voltage Range V2 | 9.5 | - | - | |
| t (2) | Data output valid time | Voltage Range V1 | - | 1 | 3 | |
| t _{v(OUT)} | Data output valid tillle | Voltage Range V2 | - | 2 | 5 | |
| t. (QUE) | Data output hold time | Voltage Range V1 | 0 | - | - | |
| t _{h(OUT)} | Data output noid time | Voltage Range V2 | 0 | ı | - | |

^{1.} Values in the table applies to Octal and Quad SPI mode.



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^{2.} Guaranteed by characterization results.

Table 107. OCTOSPI characteristics in DTR mode (with DQS)⁽¹⁾/Octal and Hyperbus

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------------|--|---|------------------------------|-----|---------------------------------|--------|
| | | 1.71 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 20 pF | - | - | 60 ⁽²⁾ | |
| F _{CK} | OCTOSPI clock | 2.7 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 20 pF | - | - | 90 ⁽²⁾⁽³⁾ | MHz |
| 1/t _(CK) | frequency | 1.71 V < V _{DD} < 3.6 V Voltage Range V1 C _{LOAD} = 15 pF | - | - | 66 ⁽³⁾ | IVITIZ |
| | | 1.71 V < V _{DD} < 3.6 V Voltage Range V2 C _{LOAD} = 20 pF | - | - | 26 ⁽²⁾ | |
| t _{w(CKH)} | OCTOSPI clock high | | t _(CK) /2-1 | - | t _(CK) /2+0.5 | |
| t _{w(CKL)} | and low time Even division | - | t _(CK) /2-0.5 | - | t _(CK) /2+0.5 | |
| t _{w(CKH)} | OCTOSPI clock high and low time | | (n/2)*t(CK)/ (n+1)- 0.5 | - | (n/2)*t(CK)/ (n+1)+0.5 | ns |
| t _{w(CKL)} | Odd division | - | (n/2+1)*t(CK)/ (n+1) -0.5 | - | (n/2+1)*t(CK)/ (n+1)+0.5 | |
| t _{v(CK)} | Clock valid time | - | - | - | t _(CK) +2 | |
| t _{h(CK)} | Clock hold time | - | t _(CK) /2 -0.5 | - | - | |
| VODr(CK) ⁽⁴⁾ | CK,CK# crossing level on CK rising edge | VDD=1v8 | 730 | - | 997 | - mV |
| VODf(CK) ⁽⁴⁾ | CK,CK# crossing level on CK falling edge | VDD=1v8 | 788 | - | 1070 | IIIV |
| t _{w(CS)} | Chip select high time | - | 3*t _(CK) | - | - | |
| t _{v(DQ)} | Data input vallid time | | | | | |
| t _{v(DS)} | Data storbe input valid time | - | 0 | - | - | |
| t _{h(DS)} | Data storbe input hold time | - | 0 | - | - | |
| t _{v(RWDS)} | Data storbe output valid time | - | - | - | 3*t _(CK) | ns |
| t maxt max | Data input setup time | Voltage Range V1 | -0.75 | - | t(CK)/2 -3.75 ⁽⁵⁾ | |
| $t_{sr(DQ)}, t_{sf(DQ)}$ | | Voltage Range V2 | -1 | - | t(CK)/2 -5 ⁽⁵⁾ | |
| t. (= 0) t · | Data input hold time | Voltage Range V1 | 3.75 | - | - | |
| $t_{hr(DQ)}, t_{hf(DQ)}$ | Data input hold time | Voltage Range V2 | 5 | _ | - | |

Table 107. OCTOSPI characteristics in DTR mode (with DQS)⁽¹⁾/Octal and Hyperbus (continued)

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|--|------------------------|----------------------|---------------------|------------------|------------------|-----------------|------|
| | | | DHQC =0 | - | 5.75 | 7.75 | |
| t _{vr(OUT)} t _{vf(OUT)} | Data output valid time | Voltage Range V1 | DHQC =1 Pres=1,2 | - | Tpclk/4 +0.75 | Tpclk/4 +1.5 | |
| | | Voltage Range V2 | DHQC =0 | - | 8 | 11 | |
| | Data output hold time | | DHQC =0 | 0.5 | - | - | ns |
| ^t hr(OUT) ^t hf(OUT) | | Voltage Range V1 | DHQC =1 Pres=1,2 | Tpclk/4 -0.25 | - | - | |
| | | Voltage Ra DHQC=0 | nge V2 | 5 | - | - | |

- 1. Guaranteed by characterization results.
- 2. Maximum frequency values are given for an RWDS to DQ skew of maximum +/-1.0ns
- 3. Activating DHQC is mandatory to reach this frequency.
- All clk/clk# pairs are in line with HyperMemory AC differential crossing voltage margins except pairs including PB10 and PH7.
- 5. Data input setup time maximum does not take into account data level switching duration.

Figure 51. OCTOSPI timing diagram - SDR mode

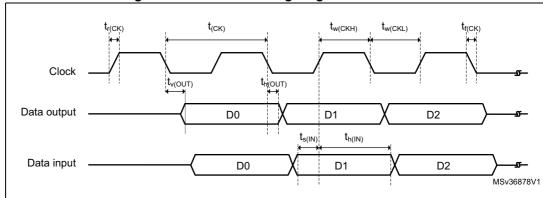


Figure 52. OCTOSPI timing diagram - DDR mode

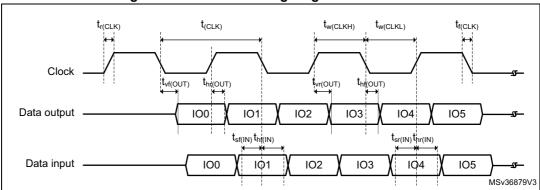


Figure 53. OCTOSPI Hyperbus clock

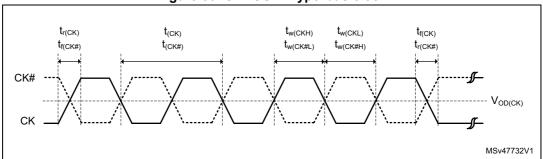


Figure 54. OCTOSPI Hyperbus read

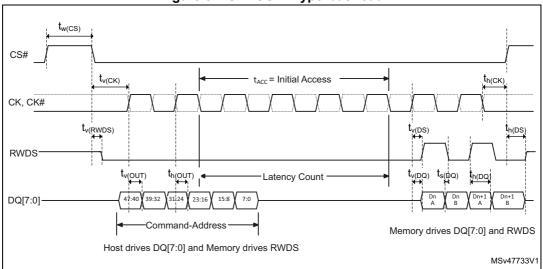
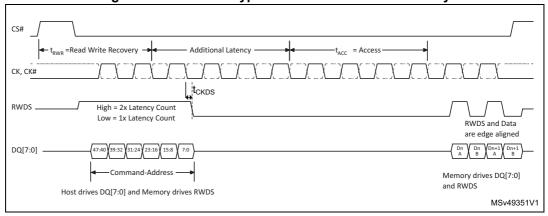


Figure 55. OCTOSPI Hyperbus read with double latency



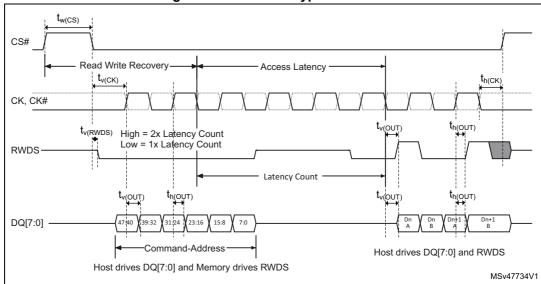


Figure 56. OCTOSPI Hyperbus write

Delay block

Unless otherwise specified, the parameters given in *Table 108* for delay block are derived from tests performed under the ambient temperature, f_{PCLKx} frequency and VDD supply voltage conditions summarized in *Table 22: Operating conditions at power-up / power-down* with the configuration shown in the table below.

Table 108. Dynamics characteristics: Delay Block characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------|---------------|------------|-----|-----|------|------|
| t _{init} | Initial delay | - | 700 | 875 | 1000 | ps |
| t_Δ | Unit Delay | - | 375 | 500 | 750 | μο |

6.3.30 Camera interface (DCMI) timing specifications

Unless otherwise specified, the parameters given in *Table 109* for DCMI are derived from tests performed under the ambient temperature, $f_{\mbox{\scriptsize HCLK}}$ frequency and $V_{\mbox{\scriptsize DD}}$ supply voltage summarized in *Table 20*, with the following configuration:

DCMI_PIXCLK polarity: falling

DCMI VSYNC and DCMI HSYNC polarity: high

Data format: 14 bits Capacitive load C = 30 pF

Measurement points are done at CMOS levels: 0.5 x V_{DD}

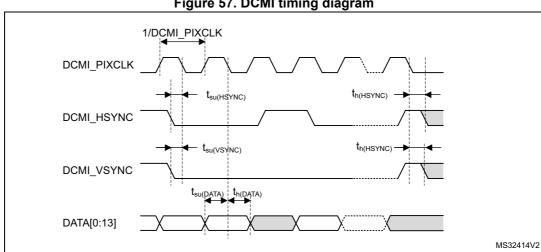


Figure 57. DCMI timing diagram

Table 109. DCMI characteristics⁽¹⁾

| Symbol | Parameter | meter Condition | | Max | Unit |
|--------------------|--|--------------------------------------|----|-----|-------|
| - | Frequency ratio DCMI_PIXCLK/f _{HCLK} | - | - | 0.4 | - |
| DCMI_PIXCLK | Pixel clock input | 1.71 < VDD < 3.6 Voltage range V1 | - | 48 | MHz |
| | Pixel Glock Input | 1.71 < VDD < 3.6 Voltage range V2 | - | 10 | IVITZ |
| D _{pixel} | Pixel clock input duty cycle | - | 30 | 70 | % |

Condition Min Unit Symbol **Parameter** Max 1.71 < VDD < 3.6 3 Voltage range V1 Data input setup time t_{su(DATA)} 1.71 < VDD < 3.6 4 Voltage range V2 1.71 < VDD < 3.6 0.5 Voltage range V1 Data hold time t_{h(DATA)} 1.71 < VDD < 3.6 0.5 Voltage range V2 ns 1.71 < VDD < 3.6 2 Voltage range V1 DCMI HSYNC/DCMI VSYNC t_{su(HSYNC)}, input setup time t_{su(VSYNC)} 1.71 < VDD < 3.6 3 Voltage range V2 1.71 < VDD < 3.6 0.5 Voltage range V1 DCMI_HSYNC/DCMI_VSYNC th(HSYNC), input hold time t_{h(VSYNC)} 1.71 < VDD < 3.6 0.5 Voltage range V2

Table 109. DCMI characteristics⁽¹⁾ (continued)

6.3.31 Parallel slave interface (PSSI)

Unless otherwise specified, the parameters given in *Table 110* for PSSI are derived from tests performed under the ambient temperature, fHCLK frequency and VDD supply voltage summarized in *Table 21*, with the following configuration:

- PSSI_PDCK polarity: falling
- PSSI_RDY and PSSI_DE polarity: low
- Data format: 16 bits
- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

^{1.} Guaranteed by characterization results.

Table 110. PSSI receive characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Max | Unit | |
|------------------------|---|--|------|------|---------|--|
| - | Frequency ratio PSSI_PDCK/f _{HCLK} | - | - | 0.4 | - | |
| DOOL DDOK | PSSI Clock input | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | - 48 | | N 41 1- | |
| PSSI_PDCK | P331 Glock Input | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | - | 10 | MHz | |
| D _{pixel} | PSSI Clock input duty cycle | - | 30 | 70 | % | |
| + (DATA) | Data input setup time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 4.5 | - | | |
| t _{su} (DATA) | Data input setup time | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 6.5 | - | | |
| t _h (DATA) | Data input hold time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 0.5 | - | | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 0.5 | - | | |
| t _{su(} (DE) | DE input setup time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 1.5 | - | | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 2 | - | 20 | |
| + (DE) | DE input hold time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 0.5 | - | ns | |
| t _h (DE) | DE Input noid time | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 0.5 | - | | |
| tov(RDY) | RDY output valid time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 18 | | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | - | 21.5 | | |
| toh/PDV\ | PDV output hold time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 7 | - | | |
| toh(RDY) | RDY output hold time | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 10.5 | - | | |

^{1.} Guaranteed by characterization results.

Table 111. PSSI transmit characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------------|---|--|-------|------|------|
| - | Frequency ratio PSSI_PDCK/f _{HCLK} | - | - | 0.4 | - |
| | PSSI Clock input | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 25 | |
| PSSI_PDCK | | 2.7 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 37 | MHz |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | - | 10 | |
| D _{pixel} | PSSI Clock input duty cycle | - | 30 | 70 | % |
| | | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 18 | |
| t _{ov} (DATA) | Data output valid time | 2.7 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 13.5 | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | - | 20 | |
| t _{oh} (DATA) | Data output hold time | <u>1</u> .71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 4.5 | - | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 6 | - | |
| t _{ov(} (DE) | | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 16.5 | ns |
| | DE output valid time | 2.7 <vdd<3.6 Voltage Range V1</vdd<3.6 | - | 12.5 | |
| | | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | - | 19.5 | |
| t _{oh} (DE) | DE output hold time | 1.71 <vdd<3.6 Voltage Range V1</vdd<3.6 | 1 6 1 | - | |
| | DE output hold time | 1.71 <vdd<3.6 Voltage Range V2</vdd<3.6 | 9 | - | |
| tsu(RDY) | RDY input setup time | - | 0 | - | |
| th(RDY) | RDY input hold time | - | 0 | - | |

^{1.} Guaranteed by characterization results.

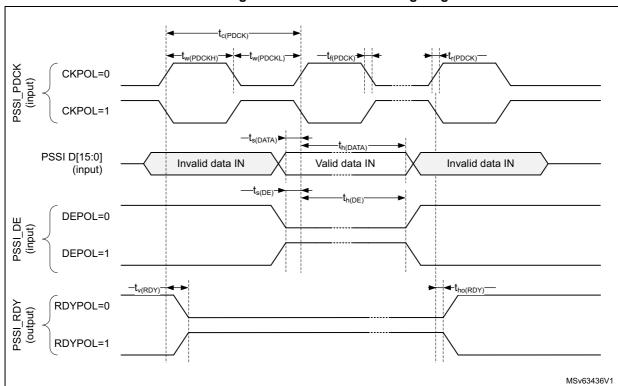
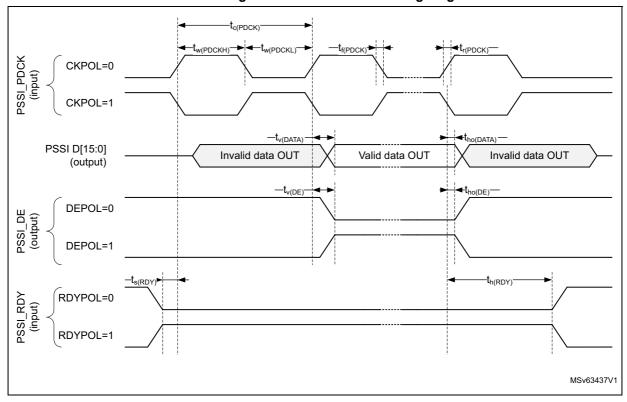


Figure 58. PSSI receive timing diagram





6.3.32 LCD-TFT controller (LTDC) characteristics

Unless otherwise specified, the parameters given in *Table 112* for LCD-TFT are derived from tests performed under the ambient temperature, fHCLK frequency and VDD supply voltage summarized in *Table 21*, with the following configuration:

- LCD_CLK polarity: high
- LCD_DE polarity: low
- LCD_VSYNC and LCD_HSYNC polarity: high
- Pixel formats: 24 bits
- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD}

Refer to Section 6.3.14: I/O port characteristics for more details on the input/output alternate function characteristics.

Table 112. LTDC characteristics⁽¹⁾

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--|-----------------------------------|----------------------------------|---------------|---------------|---------|
| f _{CLK} | LTDC clock output | 2.7 V < V _{DD} < 3.6 V | - | 83 | MHz |
| | frequency | 1.71 V < V _{DD} < 3.6 V | - | 50 | IVII IZ |
| D _{CLK} | LTDC clock output duty cycle | - | 45 | 55 | % |
| tw(CLKH) tw(CLKL) | Clock high time Clock low time | - | tw(CLK)/2-0.5 | tw(CLK)/2+0.5 | |
| t _v (DATA) | Data output valid time | - | - | 5.5 | |
| t _h (DATA) | Data output hold time | - | 1 | - | |
| $\begin{aligned} &t_{\text{V}}(\text{HSYNC})\\ &t_{\text{V}}(\text{VSYNC})\\ &t_{\text{V}}(\text{DE}) \end{aligned}$ | HSYNC/VSYNC/DE output valid time | - | - | 3 | ns |
| $\begin{aligned} &t_{h}(\text{HSYNC})\\ &t_{h}(\text{VSYNC})\\ &t_{h}(\text{DE}) \end{aligned}$ | HSYNC/VSYNC/DE output hold time | - | 1 | - | |

^{1.} Guaranteed by characterization results.

6.3.33 SD/SDIO/MMC card host interfaces (SDMMC)

Unless otherwise specified, the parameters given in *Table 113* for SDIO are derived from tests performed under the ambient temperature, f_{PCLKx} frequency and VDD supply voltage conditions summarized in *Table 21: General operating conditions* with the following configuration:

- Output speed is set to OSPEEDRy[1:0] = 11
- Capacitive load C = 30 pF
- Measurement points are done at CMOS levels: 0.5 x V_{DD} Refer to Section 6.3.14: I/O port characteristics for more details on the input/output characteristics.

Table 113. Dynamics characteristics: SD / eMMC characteristics at VDD = 2.7 V to 3.6 V ⁽¹⁾

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
|---|--|--------------|-----|-----|-----|------|--|
| fPP | Clock frequency in data transfer mode | - | 0 | - | 64 | MHz | |
| - | SDIO_CK/fPCLK2 frequency ratio | - | - | - | 8/3 | 1 | |
| tW(CKL) | Clock low time | fpp = 52 MHz | 8.5 | 9.5 | - | no | |
| tW(CKH) | Clock high time | fpp = 52 MHz | 8.5 | 9.5 | - | ns | |
| CMD, D inputs (referenced to CK) in eMMC legacy/SDR/DDR and SD HS/SDR ⁽²⁾ /DDR ⁽²⁾ mode | | | | | | | |
| tISU | Input setup time HS | - | 1.5 | - | - | | |
| tIHD | Input hold time HS | - | 2.0 | - | - | ns | |
| CMD, D outp | CMD, D outputs (referenced to CK) in eMMC legacy/SDR/DDR and SD HS/SDR ⁽²⁾ /DDR ⁽²⁾ mode | | | | | | |
| tOV | Output valid time HS | - | - | 5.5 | 7 | - ns | |
| tOH | Output hold time HS | - | 4 | - | - | | |
| | CMD, D inputs (referenced to CK) in SD default mode | | | | | | |
| tISUD | Input setup time SD | - | 0.5 | - | - | | |
| tIHD | Input hold time SD | - | 1.5 | - | - | ns | |
| CMD, D outputs (referenced to CK) in SD default mode | | | | | | | |
| tOVD | Output valid default time SD | - | - | 1 | 2 | no | |
| tOHD | Output hold default time SD | - | 0 | - | - | ns | |

^{1.} Guaranteed by characterization results.

^{2.} For SD 1.8 V support, an external voltage converter is needed.

Table 114. Dynamics characteristics: eMMC characteristics at VDD = 1.71 V to 1.9 $V^{(1)(2)}$

| Symbol | Parameter | Min | Тур | Max | Unit | | | | | | |
|---------|--|------------------------|------|-----|-------|-----|--|--|--|--|--|
| fPP | Clock frequency in data transfer mode | - | 0 | - | 52 | MHz | | | | | |
| - | SDIO_CK/fPCLK2 frequency ratio | K2 frequency | | | 8/3 | - | | | | | |
| tW(CKL) | Clock low time | fpp = 52 MHz 8.5 9.5 - | | - | 20 | | | | | | |
| tW(CKH) | Clock high time | fpp = 52 MHz | | | - 115 | ns | | | | | |
| | CMD, D inputs (referenced to CK) in eMMC mode | | | | | | | | | | |
| tISU | Input setup time HS | - | 0.5 | - | - | no | | | | | |
| tIH | Input hold time HS | - | 4.5 | - | - | ns | | | | | |
| | CMD, D outputs (referenced to CK) in eMMC mode | | | | | | | | | | |
| tOV | Output valid time HS | - | 6 7. | | 7.3 | nc | | | | | |
| tOH | Output hold time HS | - 4 - | | ı | ns | | | | | | |

- 1. Guaranteed by characterization results.
- 2. Cload = 20 pF.

See the different SDMMC diagrams in Figure 60, Figure 61 and Figure 62 below.

tW(CKH) tW(CKL) CK tov ^tOH D, CMD (output) ·tISU D, CMD (input) ai14887

Figure 60. SDIO high-speed mode

Electrical characteristics STM32L4Q5xx

Figure 61. SD default mode

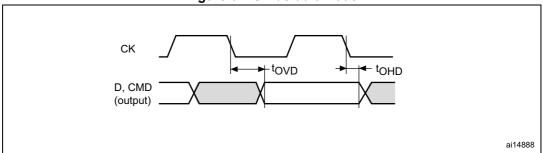
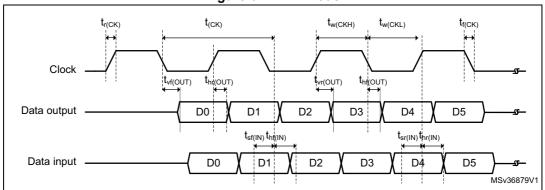


Figure 62. DDR mode



Package information 7

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

LQFP48 package information 7.1

LQFP48 is a 48-pin, 7 x 7 mm low-profile quad flat package.

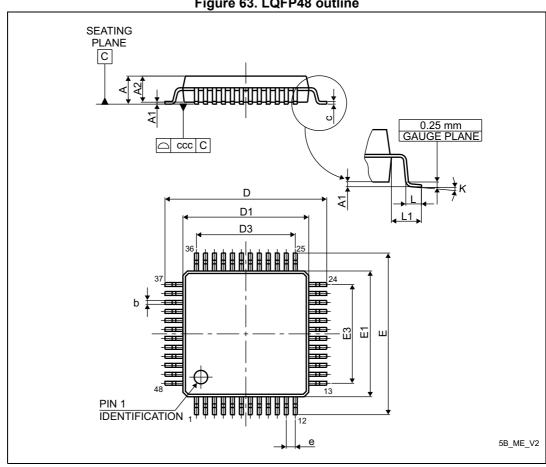


Figure 63. LQFP48 outline

1. Drawing is not to scale.

Table 115. LQFP48 mechanical data

| Symbol | millimeters | | | | inches ⁽¹⁾ | |
|--------|-------------|-------|-------|--------|-----------------------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| Α | - | - | 1.600 | - | - | 0.0630 |
| A1 | 0.050 | - | 0.150 | 0.0020 | - | 0.0059 |
| A2 | 1.350 | 1.400 | 1.450 | 0.0531 | 0.0551 | 0.0571 |



255/284

Table 115. LQFP48 mechanical data (continued)

| Symbol | millimeters | | | | inches ⁽¹⁾ | |
|--------|-------------|-------|-------|--------|-----------------------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| b | 0.170 | 0.220 | 0.270 | 0.0067 | 0.0087 | 0.0106 |
| С | 0.090 | - | 0.200 | 0.0035 | - | 0.0079 |
| D | 8.800 | 9.000 | 9.200 | 0.3465 | 0.3543 | 0.3622 |
| D1 | 6.800 | 7.000 | 7.200 | 0.2677 | 0.2756 | 0.2835 |
| D3 | - | 5.500 | - | - | 0.2165 | - |
| E | 8.800 | 9.000 | 9.200 | 0.3465 | 0.3543 | 0.3622 |
| E1 | 6.800 | 7.000 | 7.200 | 0.2677 | 0.2756 | 0.2835 |
| E3 | - | 5.500 | - | - | 0.2165 | - |
| е | - | 0.500 | - | - | 0.0197 | - |
| L | 0.450 | 0.600 | 0.750 | 0.0177 | 0.0236 | 0.0295 |
| L1 | - | 1.000 | - | - | 0.0394 | - |
| k | 0° | 3.5° | 7° | 0° | 3.5° | 7° |
| ccc | - | - | 0.080 | - | - | 0.0031 |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

1.20 0.30 7.30 9.70 5.80--7.30 9.70 ai14911d

Figure 64. LQFP48 recommended footprint

1. Dimensions are expressed in millimeters.

Device marking for LQFP48

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

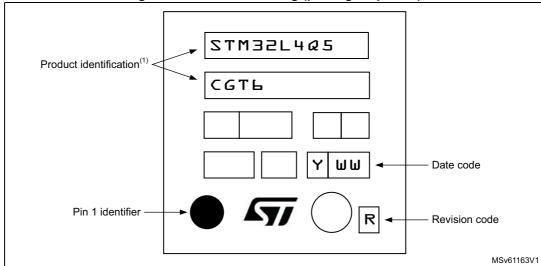


Figure 65. LQFP48 marking (package top view)

Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified
and therefore not approved for use in production. ST is not responsible for any consequences resulting
from such use. In no event will ST be liable for the customer using any of these engineering samples in
production. ST's Quality department must be contacted prior to any decision to use these engineering
samples to run a qualification activity.

7.2 UFQFPN48 package information

UFQFPN48 is a 48-lead, 7x7 mm, 0.5 mm pitch, ultra thin fine pitch quad flat package.

Pin 1 identifier laser marking area D Ε Ε Seating b Detail Y D Exposed pad D2 area C <u>0.500x45°</u> pin1 corner R 0.125 typ. Detail Z E2 Ζ A0B9 ME V3

Figure 66. UFQFPN48 outline

- 1. Drawing is not to scale.
- 2. All leads/pads should also be soldered to the PCB to improve the lead/pad solder joint life.
- 3. There is an exposed die pad on the underside of the UFQFPN package. This back-side pad must be connected and soldered to PCB ground.

| rabio Froi of QFF 1440 moonamour aata | | | | | | | |
|---------------------------------------|-------|-------------|-------|--------|-----------------------|--------|--|
| Symbol of | | millimeters | | | inches ⁽¹⁾ | | |
| Symbol | Min | Тур | Max | Min | Тур | Max | |
| Α | 0.500 | 0.550 | 0.600 | 0.0197 | 0.0217 | 0.0236 | |
| A1 | 0.000 | 0.020 | 0.050 | 0.0000 | 0.0008 | 0.0020 | |
| D | 6.900 | 7.000 | 7.100 | 0.2717 | 0.2756 | 0.2795 | |
| Е | 6.900 | 7.000 | 7.100 | 0.2717 | 0.2756 | 0.2795 | |
| D2 | 5.500 | 5.600 | 5.700 | 0.2165 | 0.2205 | 0.2244 | |

Table 116. UFQFPN48 mechanical data

Table 116. UFQFPN48 mechanical data (continued)

| Symbol | millimeters incl | | | inches ⁽¹⁾ | | |
|--------|------------------|-------|-------|-----------------------|--------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| E2 | 5.500 | 5.600 | 5.700 | 0.2165 | 0.2205 | 0.2244 |
| L | 0.300 | 0.400 | 0.500 | 0.0118 | 0.0157 | 0.0197 |
| Т | - | 0.152 | - | - | 0.0060 | - |
| b | 0.200 | 0.250 | 0.300 | 0.0079 | 0.0098 | 0.0118 |
| е | - | 0.500 | - | - | 0.0197 | - |
| ddd | - | - | 0.080 | - | - | 0.0031 |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

Dimensions are expressed in millimeters.

Device marking for UFQFPN48

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

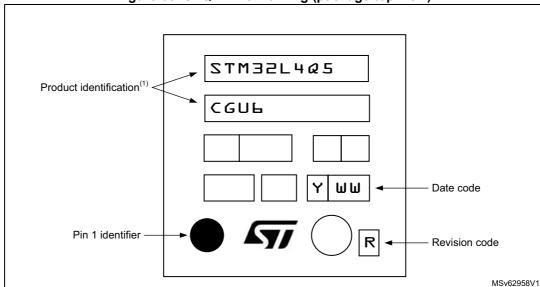


Figure 68. UFQFPN48 marking (package top view)

Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified
and therefore not approved for use in production. ST is not responsible for any consequences resulting
from such use. In no event will ST be liable for the customer using any of these engineering samples in
production. ST's Quality department must be contacted prior to any decision to use these engineering
samples to run a qualification activity.



7.3 LQFP64 package information

LQFP64 is a 64-pin, 10 x 10 mm low-profile quad flat package.

SEATING PLANE

O.25 mm

GAUGE PLANE

D1

D3

33

J1

DENTIFICATION

SW_ME_V3

Figure 69. LQFP64 outline

1. Drawing is not to scale.

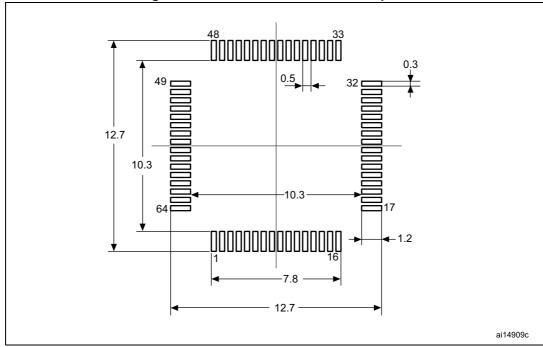
Table 117. LQFP 64 mechanical data

| Symbol | millimeters | | | | inches ⁽¹⁾ | |
|--------|-------------|--------|-------|--------|-----------------------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| А | - | - | 1.600 | - | - | 0.0630 |
| A1 | 0.050 | - | 0.150 | 0.0020 | - | 0.0059 |
| A2 | 1.350 | 1.400 | 1.450 | 0.0531 | 0.0551 | 0.0571 |
| b | 0.170 | 0.220 | 0.270 | 0.0067 | 0.0087 | 0.0106 |
| С | 0.090 | - | 0.200 | 0.0035 | - | 0.0079 |
| D | - | 12.000 | - | - | 0.4724 | - |
| D1 | - | 10.000 | - | - | 0.3937 | - |
| D3 | - | 7.500 | - | - | 0.2953 | - |
| Е | - | 12.000 | - | - | 0.4724 | - |
| E1 | - | 10.000 | - | - | 0.3937 | - |

| Symbol | | millimeters | | inches ⁽¹⁾ | | |
|--------|------------|-------------|-------|-----------------------|--------|--------|
| Symbol | Symbol Min | Тур | Max | Min | Тур | Max |
| E3 | - | 7.500 | - | - | 0.2953 | - |
| е | - | 0.500 | - | - | 0.0197 | - |
| K | 0° | 3.5° | 7° | 0° | 3.5° | 7° |
| L | 0.450 | 0.600 | 0.750 | 0.0177 | 0.0236 | 0.0295 |
| L1 | - | 1.000 | - | - | 0.0394 | - |
| ccc | - | - | 0.080 | - | - | 0.0031 |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 70. LQFP64 recommended footprint



1. Dimensions are expressed in millimeters.

Device marking for LQFP64

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

Product identification(1)

STM32L4Q5

RGTL

Y W Date code

Pin 1 identifier

MSv62960V2

Figure 71. LQFP64 marking (package top view)

1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

LQFP100 package information 7.4

LQFP100 is a 100-pin, 14 x 14 mm low-profile quad flat package.

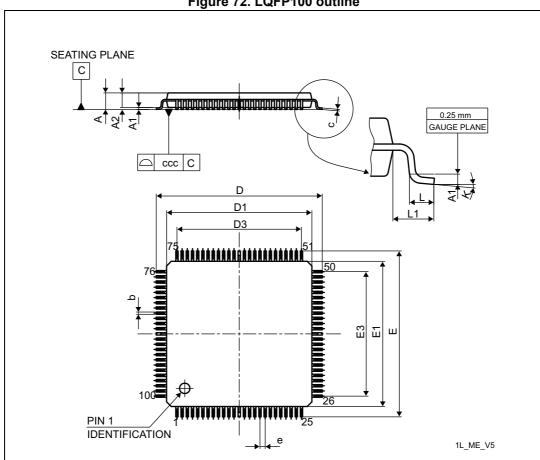


Figure 72. LQFP100 outline

1. Drawing is not to scale.

Table 118. LQPF100 mechanical data

| Symbol | | millimeters | | | millimeters inches ⁽¹⁾ | | | |
|--------|--------|-------------|--------|--------|-----------------------------------|--------|--|--|
| Symbol | Min | Тур | Max | Min | Тур | Max | | |
| Α | - | - | 1.600 | - | - | 0.0630 | | |
| A1 | 0.050 | - | 0.150 | 0.0020 | - | 0.0059 | | |
| A2 | 1.350 | 1.400 | 1.450 | 0.0531 | 0.0551 | 0.0571 | | |
| b | 0.170 | 0.220 | 0.270 | 0.0067 | 0.0087 | 0.0106 | | |
| С | 0.090 | - | 0.200 | 0.0035 | - | 0.0079 | | |
| D | 15.800 | 16.000 | 16.200 | 0.6220 | 0.6299 | 0.6378 | | |
| D1 | 13.800 | 14.000 | 14.200 | 0.5433 | 0.5512 | 0.5591 | | |
| D3 | - | 12.000 | - | - | 0.4724 | - | | |

| Table 110. Eq. 1 100 mechanical data (continued) | | | | | | |
|--|--------|-------------|--------|--------|-----------------------|--------|
| Comple at | | millimeters | | | inches ⁽¹⁾ | |
| Symbol | Min | Тур | Max | Min | Тур | Max |
| E | 15.800 | 16.000 | 16.200 | 0.6220 | 0.6299 | 0.6378 |
| E1 | 13.800 | 14.000 | 14.200 | 0.5433 | 0.5512 | 0.5591 |
| E3 | - | 12.000 | - | - | 0.4724 | - |
| е | - | 0.500 | - | - | 0.0197 | - |
| L | 0.450 | 0.600 | 0.750 | 0.0177 | 0.0236 | 0.0295 |
| L1 | - | 1.000 | - | - | 0.0394 | - |
| k | 0.0° | 3.5° | 7.0° | 0.0° | 3.5° | 7.0° |
| ccc | - | - | 0.080 | - | - | 0.0031 |

Table 118, LQPF100 mechanical data (continued)

Values in inches are converted from mm and rounded to 4 decimal digits.

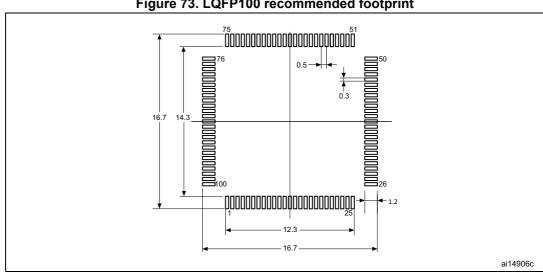


Figure 73. LQFP100 recommended footprint

1. Dimensions are expressed in millimeters.

Device marking for LQFP100

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

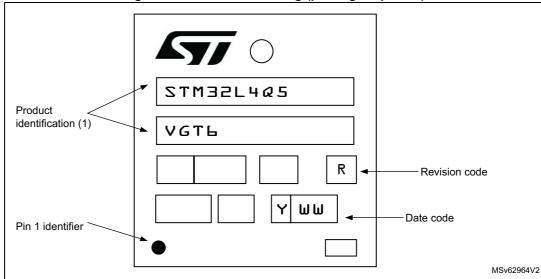


Figure 74. LQFP100 marking (package top view)

1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

7.5 WLCSP100 package information

WLCSP100 is a 100-ball, 4.618 x 4.142 mm, 0.4 mm pitch wafer level chip scale package.

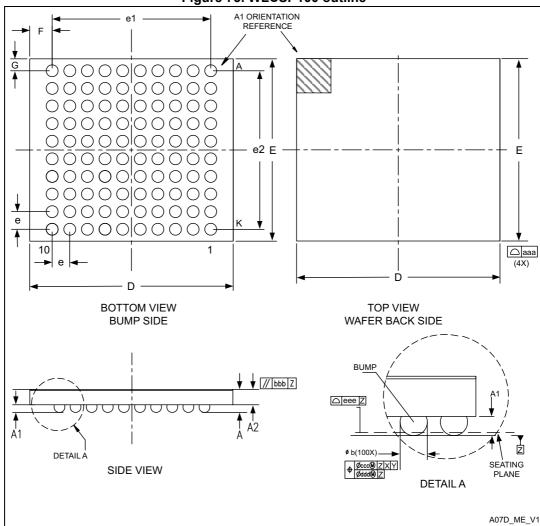


Figure 75. WLCSP100 outline

- 1. Drawing is not to scale.
- 2. Dimension is measured at the maximum bump diameter parallel to primary datum Z.
- 3. Primary datum Z and seating plane are defined by the spherical crowns of the bump.
- 4. Bump position designation per JESD 95-1, SPP-010.

Table 119. WLCSP100 mechanical data

| Council of | millimeters | | | | inches ⁽¹⁾ | |
|--------------------|-------------|-------|-------|--------|-----------------------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| Α | 0.525 | 0.555 | 0.585 | 0.0207 | 0.0219 | 0.0230 |
| A1 | - | 0.175 | - | - | 0.0069 | - |
| A2 | - | 0.380 | - | - | 0.0150 | - |
| A3 ⁽²⁾ | - | 0.025 | - | - | 0.0010 | - |
| Ø b ⁽³⁾ | 0.220 | 0.250 | 0.280 | 0.0087 | 0.0098 | 0.0110 |
| D | 4.583 | 4.618 | 4.653 | 0.1804 | 0.1818 | 0.1832 |
| E | 4.107 | 4.142 | 4.177 | 0.1617 | 0.1631 | 0.1644 |
| е | - | 0.400 | - | - | 0.0157 | - |
| e1 | - | 3.600 | - | - | 0.1417 | - |
| e2 | - | 3.600 | - | - | 0.1417 | - |
| F | - | 0.509 | - | - | 0.0200 | - |
| G | - | 0.271 | - | - | 0.0107 | - |
| aaa | - | 0.100 | - | - | 0.0039 | - |
| bbb | - | 0.100 | - | - | 0.0039 | - |
| ccc | - | 0.100 | - | - | 0.0039 | - |
| ddd | - | 0.050 | - | - | 0.0020 | - |
| eee | - | 0.050 | - | - | 0.0020 | - |

- 1. Values in inches are converted from mm and rounded to 4 decimal digits.
- 2. Back side coating.
- 3. Dimension is measured at the maximum bump diameter parallel to primary datum Z.

Figure 76. WLCSP100 recommended footprint

Dpad
Dsm

BGA_WLCSP_FT_V1

Table 120. WLCSP100 recommended PCB design rules (0.4 mm pitch)

| Dimension | Recommended values |
|-------------------|--------------------|
| Pitch | 0.4 mm |
| Dpad | 0.225 mm |
| Dsm | 0.290 mm |
| Stencil thickness | 0.1 mm |

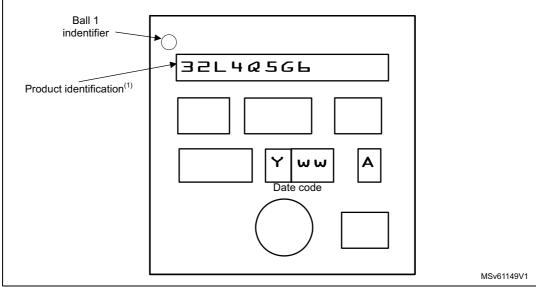
Device marking for WLCSP100

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

Figure 77. WLCSP100 marking (package top view)



1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

7.6 UFBGA132 package information

UFGBA132 is a 132-ball, 7 x 7 mm ultra thin fine pitch ball grid array package.

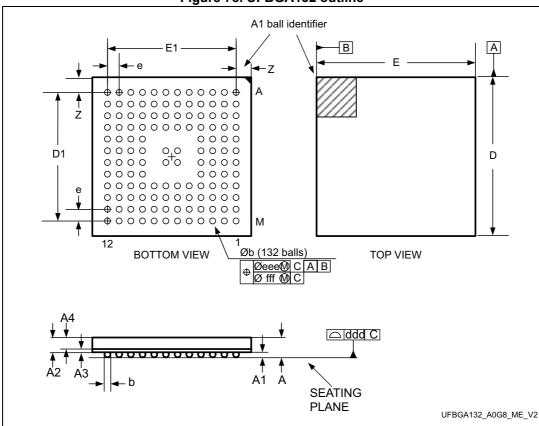


Figure 78. UFBGA132 outline

1. Drawing is not to scale.

Table 121. UFBGA132 mechanical data

| Cumbal | millimeters | | | inches ⁽¹⁾ | | |
|--------|-------------|-------|-------|-----------------------|--------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| Α | - | - | 0.600 | - | - | 0.0236 |
| A1 | - | - | 0.110 | - | - | 0.0043 |
| A2 | - | 0.450 | - | - | 0.0177 | - |
| A3 | - | 0.130 | - | - | 0.0051 | 0.0094 |
| A4 | - | 0.320 | - | - | 0.0126 | - |
| b | 0.240 | 0.290 | 0.340 | 0.0094 | 0.0114 | 0.0134 |
| D | 6.850 | 7.000 | 7.150 | 0.2697 | 0.2756 | 0.2815 |
| D1 | - | 5.500 | - | - | 0.2165 | - |
| Е | 6.850 | 7.000 | 7.150 | 0.2697 | 0.2756 | 0.2815 |
| E1 | - | 5.500 | - | - | 0.2165 | - |

| Table 121 | . UFBGA132 mechan | ical data (continued) |
|-----------|-------------------|-----------------------|
|-----------|-------------------|-----------------------|

| Cymphol | | millimeters | | inches ⁽¹⁾ | | |
|---------|-----|-------------|-----|-----------------------|--------|-----|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| е | - | 0.500 | - | - | 0.0197 | - |
| Z | - | 0.750 | - | - | 0.0295 | - |
| ddd | - | 0.080 | - | - | 0.0031 | - |
| eee | - | 0.150 | - | - | 0.0059 | - |
| fff | - | 0.050 | - | - | 0.0020 | - |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 79. UFBGA132 recommended footprint

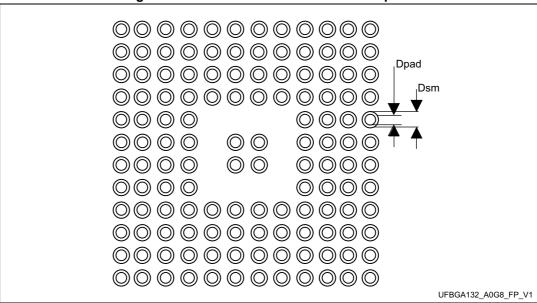


Table 122. UFBGA132 recommended PCB design rules (0.5 mm pitch BGA)

| Dimension | Recommended values |
|-------------------|--|
| Pitch | 0.5 mm |
| Dpad | 0.280 mm |
| Dsm | 0.370 mm typ. (depends on the soldermask registration tolerance) |
| Stencil opening | 0.280 mm |
| Stencil thickness | Between 0.100 mm and 0.125 mm |
| Pad trace width | 0.100 mm |
| Ball diameter | 0.280 mm |

Device marking for UFBGA132

The following figure gives an example of topside marking orientation versus ball A1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

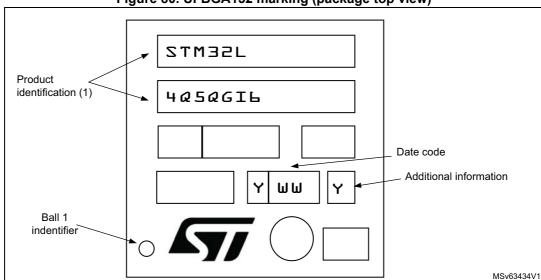


Figure 80. UFBGA132 marking (package top view)

1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

7.7 LQFP144 package information

LQFP144 is a 144-pin, 20 x 20 mm low-profile quad flat package.

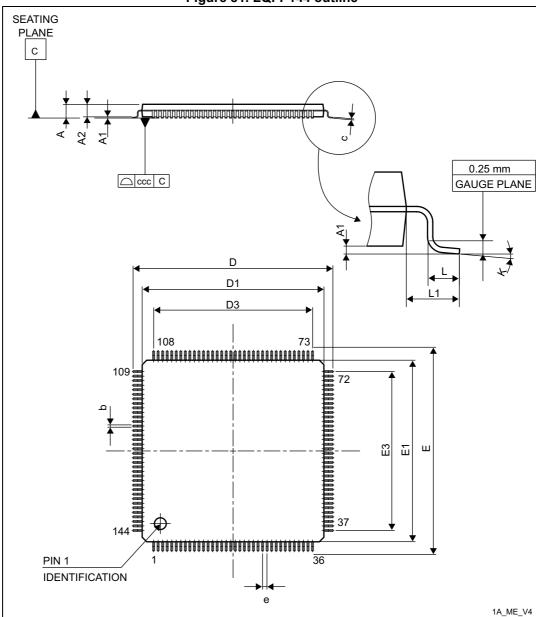


Figure 81. LQFP144 outline

1. Drawing is not to scale.

Table 123. LQFP144 mechanical data

| Cumbal | millimeters | | | inches ⁽¹⁾ | | |
|--------|-------------|--------|--------|-----------------------|--------|--------|
| Symbol | Min | Тур | Max | Min | Тур | Max |
| Α | - | - | 1.600 | - | - | 0.0630 |
| A1 | 0.050 | - | 0.150 | 0.0020 | - | 0.0059 |
| A2 | 1.350 | 1.400 | 1.450 | 0.0531 | 0.0551 | 0.0571 |
| b | 0.170 | 0.220 | 0.270 | 0.0067 | 0.0087 | 0.0106 |
| С | 0.090 | - | 0.200 | 0.0035 | - | 0.0079 |
| D | 21.800 | 22.000 | 22.200 | 0.8583 | 0.8661 | 0.8740 |
| D1 | 19.800 | 20.000 | 20.200 | 0.7795 | 0.7874 | 0.7953 |
| D3 | - | 17.500 | - | - | 0.6890 | - |
| Е | 21.800 | 22.000 | 22.200 | 0.8583 | 0.8661 | 0.8740 |
| E1 | 19.800 | 20.000 | 20.200 | 0.7795 | 0.7874 | 0.7953 |
| E3 | - | 17.500 | - | - | 0.6890 | - |
| е | - | 0.500 | - | - | 0.0197 | - |
| L | 0.450 | 0.600 | 0.750 | 0.0177 | 0.0236 | 0.0295 |
| L1 | - | 1.000 | - | - | 0.0394 | - |
| k | 0° | 3.5° | 7° | 0° | 3.5° | 7° |
| ccc | - | - | 0.080 | - | - | 0.0031 |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

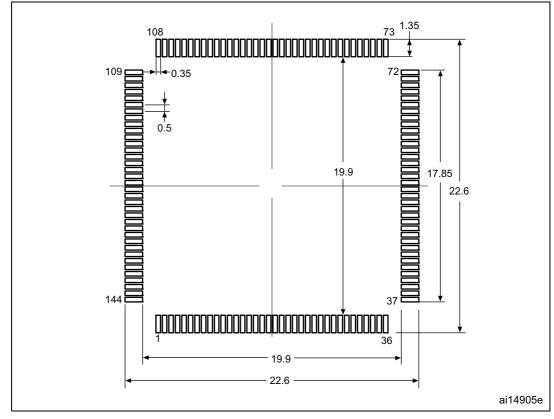


Figure 82. LQFP144 recommended footprint

1. Dimensions are expressed in millimeters.

Device marking for LQFP144

The following figures gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

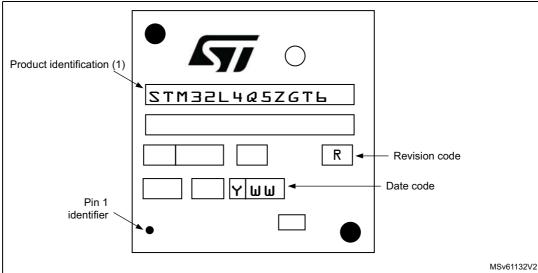


Figure 83. LQFP144 marking (package top view)

1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

7.8 UFBGA169 package information

UFBGA169 is a 169-ball, 7 x 7 mm, 0.50 mm pitch, ultra fine pitch ball grid array package.

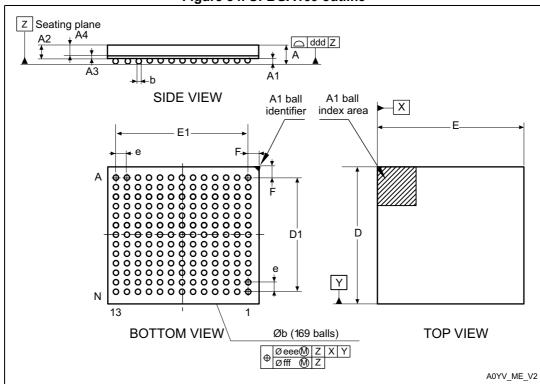


Figure 84. UFBGA169 outline

1. Drawing is not to scale.

Table 124. UFBGA169 mechanical data

| Symbol | millimeters | | | | inches ⁽¹⁾ | |
|--------|-------------|-------|-------|--------|-----------------------|--------|
| Symbol | Min. | Тур. | Max. | Min. | Тур. | Max. |
| Α | 0.460 | 0.530 | 0.600 | 0.0181 | 0.0209 | 0.0236 |
| A1 | 0.050 | 0.080 | 0.110 | 0.0020 | 0.0031 | 0.0043 |
| A2 | 0.400 | 0.450 | 0.500 | 0.0157 | 0.0177 | 0.0197 |
| A3 | - | 0.130 | - | - | 0.0051 | - |
| A4 | 0.270 | 0.320 | 0.370 | 0.0106 | 0.0126 | 0.0146 |
| b | 0.230 | 0.280 | 0.330 | 0.0091 | 0.0110 | 0.0130 |
| D | 6.950 | 7.000 | 7.050 | 0.2736 | 0.2756 | 0.2776 |
| D1 | 5.950 | 6.000 | 6.050 | 0.2343 | 0.2362 | 0.2382 |
| Е | 6.950 | 7.000 | 7.050 | 0.2736 | 0.2756 | 0.2776 |
| E1 | 5.950 | 6.000 | 6.050 | 0.2343 | 0.2362 | 0.2382 |
| е | - | 0.500 | - | - | 0.0197 | - |
| F | 0.450 | 0.500 | 0.550 | 0.0177 | 0.0197 | 0.0217 |

Table 124. UFBGA169 mechanical data (continued)

| Symbol | millimeters | | | | inches ⁽¹⁾ | |
|--------|-------------|------|-------|------|-----------------------|--------|
| Symbol | Min. | Тур. | Max. | Min. | Тур. | Max. |
| ddd | - | - | 0.100 | - | - | 0.0039 |
| eee | - | - | 0.150 | - | - | 0.0059 |
| fff | - | - | 0.050 | - | - | 0.0020 |

^{1.} Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 85. UFBGA169 recommended footprint

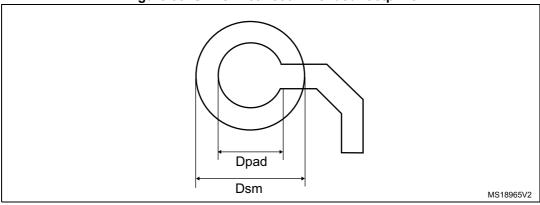


Table 125. UFBGA169 recommended PCB design rules (0.5 mm pitch BGA)

| Dimension | Recommended values |
|--------------|---|
| Pitch | 0.5 mm |
| Dpad | 0.27 mm |
| Dsm | 0.35 mm typ. (depends on the soldermask registration tolerance) |
| Solder paste | 0.27 mm aperture diameter. |

Note: Non-solder mask defined (NSMD) pads are recommended.

Note: 4 to 6 mils solder paste screen printing process.

Device marking for UFBGA169

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

The printed markings may differ depending on the supply chain.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

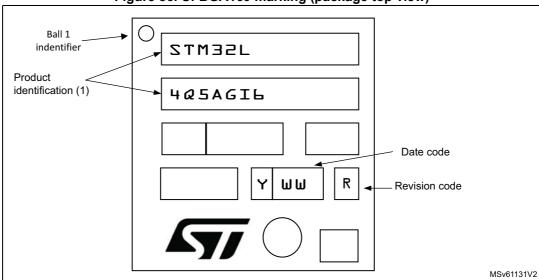


Figure 86. UFBGA169 marking (package top view)

1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

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7.9 Thermal characteristics

The maximum chip-junction temperature, T_J max, in degrees Celsius, may be calculated using the following equation:

$$T_J \max = T_A \max + (P_D \max x \Theta_{JA})$$

Where:

- T_A max is the maximum ambient temperature in °C,
- Θ_{JA} is the package junction-to-ambient thermal resistance, in °C/W,
- P_D max is the sum of P_{INT} max and $P_{I/O}$ max (P_D max = P_{INT} max + $P_{I/O}$ max),
- P_{INT} max is the product of I_{DD} and V_{DD}, expressed in Watts. This is the maximum chip internal power.

P_{I/O} max represents the maximum power dissipation on output pins where:

$$P_{I/O}$$
 max = Σ ($V_{OL} \times I_{OL}$) + Σ (($V_{DDIOx} - V_{OH}$) × I_{OH}),

taking into account the actual V_{OL} / I_{OL} and V_{OH} / I_{OH} of the I/Os at low and high level in the application.

Table 126. Package thermal characteristics

| Symbol | Parameter | Value | Unit |
|---------------|--|-------|------|
| | Thermal resistance junction-ambient UFQFPN48 - 7 × 7 mm | 24.8 | |
| | Thermal resistance junction-ambient LQFP48 - 7 × 7 mm | 50.7 | |
| | Thermal resistance junction-ambient LQFP64 - 7 × 7 mm | 49.2 | |
| Θ_{JA} | Thermal resistance junction-ambient LQFP100 - 14 × 14 mm | 47.8 | °C/W |
| JA | Thermal resistance junction-ambient WLCSP100 | 35.8 | C/VV |
| | Thermal resistance junction-ambient UFBGA132 - 7 × 7 mm | 34.2 | |
| | Thermal resistance junction-ambient LQFP144 - 20 × 20 mm | 46.3 | |
| | Thermal resistance junction-ambient UFBGA169 - 7 × 7 mm | 35.2 | |



Table 126. Package thermal characteristics (continued)

| Symbol | Parameter | Value | Unit |
|---------------|--|-------|--------|
| | Thermal resistance junction-ambient UFQFPN48 - 7 × 7 mm | 12.9 | |
| | Thermal resistance junction-ambient LQFP48 - 7 × 7 mm | 35.7 | |
| | Thermal resistance junction-ambient LQFP64 - 7 × 7 mm | 37.7 | |
| Θ_{JB} | Thermal resistance junction-ambient LQFP100 - 14 × 14 mm | 39.6 | °C/W |
| JB | Thermal resistance junction-ambient WLCSP100 | NA | - C/VV |
| | Thermal resistance junction-ambient UFBGA132 - 7 × 7 mm | 11.4 | |
| | Thermal resistance junction-ambient LQFP144 - 20 × 20 mm | 41.8 | |
| | Thermal resistance junction-ambient UFBGA169 - 7 × 7 mm | 13.4 | |
| | Thermal resistance junction-ambient UFQFPN48 - 7 × 7 mm | 1.3 | |
| | Thermal resistance junction-ambient LQFP48 - 7 × 7 mm | 13.4 | |
| | Thermal resistance junction-ambient LQFP64 - 7 × 7 mm | 13.2 | |
| 9 | Thermal resistance junction-ambient LQFP100 - 14 × 14 mm | 13 | °C/W |
| Θ_{JC} | Thermal resistance junction-ambient WLCSP100 | NA | C/vv |
| | Thermal resistance junction-ambient UFBGA132 - 7 × 7 mm | 34.7 | |
| | Thermal resistance junction-ambient LQFP144 - 20 × 20 mm | 12.8 | |
| | Thermal resistance junction-ambient UFBGA169 - 7 × 7 mm | 34.7 | |

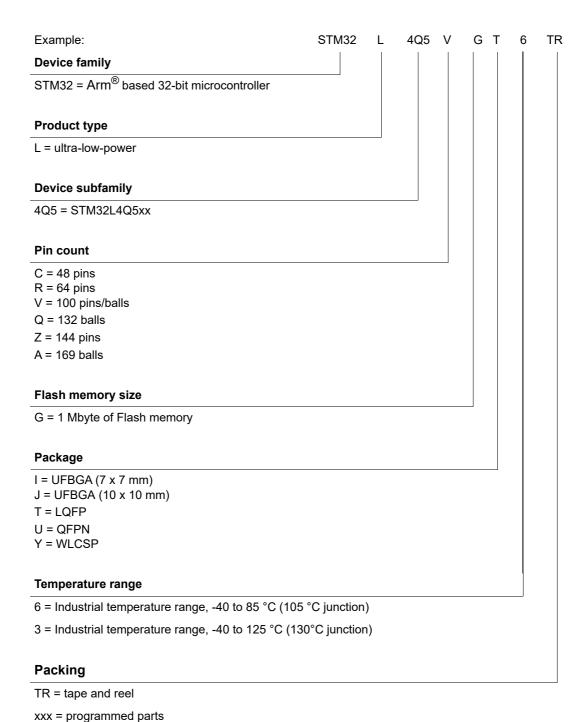
Reference document

JESD51-2 Integrated Circuits Thermal Test Method Environment Conditions - Natural Convection (Still Air). Available from www.jedec.org



Ordering information STM32L4Q5xx

8 Ordering information



For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.

STM32L4Q5xx Revision history

9 Revision history

Table 127. Document revision history

| Date | Revision | Changes |
|-------------|----------|------------------|
| 19-Dec-2019 | 1 | Initial release. |

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